



MSP432P401x Mixed-Signal Microcontrollers

1 Device Overview

1.1 Features

- Core
 - ARM® 32-Bit Cortex®-M4F CPU With Floating Point Unit and Memory Protection Unit
 - Frequency up to 48 MHz
 - Performance Benchmark:
 - 1.196 DMIPS/MHz (Dhrystone 2.1)
 - 3.41 CoreMark/MHz
 - Energy Benchmark:
 - 167.4 ULPBench® Score
- Memories
 - Up to 256KB of Flash Main Memory (Simultaneous Read and Execute During Program or Erase)
 - 16KB of Flash Information Memory
 - Up to 64KB of SRAM (Including 8KB of Backup Memory)
 - 32KB of ROM With MSPWare Driver Libraries
- Code Security Features
 - JTAG and SWD Lock
 - IP Protection (Up to Four Secure Flash Zones, Each With Configurable Start Address and Size)
- Operating Characteristics
 - Wide Supply Voltage Range: 1.62 V to 3.7 V
 - Temperature Range (Ambient): –40°C to 85°C
- Ultra-Low-Power Operating Modes
 - Active: 90 µA/MHz
 - Low-Frequency Active: 90 µA (at 128 kHz)
 - LPM3 (With RTC): 850 nA
 - LPM3.5 (With RTC): 800 nA
 - LPM4.5: 25 nA
- Flexible Clocking Features
 - Programmable Internal DCO (up to 48 MHz)
 - 32.768-kHz Low-Frequency Crystal Support (LFXT)
 - High-Frequency Crystal Support (HFXT) up to 48 MHz
 - Low-Frequency Trimmed Internal Reference Oscillator (REFO)
 - Very Low-Power Low-Frequency Internal Oscillator (VLO)
 - Module Oscillator (MODOSC)
 - System Oscillator (SYSOSC)
- Enhanced System Options
 - Programmable Supervision and Monitoring of Supply Voltage
 - Multiple-Class Resets for Better Control of Application and Debug
 - Eight-Channel DMA
 - Real-Time Clock (RTC) With Calendar and Alarm Functions
- Timing and Control
 - Up to Four 16-Bit Timers, Each With up to Five Capture, Compare, PWM Capability
 - Two 32-Bit Timers, Each With Interrupt Generation Capability
- Serial Communication
 - Up to Four eUSCI_A Modules
 - UART With Automatic Baud-Rate Detection
 - IrDA Encode and Decode
 - SPI (up to 16 Mbps)
 - Up to Four eUSCI_B Modules
 - I²C (With Multiple-Slave Addressing)
 - SPI (up to 16 Mbps)
- Flexible I/O Features
 - Ultra-Low-Leakage I/Os (±20 nA Maximum)
 - Up to Four High-Drive I/Os (20-mA Capability)
 - All I/Os With Capacitive Touch Capability
 - Up to 48 I/Os With Interrupt and Wake-up Capability
 - Up to 24 I/Os With Port Mapping Capability
 - Eight I/Os With Glitch Filtering Capability
- Advanced Low-Power Analog Features
 - 14-Bit, 1-MSPS SAR ADC
 - Internal Voltage Reference With 10-ppm/°C Typical Stability
 - Two Analog Comparators
- Encryption and Data Integrity Accelerators
 - 128-, 192-, or 256-Bit AES Encryption and Decryption Accelerator
 - 32-Bit Hardware CRC Engine
- JTAG and Debug Support
 - Support for 4-Pin JTAG and 2-Pin SWD Debug Interfaces
 - Support for Serial Wire Trace
 - Support for Power Debug and Profiling of Applications



1.2 Applications

- Industrial and Automation
 - Home Automation
 - Smoke Detectors
 - Barcode Scanners
- Metering
 - Electric Meters
 - Flow Meters
- Health and Fitness
 - Watches
 - Activity Monitors
 - Fitness Accessories
 - Blood Glucose Meters
- Consumer Electronics
 - Mobile Devices
 - Sensor Hubs

1.3 Description

The MSP432P401x device family is TI's latest addition to its portfolio of efficient ultra-low-power mixed-signal MCUs. The MSP432P401x family features the ARM Cortex-M4 processor in a wide configuration of device options including a rich set of analog, timing, and communication peripherals, thereby catering to a large number of application scenarios where both efficient data processing and enhanced low-power operation are paramount.

Overall, the MSP432P401x is an ideal combination of the TI MSP430™ low-power DNA, advance mixed-signal features, and the processing capabilities of the ARM 32-bit Cortex-M4 RISC engine. The devices ship with bundled driver libraries and are compatible with standardized components of the ARM ecosystem.

Device Information⁽¹⁾

| PART NUMBER | PACKAGE (PIN) | BODY SIZE ⁽²⁾ |
|------------------------------------|---------------|--------------------------|
| MSP432P401RIPZ MSP432P401MIPZ | LQFP (100) | 14 mm × 14 mm |
| MSP432P401RIZXH MSP432P401MIZXH | NFBGA (80) | 5 mm × 5 mm |
| MSP432P401RIRGC MSP432P401MIRGC | VQFN (64) | 9 mm × 9 mm |

(1) For the most current part, package, and ordering information for all available devices, see the *Package Option Addendum* in [Section 9](#), or see the TI website at www.ti.com.

(2) The sizes shown here are approximations. For the package dimensions with tolerances, see the *Mechanical Data* in [Section 9](#).

1.4 Functional Block Diagram

Figure 1-1 shows the functional block diagram of the MSP432P401x devices.

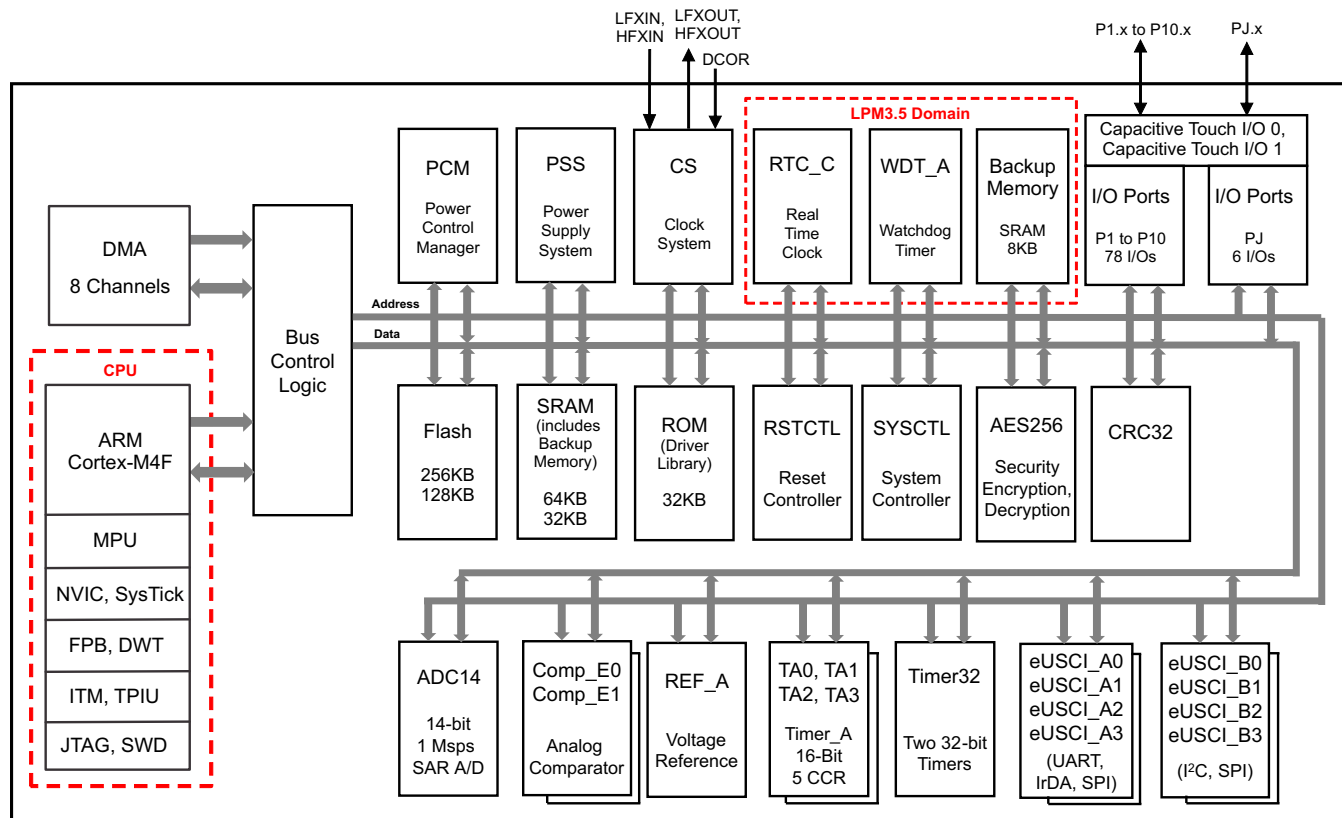


Figure 1-1. MSP432P401x Functional Block Diagram

The CPU and all the peripherals in the device interact with each other through a common AHB matrix. In some cases, there are bridges between the AHB ports and the peripherals. These bridges are transparent to the application from a memory map perspective and hence not shown in the block diagram.

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2 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| Changes from March 19, 2015 to March 30, 2015 | Page |
|--|-------------------|
| <ul style="list-style-type: none"> Changed "Energy Benchmark" score from 153.3 to 167.4 | 1 |

3 Device Comparison

Table 3-1 lists the features of the MSP432P401x devices.

Table 3-1. Device Comparison⁽¹⁾

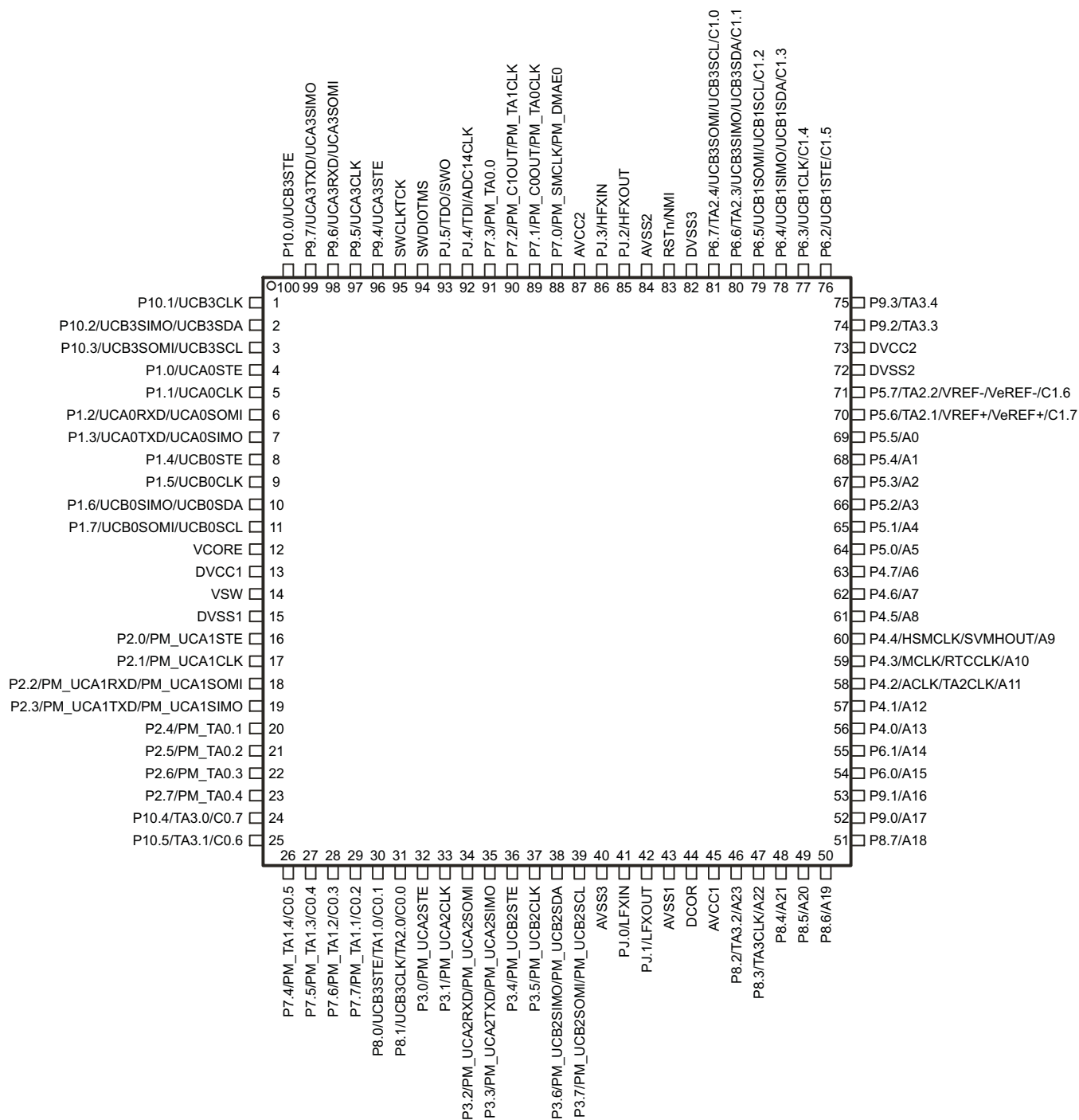
| DEVICE | FLASH (KB) | SRAM (KB) | ADC14 CHANNELS | Comparator-E0 CHANNELS | Comparator-E1 CHANNELS | Timer_A ⁽²⁾ | eUSCI | | 20-mA DRIVE I/O | TOTAL I/Os | PACKAGE TYPE |
|-----------------|---------------|--------------|-------------------|---------------------------|---------------------------|------------------------|-------------------------------------|--|--------------------|---------------|-----------------|
| | | | | | | | CHANNEL A: UART, IrDA, SPI | CHANNEL B: SPI, I ² C | | | |
| MSP432P401RIPZ | 256 | 64 | 24 ext, 2 int | 8 | 8 | 5, 5, 5, 5 | 4 | 4 | 4 | 84 | 100 PZ |
| MSP432P401MIPZ | 128 | 32 | 24 ext, 2 int | 8 | 8 | 5, 5, 5, 5 | 4 | 4 | 4 | 84 | 100 PZ |
| MSP432P401RIZXH | 256 | 64 | 16 ext, 2 int | 6 | 8 | 5, 5, 5 | 3 | 4 | 4 | 64 | 80 ZXH |
| MSP432P401MIZXH | 128 | 32 | 16 ext, 2 int | 6 | 8 | 5, 5, 5 | 3 | 4 | 4 | 64 | 80 ZXH |
| MSP432P401RIRGC | 256 | 64 | 12 ext, 2 int | 2 | 4 | 5, 5, 5 | 3 | 3 | 4 | 48 | 64 RGC |
| MSP432P401MIRGC | 128 | 32 | 12 ext, 2 int | 2 | 4 | 5, 5, 5 | 3 | 3 | 4 | 48 | 64 RGC |

- (1) For the most current part, package, and ordering information for all available devices, see the *Package Option Addendum* in Section 9, or see the TI website at www.ti.com.
- (2) Each number in the sequence represents an instantiation of Timer_A with its associated number of capture compare registers and PWM output generators available. For example, a number sequence of 3, 5 would represent two instantiations of Timer_A, the first instantiation having 3 and the second instantiation having 5 capture compare registers and PWM output generators, respectively.

4 Terminal Configuration and Functions

4.1 Pin Diagrams

[Figure 4-1](#) shows the pinout of the 100-pin PZ package.

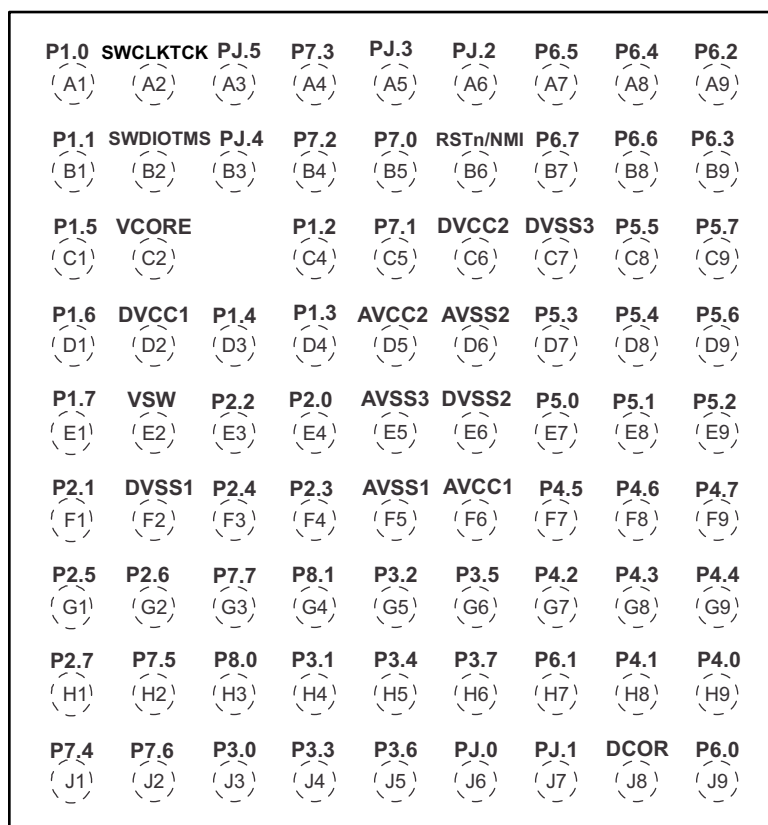


Notes:

1. The secondary digital functions on Ports P2, P3, and P7 are fully mappable. The pin designation shows only the default mapping. See [Table 6-19](#) for details.
2. Glitch filter is implemented on the following 8 digital I/Os: P1.0, P1.4, P1.5, P3.0, P3.4, P3.5, P6.6, P6.7.
3. UART BSL pins: P1.2 - BSLRXD, P1.3 - BSLTXD
4. SPI BSL pins: P1.4 - BSLSTE, P1.5 - BSLCLK, P1.6 - BSLSIMO, P1.7 - BSLSOMI
5. I²C BSL pins: P3.6 - BSLSDA, P3.7 - BSLSCL

Figure 4-1. 100-Pin PZ Package (Top View)

Figure 4-2 shows the pinout of the 80-pin ZXH package.

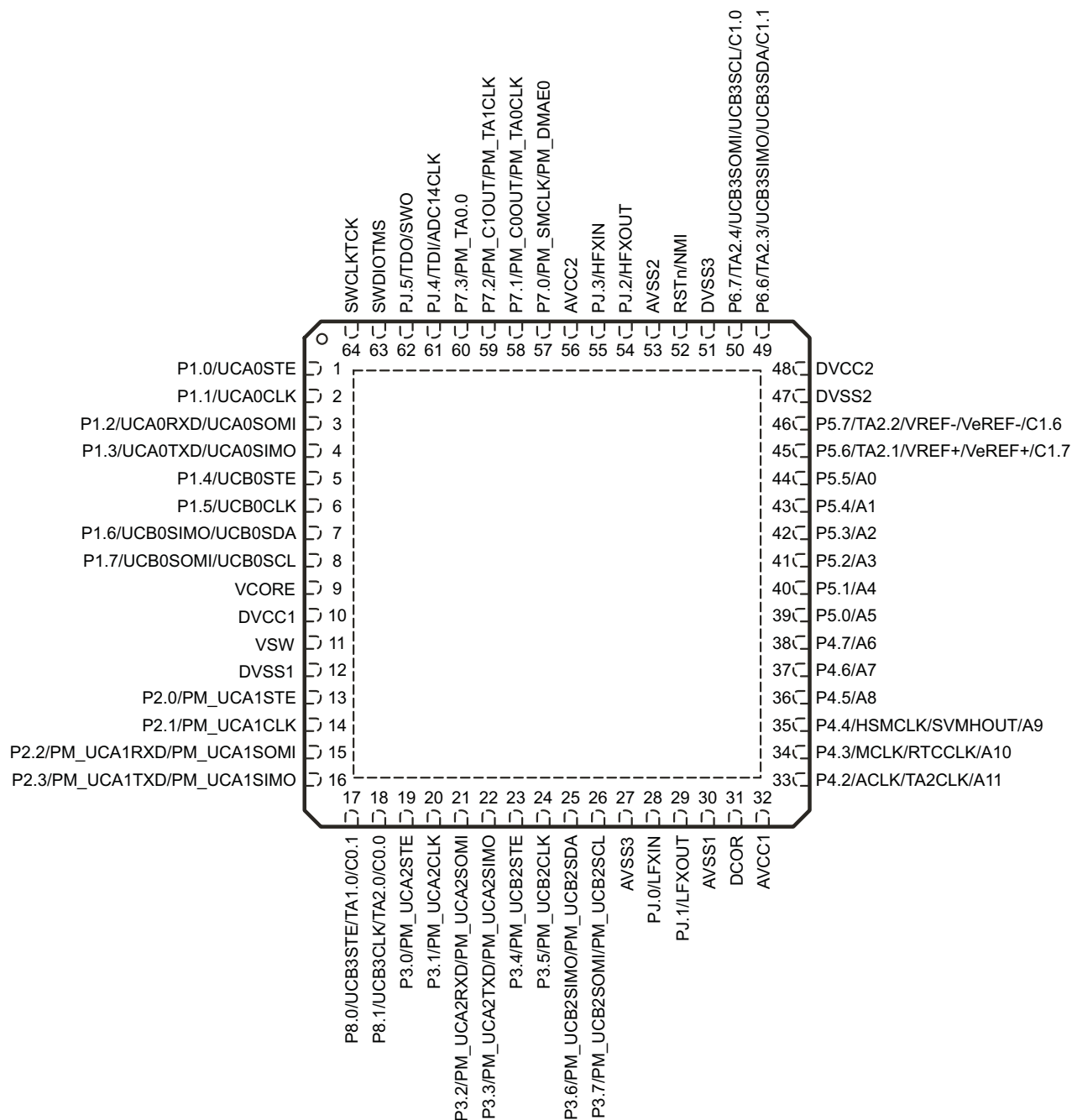


Notes:

1. Glitch filter is implemented on the following 8 digital I/Os: P1.0, P1.4, P1.5, P3.0, P3.4, P3.5, P6.6, P6.7.
2. UART BSL pins: P1.2 - BSLRXD, P1.3 - BSLTXD
3. SPI BSL pins: P1.4 - BSLSTE, P1.5 - BSLCLK, P1.6 - BSLSIMO, P1.7 - BSLSOMI
4. I²C BSL pins: P3.6 - BSLSDA, P3.7 - BSLSCL

Figure 4-2. 80-Pin ZXH Package (Top View)

Figure 4-3 shows the pinout of the 64-pin RGC package.



Notes:

1. The secondary digital functions on Ports P2, P3, and P7 are fully mappable. The pin designation shows only the default mapping. See [Table 6-19](#) for details.
2. Glitch filter is implemented on the following 8 digital I/Os: P1.0, P1.4, P1.5, P3.0, P3.4, P3.5, P6.6, P6.7. TI recommends connecting the thermal pad on the QFN package to DVSS.
4. UART BSL pins: P1.2 - BSLRXD, P1.3 - BSLTXD
5. SPI BSL pins: P1.4 - BSLSTE, P1.5 - BSLCLK, P1.6 - BLSIMO, P1.7 - BLSOMI
6. I²C BSL pins: P3.6 - BLSLSDA, P3.7 - BLSLSC

Figure 4-3. 64-Pin RGC Package (Top View)

PRODUCT PREVIEW

4.2 Signal Descriptions

Table 4-1 describes the signals for all device variants and package options.

Table 4-1. Signal Descriptions

| TERMINAL | | | | I/O ⁽¹⁾ | DESCRIPTION |
|-------------------------------------|--------------------|-----|-----|--------------------|--|
| NAME | NO. ⁽²⁾ | | | | |
| | PZ | ZXH | RGC | | |
| P10.1/ UCB3CLK | 1 | N/A | N/A | I/O | General-purpose digital I/O Clock signal input – eUSCI_B3 SPI slave mode Clock signal output – eUSCI_B3 SPI master mode |
| P10.2/ UCB3SIMO/UCB3SDA | 2 | N/A | N/A | I/O | General-purpose digital I/O Slave in, master out – eUSCI_B3 SPI mode I ² C data – eUSCI_B3 I ² C mode |
| P10.3/ UCB3SOMI/UCB3SCL | 3 | N/A | N/A | I/O | General-purpose digital I/O Slave out, master in – eUSCI_B3 SPI mode I ² C clock – eUSCI_B3 I ² C mode |
| P1.0/ UCA0STE | 4 | A1 | 1 | I/O | General-purpose digital I/O with port interrupt, wake-up and glitch filtering capability Slave transmit enable – eUSCI_A0 SPI mode |
| P1.1/ UCA0CLK | 5 | B1 | 2 | I/O | General-purpose digital I/O with port interrupt and wake-up capability Clock signal input – eUSCI_A0 SPI slave mode Clock signal output – eUSCI_Ao0 SPI master mode |
| P1.2/ UCA0RXD/UCA0SOMI | 6 | C4 | 3 | I/O | General-purpose digital I/O with port interrupt and wake-up capability Receive data – eUSCI_A0 UART mode Slave out, master in – eUSCI_A0 SPI mode |
| P1.3/ UCA0TXD/UCA0SIMO | 7 | D4 | 4 | I/O | General-purpose digital I/O with port interrupt and wake-up capability Transmit data – eUSCI_A0 UART mode Slave in, master out – eUSCI_A0 SPI mode |
| P1.4/ UCB0STE | 8 | D3 | 5 | I/O | General-purpose digital I/O with port interrupt, wake-up and glitch filtering capability Slave transmit enable – eUSCI_B0 SPI mode |
| P1.5/ UCB0CLK | 9 | C1 | 6 | I/O | General-purpose digital I/O with port interrupt, wake-up and glitch filtering capability Clock signal input – eUSCI_B0 SPI slave mode Clock signal output – eUSCI_B0 SPI master mode |
| P1.6/ UCB0SIMO/UCB0SDA | 10 | D1 | 7 | I/O | General-purpose digital I/O with port interrupt and wake-up capability Slave in, master out – eUSCI_B0 SPI mode I ² C data – eUSCI_B0 I ² C mode |
| P1.7/ UCB0SOMI/UCB0SCL | 11 | E1 | 8 | I/O | General-purpose digital I/O with port interrupt and wake-up capability Slave out, master in – eUSCI_B0 SPI mode I ² C clock – eUSCI_B0 I ² C mode |
| VCORE ⁽³⁾ | 12 | C2 | 9 | | Regulated core power supply (internal use only, no external current loading) |
| DVCC1 | 13 | D2 | 10 | | Digital power supply |
| VSW | 14 | E2 | 11 | | DC-to-DC converter switching output. |
| DVSS1 | 15 | F2 | 12 | | Digital ground supply |
| P2.0/ PM_UCA1STE | 16 | E4 | 13 | I/O | General-purpose digital I/O with port interrupt and wake-up capability Slave transmit enable – eUSCI_A1 SPI mode |
| P2.1/ PM_UCA1CLK | 17 | F1 | 14 | I/O | General-purpose digital I/O with port interrupt and wake-up capability Clock signal input – eUSCI_A1 SPI slave mode Clock signal output – eUSCI_A1 SPI master mode |
| P2.2/ PM_UCA1RXD/ PM_UCA1SOMI | 18 | E3 | 15 | I/O | General-purpose digital I/O with port interrupt and wake-up capability Receive data – eUSCI_A1 UART mode Slave out, master in – eUSCI_A1 SPI mode |

(1) I = input, O = output

(2) N/A = not available

(3) VCore is for internal use only. No external current loading is possible. VCore should only be connected to the recommended capacitor value, C_{VCore}.

Table 4-1. Signal Descriptions (continued)

| TERMINAL | | | | I/O ⁽¹⁾ | DESCRIPTION |
|-------------------------------------|--------------------|-----|-----|--------------------|--|
| NAME | NO. ⁽²⁾ | | | | |
| | PZ | ZXH | RGC | | |
| P2.3/ PM_UCA1TXD/ PM_UCA1SIMO | 19 | F4 | 16 | I/O | General-purpose digital I/O with port interrupt and wake-up capability Transmit data – eUSCI_A1 UART mode Slave in, master out – eUSCI_A1 SPI mode |
| P2.4/ PM_TA0.1 | 20 | F3 | N/A | I/O | General-purpose digital I/O with port interrupt and wake-up capability TA0 CCR1 capture: CCI1A input, compare: Out1 |
| P2.5/ PM_TA0.2 | 21 | G1 | N/A | I/O | General-purpose digital I/O with port interrupt and wake-up capability TA0 CCR2 capture: CCI2A input, compare: Out2 |
| P2.6/ PM_TA0.3 | 22 | G2 | N/A | I/O | General-purpose digital I/O with port interrupt and wake-up capability TA0 CCR3 capture: CCI3A input, compare: Out3 |
| P2.7/ PM_TA0.4 | 23 | H1 | N/A | I/O | General-purpose digital I/O with port interrupt and wake-up capability TA0 CCR4 capture: CCI4A input, compare: Out4 |
| P10.4/ TA3.0/ C0.7 | 24 | N/A | N/A | I/O | General-purpose digital I/O TA3 CCR0 capture: CCI0A input, compare: Out0 Comparator_E0 input 7 |
| P10.5/ TA3.1/ C0.6 | 25 | N/A | N/A | I/O | General-purpose digital I/O TA3 CCR1 capture: CCI1A input, compare: Out1 Comparator_E0 input 6 |
| P7.4/ PM_TA1.4/ C0.5 | 26 | J1 | N/A | I/O | General-purpose digital I/O TA1 CCR4 capture: CCI4A input, compare: Out4 Comparator_E0 input 5 |
| P7.5/ PM_TA1.3/ C0.4 | 27 | H2 | N/A | I/O | General-purpose digital I/O TA1 CCR3 capture: CCI3A input, compare: Out3 Comparator_E0 input 4 |
| P7.6/ PM_TA1.2/ C0.3 | 28 | J2 | N/A | I/O | General-purpose digital I/O TA1 CCR2 capture: CCI2A input, compare: Out2 Comparator_E0 input 3 |
| P7.7/ PM_TA1.1/ C0.2 | 29 | G3 | N/A | I/O | General-purpose digital I/O TA1 CCR1 capture: CCI1A input, compare: Out1 Comparator_E0 input 2 |
| P8.0/ UCB3STE/ TA1.0/ C0.1 | 30 | H3 | 17 | I/O | General-purpose digital I/O Slave transmit enable – eUSCI_B3 SPI mode TA1 CCR0 capture: CCI0A input, compare: Out0 Comparator_E0 input 1 |
| P8.1/ UCB3CLK/ TA2.0/ C0.0 | 31 | G4 | 18 | I/O | General-purpose digital I/O Clock signal input – eUSCI_B3 SPI slave mode Clock signal output – eUSCI_B3 SPI master mode TA2 CCR0 capture: CCI0A input, compare: Out0 Comparator_E0 input 0 |
| P3.0/ PM_UCA2STE | 32 | J3 | 19 | I/O | General-purpose digital I/O with port interrupt, wake-up and glitch filtering capability Slave transmit enable – eUSCI_A2 SPI mode |
| P3.1/ PM_UCA2CLK | 33 | H4 | 20 | I/O | General-purpose digital I/O with port interrupt and wake-up capability Clock signal input – eUSCI_A2 SPI slave mode Clock signal output – eUSCI_A2 SPI master mode |
| P3.2/ PM_UCA2RXD/ PM_UCA2SOMI | 34 | G5 | 21 | I/O | General-purpose digital I/O with port interrupt and wake-up capability Receive data – eUSCI_A2 UART mode Slave out, master in – eUSCI_A2 SPI mode |
| P3.3/ PM_UCA2TXD/ PM_UCA2SIMO | 35 | J4 | 22 | I/O | General-purpose digital I/O with port interrupt and wake-up capability Transmit data – eUSCI_A2 UART mode Slave in, master out – eUSCI_A2 SPI mode |
| P3.4/ PM_UCB2STE | 36 | H5 | 23 | I/O | General-purpose digital I/O with port interrupt, wake-up and glitch filtering capability Slave transmit enable – eUSCI_B2 SPI mode |
| P3.5/ PM_UCB2CLK | 37 | G6 | 24 | I/O | General-purpose digital I/O with port interrupt, wake-up and glitch filtering capability Clock signal input – eUSCI_B2 SPI slave mode Clock signal output – eUSCI_B2 SPI master mode |

Table 4-1. Signal Descriptions (continued)

| TERMINAL | | | | I/O ⁽¹⁾ | DESCRIPTION |
|-------------------------------------|--------------------|-----|-----|--------------------|---|
| NAME | NO. ⁽²⁾ | | | | |
| | PZ | ZXH | RGC | | |
| P3.6/ PM_UCB2SIMO/ PM_UCB2SDA | 38 | J5 | 25 | I/O | General-purpose digital I/O with port interrupt and wake-up capability Slave in, master out – eUSCI_B2 SPI mode I ² C data – eUSCI_B2 I ² C mode |
| P3.7/ PM_UCB2SOMI/ PM_UCB2SCL | 39 | H6 | 26 | I/O | General-purpose digital I/O with port interrupt and wake-up capability Slave out, master in – eUSCI_B2 SPI mode I ² C clock – eUSCI_B2 I ² C mode |
| AVSS3 | 40 | E5 | 27 | | Analog ground supply |
| PJ.0/ LFXIN | 41 | J6 | 28 | I/O | General-purpose digital I/O Input for low-frequency crystal oscillator LFXT |
| PJ.1/ LFXOUT | 42 | J7 | 29 | I/O | General-purpose digital I/O Output of low-frequency crystal oscillator LFXT |
| AVSS1 | 43 | F5 | 30 | | Analog ground supply |
| DCOR | 44 | J8 | 31 | | DCO external resistor pin |
| AVCC1 | 45 | F6 | 32 | | Analog power supply |
| P8.2/ TA3.2/ A23 | 46 | N/A | N/A | I/O | General-purpose digital I/O TA3 CCR2 capture: CCI2A input, compare: Out2 ADC analog input A23 |
| P8.3/ TA3CLK/ A22 | 47 | N/A | N/A | I/O | General-purpose digital I/O TA3 input clock ADC analog input A22 |
| P8.4/ A21 | 48 | N/A | N/A | I/O | General-purpose digital I/O ADC analog input A21 |
| P8.5/ A20 | 49 | N/A | N/A | I/O | General-purpose digital I/O ADC analog input A20 |
| P8.6/ A19 | 50 | N/A | N/A | I/O | General-purpose digital I/O ADC analog input A19 |
| P8.7/ A18 | 51 | N/A | N/A | I/O | General-purpose digital I/O ADC analog input A18 |
| P9.0/ A17 | 52 | N/A | N/A | I/O | General-purpose digital I/O ADC analog input A17 |
| P9.1/ A16 | 53 | N/A | N/A | I/O | General-purpose digital I/O ADC analog input A16 |
| P6.0/ A15 | 54 | J9 | N/A | I/O | General-purpose digital I/O with port interrupt and wake-up capability. ADC analog input A15 |
| P6.1/ A14 | 55 | H7 | N/A | I/O | General-purpose digital I/O with port interrupt and wake-up capability. ADC analog input A14 |
| P4.0/ A13 | 56 | H9 | N/A | I/O | General-purpose digital I/O with port interrupt and wake-up capability. ADC analog input A13 |
| P4.1/ A12 | 57 | H8 | N/A | I/O | General-purpose digital I/O with port interrupt and wake-up capability. ADC analog input A12 |
| P4.2/ ACLK/ TA2CLK/ A11 | 58 | G7 | 33 | I/O | General-purpose digital I/O with port interrupt and wake-up capability. ACLK clock output TA2 input clock ADC analog input A11 |
| P4.3/ MCLK/ RTCCLK/ A10 | 59 | G8 | 34 | I/O | General-purpose digital I/O with port interrupt and wake-up capability. MCLK clock output RTC_C clock calibration output ADC analog input A10 |
| P4.4/ HSMCLK/ SVMHOUT/ A9 | 60 | G9 | 35 | I/O | General-purpose digital I/O with port interrupt and wake-up capability HSMCLK clock output SVMH output ADC analog input A9 |
| P4.5/ A8 | 61 | F7 | 36 | I/O | General-purpose digital I/O with port interrupt and wake-up capability ADC analog input A8 |

Table 4-1. Signal Descriptions (continued)

| TERMINAL | | | | I/O ⁽¹⁾ | DESCRIPTION |
|--|--------------------|-----|-----|--------------------|---|
| NAME | NO. ⁽²⁾ | | | | |
| | PZ | ZXH | RGC | | |
| P4.6/ A7 | 62 | F8 | 37 | I/O | General-purpose digital I/O with port interrupt and wake-up capability ADC analog input A7 |
| P4.7/ A6 | 63 | F9 | 38 | I/O | General-purpose digital I/O with port interrupt and wake-up capability ADC analog input A6 |
| P5.0/ A5 | 64 | E7 | 39 | I/O | General-purpose digital I/O with port interrupt and wake-up capability ADC analog input A5 |
| P5.1/ A4 | 65 | E8 | 40 | I/O | General-purpose digital I/O with port interrupt and wake-up capability ADC analog input A4 |
| P5.2/ A3 | 66 | E9 | 41 | I/O | General-purpose digital I/O with port interrupt and wake-up capability ADC analog input A3 |
| P5.3/ A2 | 67 | D7 | 42 | I/O | General-purpose digital I/O with port interrupt and wake-up capability ADC analog input A2 |
| P5.4/ A1 | 68 | D8 | 43 | I/O | General-purpose digital I/O with port interrupt and wake-up capability ADC analog input A1 |
| P5.5/ A0 | 69 | C8 | 44 | I/O | General-purpose digital I/O with port interrupt and wake-up capability ADC analog input A0 |
| P5.6/ TA2.1/ VREF+/ VeREF+/ C1.7 | 70 | D9 | 45 | I/O | General-purpose digital I/O with port interrupt and wake-up capability TA2 CCR1 capture: CCI1A input, compare: Out1 Internal shared reference voltage positive terminal Positive terminal of external reference voltage to ADC Comparator_E1 input 7 |
| P5.7/ TA2.2/ VREF-/ VeREF-/ C1.6 | 71 | C9 | 46 | I/O | General-purpose digital I/O with port interrupt and wake-up capability TA2 CCR2 capture: CCI2A input, compare: Out2 Internal shared reference voltage negative terminal Negative terminal of external reference voltage to ADC (recommended to connect to onboard ground) Comparator_E1 input 6 |
| DVSS2 | 72 | E6 | 47 | | Digital ground supply |
| DVCC2 | 73 | C6 | 48 | | Digital power supply |
| P9.2/ TA3.3 | 74 | N/A | N/A | I/O | General-purpose digital I/O TA3 CCR3 capture: CCI3A input, compare: Out3 |
| P9.3/ TA3.4 | 75 | N/A | N/A | I/O | General-purpose digital I/O TA3 CCR4 capture: CCI4A input, compare: Out4 |
| P6.2/ UCB1STE/ C1.5 | 76 | A9 | N/A | I/O | General-purpose digital I/O with port interrupt and wake-up capability Slave transmit enable – eUSCI_B1 SPI mode Comparator_E1 input 5 |
| P6.3/ UCB1CLK/ C1.4 | 77 | B9 | N/A | I/O | General-purpose digital I/O with port interrupt and wake-up capability Clock signal input – eUSCI_B1 SPI slave mode Clock signal output – eUSCI_B1 SPI master mode Comparator_E1 input 4 |
| P6.4/ UCB1SIMO/UCB1SDA/ C1.3 | 78 | A8 | N/A | I/O | General-purpose digital I/O with port interrupt and wake-up capability Slave in, master out – eUSCI_B1 SPI mode I ² C data – eUSCI_B1 I ² C mode Comparator_E1 input 3 |
| P6.5/ UCB1SOMI/UCB1SCL/ C1.2 | 79 | A7 | N/A | I/O | General-purpose digital I/O with port interrupt and wake-up capability Slave out, master in – eUSCI_B1 SPI mode I ² C clock – eUSCI_B1 I ² C mode Comparator_E1 input 2 |
| P6.6/ TA2.3/ UCB3SIMO/UCB3SDA/ C1.1 | 80 | B8 | 49 | I/O | General-purpose digital I/O with port interrupt, wake-up and glitch filtering capability TA2 CCR3 capture: CCI3A input, compare: Out3 Slave in, master out – eUSCI_B3 SPI mode I ² C data – eUSCI_B3 I ² C mode Comparator_E1 input 1 |

Table 4-1. Signal Descriptions (continued)

| TERMINAL | | | | I/O ⁽¹⁾ | DESCRIPTION |
|--|--------------------|-----|-----|--------------------|--|
| NAME | NO. ⁽²⁾ | | | | |
| | PZ | ZXH | RGC | | |
| P6.7/ TA2.4/ UCB3SOMI/UCB3SCL/ C1.0 | 81 | B7 | 50 | I/O | General-purpose digital I/O with port interrupt, wake-up and glitch filtering capability TA2 CCR4 capture: CCI4A input, compare: Out4 Slave out, master in – eUSCI_B3 SPI mode I ² C clock – eUSCI_B3 I ² C mode Comparator_E1 input 0 |
| DVSS3 | 82 | C7 | 51 | | Digital ground supply |
| RSTn/ NMI | 83 | B6 | 52 | I | External reset (active low) External nonmaskable interrupt |
| AVSS2 | 84 | D6 | 53 | | Analog ground supply |
| PJ.2/ HFXOUT | 85 | A6 | 54 | I/O | General-purpose digital I/O Output for high-frequency crystal oscillator HFXT |
| PJ.3/ HFXIN | 86 | A5 | 55 | I/O | General-purpose digital I/O Input for high-frequency crystal oscillator HFXT |
| AVCC2 | 87 | D5 | 56 | | Analog power supply |
| P7.0/ PM_SMCLK/ PM_DMAE0 | 88 | B5 | 57 | I/O | General-purpose digital I/O SMCLK clock output DMA external trigger input |
| P7.1/ PM_C0OUT/ PM_TA0CLK | 89 | C5 | 58 | I/O | General-purpose digital I/O Comparator_E0 output TA0 input clock |
| P7.2/ PM_C1OUT/ PM_TA1CLK | 90 | B4 | 59 | I/O | General-purpose digital I/O Comparator_E1 output TA1 input clock |
| P7.3/ PM_TA0.0 | 91 | A4 | 60 | I/O | General-purpose digital I/O TA0 CCR0 capture: CCI0A input, compare: Out0 |
| PJ.4/ TDI/ ADC14CLK | 92 | B3 | 61 | I/O | General-purpose digital I/O JTAG test data input ADC14 clock output |
| PJ.5/ TDO/ SWO | 93 | A3 | 62 | I/O | General-purpose digital I/O JTAG test data output Serial wire trace output |
| SWDIOTMS | 94 | B2 | 63 | I/O | Serial wire data input/output (SWDIO)/JTAG test mode select (TMS) |
| SWCLKTCK | 95 | A2 | 64 | I | Serial wire clock input (SWCLK)/JTAG clock input (TCK) |
| P9.4/ UCA3STE | 96 | N/A | N/A | I/O | General-purpose digital I/O Slave transmit enable – eUSCI_A3 SPI mode |
| P9.5/ UCA3CLK | 97 | N/A | N/A | I/O | General-purpose digital I/O Clock signal input – eUSCI_A3 SPI slave mode Clock signal output – eUSCI_A3 SPI master mode |
| P9.6/ UCA3RXD/UCA3SOMI | 98 | N/A | N/A | I/O | General-purpose digital I/O Receive data – eUSCI_A3 UART mode Slave out, master in – eUSCI_A3 SPI mode |
| P9.7/ UCA3TXD/UCA3SIMO | 99 | N/A | N/A | I/O | General-purpose digital I/O Transmit data – eUSCI_A3 UART mode Slave in, master out – eUSCI_A3 SPI mode |
| P10.0/ UCB3STE | 100 | N/A | N/A | I/O | General-purpose digital I/O Slave transmit enable – eUSCI_B3 SPI mode |
| QFN Pad | N/A | N/A | Pad | | QFN package exposed thermal pad. Connection to VSS is recommended. |

5 Specifications

5.1 Absolute Maximum Ratings ⁽¹⁾

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| | MIN | MAX | UNIT |
|--|------|---|------|
| Voltage applied at DVCC and AVCC pins to V _{SS} | −0.3 | 4.17 | V |
| Voltage difference between DVCC and AVCC pins ⁽²⁾ | | ±0.3 | V |
| Voltage applied to any pin ⁽³⁾ | −0.3 | V _{CC} + 0.3 V (4.17 V MAX) | V |
| Diode current at any device pin | | ±2 | mA |
| Storage temperature, T _{stg} ⁽⁴⁾ | −40 | 125 | °C |
| Maximum junction temperature, T _J | | 95 | °C |

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) Voltage differences between DVCC and AVCC exceeding the specified limits may cause malfunction of the device.
- (3) All voltages referenced to V_{SS}.
- (4) Higher temperature may be applied during board soldering according to the current JEDEC J-STD-020 specification with peak reflow temperatures not higher than classified on the device label on the shipping boxes or reels.

5.2 ESD Ratings

| | | VALUE | UNIT |
|--|--|-------|------|
| V _(ESD) Electrostatic discharge | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾ | ±1000 | V |
| | Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾ | ±250 | |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process. Pins listed as ±1000 V may actually have higher performance.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process. Pins listed as ±250 V may actually have higher performance.

5.3 Recommended Operating Conditions

TYP data are based on V_{CC} = 3.0 V, T_A = 25°C (unless otherwise noted)

| | | MIN | NOM | MAX | UNIT |
|---------------------|---|--|------|-----|------|
| V _{CC} | Supply voltage range at all DVCC and AVCC pins ^{(1) (2) (3)} | At power-up (with internal V _{CC} supervision) | 1.65 | 3.7 | V |
| | | Normal operation, Flash not active (with internal V _{CC} supervision) | 1.62 | 3.7 | |
| | | Normal operation, Flash active (with internal V _{CC} supervision) | 1.71 | 3.7 | |
| | | Normal operation, Flash active (without internal V _{CC} supervision) | 1.62 | 3.7 | |
| V _{SS} | Supply voltage on all DVSS and AVSS pins | | 0 | | V |
| I _{INRUSH} | Inrush current into the V _{CC} pins ⁽⁴⁾ | | | 100 | mA |
| f _{MCLK} | Frequency of the CPU and AHB clock in the system ⁽⁵⁾ | 0 | | 48 | MHz |
| T _A | Operating free-air temperature | −40 | | 85 | °C |
| T _J | Operating junction temperature | −40 | | 95 | °C |

- (1) TI recommends powering AV_{CC} and DV_{CC} from the same source. A maximum difference of ±0.1 V between AV_{CC} and DV_{CC} can be tolerated during power up and operation. Refer to section [Section 5.4](#) for decoupling capacitor recommendations.
- (2) Supply voltage must not change faster than TBD. Faster changes can cause the VCCDET to trigger a reset even within the recommended supply voltage range.
- (3) Modules may have a different supply voltage range specification. See the specification of the respective module in this data sheet.
- (4) Does not include I/O currents (driven by application requirements)
- (5) Operating frequency may require the flash to be accessed with wait states. Refer to [Section 5.8](#) for further details

5.4 Recommended External Components^{(1) (2) (3)}

| | | | MIN | TYP | MAX | UNIT |
|----------------------------------|---|---|------|-----|------|------|
| C _{DVCC} | Capacitor on DVCC pin | For DC-DC operation ⁽⁴⁾ | 3.3 | 4.7 | | μF |
| | | For LDO-only operation | 3.3 | 4.7 | | |
| C _{VCORE} | Capacitor on V _{CORE} pin | For DC-DC operation, including capacitor tolerance | 1.54 | 4.7 | 9 | μF |
| | | For LDO-only operation, including capacitor tolerance | 70 | 100 | 9000 | nF |
| C _{AVCC} | Capacitor on AVCC pin | | 3.3 | 4.7 | | μF |
| L _{VSW} | Inductor between V _{SW} and V _{CORE} pins for DC-DC | | 3.3 | 4.7 | 13 | μH |
| R _{L_{VSW}-DCR} | Allowed DCR for L _{VSW} | | | 150 | 350 | mΩ |
| I _{SAT-L_{VSW}} | L _{VSW} saturation current | | 700 | | | mA |

- (1) For optimum performance, select the component value to match the typical value given in the table.
(2) Refer to the section on board guidelines for further details on component selection, placement as well as related PCB design guidelines.
(3) Tolerance of the capacitance/inductance values should be taken into account when choosing a component, in order to ensure that the Min/Max ranges are never exceeded
(4) C_{DVCC} should not be smaller than C_{VCORE}

5.5 Operating Mode V_{CC} Ranges

over operating free-air temperature (unless otherwise noted)

| PARAMETER | OPERATING MODE | TEST CONDITIONS | MIN | MAX | UNIT |
|-----------------------------|--|---|------|-----|------|
| V _{CC_LDO_VCORE0} | AM_LDO_VCORE0 ⁽¹⁾⁽²⁾ AM_LF_VCORE0 LPM0_LDO_VCORE0 LPM0_LF_VCORE0 LPM3_VCORE0 LPM4_VCORE0 LPM3.5 | LDO active, SVSMH enabled, Flash not active | 1.62 | 3.7 | V |
| | | LDO active, SVSMH enabled, Flash active | 1.71 | 3.7 | |
| | | LDO active, SVSMH disabled, Flash active | 1.62 | 3.7 | |
| V _{CC_LDO_VCORE1} | AM_LDO_VCORE1 ⁽¹⁾⁽²⁾ AM_LF_VCORE1 LPM0_LDO_VCORE1 LPM0_LF_VCORE1 LPM3_VCORE1 LPM4_VCORE1 | LDO active, SVSMH enabled, Flash active | 1.71 | 3.7 | V |
| | | LDO active, SVSMH disabled, Flash active | 1.62 | 3.7 | |
| V _{CC_DCDC_VCORE0} | AM_DCDC_VCORE0 ⁽³⁾⁽⁴⁾ LPM0_DCDC_VCORE0 | DC-DC active, SVSMH enabled or disabled | 2.18 | 3.7 | V |
| V _{CC_DCDC_VCORE1} | AM_DCDC_VCORE1 ⁽³⁾⁽⁴⁾ LPM0_DCDC_VCORE1 | DC-DC active, SVSMH enabled or disabled | 2.18 | 3.7 | V |
| V _{CC_VCORE_OFF} | LPM4.5 ⁽⁵⁾ | LDO disabled, SVSMH enabled or disabled | 1.62 | 3.7 | V |

- (1) LPM0 mode associated with each active mode will have a similar V_{CC} range restriction.
(2) Flash remains active **only** in active modes and LPM0 modes.
(3) Low frequency active, Low frequency LPM0, LPM3, LPM4, and LPM3.5 modes are based on LDO **only**.
(4) When V_{CC} falls below the specified Min value, the DC-DC operation will switch to LDO automatically, as long as the V_{CC} drop is slower than the rate that is reliably detected. Refer to <ref> for more details.
(5) Core voltage is switched off in LPM4.5 mode.

5.6 Operating Mode CPU Frequency Ranges⁽¹⁾

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | OPERATING MODE | DESCRIPTION | f_{MCLK} | | UNIT |
|------------------------|----------------|---|------------|-----|------|
| | | | MIN | MAX | |
| $f_{AM_LDO_VCORE0}$ | AM_LDO_VCORE0 | Medium-performance mode with LDO as the active regulator | 0 | 24 | MHz |
| $f_{AM_LDO_VCORE1}$ | AM_LDO_VCORE1 | High-performance mode with LDO as the active regulator | 0 | 48 | MHz |
| $f_{AM_DCDC_VCORE0}$ | AM_DCDC_VCORE0 | Medium-performance mode with DC-DC as the active regulator | 0 | 24 | MHz |
| $f_{AM_DCDC_VCORE1}$ | AM_DCDC_VCORE1 | High-performance mode with DC-DC as the active regulator | 0 | 48 | MHz |
| $f_{AM_LF_VCORE0}$ | AM_LF_VCORE0 | Low-frequency low-leakage mode with LDO as the active regulator | 0 | 128 | kHz |
| $f_{AM_LF_VCORE1}$ | AM_LF_VCORE1 | Low-frequency low-leakage mode with LDO as the active regulator | 0 | 128 | kHz |

(1) DMA can be operated at the same frequency as CPU.

5.7 Operating Mode Peripheral Frequency Ranges

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | OPERATING MODE | DESCRIPTION | MIN | MAX | UNIT |
|------------------------|------------------|--|-----|--------|------|
| $f_{AM_LPM0_VCORE0}$ | AM_LDO_VCORE0 | Peripheral frequency range in LDO or DC-DC based active or LPM0 modes for VCORE0 | 0 | 12 | MHz |
| | AM_DCDC_VCORE0 | | | | |
| | LPM0_LDO_VCORE0 | | | | |
| | LPM0_DCDC_VCORE0 | | | | |
| $f_{AM_LPM0_VCORE1}$ | AM_LDO_VCORE1 | Peripheral frequency range in LDO or DC-DC based active or LPM0 modes for VCORE1 | 0 | 24 | MHz |
| | AM_DCDC_VCORE1 | | | | |
| | LPM0_LDO_VCORE1 | | | | |
| | LPM0_DCDC_VCORE1 | | | | |
| $f_{AM_LPM0_LF}$ | AM_LF_VCORE0 | Peripheral frequency range in low-frequency active or low frequency LPM0 modes for VCORE0 and VCORE1 | 0 | 128 | kHz |
| | AM_LF_VCORE1 | | | | |
| | LPM0_LF_VCORE0 | | | | |
| | LPM0_LF_VCORE1 | | | | |
| $f_{LPM3}^{(1)}$ | LPM3_VCORE0 | Peripheral frequency in LPM3 mode for VCORE0 and VCORE1 | 0 | 32.768 | kHz |
| | LPM3_VCORE1 | | | | |
| $f_{LPM3.5}^{(1)}$ | LPM3.5 | Peripheral frequency in LPM3.5 mode | 0 | 32.768 | kHz |

(1) Only RTC and WDT can be active.

5.8 Operating Mode Execution Frequency vs Flash Wait-State Requirements

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | NUMBER OF FLASH WAIT STATES | FLASH READ MODE | MAXIMUM SUPPORTED MCLK FREQUENCY ⁽¹⁾ , ⁽²⁾ | | UNIT |
|------------------------------|-----------------------------|---------------------------------|--|----------------------------------|------|
| | | | AM_LDO_VCORE0, AM_DCDC_VCORE0 | AM_LDO_VCORE1, AM_DCDC_VCORE1 | |
| f _{MAX_NRM_FLWAIT0} | 0 | Normal read mode | 12 | 16 | MHz |
| f _{MAX_NRM_FLWAIT1} | 1 | Normal read mode | 24 | 32 | MHz |
| f _{MAX_NRM_FLWAIT2} | 2 | Normal read mode | 24 | 48 | MHz |
| f _{MAX_ORM_FLWAIT0} | 0 | Other read modes ⁽³⁾ | 6 | 8 | MHz |
| f _{MAX_ORM_FLWAIT1} | 1 | Other read modes ⁽³⁾ | 12 | 16 | MHz |
| f _{MAX_ORM_FLWAIT2} | 2 | Other read modes ⁽³⁾ | 18 | 24 | MHz |
| f _{MAX_ORM_FLWAIT3} | 3 | Other read modes ⁽³⁾ | 24 | 32 | MHz |
| f _{MAX_ORM_FLWAIT4} | 4 | Other read modes ⁽³⁾ | 24 | 40 | MHz |
| f _{MAX_ORM_FLWAIT5} | 5 | Other read modes ⁽³⁾ | 24 | 48 | MHz |

- (1) Violation of the maximum frequency limitation for a given wait-state configuration results in nondeterministic data or instruction fetches from the flash memory.
- (2) In low-frequency active modes, the flash can always be accessed in zero wait-state because the maximum MCLK frequency is limited to 128 kHz.
- (3) Other read modes refer to Read Margin 0/1, Read Margin 0B/1B, Program Verify, Erase Verify, and Leakage Verify.

5.9 Current Consumption

Table 5-1. Current Consumption During Device Reset

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) ⁽¹⁾⁽²⁾⁽³⁾

| PARAMETER | V _{CC} | TYP | MAX | UNIT |
|--------------------|-----------------|-----|------|------|
| I _{RESET} | 2.2 V | | | μA |
| | 3.0 V | 540 | 1300 | |

- (1) Device held in reset through RSTn/NMI pin.
(2) Current measured into V_{CC}.
(3) All other input pins tied to 0 V or V_{CC}. Outputs do not source or sink any current.

Table 5-2. Current Consumption in LDO-Based Active Modes

over recommended operating free-air temperature (unless otherwise noted) ⁽¹⁾⁽²⁾⁽³⁾⁽⁴⁾⁽⁵⁾

| PARAMETER | EXECUTION MEMORY | V _{CC} | MCLK = 8 MHz | | MCLK = 16 MHz | | MCLK = 24 MHz | | MCLK = 32 MHz | | MCLK = 40 MHz | | MCLK = 48 MHz | | UNIT |
|---|------------------|-----------------|--------------|-----|---------------|-----|---------------|------|---------------|-----|---------------|-----|---------------|------|------|
| | | | TYP | MAX | TYP | MAX | TYP | MAX | TYP | MAX | TYP | MAX | TYP | MAX | |
| I _{AM_LDO_VCORE0,Flash} ^{(6) (7)} | Flash | 3.0 V | | | | | 3950 | 4700 | | | | | | | μA |
| I _{AM_LDO_VCORE1,Flash} ^{(6) (7)} | Flash | 3.0 V | | | | | | | | | | | 7600 | 8500 | μA |
| I _{AM_LDO_VCORE0,SRAM} ⁽⁸⁾ | SRAM | 3.0 V | | | | | | | | | | | | | μA |
| I _{AM_LDO_VCORE1,SRAM} ⁽⁸⁾ | SRAM | 3.0 V | | | | | | | | | | | | | μA |

- (1) MCLK sourced by DCO.
(2) Current measured into V_{CC}.
(3) All other input pins tied to 0 V or V_{CC}. Outputs do not source or sink any current.
(4) All SRAM banks kept active.
(5) All peripherals are inactive.
(6) Device executing the Dhrystone 2.1 algorithm. Code execution from Flash, stack and data in SRAM.
(7) Flash configured to minimum wait states required to support operation at given frequency and core voltage level.
(8) Device executing the Dhrystone 2.1 algorithm. Code execution from SRAM, stack and data in SRAM.

Table 5-3. Current Consumption in DC-DC-Based Active Modes

over recommended operating free-air temperature (unless otherwise noted) ⁽¹⁾⁽²⁾⁽³⁾⁽⁴⁾⁽⁵⁾

| PARAMETER | EXECUTION MEMORY | V _{CC} | MCLK = 8 MHz | | MCLK = 16 MHz | | MCLK = 24 MHz | | MCLK = 32 MHz | | MCLK = 40 MHz | | MCLK = 48 MHz | | UNIT |
|--|------------------|-----------------|--------------|-----|---------------|-----|---------------|------|---------------|-----|---------------|-----|---------------|------|------|
| | | | TYP | MAX | TYP | MAX | TYP | MAX | TYP | MAX | TYP | MAX | TYP | MAX | |
| I _{AM_DCDC_VCORE0,Flash} ^{(6) (7)} | Flash | 3.0 V | | | | | 2200 | 2800 | | | | | | | μA |
| I _{AM_DCDC_VCORE1,Flash} ^{(6) (7)} | Flash | 3.0 V | | | | | | | | | | | 4600 | 5400 | μA |
| I _{AM_DCDC_VCORE0,SRAM} ⁽⁸⁾ | SRAM | 3.0 V | | | | | | | | | | | | | μA |
| I _{AM_DCDC_VCORE1,SRAM} ⁽⁸⁾ | SRAM | 3.0 V | | | | | | | | | | | | | μA |

- (1) MCLK sourced by DCO.
(2) Current measured into V_{CC}.
(3) All other input pins tied to 0 V or V_{CC}. Outputs do not source or sink any current.
(4) All SRAM banks kept active.
(5) All peripherals are inactive.
(6) Device executing the Dhrystone 2.1 algorithm. Code execution from Flash, stack and data in SRAM.
(7) Flash configured to minimum wait states required to support operation at given frequency and core voltage level.
(8) Device executing the Dhrystone 2.1 algorithm. Code execution from SRAM, stack and data in SRAM.

Table 5-4. Current Consumption in Low-Frequency Active Modesover recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) ⁽¹⁾⁽²⁾⁽³⁾⁽⁴⁾⁽⁵⁾

| PARAMETER | EXECUTION MEMORY | V _{CC} | –40°C | | 25°C | | 60°C | | 85°C | | UNIT |
|--|------------------|-----------------|-------|-----|------|-----|------|-----|------|-----|------|
| | | | TYP | MAX | TYP | MAX | TYP | MAX | TYP | MAX | |
| I _{AM_LF_VCORE0} , Flash ^{(6) (7)} | Flash | 2.2 V | | | | | | | | | μA |
| | | 3.0 V | | | 90 | | | | 570 | | |
| I _{AM_LF_VCORE1} , Flash ^{(6) (7)} | Flash | 2.2 V | | | | | | | | | μA |
| | | 3.0 V | | | 95 | | | | 680 | | |
| I _{AM_LF_VCORE0} , SRAM ⁽⁸⁾ | SRAM | 2.2 V | | | | | | | | | μA |
| | | 3.0 V | | | | | | | | | |
| I _{AM_LF_VCORE1} , SRAM ⁽⁸⁾ | SRAM | 2.2 V | | | | | | | | | μA |
| | | 3.0 V | | | | | | | | | |

(1) Current measured into V_{CC}.(2) All other input pins tied to 0 V or V_{CC}. Outputs do not source or sink any current.

(3) MCLK sourced by REFO at 128 kHz.

(4) All peripherals are inactive.

(5) SRAM banks 0,1 enabled for execution from flash and SRAM banks 0 to 3 enabled for execution from SRAM.

(6) Flash configured to 0 wait states.

(7) Device executing the Dhrystone 2.1 algorithm. Code execution from Flash, stack and data in SRAM.

(8) Device executing the Dhrystone 2.1 algorithm. Code execution from SRAM, stack and data also in SRAM.

Table 5-5. Current Consumption in LDO-Based LPM0 Modesover recommended operating free-air temperature (unless otherwise noted) ⁽¹⁾⁽²⁾⁽³⁾⁽⁴⁾⁽⁵⁾⁽⁶⁾

| PARAMETER | V _{CC} | MCLK = 8 MHz | | MCLK = 16 MHz | | MCLK = 24 MHz | | MCLK = 32 MHz | | MCLK = 40 MHz | | MCLK = 48 MHz | | UNIT |
|------------------------------|-----------------|--------------|-----|---------------|-----|---------------|------|---------------|-----|---------------|-----|---------------|------|------|
| | | TYP | MAX | TYP | MAX | TYP | MAX | TYP | MAX | TYP | MAX | TYP | MAX | |
| I _{LPM0_LDO_VCORE0} | 2.2 V | | | | | | | | | | | | | μA |
| | 3.0 V | | | | | 700 | 1350 | | | | | | | |
| I _{LPM0_LDO_VCORE1} | 2.2 V | | | | | | | | | | | | | μA |
| | 3.0 V | | | | | | | | | | | 1130 | 1900 | |

(1) MCLK sourced by DCO.

(2) Current measured into V_{CC}.(3) All other input pins tied to 0 V or V_{CC}. Outputs do not source or sink any current.

(4) CPU is OFF, Flash or SRAM not being accessed.

(5) All SRAM banks kept active.

(6) All peripherals are inactive.

Table 5-6. Current Consumption in DC-DC-Based LPM0 Modesover recommended operating free-air temperature (unless otherwise noted) ⁽¹⁾⁽²⁾⁽³⁾⁽⁴⁾⁽⁵⁾⁽⁶⁾

| PARAMETER | V _{CC} | MCLK = 8 MHz | | MCLK = 16 MHz | | MCLK = 24 MHz | | MCLK = 32 MHz | | MCLK = 40 MHz | | MCLK = 48 MHz | | UNIT |
|-------------------------------|-----------------|--------------|-----|---------------|-----|---------------|-----|---------------|-----|---------------|-----|---------------|------|------|
| | | TYP | MAX | TYP | MAX | TYP | MAX | TYP | MAX | TYP | MAX | TYP | MAX | |
| I _{LPM0_DCDC_VCORE0} | 2.2 V | | | | | | | | | | | | | μA |
| | 3.0 V | | | | | 500 | 950 | | | | | | | |
| I _{LPM0_DCDC_VCORE1} | 2.2 V | | | | | | | | | | | | | μA |
| | 3.0 V | | | | | | | | | | | 800 | 1350 | |

(1) MCLK sourced by DCO.

(2) Current measured into V_{CC}.(3) All other input pins tied to 0 V or V_{CC}. Outputs do not source or sink any current.

(4) CPU is OFF, Flash or SRAM not being accessed.

(5) All SRAM banks kept active.

(6) All peripherals are inactive.

Table 5-7. Current Consumption in Low-Frequency LPM0 Modes

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) ⁽¹⁾⁽²⁾⁽³⁾⁽⁴⁾⁽⁵⁾⁽⁶⁾

| PARAMETER | V _{CC} | –40°C | | 25°C | | 60°C | | 85°C | | UNIT |
|-----------------------------|-----------------|-------|-----|------|-----|------|-----|------|-----|------|
| | | TYP | MAX | TYP | MAX | TYP | MAX | TYP | MAX | |
| I _{LPM0_LF_VCORE0} | 2.2 V | | | | | | | | | μA |
| | 3.0 V | | | 70 | | | | | 530 | |
| I _{LPM0_LF_VCORE1} | 2.2 V | | | | | | | | | μA |
| | 3.0 V | | | 70 | | | | | 625 | |

- (1) Current measured into V_{CC}.
- (2) All other input pins tied to 0 V or V_{CC}. Outputs do not source or sink any current.
- (3) MCLK sourced by REFO at 128 kHz.
- (4) All peripherals are inactive.
- (5) Bank-0 of SRAM kept active. Rest of the banks are powered down.
- (6) CPU is OFF, Flash or SRAM not being accessed.

Table 5-8. Current Consumption in LPM3, LPM4 Modes

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) ⁽¹⁾⁽²⁾⁽³⁾⁽⁴⁾⁽⁵⁾⁽⁶⁾

| PARAMETER | V _{CC} | –40°C | | 25°C | | 60°C | | 85°C | | UNIT |
|--|-----------------|-------|-----|------|-----|------|-----|------|-----|------|
| | | TYP | MAX | TYP | MAX | TYP | MAX | TYP | MAX | |
| I _{LPM3_VCORE0_RTCLF} ⁽⁷⁾⁽⁸⁾ | 2.2 V | | | | | | | | | μA |
| | 3.0 V | | | 0.85 | | | | | 17 | |
| I _{LPM3_VCORE0_RTCREFO} ⁽⁹⁾⁽⁸⁾ | 2.2 V | | | | | | | | | μA |
| | 3.0 V | | | 1.35 | | | | | 18 | |
| I _{LPM3_VCORE1_RTCLF} ⁽⁷⁾⁽⁸⁾ | 2.2 V | | | | | | | | | μA |
| | 3.0 V | | | 1.16 | | | | | 24 | |
| I _{LPM3_VCORE1_RTCREFO} ⁽⁹⁾⁽⁸⁾ | 2.2 V | | | | | | | | | μA |
| | 3.0 V | | | 1.67 | | | | | 25 | |
| I _{LPM4_VCORE0} ⁽¹⁰⁾ | 2.2 V | | | | | | | | | μA |
| | 3.0 V | | | | | | | | | |
| I _{LPM4_VCORE1} ⁽¹⁰⁾ | 2.2 V | | | | | | | | | μA |
| | 3.0 V | | | | | | | | | |

- (1) Current measured into V_{CC}.
- (2) All other input pins tied to 0 V or V_{CC}. Outputs do not source or sink any current.
- (3) CPU is OFF, Flash powered down.
- (4) Bank-0 of SRAM retained, all other banks powered down.
- (5) Refer to [Table 5-54](#) for details on additional current consumed for each extra Bank that is enabled for retention.
- (6) SVSMH and SVSL are disabled.
- (7) RTC sourced by LFXT. Effective load capacitance of LF crystal is 3.7 pF.
- (8) WDT module is disabled.
- (9) RTC sourced by REFO.
- (10) RTC and WDT modules disabled.

Table 5-9. Current Consumption in LPM3.5, LPM4.5 Modesover recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)⁽¹⁾⁽²⁾

| PARAMETER | V _{CC} | –40°C | | 25°C | | 60°C | | 85°C | | UNIT |
|--|-----------------|-------|-----|------|-----|------|-----|------|-----|------|
| | | TYP | MAX | TYP | MAX | TYP | MAX | TYP | MAX | |
| I _{LPM3.5_RTCLF} ⁽³⁾⁽⁴⁾⁽⁵⁾⁽⁶⁾⁽⁷⁾ | 2.2 V | | | | | | | | | μA |
| | 3.0 V | | | 0.8 | | | | 17 | | |
| I _{LPM3.5_RTCREFO} ⁽³⁾⁽⁴⁾⁽⁸⁾⁽⁶⁾⁽⁷⁾ | 2.2 V | | | | | | | | | μA |
| | 3.0 V | | | 1.3 | | | | 18 | | |
| I _{LPM4.5} ⁽⁹⁾⁽¹⁰⁾ | 2.2 V | | | | | | | | | μA |
| | 3.0 V | | | 0.1 | | | | 7 | | |

(1) Current measured into V_{CC}.(2) All other input pins tied to 0 V or V_{CC}. Outputs do not source or sink any current.

(3) CPU and Flash are powered down.

(4) Bank-0 of SRAM retained, all other banks powered down.

(5) RTC sourced by LFXT. Effective load capacitance of LF crystal is 3.7 pF.

(6) WDT module is disabled.

(7) SVSMH and SVSL are disabled.

(8) RTC sourced by REFO.

(9) No core voltage. CPU, Flash and all banks of SRAM are powered down.

(10) SVSMH is disabled.

Table 5-10. Current Consumption of Digital Peripheralsover recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)⁽¹⁾

| PARAMETER | TEST CONDITIONS | TYP | MAX | UNIT |
|-----------------------|--|-----|-----|--------|
| I _{TIMER_A0} | Timer_A0 configured as PWM timer with 50% duty cycle | TBD | TBD | μA/MHz |
| I _{TIMER32} | Timer32 enabled | TBD | TBD | μA/MHz |
| I _{UART} | eUSCI_A configured in UART mode. | TBD | TBD | μA/MHz |
| I _{SPI} | eUSCI_A configured in SPI master mode | TBD | TBD | μA/MHz |
| I _{I2C} | eUSCI_B configured in I ² C master mode | TBD | TBD | μA/MHz |
| I _{WDT_A} | WDT_A configured in interval timer mode | TBD | TBD | μA/MHz |
| I _{RTC_C} | RTC_C enabled and sourced from 32-kHz LFXT | TBD | TBD | nA |
| I _{AES256} | AES256 active. | TBD | TBD | μA/MHz |
| I _{CRC32} | CRC32 active. | TBD | TBD | μA/MHz |

(1) Measured with V_{CORE} = 1.2 V.

5.10 Timing and Switching Characteristics

5.10.1 Mode Transition Timing

Table 5-11. Active Mode Transition Latencies

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | ORIGINAL OPERATING MODE | FINAL OPERATING MODE | TEST CONDITIONS | LATENCY | | UNIT |
|---|----------------------------|-------------------------|---|---------|-----|---------------|
| | | | | TYP | MAX | |
| $t_{\text{OFF_AMLD00}, 100 \text{ nF}}$ | Power Off | AM_LDO_VCORE0 | From V_{CC} reaching 1.65 V to start of application code. $C_{\text{VCORE}} = 100 \text{ nF}$. | 4.5 | 5.2 | ms |
| $t_{\text{OFF_AMLD00}, 4.7 \text{ }\mu\text{F}}$ | Power Off | AM_LDO_VCORE0 | From V_{CC} reaching 1.65 V to start of application code. $C_{\text{VCORE}} = 4.7 \text{ }\mu\text{F}$. | 4.7 | 5.8 | ms |
| $t_{\text{AMLD00_AMLD01}}$ | AM_LDO_VCORE0 | AM_LDO_VCORE1 | Transition from AM_LDO_VCORE0 to AM_LDO_VCORE1. MCLK frequency = 24 MHz. | 285 | 340 | μs |
| $t_{\text{AMLD01_AMLD00}}$ | AM_LDO_VCORE1 | AM_LDO_VCORE0 | Transition from AM_LDO_VCORE1 to AM_LDO_VCORE0. MCLK frequency = 24 MHz. | 4 | 5 | μs |
| $t_{\text{AMLD00_AMDCDC0}}$ | AM_LDO_VCORE0 | AM_DCDC_VCORE0 | Transition from AM_LDO_VCORE0 to AM_DCDC_VCORE0. MCLK frequency = 24 MHz. | 15 | 32 | μs |
| $t_{\text{AMDCDC0_AMLD00}}$ | AM_DCDC_VCORE0 | AM_LDO_VCORE0 | Transition from AM_DCDC_VCORE0 to AM_LDO_VCORE0. MCLK frequency = 24 MHz. | 15 | 27 | μs |
| $t_{\text{AMLD01_AMDCDC1}}$ | AM_LDO_VCORE1 | AM_DCDC_VCORE1 | Transition from AM_LDO_VCORE1 to AM_DCDC_VCORE1. MCLK frequency = 48 MHz. | 15 | 32 | μs |
| $t_{\text{AMDCDC1_AMLD01}}$ | AM_DCDC_VCORE1 | AM_LDO_VCORE1 | Transition from AM_DCDC_VCORE1 to AM_LDO_VCORE1. MCLK frequency = 48 MHz. | 15 | 27 | μs |
| $t_{\text{AMLD00_AMLF0}}$ | AM_LDO_VCORE0 | AM_LF_VCORE0 | Transition from AM_LDO_VCORE0 to AM_LF_VCORE0. All high frequency clock sources (DCO, HFXT, MODOSC) disabled. SELM = 2, REFO frequency = 128 kHz. | 115 | 125 | μs |
| $t_{\text{AMLF0_AMLD00}}$ | AM_LF_VCORE0 | AM_LDO_VCORE0 | Transition from AM_LF_VCORE0 to AM_LDO_VCORE0. All high frequency clock sources (DCO, HFXT, MODOSC) disabled. SELM = 2, REFO frequency = 128 kHz. | 115 | 130 | μs |
| $t_{\text{AMLD01_AMLF1}}$ | AM_LDO_VCORE1 | AM_LF_VCORE1 | Transition from AM_LDO_VCORE1 to AM_LF_VCORE1. All high frequency clock sources (DCO, HFXT, MODOSC) disabled. SELM = 2, REFO frequency = 128 kHz. | 110 | 115 | μs |
| $t_{\text{AMLF1_AMLD01}}$ | AM_LF_VCORE1 | AM_LDO_VCORE1 | Transition from AM_LF_VCORE1 to AM_LDO_VCORE1. All high frequency clock sources (DCO, HFXT, MODOSC) disabled. SELM = 2, REFO frequency = 128 kHz. | 110 | 120 | μs |

Table 5-12. LPM0 Mode Transition Latencies

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | ORIGINAL OPERATING MODE | FINAL OPERATING MODE | TEST CONDITIONS | LATENCY | | UNIT |
|---------------------------------------|-------------------------|----------------------|---|---------|-----|-------------|
| | | | | TYP | MAX | |
| $t_{\text{AMLDO0_LPM0LDO0}}^{(1)}$ | AM_LDO_VCORE0 | LPM0_LDO_VCORE0 | Transition from AM_LDO_VCORE0 to LPM0_LDO_VCORE0 | 1 | | MCLK cycles |
| $t_{\text{LPM0LDO0_AMLDO0}}^{(2)}$ | LPM0_LDO_VCORE0 | AM_LDO_VCORE0 | Transition from LPM0_LDO_VCORE0 to AM_LDO_VCORE0 through I/O interrupt | 3 | 4 | MCLK cycles |
| $t_{\text{AMDCDC0_LPM0DCDC0}}^{(1)}$ | AM_DCDC_VCORE0 | LPM0_DCDC_VCORE0 | Transition from AM_DCDC_VCORE0 to LPM0_DCDC_VCORE0 | 1 | | MCLK cycles |
| $t_{\text{LPM0DCDC0_AMDCDC0}}^{(2)}$ | LPM0_DCDC_VCORE0 | AM_DCDC_VCORE0 | Transition from LPM0_DCDC_VCORE0 to AM_DCDC_VCORE0 through I/O interrupt | 3 | 4 | MCLK cycles |
| $t_{\text{AMLF0_LPM0LF0}}^{(1)}$ | AM_LF_VCORE0 | LPM0_LF_VCORE0 | Transition from AM_LF_VCORE0 to LPM0_LF_VCORE0, All high frequency clock sources (DCO, HFXT, MODOSC) disabled | 1 | | MCLK cycles |
| $t_{\text{LPM0LF0_AMLF0}}^{(2)}$ | LPM0_LF_VCORE0 | AM_LF_VCORE0 | Transition from LPM0_LF_VCORE0 to AM_LF_VCORE0 through I/O interrupt, All high frequency clock sources (DCO, HFXT, MODOSC) disabled | 3 | 4 | MCLK cycles |
| $t_{\text{AMLDO1_LPM0LDO1}}^{(1)}$ | AM_LDO_VCORE1 | LPM0_LDO_VCORE1 | Transition from AM_LDO_VCORE1 to LPM0_LDO_VCORE1 | 1 | | MCLK cycles |
| $t_{\text{LPM0LDO1_AMLDO1}}^{(2)}$ | LPM0_LDO_VCORE1 | AM_LDO_VCORE1 | Transition from LPM0_LDO_VCORE1 to AM_LDO_VCORE1 through I/O interrupt | 3 | 4 | MCLK cycles |
| $t_{\text{AMDCDC1_LPM0DCDC1}}^{(1)}$ | AM_DCDC_VCORE1 | LPM0_DCDC_VCORE1 | Transition from AM_DCDC_VCORE1 to LPM0_DCDC_VCORE1 | 1 | | MCLK cycles |
| $t_{\text{LPM0DCDC1_AMDCDC1}}^{(2)}$ | LPM0_DCDC_VCORE1 | AM_DCDC_VCORE1 | Transition from LPM0_DCDC_VCORE1 to AM_DCDC_VCORE1 through I/O interrupt | 3 | 4 | MCLK cycles |
| $t_{\text{AMLF1_LPM0LF1}}^{(1)}$ | AM_LF_VCORE1 | LPM0_LF_VCORE1 | Transition from AM_LF_VCORE1 to LPM0_LF_VCORE1. All high frequency clock sources (DCO, HFXT, MODOSC) disabled | 1 | | MCLK cycles |
| $t_{\text{LPM0LF1_AMLF1}}^{(2)}$ | LPM0_LF_VCORE1 | AM_LF_VCORE1 | Transition from LPM0_LF_VCORE1 to AM_LF_VCORE1 through I/O interrupt. All high frequency clock sources (DCO, HFXT, MODOSC) disabled | 3 | 4 | MCLK cycles |

(1) This is the latency between execution of WFI instruction by CPU to assertion of SLEEPING signal at CPU output.

(2) This is the latency between I/O interrupt event to deassertion of SLEEPING signal at CPU output.

Table 5-13. LPM3, LPM4 Mode Transition Latencies

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | ORIGINAL OPERATING MODE | FINAL OPERATING MODE | TEST CONDITIONS | LATENCY | | UNIT |
|--|----------------------------|-------------------------|---|--|--|---------------|
| | | | | TYP | MAX | |
| $t_{\text{AMLDO0_LPMx0}}^{(1)}$ | AM_LDO_VCORE0 | LPM3_LPM4_VCORE0 | Transition from AM_LDO_VCORE0 to LPM3 or LPM4 at VCORE0. | SELN = 3, DCO frequency = 16 MHz TBD | SELN = 3, DCO frequency = 24 MHz 24 | μs |
| $t_{\text{LPMx0_AMLDO0_NORIO}}^{(2)}$ | LPM3_LPM4_VCORE0 | AM_LDO_VCORE0 | Transition from LPM3 or LPM4 at VCORE0 to AM_LDO_VCORE0 through wake-up event from nonglitch filter type I/O. | SELN = 3, DCO frequency = 16 MHz TBD | SELN = 3, DCO frequency = 24 MHz 15 | μs |
| $t_{\text{LPMx0_AMLDO0_GFLTIO}}^{(2)}$ | LPM3_LPM4_VCORE0 | AM_LDO_VCORE0 | Transition from LPM3 or LPM4 at VCORE0 to AM_LDO_VCORE0 through wake-up event from glitch filter type I/O, GLTFLT_EN = 1 | SELN = 3, DCO frequency = 16 MHz TBD | SELN = 3, DCO frequency = 24 MHz 16 | μs |
| $t_{\text{AMLDO1_LPMx1}}^{(1)}$ | AM_LDO_VCORE1 | LPM3_LPM4_VCORE1 | Transition from AM_LDO_VCORE1 to LPM3 or LPM4 at VCORE1. | SELN = 3, DCO frequency = 32 MHz TBD | SELN = 3, DCO frequency = 48 MHz TBD | μs |
| $t_{\text{AMLDO1_LPMx1}}^{(1)}$ | AM_LDO_VCORE1 | LPM3_LPM4_VCORE1 | Transition from AM_LDO_VCORE1 to LPM3 or LPM4 at VCORE1 | SELN = 3, DCO frequency = 48 MHz 21 | SELN = 3, DCO frequency = 32 MHz 23 | μs |
| $t_{\text{LPMx1_AMLDO1_NORIO}}^{(2)}$ | LPM3_LPM4_VCORE1 | AM_LDO_VCORE1 | Transition from LPM3 or LPM4 at VCORE1 to AM_LDO_VCORE1 through wake-up event from nonglitch filter type I/O. | SELN = 3, DCO frequency = 32 MHz TBD | SELN = 3, DCO frequency = 48 MHz TBD | μs |
| $t_{\text{LPMx1_AMLDO1_NORIO}}^{(2)}$ | LPM3_LPM4_VCORE1 | AM_LDO_VCORE1 | Transition from LPM3 or LPM4 at VCORE1 to AM_LDO_VCORE1 through wake-up event from nonglitch filter type I/O. | SELN = 3, DCO frequency = 48 MHz 10 | SELN = 3, DCO frequency = 32 MHz 15 | μs |
| $t_{\text{LPMx1_AMLDO1_GFLTIO}}^{(2)}$ | LPM3_LPM4_VCORE1 | AM_LDO_VCORE1 | Transition from LPM3 or LPM4 at VCORE1 to AM_LDO_VCORE1 through wake-up event from glitch filter type I/O, GLTFLT_EN = 1. | SELN = 3, DCO frequency = 32 MHz TBD | SELN = 3, DCO frequency = 48 MHz TBD | μs |
| $t_{\text{LPMx1_AMLDO1_GFLTIO}}^{(2)}$ | LPM3_LPM4_VCORE1 | AM_LDO_VCORE1 | Transition from LPM3 or LPM4 at VCORE1 to AM_LDO_VCORE1 through wake-up event from glitch filter type I/O, GLTFLT_EN = 1 | SELN = 3, DCO frequency = 48 MHz 10 | SELN = 3, DCO frequency = 32 MHz 16 | μs |

(1) This is the latency from WFI instruction execution by CPU to LPM3 or LPM4 entry.

(2) This is the latency from I/O wake-up event to MCLK clock start at device pin.

Table 5-14. LPM3.5, LPM4.5 Mode Transition Latencies

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | ORIGINAL OPERATING MODE | FINAL OPERATING MODE | TEST CONDITIONS | LATENCY | | UNIT |
|--|-------------------------|----------------------|---|---------|------|---------------|
| | | | | TYP | MAX | |
| $t_{\text{AMLDO0_LPM3.5}}^{(1)}$ | AM_LDO_VCORE0 | LPM3.5 | Transition from AM_LDO_VCORE0 to LPM3.5 | 22 | 25 | μs |
| $t_{\text{AMDCDC0_LPM3.5}}^{(1)}$ | AM_DCDC_VCORE0 | LPM3.5 | Transition from AM_DCDC_VCORE0 to LPM3.5 | 34 | 47 | μs |
| $t_{\text{AMLF0_LPM3.5}}^{(1)}$ | AM_LF_VCORE0 | LPM3.5 | Transition from AM_LF_VCORE0 to LPM3.5 | 225 | 240 | μs |
| $t_{\text{AMLDO1_LPM3.5}}^{(1)}$ | AM_LDO_VCORE1 | LPM3.5 | Transition from AM_LDO_VCORE1 to LPM3.5 | 22 | 25 | μs |
| $t_{\text{AMDCDC1_LPM3.5}}^{(1)}$ | AM_DCDC_VCORE1 | LPM3.5 | Transition from AM_DCDC_VCORE1 to LPM3.5 | 32 | 45 | μs |
| $t_{\text{AMLF1_LPM3.5}}^{(1)}$ | AM_LF_VCORE1 | LPM3.5 | Transition from AM_LF_VCORE1 to LPM3.5 | 225 | 240 | μs |
| $t_{\text{AMLDO0_LPM4.5}}^{(2)}$ | AM_LDO_VCORE0 | LPM4.5 | Transition from AM_LDO_VCORE0 to LPM4.5 | 22 | 25 | μs |
| $t_{\text{AMDCDC0_LPM4.5}}^{(2)}$ | AM_DCDC_VCORE0 | LPM4.5 | Transition from AM_DCDC_VCORE0 to LPM4.5 | 32 | 45 | μs |
| $t_{\text{AMLF0_LPM4.5}}^{(2)}$ | AM_LF_VCORE0 | LPM4.5 | Transition from AM_LF_VCORE0 to LPM4.5 | 180 | 195 | μs |
| $t_{\text{AMLDO1_LPM4.5}}^{(2)}$ | AM_LDO_VCORE1 | LPM4.5 | Transition from AM_LDO_VCORE1 to LPM4.5 | 22 | 25 | μs |
| $t_{\text{AMDCDC1_LPM4.5}}^{(2)}$ | AM_DCDC_VCORE1 | LPM4.5 | Transition from AM_DCDC_VCORE1 to LPM4.5 | 22 | 25 | μs |
| $t_{\text{AMLF1_LPM4.5}}^{(2)}$ | AM_LF_VCORE1 | LPM4.5 | Transition from AM_LF_VCORE1 to LPM4.5 | 180 | 195 | μs |
| $t_{\text{LPM3.5_AMLDO0}}^{(3)}$ | LPM3.5 | AM_LDO_VCORE0 | Transition from LPM3.5 to AM_LDO_VCORE0 | 0.9 | 0.95 | ms |
| $t_{\text{LPM4.5_AMLDO0_SVSMON,100 nF}}^{(3)}$ | LPM4.5 | AM_LDO_VCORE0 | Transition from LPM4.5 to AM_LDO_VCORE0, SVSMH enabled while in LPM4.5, $C_{\text{VCORE}} = 100 \text{ nF}$ | 1 | TBD | ms |
| $t_{\text{LPM4.5_AMLDO0_SVSMON,4.7 }\mu\text{F}}^{(3)}$ | LPM4.5 | AM_LDO_VCORE0 | Transition from LPM4.5 to AM_LDO_VCORE0, SVSMH enabled while in LPM4.5, $C_{\text{VCORE}} = 4.7 \mu\text{F}$ | TBD | TBD | ms |
| $t_{\text{LPM4.5_AMLDO0_SVSMOFF,100 nF}}^{(3)}$ | LPM4.5 | AM_LDO_VCORE0 | Transition from LPM4.5 to AM_LDO_VCORE0, SVSMH disabled while in LPM4.5, $C_{\text{VCORE}} = 100 \text{ nF}$ | 1.7 | TBD | ms |
| $t_{\text{LPM4.5_AMLDO0_SVSMOFF,4.7 }\mu\text{F}}^{(3)}$ | LPM4.5 | AM_LDO_VCORE0 | Transition from LPM4.5 to AM_LDO_VCORE0, SVSMH disabled while in LPM4.5, $C_{\text{VCORE}} = 4.7 \mu\text{F}$ | TBD | TBD | ms |

(1) This is the latency from WFI instruction execution by CPU to LPM3.5 mode entry.

(2) This is the latency from WFI instruction execution by CPU to LPM4.5 mode entry.

(3) This is the latency from I/O wake-up event to start of application code.

5.10.2 Reset Timing

Table 5-15. Reset Recovery Latencies

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) ⁽¹⁾

| PARAMETER | MIN | TYP | MAX | UNIT |
|--|-----|-----|------|-------------|
| t_{SOFT} Latency from release of soft reset to first CPU instruction fetch | | 5 | | MCLK cycles |
| t_{HARD} Latency from release of hard reset to release of soft reset | | 25 | | MCLK cycles |
| t_{POR} Latency from release of device POR to release of hard reset | | 15 | 25 | μs |
| $t_{COLDPWR, 100\text{ nF}}$ Latency from a cold power-up condition to release of device POR, $C_{V_{CORE}} = 100\text{ nF}$ | | 410 | 1000 | μs |
| $t_{COLDPWR, 4.7\text{ }\mu F}$ Latency from a cold power-up condition to release of device POR, $C_{V_{CORE}} = 4.7\text{ }\mu F$ | | 530 | 1600 | μs |

(1) Refer to [Section 6.7.1](#) for details on the various classes of resets on the device

Table 5-16. External Reset (RSTn) Recovery Latencies

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--------------------------------------|---|-----|-----|-----|------|
| $t_{AMLDO0_RSTn, 16\text{ MHz}}$ | External reset applied on RSTn pin while the device is in AM_LDO_VCORE0 mode with MCLK = 16 MHz, The latency is from release of external reset to start of application code | | TBD | 4 | ms |
| $t_{AMLDO1_RSTn, 32\text{ MHz}}$ | External reset applied on RSTn pin while the device is in AM_LDO_VCORE1 mode with MCLK = 32 MHz, The latency is from release of external reset to start of application code | | TBD | 4 | ms |
| $t_{AMLDO1_RSTn, 48\text{ MHz}}$ | External reset applied on RSTn pin while the device is in AM_LDO_VCORE1 mode with MCLK = 48 MHz, The latency is from release of external reset to start of application code | | TBD | 4 | ms |
| $t_{AMDCC0_RSTn, 16\text{ MHz}}$ | External reset applied on RSTn pin while the device is in AM_DCDC_VCORE0 mode with MCLK = 16 MHz, The latency is from release of external reset to start of application code | | TBD | 4 | ms |
| $t_{AMDCC1_RSTn, 48\text{ MHz}}$ | External reset applied on RSTn pin while the device is in AM_DCDC_VCORE1 mode with MCLK = 48 MHz, The latency is from release of external reset to start of application code | | TBD | 4 | ms |
| $t_{AMLF0_RSTn, 128\text{ kHz}}$ | External reset applied on RSTn pin while the device is in AM_LF_VCORE0 mode with MCLK = 128 kHz from REFO, The latency is from release of external reset to start of application code | | TBD | 4 | ms |
| $t_{AMLF0_RSTn, 32\text{ kHz}}$ | External reset applied on RSTn pin while the device is in AM_LF_VCORE0 mode with MCLK = 32 kHz from LFXT, The latency is from release of external reset to start of application code | | TBD | 4 | ms |
| $t_{AMLF1_RSTn, 128\text{ kHz}}$ | External reset applied on RSTn pin while the device is in AM_LF_VCORE1 mode with MCLK = 128 kHz from REFO, The latency is from release of external reset to start of application code | | TBD | 4 | ms |
| $t_{LPM0LDO0_RSTn, 16\text{ MHz}}$ | External reset applied on RSTn pin while the device is in LPM0_LDO_VCORE0 mode with MCLK = 16 MHz, The latency is from release of external reset to start of application code | | TBD | 4 | ms |
| $t_{LPM0LDO1_RSTn, 48\text{ MHz}}$ | External reset applied on RSTn pin while the device is in LPM0_LDO_VCORE1 mode with MCLK = 48 MHz, The latency is from release of external reset to start of application code | | TBD | 4 | ms |
| $t_{LPM0DCDC0_RSTn, 16\text{ MHz}}$ | External reset applied on RSTn pin while the device is in LPM0_DCDC_VCORE0 mode with MCLK = 16 MHz, The latency is from release of external reset to start of application code | | TBD | 4 | ms |
| $t_{LPM0DCDC1_RSTn, 48\text{ MHz}}$ | External reset applied on RSTn pin while the device is in LPM0_DCDC_VCORE1 mode with MCLK = 48 MHz, The latency is from release of external reset to start of application code | | TBD | 4 | ms |
| $t_{LPM0LF0_RSTn, 128\text{ kHz}}$ | External reset applied on RSTn pin while the device is in LPM0_LF_VCORE0 mode with MCLK = 128 kHz from REFO, The latency is from release of external reset to start of application code | | TBD | 4 | ms |

External Reset (RSTn) Recovery Latencies (*continued*)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--------------------------------|---|-----|-----|-----|------|
| $t_{LPM0LF0_RSTn, 32kHz}$ | External reset applied on RSTn pin while the device is in LPM0_LF_VCORE0 mode with MCLK = 32 kHz from LFXT, The latency is from release of external reset to start of application code | | TBD | 4 | ms |
| $t_{LPM0LF1_RSTn, 128kHz}$ | External reset applied on RSTn pin while the device is in LPM0_LF_VCORE1 mode with MCLK = 128 kHz from REFO, The latency is from release of external reset to start of application code | | TBD | 4 | ms |
| $t_{LPM3_LPM4_VCORE0_RSTn}$ | External reset applied on RSTn pin while the device is in LPM3 or LPM4 modes at VCORE0, The latency is from release of external reset to start of application code | | TBD | 4 | ms |
| $t_{LPM3_LPM4_VCORE1_RSTn}$ | External reset applied on RSTn pin while the device is in LPM3 or LPM4 modes at VCORE1, The latency is from release of external reset to start of application code | | TBD | 4 | ms |
| $t_{LPM3.5_RSTn}$ | External reset applied on RSTn pin while the device is in LPM3.5 mode, The latency is from release of external reset to start of application code | | TBD | 4 | ms |
| $t_{LPM4.5_RSTn}$ | External reset applied on RSTn pin while the device is in LPM4.5 mode, The latency is from release of external reset to start of application code | | TBD | 4 | ms |

5.10.3 Clock Specifications

Table 5-17. Low-Frequency Crystal Oscillator, LFXT, Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--|--------------------------------|-----|-----|-----|------------|
| ESR Crystal equivalent series resistance | $f_{OSC} = 32.768 \text{ kHz}$ | 16 | 40 | 65 | k Ω |
| C_{LFXT} Capacitance from LFXT input to ground and from LFXT output to ground ⁽¹⁾ | | 7.4 | 12 | 24 | pF |
| C_{SHUNT} Crystal shunt capacitance | | 0.6 | 0.8 | 1.6 | pF |
| C_m Crystal motional capacitance | | 1 | 2 | 10 | fF |

(1) Does not include board parasitics. Package and board will add additional capacitance to C_{LFXT} .

Table 5-18. Low-Frequency Crystal Oscillator, LFXT

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|--|---|-----------------|-----|--------|-----|------|
| I _{VCC,LFXT} Current consumption ⁽¹⁾ | f _{OSC} = 32.768 kHz LFXTBYPASS = 0, LFXTDRIVE = {0}, C _{L,eff} = 3.7 pF Typical ESR, C _{SHUNT} | 3.0 V | | 100 | | nA |
| | f _{OSC} = 32.768 kHz LFXTBYPASS = 0, LFXTDRIVE = {1}, C _{L,eff} = 6 pF Typical ESR, C _{SHUNT} | 3.0 V | | 200 | | |
| | f _{OSC} = 32.768 kHz LFXTBYPASS = 0, LFXTDRIVE = {2}, C _{L,eff} = 9 pF, Typical ESR, C _{SHUNT} | 3.0 V | | 300 | | |
| | f _{OSC} = 32.768 kHz LFXTBYPASS = 0, LFXTDRIVE = {3}, C _{L,eff} = 12 pF, Typical ESR, C _{SHUNT} | 3.0 V | | 500 | | |
| f _{LFXT} LFXT oscillator crystal frequency | LFXTBYPASS = 0 ⁽²⁾ | | | 32.768 | | kHz |
| DC _{LFXT} LFXT oscillator duty cycle | f _{LFXT} = 32.768 kHz ⁽²⁾ | | 30% | | 70% | |
| f _{LFXT,SW} LFXT oscillator logic-level square-wave input frequency | LFXTBYPASS = 1 ⁽³⁾ ⁽⁴⁾ | | 10 | 32.768 | 50 | kHz |
| DC _{LFXT,SW} LFXT oscillator logic-level square-wave input duty cycle | LFXTBYPASS = 1 | | 30% | | 70% | |
| O _A _{LFXT} Oscillation allowance for LF crystals ⁽⁵⁾ | LFXTBYPASS = 0, LFXTDRIVE = {1}, f _{LFXT} = 32.768 kHz, C _{L,eff} = 6 pF | | | TBD | | kΩ |
| | LFXTBYPASS = 0, LFXTDRIVE = {3}, f _{LFXT} = 32.768 kHz, C _{L,eff} = 12 pF | | | 300 | | |
| C _{L,eff} Integrated effective load capacitance ⁽⁶⁾ ⁽⁷⁾ | | | | 1 | | pF |
| t _{START,LFXT} Start-up time ⁽⁸⁾ | f _{OSC} = 32.768 kHz LFXTBYPASS = 0, LFXTDRIVE = {0}, C _{L,eff} = 3.7 pF Typical ESR, C _{SHUNT} FCNTLF_EN = 0 ⁽²⁾ | 3.0 V | | 0.6 | | s |
| | f _{OSC} = 32.768 kHz LFXTBYPASS = 0, LFXTDRIVE = {3}, C _{L,eff} = 12 pF Typical ESR, C _{SHUNT} FCNTLF_EN = 0 ⁽²⁾ | | | 2 | | |
| f _{Fault,LFXT} Oscillator fault frequency ⁽⁹⁾ ⁽¹⁰⁾ | | | 1 | | 8 | kHz |

(1) Total current measured on both AVCC and DVCC supplies.

(2) Measured at ACLK pin.

(3) When LFXTBYPASS is set, LFXT circuits are automatically powered down. Input signal is a digital square wave with parametrics defined in the Schmitt-trigger Inputs section of this datasheet. Duty cycle requirements are defined by DC_{LFXT, SW}.

(4) Maximum frequency of operation of the entire device cannot be exceeded.

(5) Oscillation allowance is based on a safety factor of 5 for recommended crystals. The oscillation allowance is a function of the LFXTDRIVE settings and the effective load. In general, comparable oscillator allowance can be achieved based on the following guidelines, but should be evaluated based on the actual crystal selected for the application:

- For LFXTDRIVE = {0}, C_{L,eff} = 3.7 pF.
- For LFXTDRIVE = {1}, 6 pF ≤ C_{L,eff} ≤ 9 pF.
- For LFXTDRIVE = {2}, 6 pF ≤ C_{L,eff} ≤ 10 pF.
- For LFXTDRIVE = {3}, 6 pF ≤ C_{L,eff} ≤ 12 pF.

(6) Includes parasitic bond and package capacitance (approximately 2 pF per pin).

(7) Requires external capacitors at both terminals. Values are specified by crystal manufacturers. Recommended values supported are 3.7 pF, 6 pF, 9 pF, and 12 pF. Maximum shunt capacitance of 1.6 pF. Because the PCB adds additional capacitance, it must be considered, and TI recommends verifying proper oscillator performance.

(8) Does not include programmable startup counter.

(9) Frequencies above the MAX specification do not set the fault flag. Frequencies in between the MIN and MAX specification may set the flag. A static condition or stuck at fault condition will set the fault flag.

(10) Measured with logic-level input frequency but also applies to operation with crystals.

Table 5-19. High-Frequency Crystal Oscillator, HFXT, Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-------------|---|--|-----|-----|-----|----------|
| ESR | Crystal Equivalent Series Resistance | $f_{OSC} = 1 \text{ MHz to } \leq 4 \text{ MHz}$ | | 75 | 150 | Ω |
| | | $f_{OSC} = > 4 \text{ MHz to } \leq 8 \text{ MHz}$ | | 75 | 150 | |
| | | $f_{OSC} = > 8 \text{ MHz to } \leq 16 \text{ MHz}$ | | 40 | 80 | |
| | | $f_{OSC} = > 16 \text{ MHz to } \leq 24 \text{ MHz}$ | | 30 | 60 | |
| | | $f_{OSC} = > 24 \text{ MHz to } \leq 32 \text{ MHz}$ | | 20 | 40 | |
| | | $f_{OSC} = > 32 \text{ MHz to } \leq 48 \text{ MHz}$ | | 15 | 30 | |
| C_{HFXT} | Capacitance from HFXT input to ground and from HFXT output to ground. | $f_{OSC} = 1 \text{ MHz to } 48 \text{ MHz}$ | 28 | 32 | 36 | pF |
| C_{SHUNT} | Crystal shunt capacitance | $f_{OSC} = 1 \text{ MHz to } 48 \text{ MHz}$ | 1 | 3 | 7 | pF |
| C_m | Crystal motional capacitance | $f_{OSC} = 1 \text{ MHz to } 48 \text{ MHz}$ | 3 | 7 | 30 | fF |

Table 5-20. High-Frequency Crystal Oscillator, HFXT

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|---|---|-----------------|-------|-----|-----|------|
| I _{DVCC,HFXT} HFXT oscillator crystal current HF mode at typical ESR | f _{OSC} = 1 MHz, HFXTBYPASS = 0, HFXTDRIVE = 0, HFFREQ = 0 C _{L,eff} = 16 pF Typical ESR, C _{SHUNT} | 3.0 V | | 40 | | μA |
| | f _{OSC} = 4 MHz, HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 0 C _{L,eff} = 16 pF Typical ESR, C _{SHUNT} | | | 60 | | |
| | f _{OSC} = 8 MHz, HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 1 C _{L,eff} = 16 pF Typical ESR, C _{SHUNT} | | | 120 | | |
| | f _{OSC} = 16 MHz, HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 2 C _{L,eff} = 16 pF Typical ESR, C _{SHUNT} | | | 200 | | |
| | f _{OSC} = 24 MHz, HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 3 C _{L,eff} = 16 pF Typical ESR, C _{SHUNT} | | | 260 | | |
| | f _{OSC} = 32 MHz, HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 4 C _{L,eff} = 16 pF Typical ESR, C _{SHUNT} | | | 330 | | |
| | f _{OSC} = 40 MHz, HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 5 C _{L,eff} = 16 pF Typical ESR, C _{SHUNT} | | | 460 | | |
| | f _{OSC} = 48 MHz, HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 6 C _{L,eff} = 16 pF Typical ESR, C _{SHUNT} | | | 530 | | |
| f _{HFXT} HFXT oscillator crystal frequency, crystal mode | HFXTBYPASS = 0, HFFREQ = 0 ⁽¹⁾ | | 1 | | 4 | MHz |
| | HFXTBYPASS = 0, HFFREQ = 1 ⁽¹⁾ | | 4.01 | | 8 | |
| | HFXTBYPASS = 0, HFFREQ = 2 ⁽¹⁾ | | 8.01 | | 16 | |
| | HFXTBYPASS = 0, HFFREQ = 3 ⁽¹⁾ | | 16.01 | | 24 | |
| | HFXTBYPASS = 0, HFFREQ = 4 ⁽¹⁾ | | 24.01 | | 32 | |
| | HFXTBYPASS = 0, HFFREQ = 5 ⁽¹⁾ | | 32.01 | | 40 | |
| | HFXTBYPASS = 0, HFFREQ = 6 ⁽¹⁾ | | 40.01 | | 48 | |
| DC _{HFXT} HFXT oscillator duty cycle | Measured at MCLK or HSMCLK. f _{HFXT} = 1 MHz - 48 MHz | | 40% | 50% | 60% | |
| f _{HFXT,SW} HFXT oscillator logic-level square-wave input frequency, bypass mode | HFXTBYPASS = 1 ⁽²⁾ ⁽¹⁾ | | 0.8 | | 48 | MHz |

(1) Maximum frequency of operation of the entire device cannot be exceeded.

(2) When HFXTBYPASS is set, HFXT circuits are automatically powered down. Input signal is a digital square wave with parametrics defined in the Schmitt-trigger Inputs section of this datasheet. Duty cycle requirements are defined by DC_{HFXT, SW}.

High-Frequency Crystal Oscillator, HFXT (continued)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|------------------------|--|---|-----------------|-----|------|-----|------|
| DC _{HFXT, SW} | HFXT oscillator logic-level square-wave input duty cycle | HFXTBYPASS = 1 External clock used as a direct source to MCLK or HSMCLK with no divider (DIVM = 0 or DIVHS = 0). | | 45% | | 55% | |
| | | HFXTBYPASS = 1 External clock used as a direct source to MCLK or HSMCLK with divider (DIVM > 0 or DIVHS > 0) or not used as a direct source to MCLK or HSMCLK. | | 40% | | 60% | |
| OA _{HFXT} | Oscillation allowance for HFXT crystals ⁽³⁾ | HFXTBYPASS = 0, HFXTDRIVE = 0, HFFREQ = 0 f _{HFXT,HF} = 1 MHz, C _{L,eff} = 16 pF | | | 5000 | | Ω |
| | | HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 0 f _{HFXT,HF} = 4 MHz, C _{L,eff} = 16 pF | | | 1250 | | |
| | | HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 1 f _{HFXT,HF} = 8 MHz, C _{L,eff} = 16 pF | | | 750 | | |
| | | HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 2 f _{HFXT,HF} = 16 MHz, C _{L,eff} = 16 pF | | | 425 | | |
| | | HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 3 f _{HFXT,HF} = 24 MHz, C _{L,eff} = 16 pF | | | 275 | | |
| | | HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 4 f _{HFXT,HF} = 32 MHz, C _{L,eff} = 16 pF | | | 225 | | |
| | | HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 5 f _{HFXT,HF} = 40 MHz, C _{L,eff} = 16 pF | | | 160 | | |
| | | HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 6 f _{HFXT,HF} = 48 MHz, C _{L,eff} = 16 pF | | | 140 | | |

(3) Oscillation allowance is based on a safety factor of 5 for recommended crystals.

High-Frequency Crystal Oscillator, HFXT (continued)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|--|---|-----------------|-----|------|-----|------|
| t _{START,HFXT} Start-up time ⁽⁴⁾ | f _{OSC} = 1 MHz HFXTBYPASS = 0, HFXTDRIVE = 0, HFFREQ = 0 C _{L,eff} = 16 pF Typical ESR, C _{SHUNT} FCNTHF_EN = 0 | 3.0 V | | 3.57 | | ms |
| | f _{OSC} = 4 MHz HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 0 C _{L,eff} = 16 pF Typical ESR, C _{SHUNT} FCNTHF_EN = 0 | | | 0.89 | | |
| | f _{OSC} = 8 MHz HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 1 C _{L,eff} = 16 pF Typical ESR, C _{SHUNT} FCNTHF_EN = 0 | | | 0.66 | | |
| | f _{OSC} = 16 MHz HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 2 C _{L,eff} = 16 pF Typical ESR, C _{SHUNT} FCNTHF_EN = 0 | | | 0.53 | | |
| | f _{OSC} = 24 MHz HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 3 C _{L,eff} = 16 pF Typical ESR, C _{SHUNT} FCNTHF_EN = 0 | | | 470 | | μs |
| | f _{OSC} = 32 MHz HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 4 C _{L,eff} = 16 pF Typical ESR, C _{SHUNT} FCNTHF_EN = 0 | | | 435 | | |
| | f _{OSC} = 40 MHz HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 5 C _{L,eff} = 16 pF Typical ESR, C _{SHUNT} FCNTHF_EN = 0 | | | 425 | | |
| | f _{OSC} = 48 MHz HFXTBYPASS = 0, HFXTDRIVE = 1, HFFREQ = 6 C _{L,eff} = 16 pF Typical ESR, C _{SHUNT} FCNTHF_EN = 0 | | | 420 | | |
| C _{L,eff} Integrated effective load capacitance ⁽⁵⁾ ⁽⁶⁾ | | | | 1 | | pF |
| f _{Fault,HFXT} Oscillator fault frequency ⁽⁷⁾ ⁽⁸⁾ | | | 400 | | 700 | kHz |

(4) Does not include programmable startup counter.

(5) Includes parasitic bond and package capacitance (approximately 2 pF per pin).

Because the PCB adds additional capacitance, TI recommends verifying the correct load by measuring the oscillator frequency through MCLK or SMCLK. For a correct setup, the effective load capacitance should always match the specification of the crystal.

(6) Requires external capacitors at both terminals. Values are specified by crystal manufacturers. Recommended values supported are 14 pF, 16 pF, and 18 pF. Maximum shunt capacitance of 7 pF.

(7) Frequencies above the MAX specification do not set the fault flag. Frequencies in between the MIN and MAX might set the flag. A static condition or stuck at fault condition will set the flag.

(8) Measured with logic-level input frequency but also applies to operation with crystals.

Table 5-21. DCO

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | V _{CC} , T _A | MIN | TYP | MAX | UNIT |
|--------------------------------------|--|---|----------------------------------|--------|------|--------|--------|
| f _{RSEL0_CTR} | DCO frequency center range 0 initial accuracy, with trimmed factory settings | Internal resistor option DCORSEL = 0, DCOTUNE = 0 | 3.0 V 25°C | 1.4925 | 1.5 | 1.5075 | MHz |
| | | External resistor option DCORSEL = 0, DCOTUNE = 0 | 3.0 V 25°C | 1.4925 | 1.5 | 1.5075 | |
| f _{RSEL1_CTR} | DCO frequency center range 1 initial accuracy, with trimmed factory settings | Internal resistor option DCORSEL = 1, DCOTUNE = 0 | 3.0 V 25°C | 2.985 | 3 | 3.015 | MHz |
| | | External resistor option DCORSEL = 1, DCOTUNE = 0 | 3.0 V 25°C | 2.985 | 3 | 3.015 | |
| f _{RSEL2_CTR} | DCO frequency center range 2 initial accuracy, with trimmed factory settings | Internal resistor option DCORSEL = 2, DCOTUNE = 0 | 3.0 V 25°C | 5.97 | 6 | 6.03 | MHz |
| | | External resistor option DCORSEL = 2, DCOTUNE = 0 | 3.0 V 25°C | 5.97 | 6 | 6.03 | |
| f _{RSEL3_CTR} | DCO frequency center range 3 initial accuracy, with trimmed factory settings | Internal resistor option DCORSEL = 3, DCOTUNE = 0 | 3.0 V 25°C | 11.94 | 12 | 12.06 | MHz |
| | | External resistor option DCORSEL = 3, DCOTUNE = 0 | 3.0 V 25°C | 11.94 | 12 | 12.06 | |
| f _{RSEL4_CTR} | DCO frequency center range 4 initial accuracy, with trimmed factory settings | Internal resistor option DCORSEL = 4, DCOTUNE = 0 | 3.0 V 25°C | 23.88 | 24 | 24.12 | MHz |
| | | External resistor option DCORSEL = 4, DCOTUNE = 0 | 3.0 V 25°C | 23.88 | 24 | 24.12 | |
| f _{RSEL5_CTR} | DCO frequency center range 5 initial accuracy, with trimmed factory settings | Internal resistor option DCORSEL = 5, DCOTUNE = 0 | 3.0 V 25°C | 47.76 | 48 | 48.24 | MHz |
| | | External resistor option DCORSEL = 5, DCOTUNE = 0 | 3.0 V 25°C | 47.76 | 48 | 48.24 | |
| df _{DCO} /dT ⁽¹⁾ | DCO frequency drift with temperature | Internal resistor option At fixed voltage. | 1.62 V to 3.7 V | –250 | | 250 | ppm/°C |
| | | External resistor option ⁽²⁾ At fixed voltage. | 1.62 V to 3.7 V | –35 | | 35 | |
| df _{DCO} /dV _{CC} | DCO frequency voltage drift with voltage | At fixed temperature. | –40°C to 85 °C | –0.10 | | 0.10 | %/V |
| f _{RSEL0} | DCO frequency range 0 | DCORSEL = 0, DCOTUNE = value TBD in the negative scale to value TBD in the positive scale | 1.62 V to 3.7 V –40°C to 85°C | 0.98 | | 2.7 | MHz |
| f _{RSEL1} | DCO frequency range 1 | DCORSEL = 1, DCOTUNE = value TBD in the negative scale to value TBD in the positive scale | 1.62 V to 3.7 V –40°C to 85°C | 1.96 | | 5.4 | MHz |
| f _{RSEL2} | DCO frequency range 2 | DCORSEL = 2, DCOTUNE = value TBD in the negative scale to value TBD in the positive scale | 1.62 V to 3.7 V –40°C to 85°C | 3.92 | | 10.8 | MHz |
| f _{RSEL3} | DCO frequency range 3 | DCORSEL = 3, DCOTUNE = value TBD in the negative scale to value TBD in the positive scale | 1.62 V to 3.7 V –40°C to 85°C | 7.84 | | 21.6 | MHz |
| f _{RSEL4} | DCO frequency range 4 | DCORSEL = 4, DCOTUNE = value TBD in the negative scale to value TBD in the positive scale | 1.62 V to 3.7 V –40°C to 85°C | 15.68 | | 43.2 | MHz |
| f _{RSEL5} | DCO frequency range 5 | DCORSEL = 5, DCOTUNE = value TBD in the negative scale to value TBD in the positive scale | 1.62 V to 3.7 V –40°C to 85°C | 31.36 | | 86.5 | MHz |
| f _{DCO_DC} | Duty cycle | No external divide, all DCO settings | 1.62 V to 3.7 V –40°C to 85°C | 48% | 50% | 52% | |
| t _{DCO_JITTER} | DCO jitter | | 1.62 V to 3.7 V –40°C to 85°C | | 120 | 200 | ps |
| T _{DCO_STEP} | Step size | Step size of the DCO. | 1.62 V to 3.7 V –40°C to 85°C | | 0.2% | | |

(1) Average calculated using the box method, (f_{DCO_MAX} - f_{DCO_MIN}) / (T_{MAX} - T_{MIN}).

(2) Does not include temperature coefficient of external resistor.

The recommended value of External Resistor at DCOR pin: 91kΩ, 0.1%, ±25 ppm/°C.

DCO (continued)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} , T _A | MIN | TYP | MAX | UNIT |
|----------------------------------|---|----------------------------------|------|-----|-----|------|
| t _{DCO_SETTLE_RANGE} | DCO settling from worst case DCORSELn to DCORSELm See Figure 5-1 . | 1.62 V to 3.7 V –40°C to 85°C | | | 5 | μs |
| t _{DCO_SETTLE_TUNE_LSB} | DCO settling LSB change of DCOTUNE within any DCORSEL setting See Figure 5-1 . | 1.62 V to 3.7 V –40°C to 85°C | | | 2.2 | μs |
| t _{DCO_SETTLE_TUNE} | DCO settling worst case DCOTUNEn to DCOTUNEm within any DCORSEL setting See Figure 5-1 . | 1.62 V to 3.7 V –40°C to 85°C | | | 5 | μs |
| DCO _{OVERSHOOT} | DCO overshoot See Figure 5-1 . | 1.62 V to 3.7 V –40°C to 85°C | –10% | | 5% | |
| t _{START} | DCO startup time ⁽³⁾ DCO settled to within 0.5% of steady state frequency. | 1.62 V to 3.7 V –40°C to 85°C | | 5 | | μs |

(3) The maximum parasitic capacitance at the DCO External Resistance pin (DCOR) should not exceed 5pF to guarantee the specified DCO startup time.

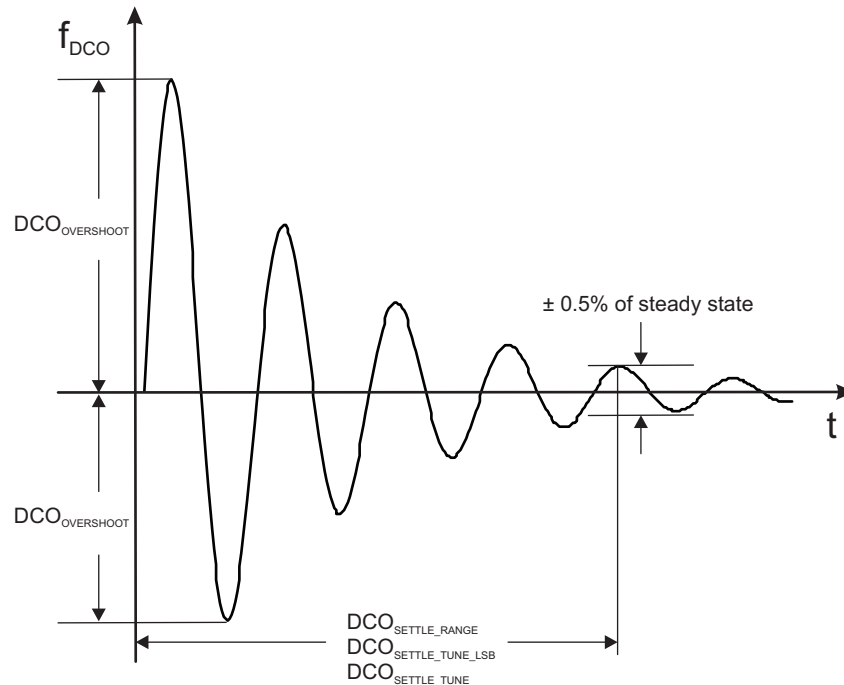


Figure 5-1. DCO Settling

Table 5-22. DCO Overall Tolerance

over operating free-air temperature range (unless otherwise noted)

| RESISTOR OPTION | TEMPERATURE CHANGE | TEMPERATURE DRIFT (%) | VOLTAGE CHANGE | VOLTAGE DRIFT (%) | OVERALL DRIFT (%) | OVERALL ACCURACY (%) |
|-----------------------------------|--------------------|-----------------------|-----------------|-------------------|-------------------|----------------------|
| Internal resistor | –40°C to 85 °C | ±3.125 | 1.62 V to 3.7 V | ±0.2 | ±3.325 | ±3.825 |
| | 0°C | 0 | 1.62 V to 3.7 V | ±0.2 | ±0.2 | ±0.7 |
| | –40°C to 85 °C | ±3.125 | 0 V | 0 | ±3.125 | ±3.625 |
| External resistor with 25-ppm TCR | –40°C to 85 °C | ±0.438 | 1.62 V to 3.7 V | ±0.2 | ±0.638 | ±1.138 |
| | 0°C | 0 | 1.62 V to 3.7 V | ±0.2 | ±0.2 | ±0.7 |
| | –40°C to 85 °C | ±0.438 | 0 V | 0 | ±0.438 | ±0.938 |

Table 5-23. Internal Very-Low-Power Low-Frequency Oscillator (VLO)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|---|-----------------|-----------------|-----|-----|-----|------|
| I _{VLO} Current consumption ⁽¹⁾ | | 1.62 V to 3.7 V | | 100 | | nA |
| f _{VLO} VLO frequency | (2) | 1.62 V to 3.7 V | 6 | 9.4 | 14 | kHz |
| df _{VLO} /dT VLO frequency temperature drift ⁽³⁾ | (2) | 1.62 V to 3.7 V | | 0.5 | | %/°C |
| df _{VLO} /dV _{CC} VLO frequency supply voltage drift ⁽⁴⁾ | (2) | 1.62 V to 3.7 V | | 4 | | %/V |
| DC _{VLO} Duty cycle | (2) | 1.62 V to 3.7 V | 40% | 50% | 60% | |

(1) Current measured on DVCC supply

(2) Measured at ACLK pin

(3) Calculated using the box method: (MAX(–40°C to 85°C) – MIN(–40°C to 85°C)) / MIN(–40°C to 85°C) / (85°C – (–40°C))

(4) Calculated using the box method: (MAX(1.62 V to 3.7 V) – MIN(1.62 V to 3.7 V)) / MIN(1.62 V to 3.7 V) / (3.7 V – 1.62 V)

Table 5-24. Internal Reference, Low-Frequency Oscillator (REFO)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|---|--|-----------------|-------|--------|------|------|
| I _{REFO} REFO current consumption ⁽¹⁾ | REFOFSEL = 0 | 1.62 V to 3.7 V | | 0.6 | | μA |
| | REFOFSEL = 1 | 1.62 V to 3.7 V | | 1 | | |
| f _{REFO} REFO frequency calibrated | REFOFSEL = 0 ⁽²⁾ | 1.62 V to 3.7 V | | 32.768 | | kHz |
| | REFOFSEL = 1 ⁽²⁾ | 1.62 V to 3.7 V | | 128 | | |
| | Full temperature range REFOFSEL = 0 ⁽²⁾ | 1.62 V to 3.7 V | –3% | | 3% | |
| | Full temperature range REFOFSEL = 1 ⁽²⁾ | 1.62 V to 3.7 V | –6% | | 6% | |
| | T _A = 25°C REFOFSEL = 0,1 ⁽²⁾ | 3 V | –1.5% | | 1.5% | |
| df _{REFO} /dT REFO frequency temperature drift ⁽³⁾ | (2) | 1.62 V to 3.7 V | | 0.01 | | %/°C |
| df _{REFO} /dV _{CC} REFO frequency supply voltage drift ⁽⁴⁾ | (2) | 1.62 V to 3.7 V | | 1.0 | | %/V |
| DC _{REFO} REFO duty cycle | (2) | 1.62 V to 3.7 V | 40% | 50% | 60% | |

(1) Total current measured on both AVCC and DVCC supplies.

(2) Measured at ACLK pin

(3) Calculated using the box method: (MAX(–40°C to 85°C) – MIN(–40°C to 85°C)) / MIN(–40°C to 85°C) / (85°C – (–40°C))

(4) Calculated using the box method: (MAX(1.62 V to 3.7 V) – MIN(1.62 V to 3.7 V)) / MIN(1.62 V to 3.7 V) / (3.7 V – 1.62 V)

Table 5-25. Module Oscillator (MODOSC)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|---|-----------------|--------------------------------|-----|-------|-----|------|
| I _{MODOSC} Current consumption ⁽¹⁾ | | 1.62 V to 3.7 V | | 50 | | μA |
| f _{MODOSC} MODOSC frequency | | ⁽²⁾ 1.62 V to 3.7 V | 23 | 25 | 27 | MHz |
| df _{MODOSC} /dT MODOSC frequency temperature drift ⁽³⁾ | (2) | 1.62 V to 3.7 V | | 0.017 | | %/°C |
| df _{MODOSC} /dV _{CC} MODOSC frequency supply voltage drift ⁽⁴⁾ | (2) | 1.62 V to 3.7 V | | 0.36 | | %/V |
| DC _{MODOSC} Duty cycle | (2) | 1.62 V to 3.7 V | 40% | 50% | 60% | |

(1) Total current measured on both AVCC and DVCC supplies.

(2) Measured at SMCLK pin with divide by 2 setting for MODOSC clock.

(3) Calculated using the box method: (MAX(–40°C to 85°C) – MIN(–40°C to 85°C)) / MIN(–40°C to 85°C) / (85°C – (–40°C))

(4) Calculated using the box method: (MAX(1.62 V to 3.7 V) – MIN(1.62 V to 3.7 V)) / MIN(1.62 V to 3.7 V) / (3.7 V – 1.62 V)

Table 5-26. System Oscillator (SYSOSC)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|--|--|-----------------|-----------------|------|------|------|------|
| I _{SYSOSC} | Current consumption ⁽¹⁾ | | 1.62 V to 3.7 V | | 25 | | μA |
| f _{SYSOSC} | SYSOSC frequency | | 1.62 V to 3.7 V | 4.25 | 5.0 | 5.75 | MHz |
| df _{SYSOSC} /dT | SYSOSC frequency temperature drift ⁽²⁾ | | 1.62 V to 3.7 V | | 0.03 | | %/°C |
| df _{SYSOSC} /dV _{CC} | SYSOSC frequency supply voltage drift ⁽³⁾ | | 1.62 V to 3.7 V | | 0.6 | | %/V |
| DC _{SYSOSC} | Duty cycle | | 1.62 V to 3.7 V | 40% | 50% | 60% | |

(1) Total current measured on both AVCC and DVCC supplies.

(2) Calculated using the box method: (MAX(–40°C to 85°C) – MIN(–40°C to 85°C)) / MIN(–40°C to 85°C) / (85°C – (–40°C))

(3) Calculated using the box method: (MAX(1.62 V to 3.7 V) – MIN(1.62 V to 3.7 V)) / MIN(1.62 V to 3.7 V) / (3.7 V – 1.62 V)

Table 5-27. Recommended Parts for L_{VSW}

| PART NAME | VALUE | TOLERANCE | FOOTPRINT | DCR ⁽¹⁾ | CURRENT RATING | TEMPERATURE RATING |
|-----------------|--------|-----------|-----------|--------------------|----------------|--------------------|
| LQM2MPN4R7NG0 | 4.7 μH | ±30% | 0806 | 140 mΩ ± 25% | 1100 mA | –55°C to +125°C |
| LQM21PN4R7NGR | 4.7 μH | ±30% | 0806 | 230 mΩ ± 25% | 800 mA | –55°C to +125°C |
| LQM2HPN4R7MGC | 4.7 μH | ±20% | 1008 | 180 mΩ ± 25% | 800 mA | –55°C to +125°C |
| VLS252010ET4R7M | 4.7 μH | ±20% | 1008 | 398 mΩ max | 890 mA | –40°C to +105°C |
| VLS252010ET6R8M | 6.8 μH | ±20% | 1008 | 532 mΩ max | 760 mA | –40°C to +105°C |
| VLS252015ET100M | 10 μH | ±20% | 1008 | 588 mΩ max | 800 mA | –40°C to +105°C |

(1) Higher DCR will result in lower DC-DC efficiency

5.10.4 Voltage Regulators

Table 5-28. V_{CORE} Regulator (LDO) Characteristics

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|--------------------------|--|---|------|-----|------|------|
| V _{CORE0-HP} | Static V _{CORE} voltage Level 0 in active and LPM0 modes | Device power modes AM_LDO_VCORE0, LPM0_LDO_VCORE0 | 1.07 | 1.2 | 1.27 | V |
| V _{CORE1-HP} | Static V _{CORE} voltage Level 1 in active and LPM0 modes | Device power modes AM_LDO_VCORE1, LPM0_LDO_VCORE1 | 1.25 | 1.4 | 1.48 | V |
| V _{CORE0-LF} | Static V _{CORE} voltage Level 0 in low-frequency active and low frequency LPM0 modes | Device power modes AM_LF_VCORE0 | 1.07 | 1.2 | 1.27 | V |
| V _{CORE1-LF} | Static V _{CORE} voltage Level 1 in low-frequency active and low frequency LPM0 modes | Device power modes AM_LF_VCORE1 | 1.25 | 1.4 | 1.48 | V |
| V _{CORE0-LPM34} | Static V _{CORE} voltage Level 0 in LPM3 and LPM4 modes | Device power modes LPM3, LPM4 | 0.98 | 1.2 | 1.31 | V |
| V _{CORE1-LPM34} | Static V _{CORE} voltage Level 1 in LPM3 and LPM4 modes | Device power modes LPM3, LPM4 | 1.14 | 1.4 | 1.52 | V |
| V _{CORE0-LPM35} | Static V _{CORE} voltage Level 0 in LPM3.5 mode | Device power mode LPM3.5 | 0.98 | 1.2 | 1.31 | V |
| I _{INRUSH-ST} | Inrush current at startup | Device power-up | | | 200 | mA |
| I _{PEAK-LDO} | Peak current drawn by LDO from DV _{CC} | Highest peak current expected during TBD | | | 350 | mA |
| T _{LPMLDO_RDY} | Time taken by LPM LDO (LDO in LPM3, LPM4, or LPM3.5) to get ready after a cold powerup or LPM4.5, before it may be enabled. ⁽¹⁾ | | | | 650 | μs |
| I _{SC-coreLDO} | Short circuit current limit for core LDO | Measured when output is shorted to ground | | | 350 | mA |

(1) If LPM LDO is attempted to be enabled before this time, the active mode LDO automatically remains ON at the expense of system power to allow the SOC operations to continue smoothly.

Table 5-29. V_{CORE} Regulator (DC-DC) Characteristics

| PARAMETER | TEST CONDITIONS | MIN | TYP | MAX | UNIT | |
|-------------------------|--|---|------|-----|------|---|
| DV _{CC-DCDC} | Allowed DV _{CC} range for DC-DC operation | 2.0 | | 3.7 | V | |
| V _{CORE0-DCDC} | Static V _{CORE} voltage Level 0 in DC-DC high-performance modes | Device power modes AM_DCDC_VCORE0, LPM0_DCDC_VCORE0 | 1.07 | 1.2 | 1.27 | V |
| V _{CORE1-DCDC} | Static V _{CORE} voltage Level 1 in DC-DC high-performance modes | Device power modes AM_DCDC_VCORE1, LPM0_DCDC_VCORE1 | 1.25 | 1.4 | 1.48 | V |
| I _{PEAK-DCDC} | Peak current drawn by DC-DC from DV _{CC} | | | 500 | mA | |
| I _{SC-DCDC} | Short circuit current limit for DC-DC | Measured when output is shorted to ground | | 700 | mA | |

Table 5-30. PSS, VCCDET

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---------------------|--|---------------------------------------|------|-------|------|------|
| $V_{VCC_VCCDET-}$ | VCCDET power-down level - trip point with falling V_{CC} | $ dDV_{CC}/dt < 3 \text{ V/s}^{(1)}$ | 0.64 | 1.1 | 1.62 | V |
| $V_{VCC_VCCDET+}$ | VCCDET power-up level - trip point with rising V_{CC} | $ dDV_{CC}/dt < 3 \text{ V/s}^{(1)}$ | 0.70 | 1.165 | 1.65 | V |
| $V_{VCC_VCC_hys}$ | VCCDET hysteresis | | 40 | 65 | 100 | mV |

(1) The VCCDET levels are measured with a slow-changing supply. Faster slopes can result in different levels.

Table 5-31. PSS, SVSMH

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-----------------|---|---|-------|-------|-------|---------------|
| I_{SVSMH} | SVSMH leakage current consumption, power down | SVSMHOFF = 1 | | 0.05 | 15 | nA |
| | SVSMH current consumption, low-power mode | SVSMHOFF = 0, SVSMHLP = 1 | | 300 | 500 | |
| | SVSMH current consumption, high-performance mode | SVSMHOFF = 0, SVSMHLP = 0 | | 4.5 | 8 | μA |
| $V_{SVSMH+,ST}$ | SVSMH threshold level during start up [(rising DV_{CC})] | <i>untrimmed (at initial powerup)</i> , DC ($dDV_{CC}/dt < 1 \text{ V/s}$) | 1.47 | 1.565 | 1.65 | V |
| $V_{SVSMH-,HP}$ | SVSMH threshold level during high-performance mode (falling DV_{CC}) | SVSMHOFF = 0, SVSMHLP = 0, SVSMHTH = 0, DC ($dDV_{CC}/dt < 1 \text{ V/s}$) <i>trimmed</i> | 1.54 | 1.58 | 1.62 | V |
| | | SVSMHOFF = 0, SVSMHLP = 0, SVSMHTH = 1, DC ($dDV_{CC}/dt < 1 \text{ V/s}$) <i>trimmed</i> | 1.57 | 1.61 | 1.65 | |
| | | SVSMHOFF = 0, SVSMHLP = 0, SVSMHTH = 2, DC ($dDV_{CC}/dt < 1 \text{ V/s}$) <i>trimmed</i> | 1.59 | 1.64 | 1.71 | |
| | | SVSMHOFF = 0, SVSMHLP = 0, SVSMHTH = 3, DC ($dDV_{CC}/dt < 1 \text{ V/s}$) <i>trimmed</i> | 2.0 | 2.05 | 2.12 | |
| | | SVSMHOFF = 0, SVSMHLP = 0, SVSMHTH = 4, DC ($dDV_{CC}/dt < 1 \text{ V/s}$) <i>trimmed</i> | 2.2 | 2.25 | 2.32 | |
| | | SVSMHOFF = 0, SVSMHLP = 0, SVSMHTH = 5, DC ($dDV_{CC}/dt < 1 \text{ V/s}$) <i>trimmed</i> | 2.4 | 2.46 | 2.54 | |
| | | SVSMHOFF = 0, SVSMHLP = 0, SVSMHTH = 6, DC ($dDV_{CC}/dt < 1 \text{ V/s}$) <i>trimmed</i> | 2.7 | 2.77 | 2.86 | |
| | | SVSMHOFF = 0, SVSMHLP = 0, SVSMHTH = 7, DC ($dDV_{CC}/dt < 1 \text{ V/s}$) <i>trimmed</i> | 2.92 | 3.0 | 3.1 | |
| $V_{SVSMH+,HP}$ | SVSMH threshold level; High Performance Mode [rising DV_{CC}] | SVSMHOFF = 0, SVSMHLP = 0, SVSMHTH = 0, DC ($dDV_{CC}/dt < 1 \text{ V/s}$) <i>trimmed</i> | 1.555 | 1.595 | 1.635 | V |
| | | SVSMHOFF = 0, SVSMHLP = 0, SVSMHTH = 1, DC ($dDV_{CC}/dt < 1 \text{ V/s}$) <i>trimmed</i> | 1.585 | 1.625 | 1.665 | |
| | | SVSMHOFF = 0, SVSMHLP = 0, SVSMHTH = 2, DC ($dDV_{CC}/dt < 1 \text{ V/s}$) <i>trimmed</i> | 1.605 | 1.655 | 1.71 | |
| | | SVSMHOFF = 0, SVSMHLP = 0, SVSMHTH = 3, DC ($dDV_{CC}/dt < 1 \text{ V/s}$) <i>trimmed</i> | 2.015 | 2.065 | 2.12 | |
| | | SVSMHOFF = 0, SVSMHLP = 0, SVSMHTH = 4, DC ($dDV_{CC}/dt < 1 \text{ V/s}$) <i>trimmed</i> | 2.215 | 2.265 | 2.32 | |
| | | SVSMHOFF = 0, SVSMHLP = 0, SVSMHTH = 5, DC ($dDV_{CC}/dt < 1 \text{ V/s}$) <i>trimmed</i> | 2.415 | 2.475 | 2.54 | |
| | | SVSMHOFF = 0, SVSMHLP = 0, SVSMHTH = 6, DC ($dDV_{CC}/dt < 1 \text{ V/s}$) <i>trimmed</i> | 2.715 | 2.785 | 2.86 | |
| | | SVSMHOFF = 0, SVSMHLP = 0, SVSMHTH = 7, DC ($dDV_{CC}/dt < 1 \text{ V/s}$) <i>trimmed</i> | 2.935 | 3.015 | 3.1 | |

PSS, SVSMH (continued)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|------------------|---|--|------|------|------|------|
| V_{SVSMH_LP} | SVSMH threshold level; Low Power Mode [falling DV _{CC}] | SVSMHOFF = 0, SVSMHLP = 1, SVSMHTH = 0, DC (dDV _{CC} /dt < 1V/s) <i>trimmed</i> | 1.47 | 1.54 | 1.62 | V |
| | | SVSMHOFF = 0, SVSMHLP = 1, SVSMHTH = 1, DC (dDV _{CC} /dt < 1V/s) <i>trimmed</i> | 1.5 | 1.57 | 1.65 | |
| | | SVSMHOFF = 0, SVSMHLP = 1, SVSMHTH = 2, DC (dDV _{CC} /dt < 1V/s) <i>trimmed</i> | 1.55 | 1.62 | 1.71 | |
| | | SVSMHOFF = 0, SVSMHLP = 1, SVSMHTH = 3, DC (dDV _{CC} /dt < 1V/s) <i>trimmed</i> | 2 | 2.09 | 2.18 | |
| | | SVSMHOFF = 0, SVSMHLP = 1, SVSMHTH = 4, DC (dDV _{CC} /dt < 1V/s) <i>trimmed</i> | 2.2 | 2.3 | 2.4 | |
| | | SVSMHOFF = 0, SVSMHLP = 1, SVSMHTH = 5, DC (dDV _{CC} /dt < 1V/s) <i>trimmed</i> | 2.4 | 2.51 | 2.62 | |
| | | SVSMHOFF = 0, SVSMHLP = 1, SVSMHTH = 6, DC (dDV _{CC} /dt < 1V/s) <i>trimmed</i> | 2.7 | 2.82 | 2.94 | |
| | | SVSMHOFF = 0, SVSMHLP = 1, SVSMHTH = 7, DC (dDV _{CC} /dt < 1V/s) <i>trimmed</i> | 2.87 | 3.0 | 3.13 | |
| V_{SVSMH_hys} | SVSMH hysteresis | | | 15 | | mV |
| $t_{PD,SVSMH}$ | SVS _H propagation delay, high-performance mode | SVSMHOFF = 0, SVSMHLP = 0, very fast dV _{DVCC} /dt | | 2 | 10 | μs |
| | SVS _H propagation delay, low-power mode | SVSMHOFF = 0, SVSMHLP = 1, very fast dV _{DVCC} /dt | | 15 | 100 | |
| $t_{(SVSMH)}$ | SVSMH on or off delay time | SVSMHOFF = 1 → 0 SVSMHLP = 0 ⁽¹⁾ | | 17 | 40 | μs |

- (1) If the SVSMH is kept disabled in active mode and is enabled before entering a low-power mode of the device (LPM3, LPM4, LPM3.5, or LPM4.5) care should be taken that sufficient time has elapsed since enabling of the module before entry into the device low-power mode to allow for successful wakeup of SVSMH module as per the SVSMH on or off delay time specification. Otherwise, SVSMH may trip, causing device to get a Reset & wakeup from the Low Power Mode.

Table 5-32. PSS, SVSL

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|---------------------|---|--|-----|-----|-----|------|
| $I_{SVSL,leak}$ | SVS _L leakage current consumption, power down | SVSLOFF = 1 | | 0.1 | 10 | nA |
| $I_{SVSL-DVCC,LP}$ | SVS _L current consumption, low-power mode, from DV _{CC} | SVSLOFF = 0, SVSLLP = 1 | | 110 | 200 | nA |
| $I_{SVSL-VCORE,LP}$ | SVS _L current consumption, low-power mode, from V _{CORE} | | | 95 | 200 | |
| $I_{SVSL-DVCC,HP}$ | SVS _L current consumption, high-performance mode, from DV _{CC} | SVSLOFF = 0, SVSLLP = 0 | | 1.5 | 2 | μA |
| $I_{SVSL-VCORE,HP}$ | SVS _L current consumption, high-performance mode, from V _{CORE} | | | 1.5 | 3 | |
| $t_{PD,SVSL, AM}$ | SVS _L propagation delay, high-performance mode | SVSLOFF = 0, SVSLLP = 0, very fast dV _{VCORE} /dt | | 2 | 10 | μs |
| | SVS _L propagation delay, low-power mode | SVSLOFF = 0, SVSLLP = 1, very fast dV _{VCORE} /dt | | 16 | 100 | |
| $t_{(SVSL)}$ | SVS _L on or off delay time | SVSLOFF = 0 → 1, SVSLLP = 0 | | 16 | 40 | μs |

5.10.5 Digital I/Os

Table 5-33. Digital Inputs (Applies to Both Normal and High-Drive I/Os)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|---|---|-----------------|------|-----|------|------|
| V _{IT+} Positive-going input threshold voltage | | 2.2 V | 0.99 | | 1.65 | V |
| | | 3 V | 1.35 | | 2.25 | |
| V _{IT-} Negative-going input threshold voltage | | 2.2 V | 0.55 | | 1.21 | V |
| | | 3 V | 0.75 | | 1.65 | |
| V _{hys} Input voltage hysteresis (V _{IT+} – V _{IT-}) | | 2.2 V | 0.32 | | 0.84 | V |
| | | 3 V | 0.4 | | 1.0 | |
| R _{Pull} Pullup or pulldown resistor | For pullup: V _{IN} = V _{SS} For pulldown: V _{IN} = V _{CC} | | 20 | 35 | 50 | kΩ |
| C _{I,dig} Input capacitance, digital only port pins | V _{IN} = V _{SS} or V _{CC} | | | 3 | | pF |
| C _{I,ana} Input capacitance, port pins shared with analog functions | V _{IN} = V _{SS} or V _{CC} | | | 5 | | pF |
| I _{Ikg,ndio} Normal I/O high-impedance input leakage current (refer also to and) | (1) (2) | 2.2 V, 3 V | –20 | | +20 | nA |
| I _{Ikg,hdio} High-drive I/O high-impedance input leakage current (refer also to and) | (1) (2) | 2.2 V, 3 V | –20 | | +20 | nA |
| t _{int} External interrupt timing (external trigger pulse duration to set interrupt flag) ⁽³⁾ | Ports with interrupt capability and without glitch filter | 2.2 V, 3 V | 20 | | | ns |
| | Ports with interrupt capability and with glitch filter but glitch filter disabled (GLTFLT_EN = 0) | 2.2 V, 3 V | 20 | | | ns |
| | Ports with interrupt capability and with glitch filter, Glitch filter enabled (GLTFTL_EN = 1) | 2.2 V, 3 V | 2 | | | μs |
| t _{RST} External reset pulse duration on RSTn pin ⁽⁴⁾ | | 2.2 V, 3 V | 2 | | | μs |

(1) The input leakage current is measured with V_{SS} or V_{CC} applied to the corresponding pins, unless otherwise noted.

(2) The input leakage of the digital port pins is measured individually. The port pin is selected for input and the pullup/pulldown resistor is disabled.

(3) An external signal sets the interrupt flag every time the minimum interrupt pulse duration t_{int} is met. It may be set by trigger signals shorter than t_{int}.

(4) Not applicable if RSTn/NMI pin configured as NMI.

Table 5-34. Digital Outputs, Normal I/Os

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | MAX | UNIT |
|---|--|-----------------|------------------------|------------------------|------|
| V _{OH} High-level output voltage | I _(OHmax) = –1 mA ⁽¹⁾ | 2.2 V | V _{CC} – 0.25 | V _{CC} | V |
| | I _(OHmax) = –3 mA ⁽²⁾ | | V _{CC} – 0.60 | V _{CC} | |
| | I _(OHmax) = –2 mA ⁽¹⁾ | 3.0 V | V _{CC} – 0.25 | V _{CC} | |
| | I _(OHmax) = –6 mA ⁽²⁾ | | V _{CC} – 0.60 | V _{CC} | |
| V _{OL} Low-level output voltage | I _(OLmax) = 1 mA ⁽¹⁾ | 2.2 V | V _{SS} | V _{SS} + 0.25 | V |
| | I _(OLmax) = 3 mA ⁽²⁾ | | V _{SS} | V _{SS} + 0.60 | |
| | I _(OLmax) = 2 mA ⁽¹⁾ | 3.0 V | V _{SS} | V _{SS} + 0.25 | |
| | I _(OLmax) = 6 mA ⁽²⁾ | | V _{SS} | V _{SS} + 0.60 | |
| f _{Px,y} Port output frequency (with RC load) ⁽³⁾ | V _{CORE} = 1.4 V, C _L = 20 pF, R _L ^{(4) (5)} | 1.62 V | 20 | | MHz |
| | | 2.2 V | 24 | | |
| | | 3.0 V | 24 | | |
| d _{Px,y} Port output duty cycle (with RC Load) | V _{CORE} = 1.4 V, C _L = 20 pF, R _L ^{(4) (5)} | 1.62 V | 40% | 60% | |
| | | 2.2 V | 40% | 60% | |
| | | 3.0 V | 45% | 55% | |
| f _{Port_CLK} Clock output frequency ⁽³⁾ | V _{CORE} = 1.4 V, C _L = 20 pF ⁽⁵⁾ | 1.62 V | 20 | | MHz |
| | | 2.2 V | 24 | | |
| | | 3.0 V | 24 | | |
| d _{Port_CLK} Clock output duty cycle | V _{CORE} = 1.4 V, C _L = 20 pF ⁽⁵⁾ | 1.62 V | 40% | 60% | |
| | | 2.2 V | 40% | 60% | |
| | | 3.0 V | 45% | 55% | |
| t _{rise,dig} Port output rise time, digital only port pins | C _L = 20 pF ⁽⁶⁾ | 1.62 V | | 8 | ns |
| | | 2.2 V | | 5 | |
| | | 3.0 V | | 3 | |
| t _{fall,dig} Port output fall time, digital only port pins | C _L = 20 pF ⁽⁷⁾ | 1.62 V | | 8 | ns |
| | | 2.2 V | | 5 | |
| | | 3.0 V | | 3 | |
| t _{rise,ana} Port output rise time, port pins with shared analog functions | C _L = 20 pF ⁽⁶⁾ | 1.62 V | | 8 | ns |
| | | 2.2 V | | 5 | |
| | | 3.0 V | | 3 | |
| t _{fall,ana} Port output fall time, port pins with shared analog functions | C _L = 20 pF ⁽⁷⁾ | 1.62 V | | 8 | ns |
| | | 2.2 V | | 5 | |
| | | 3.0 V | | 3 | |

- (1) The maximum total current, I_(OHmax) and I_(OLmax), for all outputs combined should not exceed ±48 mA to hold the maximum voltage drop specified.
- (2) The maximum total current, I_(OHmax) and I_(OLmax), for all outputs combined should not exceed ±100 mA to hold the maximum voltage drop specified.
- (3) The port can output frequencies at least up to the specified limit - it might support higher frequencies.
- (4) A resistive divider with 2 × R1 and R1 = 3.2kΩ between V_{CC} and V_{SS} is used as load. The output is connected to the center tap of the divider. C_L = 20pF is connected to the output to V_{SS}.
- (5) The output voltage reaches at least 20% and 80% V_{CC} at the specified toggle frequency.
- (6) Measured between 20% of V_{CC} to 80% of V_{CC}.
- (7) Measured between 80% of V_{CC} to 20% of V_{CC}.

Table 5-35. Digital Outputs, High-Drive I/Os

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | MAX | UNIT |
|---|--|-----------------|------------------------|------------------------|------|
| V _{OH} High-level output voltage | I _(OHmax) = -5 mA ⁽¹⁾ | 2.2 V | V _{CC} - 0.25 | V _{CC} | V |
| | I _(OHmax) = -15 mA ⁽²⁾ | | V _{CC} - 0.60 | V _{CC} | |
| | I _(OHmax) = -10 mA ⁽¹⁾ | 3.0 V | V _{CC} - 0.25 | V _{CC} | |
| | I _(OHmax) = -20 mA ⁽²⁾ | | V _{CC} - 0.30 | V _{CC} | |
| V _{OL} Low-level output voltage | I _(OLmax) = 5 mA ⁽¹⁾ | 2.2 V | V _{SS} | V _{SS} + 0.25 | V |
| | I _(OLmax) = 15 mA ⁽²⁾ | | V _{SS} | V _{SS} + 0.60 | |
| | I _(OLmax) = 10 mA ⁽¹⁾ | 3.0 V | V _{SS} | V _{SS} + 0.25 | |
| | I _(OLmax) = 20 mA ⁽²⁾ | | V _{SS} | V _{SS} + 0.30 | |
| f _{Px,y} Port output frequency (with RC load) ⁽³⁾ | V _{CORE} = 1.4 V, C _L = 20 pF, R _L ^{(4) (5)} | 1.62 V | 24 | | MHz |
| | | 2.2 V | 24 | | |
| | | 3.0 V | 24 | | |
| d _{Px,y} Port output duty cycle (with RC Load) | V _{CORE} = 1.4 V, C _L = 20 pF, R _L ^{(4) (5)} | 1.62 V | 40% | 60% | |
| | | 2.2 V | 45% | 55% | |
| | | 3.0 V | 45% | 55% | |
| f _{Port_CLK} Clock output frequency ⁽³⁾ | V _{CORE} = 1.4 V, C _L = 20 pF ⁽⁵⁾ | 1.62 V | 24 | | MHz |
| | | 2.2 V | 24 | | |
| | | 3.0 V | 24 | | |
| d _{Port_CLK} Clock output duty cycle | V _{CORE} = 1.4 V, C _L = 20 pF ⁽⁵⁾ | 1.62 V | 40% | 60% | |
| | | 2.2 V | 45% | 55% | |
| | | 3.0 V | 45% | 55% | |
| t _{rise} Port output rise time | C _L = 20 pF ⁽⁶⁾ | 1.62 V | | 8 | ns |
| | | 2.2 V | | 5 | |
| | | 3.0 V | | 3 | |
| t _{fall} Port output fall time | C _L = 20 pF ⁽⁷⁾ | 1.62 V | | 8 | ns |
| | | 2.2 V | | 5 | |
| | | 3.0 V | | 3 | |

(1) The maximum total current, I_(OHmax) and I_(OLmax), for all outputs combined should not exceed ±48 mA to hold the maximum voltage drop specified.(2) The maximum total current, I_(OHmax) and I_(OLmax), for all outputs combined should not exceed ±100 mA to hold the maximum voltage drop specified.

(3) The port can output frequencies at least up to the specified limit - it might support higher frequencies.

(4) A resistive divider with 2 × R1 and R1 = 3.2kΩ between V_{CC} and V_{SS} is used as load. The output is connected to the center tap of the divider. C_L = 20pF is connected to the output to V_{SS}.(5) The output voltage reaches at least 20% and 80% V_{CC} at the specified toggle frequency.(6) Measured between 20% of V_{CC} to 80% of V_{CC}.(7) Measured between 80% of V_{CC} to 20% of V_{CC}.**Table 5-36. Pin-Oscillator Frequency, Ports Px**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|---|---|-----------------|-----|------|-----|------|
| f _{OPx,y} Pin-Oscillator Frequency | Px.y, C _L = 10 pF ⁽¹⁾ | 3.0 V | | 2000 | | kHz |
| | Px.y, C _L = 20 pF ⁽¹⁾ | 3.0 V | | 1300 | | kHz |

(1) C_L is the external load capacitance connected from the output to V_{SS} and includes all parasitic effects such as PCB traces.

5.10.6 14-Bit ADC

Table 5-37. 14-Bit ADC, Power Supply and Input Range Conditions

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | V _{CC} | MIN | NOM | MAX | UNIT |
|-----------------------------------|---|---|-----------------|------|-------|------|------|
| AV _{CC} | Analog supply voltage | AVCC and DVCC are connected together, AVSS and DVSS are connected together, V(AVSS) = V(DVSS) = 0 V, ADC14PWRMD = 2 | | 1.62 | | 3.7 | V |
| AV _{CC} | Analog supply voltage | AVCC and DVCC are connected together, AVSS and DVSS are connected together, V(AVSS) = V(DVSS) = 0 V, ADC14PWRMD = 0 | | 1.8 | | 3.7 | V |
| V(A _x) | Analog input voltage range ⁽¹⁾ | All ADC14 analog input pins A _x | | 0 | | AVCC | V |
| I(ADC14) single- ended mode | Operating supply current into AVCC plus DVCC terminal ⁽²⁾ | f _{ADC14CLK} = 25 MHz, 1 Msps (ADC14PWRMD = 0), ADC14ON = 1, ADC14DIF = 0, ADC14VRSEL = 1110 ⁽³⁾ , REFON = 0, ADC14SHT0x = 0, ADC14SHT1x = 0 | 3.0 V | | 375 | TBD | μA |
| | | | 2.2 V | | 355 | TBD | |
| | | f _{ADC14CLK} = 5 MHz, 200 ksps (ADC14PWRMD = 2), ADC14ON = 1, ADC14DIF = 0, ADC14VRSEL = 1110 ⁽³⁾ , REFON = 0, ADC14SHT0x = 0, ADC14SHT1x = 0 | 3.0 V | | 175 | TBD | |
| | | | 2.2 V | | 170 | TBD | |
| I(ADC14) differential mode | Operating supply current into AVCC plus DVCC terminal ⁽²⁾ | f _{ADC14CLK} = 25 MHz, 1 Msps (ADC14PWRMD = 0), ADC14ON = 1, ADC14DIF = 1, ADC14VRSEL = 1110 ⁽³⁾ , REFON = 0, ADC14SHT0x = 0, ADC14SHT1x = 0 | 3.0 V | | 535 | TBD | μA |
| | | | 2.2 V | | 495 | TBD | |
| | | f _{ADC14CLK} = 5 MHz, 200 ksps (ADC14PWRMD = 2), ADC14ON = 1, ADC14DIF = 1, ADC14VRSEL = 1110 ⁽³⁾ , REFON = 0, ADC14SHT0x = 0, ADC14SHT1x = 0 | 3.0 V | | 215 | TBD | |
| | | | 2.2 V | | 210 | TBD | |
| Resolution | | | | | 14 | | bits |
| C _I | Input capacitance into a single terminal | | | | 10 | 15 | pF |
| R _I | Input MUX ON-resistance | 0 V ≤ V(A _x) ≤ AVCC | 1.8V - 3.7V | | 0.135 | 1 | kΩ |
| | | | 1.62V - 1.8V | | 0.15 | 1.5 | kΩ |

(1) The analog input voltage range must be within the selected reference voltage range V_{R+} to V_{R-} for valid conversion results.

(2) The internal reference supply current is not included in current consumption parameter I(ADC14).

(3) VeREF- pin should be connected to onboard ground for ADC14VRSEL = 1110.

Table 5-38. 14-Bit ADC, Timing Parameters

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|-----------------------|---|---|-----------------|-------|-----|-----|--------|
| f _{ADC14CLK} | For specified performance of ADC14 linearity parameters | 1 Msps, ADC14PWRMD = 0 | 1.8 V to 3.7 V | | 25 | | MHz |
| | | 200 ksps, ADC14PWRMD = 2 | 1.62 V to 3.7 V | | 5 | | |
| N _{CONVERT} | Clock cycles for conversion | ADC14RES = 11 | | | 16 | | cycles |
| | | ADC14RES = 10 | | | 14 | | |
| | | ADC14RES = 01 | | | 11 | | |
| | | ADC14RES = 00 | | | 9 | | |
| t _{ADC14ON} | Turnon settling time of the ADC | See ⁽¹⁾ | | | | 100 | ns |
| t _{Sample} | Sampling time ⁽²⁾ | R _S = 200 Ω, C _S = 10pF | | 0.215 | | | μs |

(1) The condition is that the error in a conversion started after t_{ADC14ON} is less than ±0.5 LSB. The reference and input signal are already settled.(2) Sampling time should be at-least 4x 1/f_{ADC14CLK}.**Table 5-39. 14-Bit ADC, Linearity Parameters, LDO Operation**

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|----------------|------------------------------------|--|-----------------|-------|-------|-----|------|
| SINAD | With single-ended input | 1Msps, ADC14DIF = 0, ADC14VRSEL = 1110 ⁽¹⁾ , 2.5-V reference, 20-kHz input sine | 1.8 V to 3.7 V | TBD | 75 | | dB |
| | With differential input | 1Msps, ADC14DIF = 1, ADC14VRSEL = 1110 ⁽¹⁾ , 2.5-V reference, 20-kHz input sine | 1.8 V to 3.7 V | TBD | 80 | | |
| ENOB | With single-ended input | 1Msps, ADC14DIF = 0, ADC14VRSEL = 1110 ⁽¹⁾ , 2.5-V reference, 20-kHz input sine | 1.8 V to 3.7 V | TBD | 12.1 | | bit |
| | With differential input | 1Msps, ADC14DIF = 1, ADC14VRSEL = 1110 ⁽¹⁾ , 2.5-V reference, 20-kHz input sine | 1.8 V to 3.7 V | TBD | 13 | | |
| E _I | Integral linearity error (INL) | 1.45 V ≤ V _{R+} - V _{R-} ≤ AVCC | | -2.0 | | 2.0 | LSB |
| | | 1.2 V < V _{R+} - V _{R-} < 1.45 | | TBD | | TBD | |
| E _D | Differential linearity error (DNL) | | | -0.99 | | 1.0 | LSB |
| E _O | Offset error | | | -0.7 | ±0.35 | 0.7 | mV |
| E _G | Gain error | | | -2.0 | ±1 | 2.0 | LSB |
| E _T | Total unadjusted error | | | -10 | ±TBD | 10 | LSB |

(1) VeREF- pin should be connected to onboard ground for ADC14VRSEL = 1110.

Table 5-40. 14-Bit ADC, Temperature Sensor and Built-In $V_{1/2}$

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V_{CC} | MIN | TYP | MAX | UNIT |
|--|---|----------|-----|-----|-----|----------------------|
| V_{SENSOR} See ⁽¹⁾ ⁽²⁾ | ADC14ON = 1, ADC14TCMAP = 1, $T_A = 0^\circ\text{C}$ | | | 730 | | mV |
| TC_{SENSOR} See ⁽²⁾ | ADC14ON = 1, ADC14TCMAP = 1 | | | 1.9 | | mV/ $^\circ\text{C}$ |
| $t_{SENSOR(sa\ sample)}$ Sample time required if ADCTCMAP = 1 and channel MAX-1 is selected ⁽³⁾ | ADC14ON = 1, ADC14TCMAP = 1, Error of conversion result ≤ 1 LSB | | | 5 | | μs |
| $V_{1/2}$ AVCC voltage divider for ADC14BATMAP = 1 on MAX input channel | ADC14ON = 1, ADC14BATMAP = 1 | | 48% | 50% | 52% | |
| $t_{V\ 1/2\ (sample)}$ Sample time required if ADC14BATMAP = 1 and channel MAX is selected ⁽⁴⁾ | ADC14ON = 1, ADC14BMAP = 1 | | | 1 | | μs |

(1) The temperature sensor offset can be as much as $\pm 20^\circ\text{C}$. TI recommends a single-point calibration to minimize the offset error of the built-in temperature sensor.

(2) The TLV structure contains calibration values for $30^\circ\text{C} \pm 3^\circ\text{C}$ and $85^\circ\text{C} \pm 3^\circ\text{C}$ for each of the available reference voltage levels. The sensor voltage can be computed as $V_{SENSE} = TC_{SENSOR} \times (\text{Temperature}, ^\circ\text{C}) + V_{SENSOR}$, where TC_{SENSOR} and V_{SENSOR} can be computed from the calibration values for higher accuracy.

(3) The typical equivalent impedance of the sensor is 250 k Ω . The sample time required includes the sensor-on time $t_{SENSOR(on)}$.

(4) The on-time $t_{V1/2(on)}$ is included in the sampling time $t_{V\ 1/2\ (sample)}$. No additional on time is needed.

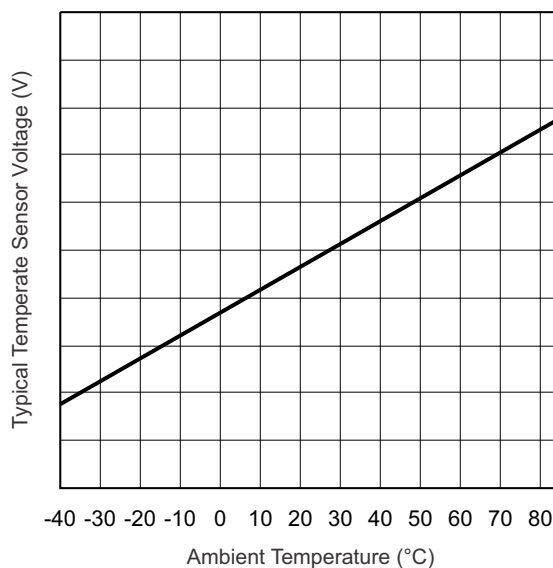


Figure 5-2. Typical Temperature Sensor Voltage

Table 5-41. 14-Bit ADC, Internal Reference Buffers

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V_{CC} | MIN | TYP | MAX | UNIT |
|--|--|----------|-----|-----|------|---------------|
| I_{REF+} Operating supply current into AVCC terminal ⁽¹⁾ | ADC ON, REFOUT = 0, ADC14PWRMD = 0, REFVSEL = {0, 1, 3} | 3 V | | 600 | 1000 | μA |
| | ADC ON, REFOUT = 0, ADC14PWRMD = 2, REFVSEL = {0, 1, 3} | 3 V | | 200 | 360 | |
| | ADC ON, REFOUT = 1, ADC14PWRMD = 2, REFVSEL = {0, 1, 3} | 3 V | | 560 | 870 | |
| t_{on} Time to turn on | | 3V | | | 5 | μs |

(1) The internal reference current is supplied via terminal AVCC.

Table 5-42. 14-Bit ADC, External Reference

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|------------------------------|---|--|------------------|-----|------------------|------|
| V_{eREF+} | Positive external reference voltage input | $V_{eREF+} > V_{eREF-}$ ⁽¹⁾ | 1.45 | | AV_{CC} | V |
| V_{eREF-} | Negative external reference voltage input | $V_{eREF+} > V_{eREF-}$ ⁽²⁾ | 0 | | $AV_{CC} - 1.45$ | V |
| $(V_{eREF+} - V_{eREF-})$ | Differential external reference voltage input | $V_{eREF+} > V_{eREF-}$ ⁽³⁾ | 1.45 | | AV_{CC} | V |
| I_{VeREF+} I_{VeREF-} | Static input current single ended input mode | $1.45\text{ V} \leq V_{eREF+} \leq V_{AVCC}$, $V_{eREF-} = 0\text{ V}$, $f_{ADC14CLK} = 25\text{ MHz}$, $ADC14SHTx = 1h$, $ADC14DIF = 0$, Conversion rate 1 Msps | -45 | | 45 | uA |
| | | $1.45\text{ V} \leq V_{eREF+} \leq V_{AVCC}$, $V_{eREF-} = 0\text{ V}$, $f_{ADC14CLK} = 5\text{ MHz}$, $ADC14SHTx = 1h$, $ADC14DIF = 0$, Conversion rate 200 ksps | -9 | | 9 | μA |
| I_{VeREF+} I_{VeREF-} | Static input current differential input mode | $1.45\text{ V} \leq V_{eREF+} \leq V_{AVCC}$, $V_{eREF-} = 0\text{ V}$, $f_{ADC14CLK} = 25\text{ MHz}$, $ADC14SHTx = 1h$, $ADC14DIF = 1$, Conversion rate 1Msps | -90 | | 90 | uA |
| | | $1.45\text{ V} \leq V_{eREF+} \leq V_{AVCC}$, $V_{eREF-} = 0\text{ V}$, $f_{ADC14CLK} = 5\text{ MHz}$, $ADC14SHTx = 1h$, $ADC14DIF = 1$, Conversion rate 200ksps | -18 | | 18 | uA |
| I_{VeREF+} | Peak input current single ended input mode | $0\text{ V} \leq V_{eREF+} \leq V_{AVCC}$, $ADC14DIF = 0$ | | | TBD | mA |
| I_{VeREF+} | Peak input current differential input mode | $0\text{ V} \leq V_{eREF+} \leq V_{AVCC}$, $ADC14DIF = 1$ | | | TBD | mA |
| $C_{VeREF\pm}$ | Capacitance at $VeREF\pm$ terminal | | ⁽⁴⁾ 5 | | | μF |
| PSRR_DC | Power supply rejection ratio (DC) | $AV_{CC} = AV_{CC}(\text{min}) - AV_{CC}(\text{max})$ $T_A = 25^\circ\text{C}$ | | | TBD | μV/V |
| PSRR_AC | Power supply rejection ratio (AC) | $dAV_{CC} = 0.1\text{V}$ at 1 kHz | | TBD | | mV/V |

- (1) The accuracy limits the minimum positive external reference voltage. Lower reference voltage levels down to 1.2 V may be applied with reduced accuracy requirements for DNL, INL and SNR at 1 Msps or for ≤500-ksps specified accuracy can still be achieved.
- (2) The accuracy limits the maximum negative external reference voltage. For 1-Msps, higher reference voltage levels up to $AV_{CC} - 1.2\text{ V}$ may be applied with reduced speed and accuracy, or for ≤500 ksps, specified accuracy can still be achieved.
- (3) The accuracy limits minimum external differential reference voltage. Lower differential reference voltage levels may be applied with reduced accuracy requirements.
- (4) Two decoupling capacitors, 5 μF and 50 nF, should be connected to $VeREF$ to decouple the dynamic current required for an external reference source if it is used for the ADC14. See also the *MSP432P4xx Family Technical Reference Manual* ([SLAU356](#)).

5.10.7 REF_A

Table 5-43. REF_A, Built-In Reference

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|-----------------------------------|---|-----------------|------|------|------|--------|
| V _{REF+} | REFVSEL = {0} for 1.2 V REFON = 1 | 1.62 V | | 1.2 | ±1% | V |
| | REFVSEL = {1} for 1.45 V REFON = 1 | 1.75 V | | 1.45 | ±1% | |
| | REFVSEL = {2} for 2.0 V REFON = 1 | 2.3 V | | 2.0 | ±1% | |
| | REFVSEL = {3} for 2.5 V REFON = 1 | 2.8 V | | 2.5 | ±1% | |
| AV _{CC(min)} | REFVSEL = {0} for 1.2 V | | 1.62 | | | V |
| | REFVSEL = {1} for 1.45 V | | 1.75 | | | |
| | REFVSEL = {2} for 2.0 V | | 2.3 | | | |
| | REFVSEL = {3} for 2.5 V | | 2.8 | | | |
| I _{REF+} | Operating supply current into AVCC terminal ⁽¹⁾ REFON = 1 | 3 V | | 12 | 20 | μA |
| I _{L(VREF+)} | Load-current regulation, VREF+ terminal REFVSEL = {0, 1, 2, 3}, I(VREF+) = +10 μA/–1000 μA, AVCC = AVCC(min) for each reference level, REFON = REFOUT = 1 | | | | 2500 | μV/mA |
| C _{VREF±} | Capacitance at VREF+, VREF- terminals REFON = REFOUT = 1 | | 0 | | 100 | pF |
| PSRR_DC REFOUT0 | Power supply rejection ratio (DC) after ADC buffer AVCC = AVCC(min) for each reference level, REFVSEL = {0,1,2, 3}, REFON = 1, REFOUT = 0 | | | 120 | 300 | μV/V |
| PSRR_DC REFOUT1 | Power supply rejection ratio (DC) after ADC buffer AVCC = AVCC(min) for each reference level, REFVSEL = {0,1,2, 3}, REFON = 1, REFOUT = 1 | | | 50 | 100 | μV/V |
| PSRR_AC REFOUT0 | Power supply rejection ratio (AC) after ADC buffer AVCC = AVCC(min) for each reference level, dAVCC = 0.1V at 1 kHz, REFVSEL = {0,1,2, 3}, REFON = 1, REFOUT = 0 | | | 6.4 | 10 | mV/V |
| PSRR_AC REFOUT1 | Power supply rejection ratio (AC) after ADC buffer AVCC = AVCC(min) for each reference level, dAVCC = 0.1V at 1 kHz, REFVSEL = {0,1,2, 3}, REFON = 1, REFOUT = 1 | | | 2 | 5 | mV/V |
| TC _{REF+} ⁽²⁾ | Temperature coefficient of built-in reference REFVSEL = {0, 1, 2, 3}, REFON = 1, T _A = –40°C to 85°C | | | <10 | 20 | ppm/°C |
| TC _{REF+} ⁽²⁾ | Temperature coefficient of built-in reference REFVSEL = {0, 1, 2, 3}, REFON = 1, T _A = 0°C to 50°C | | | <5 | 15 | ppm/°C |
| t _{SETTLE} | Settling time of reference voltage ⁽³⁾ AV _{CC} = AV _{CC(min)} – AV _{CC(max)} REFVSEL = {0, 1, 2, 3}, REFON = 0 → 1 | | | 75 | 90 | μs |

(1) The internal reference current is supplied from terminal AVCC.

(2) Calculated using the box method: (MAX(–40°C to 85°C) – MIN(–40°C to 85°C)) / MIN(–40°C to 85°C)/(85°C – (–40°C)).

(3) The condition is that the error in a ADC conversion started after t_{SETTLE} is less than ±0.5 LSB.

5.10.8 Comparator_E

Table 5-44. Comparator_E

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|------------------------|---|---|-----------------|------|-----|--------------------|------|
| V _{CC} | Supply voltage | | | 1.62 | | 3.7 | V |
| I _{AVCC_COMP} | Comparator operating supply current into AVCC, Excludes reference resistor ladder | CMPPWRMD = 00, CMPON = 1, CMPRSx = 00 (fast) | 2.2 V, 3 V | | 11 | 15 | μA |
| | | CMPPWRMD = 01, CMPON = 1, CMPRSx = 00 (medium) | 2.2 V, 3 V | | 6.5 | 10 | |
| | | CMPPWRMD = 10, CMPON = 1, CMPRSx = 00 (slow), T _A = 30°C | 2.2 V, 3 V | | | 0.5 | |
| | | CMPPWRMD = 10, CMPON = 1, CMPRSx = 00 (slow), T _A = 85°C | 2.2 V, 3 V | | | 1.2 | |
| I _{AVCC_REF} | Quiescent current of resistor ladder into AVCC, Includes REF_A module current | CMPPREFACC = 0, CMPREFLx = 01, CMPRSx = 10, REFON = 0, CMPON = 0 | 2.2 V, 3 V | | 15 | 26 | μA |
| | | CMPPREFACC = 1, CMPREFLx = 01, CMPRSx = 10, REFON = 0, CMPON = 0 | 2.2 V, 3 V | | 7 | 10 | |
| V _{REF} | Reference voltage level | CMPPRSx = 11, CMPREFLx = 01, CMPPREFACC = 0 | 1.62 V | 1.17 | 1.2 | 1.23 | V |
| | | CMPPRSx = 11, CMPREFLx = 10, CMPPREFACC = 0 | 2.2 V | 1.95 | 2.0 | 2.05 | |
| | | CMPPRSx = 11, CMPREFLx = 11, CMPPREFACC = 0 | 2.7 V | 2.40 | 2.5 | 2.60 | |
| | | CMPPRSx = 11, CMPREFLx = 01, CMPPREFACC = 1 | 1.62 V | 1.10 | 1.2 | 1.23 | |
| | | CMPPRSx = 11, CMPREFLx = 10, CMPPREFACC = 1 | 2.2 V | 1.90 | 2.0 | 2.05 | |
| | | CMPPRSx = 11, CMPREFLx = 11, CMPPREFACC = 1 | 2.7 V | 2.4 | 2.5 | 2.6 | |
| V _{IC} | Common mode input range | | | 0 | | V _{CC} –1 | V |
| V _{OFFSET} | Input offset voltage | CMPPWRMD = 00 | | –10 | | +10 | mV |
| | | CMPPWRMD = 01 | | –20 | | +20 | |
| | | CMPPWRMD = 10 | | –20 | | +20 | |
| C _{IN} | Input capacitance | CMPPWRMD = 00 or CMPPWRMD = 01 | | | 5 | | pF |
| | | CMPPWRMD = 10 | | | 5 | | pF |
| R _{SIN} | Series input resistance | ON (switch closed) | | | 2 | 4 | kΩ |
| | | OFF (switch opened) | | 50 | | | MΩ |
| t _{PD} | Propagation delay, response time | CMPPWRMD = 00, CMPF = 0, Overdrive = 20 mV | | | 150 | 300 | ns |
| | | CMPPWRMD = 01, CMPF = 0, Overdrive = 20 mV | | | 200 | 400 | |
| | | CMPPWRMD = 10, CMPF = 0, Overdrive = 20 mV | | | 5 | 10 | μs |
| | | CMPPWRMD = 00, CMPF = 0, Overdrive = 100 mV | | | 150 | 300 | ns |
| | | CMPPWRMD = 01, CMPF = 0, Overdrive = 100 mV | | | 200 | 400 | |
| | | CMPPWRMD = 10, CMPF = 0, Overdrive = 100 mV | | | 5 | 10 | μs |
| t _{PD,filter} | Propagation delay with filter active | CMPPWRMD = 00 or 01, CMPF = 1, Overdrive = 20 mV, CMPFDLY = 00 | | | 1.1 | 1.8 | μs |
| | | CMPPWRMD = 00 or 01, CMPF = 1, Overdrive = 20 mV, CMPFDLY = 01 | | | 1.4 | 2.6 | |
| | | CMPPWRMD = 00 or 01, CMPF = 1, Overdrive = 20 mV, CMPFDLY = 10 | | | 2 | 3.5 | |
| | | CMPPWRMD = 00 or 01, CMPF = 1, Overdrive = 20 mV, CMPFDLY = 11 | | | 3 | 5 | |

Comparator_E (continued)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|--|---|-----------------|---------------------------------|-------------------------------|---------------------------------|------|
| t _{EN_CMP} Comparator enable time | CMPON = 0 to CMPON = 1, CMPPWRMD = 00, VIN+, VIN- from pins, Overdrive = 20 mV | | 0.6 | 1 | | μs |
| | CMPON = 0 to CMPON = 1, CMPPWRMD = 01, VIN+, VIN- from pins, Overdrive = 20 mV | | 0.7 | 1 | | |
| | CMPON = 0 to CMPON = 1, CMPPWRMD = 10, VIN+, VIN- from pins, Overdrive = 20 mV | | 20 | 30 | | |
| t _{EN_CMP_VREF} Comparator and reference ladder and reference voltage enable time | CMPON = 0 to CMPON = 1, CMPPWRMD = 00, CMPREFLx = 10, CMPRSx = 11, REFON = 0, Overdrive = 20 mV | | 2 | 3 | | μs |
| | CMPON = 0 to CMPON = 1, CMPPWRMD = 01, CMPREFLx = 10, CMPRSx = 11, REFON = 0, Overdrive = 20 mV | | 2 | 3 | | |
| | CMPON = 0 to CMPON = 1, CMPPWRMD = 10, CMPREFLx = 10, CMPRSx = 11, REFON = 0, Overdrive = 20 mV | | 20 | 30 | | |
| | CMPON = 0 to CMPON = 1, CMPPWRMD = 00, CMPREFLx = 10, CMPRSx = 10, REFON = 0, CMPREF0/1 = 0x0F, Overdrive = 20 mV | | 2.5 | 5 | | |
| | CMPON = 0 to CMPON = 1, CMPPWRMD = 01, CMPREFLx = 10, CMPRSx = 10, REFON = 0, CMPREF0/1 = 0x0F, Overdrive = 20 mV | | 2.5 | 5 | | |
| | CMPON = 0 to CMPON = 1, CMPPWRMD = 10, CMPREFLx = 10, CMPRSx = 10, REFON = 0, CMPREF0/1 = 0x0F, Overdrive = 20 mV | | 20 | 30 | | |
| t _{EN_CMP_RL} Comparator and reference ladder enable time | CMPON = 0 to CMPON = 1, CMPPWRMD = 00, CMPREFLx = 10, CMPRSx = 10, REFON = 1, CMPREF0/1 = 0x0F | | 1 | 2 | | μs |
| | CMPON = 0 to CMPON = 1, CMPPWRMD = 01, CMPREFLx = 10, CMPRSx = 10, REFON = 1, CMPREF0/1 = 0x0F | | 1 | 2 | | |
| | CMPON = 0 to CMPON = 1, CMPPWRMD = 10, CMPREFLx = 10, CMPRSx = 10, REFON = 1, CMPREF0/1 = 0x0F | | 20 | 30 | | |
| V _{CMP_REF} Reference voltage for a given tap | VIN = reference into resistor ladder, n = 0 to 31 | | $\frac{VIN \times (n+0.9)}{32}$ | $\frac{VIN \times (n+1)}{32}$ | $\frac{VIN \times (n+1.1)}{32}$ | V |

5.10.9 eUSCI

Table 5-45. eUSCI (UART Mode), Recommended Operating Conditions

| PARAMETER | TEST CONDITIONS | V _{CORE} | V _{CC} | MIN | TYP | MAX | UNIT |
|--|---|-------------------|-----------------|-----|-----|-----|------|
| f _{eUSCI} eUSCI input clock frequency | Internal: SMCLK External: UCLK Duty cycle = 50% ± 10% | 1.2 V | | | | 12 | MHz |
| | | 1.4 V | | | | 24 | |
| f _{BITCLK} BITCLK clock frequency (equals baud rate in Mbaud) | | 1.2 V | | | | 1 | MHz |
| | | 1.4 V | | | | 3 | |

Table 5-46. eUSCI (UART Mode)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|--|-----------------|-----------------|-----|-----|-----|------|
| t _t UART receive deglitch time ⁽¹⁾ | UCGLITx = 0 | | 10 | | 40 | ns |
| | UCGLITx = 1 | | 25 | | 90 | |
| | UCGLITx = 2 | | 45 | | 140 | |
| | UCGLITx = 3 | | 60 | | 190 | |

- (1) Pulses on the UART receive input (UCxRX) shorter than the UART receive deglitch time are suppressed. Thus the selected deglitch time can limit the max. useable baud rate. To ensure that pulses are correctly recognized, their duration should exceed the maximum specification of the deglitch time.

Table 5-47. eUSCI (SPI Master Mode), Recommended Operating Conditions

| PARAMETER | CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|--|---------------------------------|---------------------------|-----|-----|-----|------|
| f _{eUSCI} eUSCI input clock frequency | SMCLK Duty cycle = 50% ± 10% | V _{CORE} = 1.2 V | | | 12 | MHz |
| | | V _{CORE} = 1.4 V | | | 24 | |

Table 5-48. eUSCI (SPI Master Mode)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)⁽¹⁾

| PARAMETER | TEST CONDITIONS | V _{CORE} | V _{CC} | MIN | TYP | MAX | UNIT |
|--|--|-------------------|-----------------|-----|-----|-----|---------------|
| t _{STE,LEAD} STE lead time, STE active to clock | UCSTEM = 1, UCMODEx = 01 or 10 | | | 1 | | | UCxCLK cycles |
| t _{STE,LAG} STE lag time, Last clock to STE inactive | UCSTEM = 1, UCMODEx = 01 or 10 | | | 1 | | | |
| t _{STE,ACC} STE access time, STE active to SIMO data out | UCSTEM = 0, UCMODEx = 01 or 10 | 1.2 V | 1.62 V | | | 90 | ns |
| | | 1.4 V | 3.7 V | | | 50 | |
| t _{STE,DIS} STE disable time, STE inactive to SIMO high impedance | UCSTEM = 0, UCMODEx = 01 or 10 | 1.2 V | 1.62 V | | | 35 | ns |
| | | 1.4 V | 3.7 V | | | 10 | |
| t _{SU,MI} SOMI input data setup time | | 1.2 V | 1.62 V | 50 | | | ns |
| | | 1.4 V | 3.7 V | 25 | | | |
| t _{HD,MI} SOMI input data hold time | | 1.2 V | 1.62 V | 0 | | | ns |
| | | 1.4 V | 3.7 V | 0 | | | |
| t _{VALID,MO} SIMO output data valid time ⁽²⁾ | UCLK edge to SIMO valid, C _L = 20 pF | 1.2 V | 1.62 V | | | 5 | ns |
| | | 1.4 V | 3.7 V | | | 1 | |
| t _{HD,MO} SIMO output data hold time ⁽³⁾ | C _L = 20 pF | 1.2 V | 1.62 V | 0 | | | ns |
| | | 1.4 V | 3.7 V | 0 | | | |

- (1) f_{UCxCLK} = 1/2t_{LO/Hi} with t_{LO/Hi} = max(t_{VALID,MO}(eUSCI) + t_{SU,SI}(Slave), t_{SU,MI}(eUSCI) + t_{VALID,SO}(Slave)). For the slave parameters t_{SU,SI}(Slave) and t_{VALID,SO}(Slave) refer to the SPI parameters of the attached slave.
- (2) Specifies the time to drive the next valid data to the SIMO output after the output changing UCLK clock edge. Refer to the timing diagrams in [Figure 5-3](#) and [Figure 5-4](#).
- (3) Specifies how long data on the SIMO output is valid after the output changing UCLK clock edge. Negative values indicate that the data on the SIMO output can become invalid before the output changing clock edge observed on UCLK. Refer to the timing diagrams in [Figure 5-3](#) and [Figure 5-4](#).

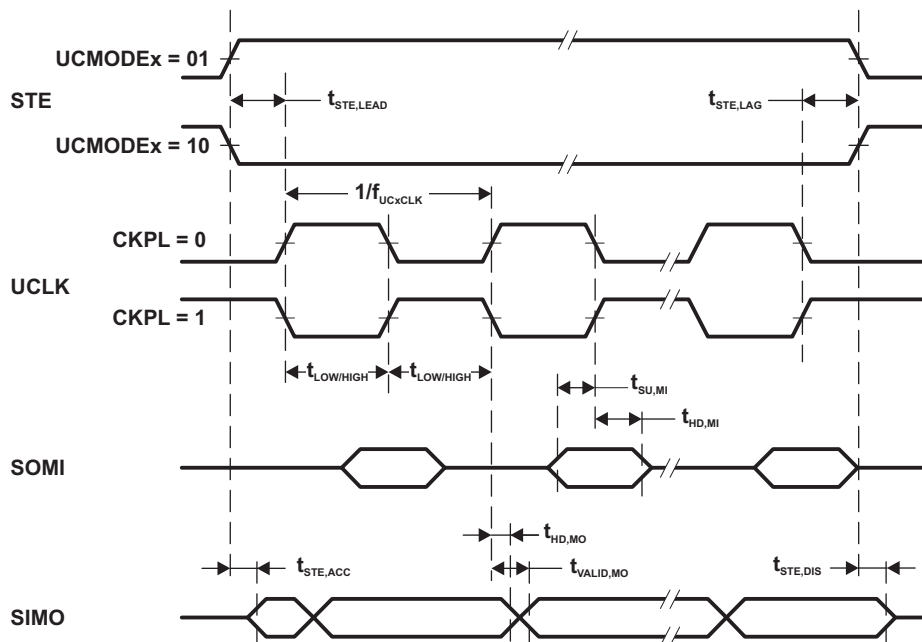


Figure 5-3. SPI Master Mode, CKPH = 0

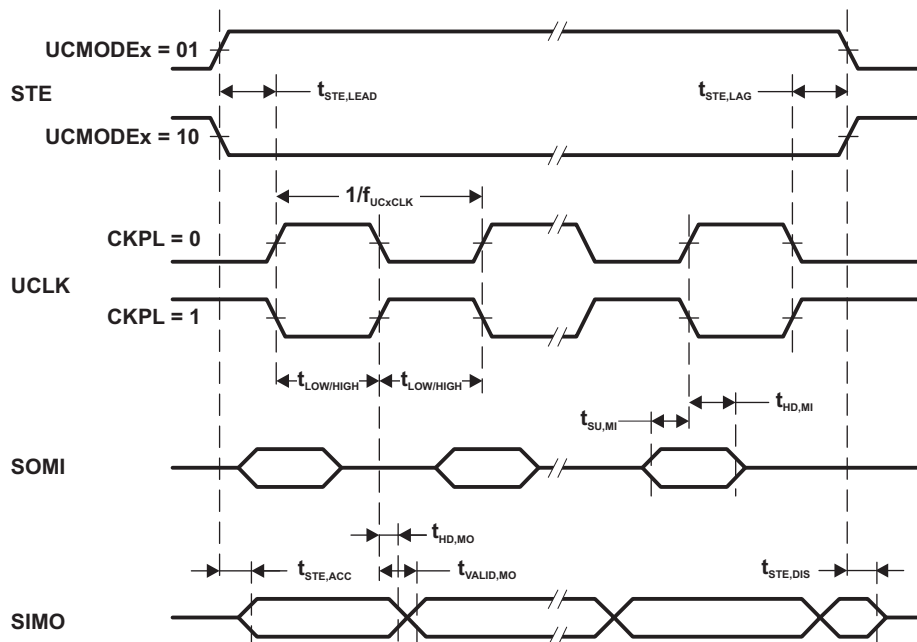


Figure 5-4. SPI Master Mode, CKPH = 1

Table 5-49. eUSCI (SPI Slave Mode)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)
(see Note ⁽¹⁾)

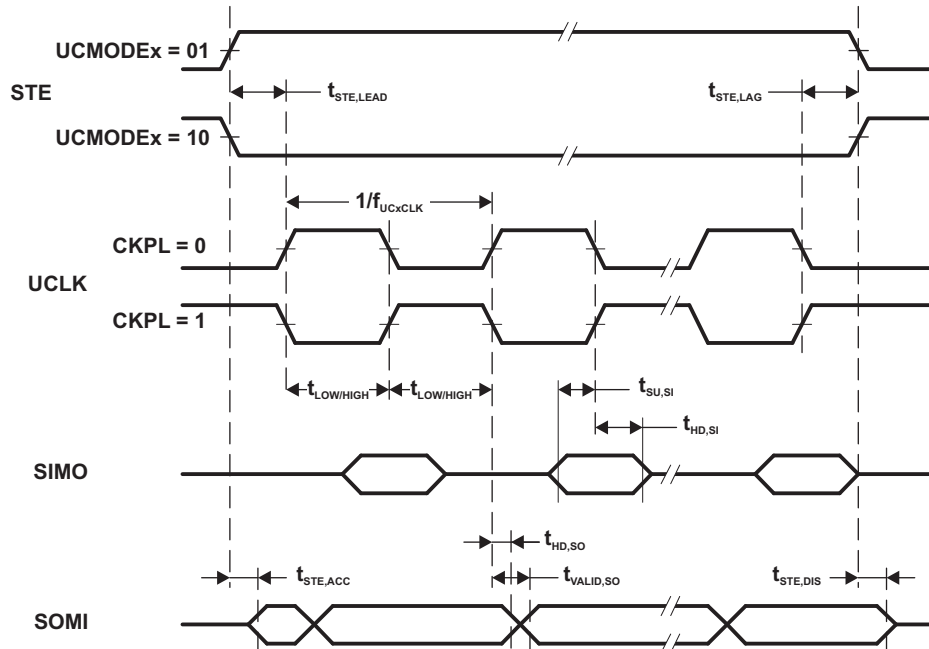
| PARAMETER | TEST CONDITIONS | V _{CORE} | V _{CC} | MIN | TYP | MAX | UNIT |
|--|---|-------------------|-----------------|-----|-----|-----|------|
| t _{STE,LEAD} STE lead time, STE active to clock | | 1.2 V | 1.62 V | 65 | | | ns |
| | | 1.4 V | 3.7 V | 45 | | | |
| t _{STE,LAG} STE lag time, Last clock to STE inactive | | 1.2 V | 1.62 V | 5 | | | ns |
| | | 1.4 V | 3.7 V | 5 | | | |
| t _{STE,ACC} STE access time, STE active to SOMI data out | | 1.2 V | 1.62 V | | | 90 | ns |
| | | 1.4 V | 3.7 V | | | 50 | |
| t _{STE,DIS} STE disable time, STE inactive to SOMI high impedance | | 1.2 V | 1.62 V | | | 30 | ns |
| | | 1.4 V | 3.7 V | | | 10 | |
| t _{SU,SI} SIMO input data setup time | | 1.2 V | 1.62 V | 8 | | | ns |
| | | 1.4 V | 3.7 V | 4 | | | |
| t _{HD,SI} SIMO input data hold time | | 1.2 V | 1.62 V | 7 | | | ns |
| | | 1.4 V | 3.7 V | 6 | | | |
| t _{VALID,SO} SOMI output data valid time ⁽²⁾ | UCLK edge to SOMI valid, C _L = 20 pF | 1.2 V | 1.62 V | | | 50 | ns |
| | | 1.4 V | 3.7 V | | | 10 | |
| t _{HD,SO} SOMI output data hold time ⁽³⁾ | C _L = 20 pF | 1.2 V | 1.62 V | 0 | | | ns |
| | | 1.4 V | 3.7 V | 0 | | | |

(1) $f_{UCxCLK} = 1/2t_{LO/HI}$ with $t_{LO/HI} \geq \max(t_{VALID,MO(Master)} + t_{SU,SI(eUSCI)}, t_{SU,MI(Master)} + t_{VALID,SO(eUSCI)})$.

For the master parameters $t_{SU,MI(Master)}$ and $t_{VALID,MO(Master)}$ refer to the SPI parameters of the attached slave.

(2) Specifies the time to drive the next valid data to the SOMI output after the output changing UCLK clock edge. Refer to the timing diagrams in [Figure 5-5](#) and [Figure 5-6](#).

(3) Specifies how long data on the SOMI output is valid after the output changing UCLK clock edge. Refer to the timing diagrams in [Figure 5-5](#) and [Figure 5-6](#).

**Figure 5-5. SPI Slave Mode, CKPH = 0**

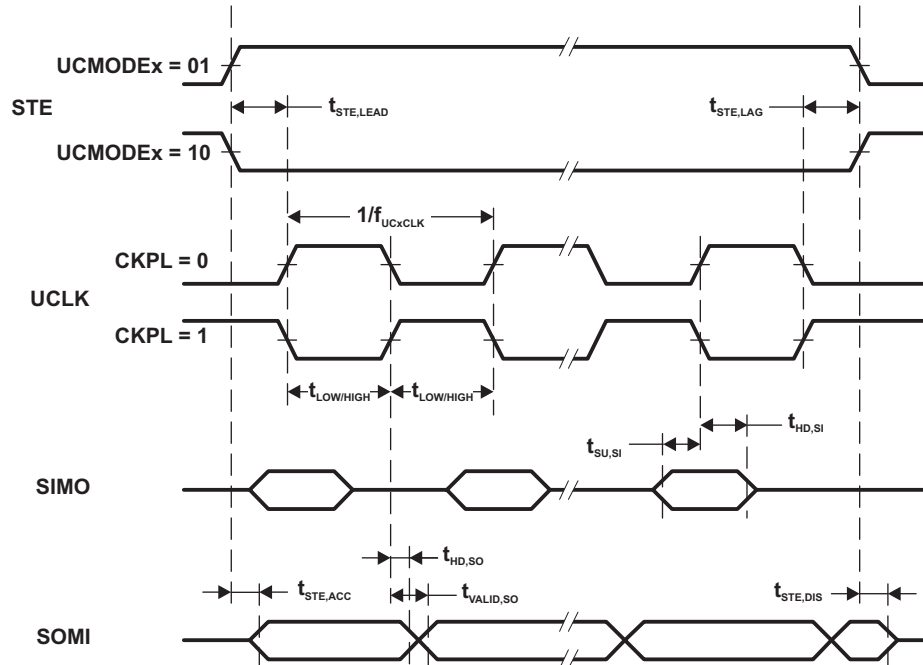


Figure 5-6. SPI Slave Mode, CKPH = 1

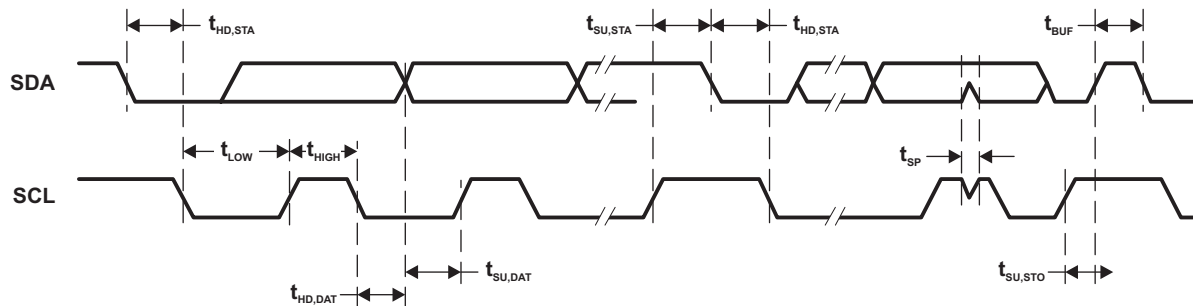
Table 5-50. eUSCI (I²C Mode), Recommended Operating Conditions

| PARAMETER | TEST CONDITIONS | V _{CORE} | V _{CC} | MIN | TYP | MAX | UNIT |
|--------------------|--|-------------------|-----------------|-----|-----|-----|------|
| f _{eUSCI} | eUSCI input clock frequency Internal: SMCLK External: UCLK Duty cycle = 50% ± 10% | 1.2 V | | | | 12 | MHz |
| | | 1.4 V | | | | 24 | |
| f _{SCL} | SCL clock frequency | | | | | 1 | MHz |

Table 5-51. eUSCI (I²C Mode)

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see [Figure 5-7](#))

| PARAMETER | TEST CONDITIONS | V _{CC} | MIN | TYP | MAX | UNIT |
|--|-----------------------------|-----------------|------|-----|-----|---------------|
| $t_{HD,STA}$ Hold time (repeated) START | $f_{SCL} = 100 \text{ kHz}$ | 2.2 V, 3.0 V | 5.0 | | | μs |
| | $f_{SCL} = 400 \text{ kHz}$ | | 1.25 | | | |
| | $f_{SCL} = 1 \text{ MHz}$ | | 500 | | | ns |
| $t_{SU,STA}$ Setup time for a repeated START | $f_{SCL} = 100 \text{ kHz}$ | 2.2 V, 3.0 V | 5.0 | | | μs |
| | $f_{SCL} = 400 \text{ kHz}$ | | 1.25 | | | |
| | $f_{SCL} = 1 \text{ MHz}$ | | 500 | | | ns |
| $t_{HD,DAT}$ Data hold time | $f_{SCL} = 100 \text{ kHz}$ | 2.2 V, 3.0 V | 0 | | | ns |
| | $f_{SCL} = 400 \text{ kHz}$ | | 0 | | | |
| | $f_{SCL} = 1 \text{ MHz}$ | | 0 | | | |
| $t_{SU,DAT}$ Data setup time | $f_{SCL} = 100 \text{ kHz}$ | 2.2 V, 3.0 V | 250 | | | ns |
| | $f_{SCL} = 400 \text{ kHz}$ | | 100 | | | |
| | $f_{SCL} = 1 \text{ MHz}$ | | 50 | | | |
| $t_{SU,STO}$ Setup time for STOP | $f_{SCL} = 100 \text{ kHz}$ | 2.2 V, 3.0 V | 5.0 | | | μs |
| | $f_{SCL} = 400 \text{ kHz}$ | | 1.25 | | | |
| | $f_{SCL} = 1 \text{ MHz}$ | | 500 | | | ns |
| t_{SP} Pulse duration of spikes suppressed by input filter | UCGLITx = 0 | 2.2 V, 3.0 V | 60 | | 200 | ns |
| | UCGLITx = 1 | | 35 | | 110 | |
| | UCGLITx = 2 | | 20 | | 65 | |
| | UCGLITx = 3 | | 10 | | 45 | |
| $t_{TIMEOUT}$ Clock low time-out | UCCLTOx = 1 | 2.2 V, 3.0 V | | 27 | | ms |
| | UCCLTOx = 2 | | | 30 | | |
| | UCCLTOx = 3 | | | 33 | | |

**Figure 5-7. I²C Mode Timing**

5.10.10 Timer_A

Table 5-52. Timer_A

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | V _{CORE} | V _{CC} | MIN | TYP | MAX | UNIT |
|---------------------|-------------------------------|--|-------------------|-----------------|-----|-----|-----|------|
| f _{TA} | Timer_A input clock frequency | Internal: SMCLK External: TACLK Duty cycle = 50% ± 10% | 1.2V | | | | 12 | MHz |
| | | | 1.4V | | | | 24 | |
| t _{TA,cap} | Timer_A capture timing | All capture inputs, Minimum pulse duration required for capture | | | 20 | | | ns |

5.10.11 Memories

Table 5-53. Flash Memory

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|-----------------------------|---|----------------------|-----------------|------|-----|--------|
| DVCC _{PGM/ERS} | Supply voltage for program or erase | | 1.62 | | 3.7 | V |
| I _{PGM/ERS, AVG} | Average supply current from DVCC during program or erase | | | TBD | 35 | mA |
| I _{PGM/ERS, PEAK} | Peak supply current from DVCC during program or erase | | | | 50 | mA |
| N _{Endurance} | Program or erase endurance | | 10 ⁵ | | | cycles |
| t _{Retention} | Data retention duration | T _J = TBD | 20 | | | years |
| t _{word} | Word program time without preverify (VER_PRE = 0) ⁽¹⁾ | | | 37 | 39 | μs |
| t _{word, ver} | Word program time with preverify (VER_PRE = 1) ⁽¹⁾ | | | 62 | 63 | μs |
| t _{block, 0} | Block program time for the first data | | | 11 | 12 | μs |
| t _{block, 1-(N-1)} | Block program time for each additional data, except for last data | | | 8 | 9 | μs |
| t _{block, N} | Block program time for the last data | | | 13 | 14 | μs |
| t _{ERS} | Segment or mass erase time | | | 2.5 | 3 | ms |
| t _{ers2ersver} | Erase to erase verify mode transition time | | | 2 | 3 | μs |
| t _{nr2ersver} | Normal read to erase verify mode transition time | | | 11 | 12 | μs |
| t _{pgm2pgmver} | Program to program verify mode transition time | | | 13.5 | 15 | μs |
| t _{nr2pgmver} | Normal read to program verify mode transition time | | | 13.5 | 15 | μs |

(1) After verify enabled (VER_PST = 1).

Table 5-54. SRAM

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | | TEST CONDITIONS | MIN | TYP | MAX | UNIT |
|----------------------------|--|-----------------|-----|-----|-----|------|
| I _{SRAM_EN} | Current consumption of one SRAM bank when enabled | VCORE = 1.2 V | | 80 | | nA |
| | | VCORE = 1.4 V | | 290 | | |
| I _{SRAM_RET} | Current consumption of one SRAM bank under retention | VCORE = 1.2 V | | 27 | | nA |
| | | VCORE = 1.4 V | | 31 | | |
| t _{SRAM_EN, one} | Time taken to enable one SRAM bank | | | 4 | 5 | μs |
| t _{SRAM_DIS, one} | Time taken to disable one SRAM bank | | | 4 | 5 | μs |
| t _{SRAM_EN, all} | Time taken to enable all SRAM banks except Bank-0 | | | 7 | 8 | μs |
| t _{SRAM_DIS, all} | Time taken to disable all SRAM banks except Bank-0 | | | 4 | 5 | μs |

5.10.12 Emulation and Debug

Table 5-55. JTAG

over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

| PARAMETER | | MIN | TYP | MAX | UNIT |
|-----------------------|--|-----|---------------------|-----|------|
| f _{TCK} | TCK clock frequency | 0 | | 10 | MHz |
| t _{TCK} | TCK clock period | 100 | | | ns |
| t _{TCK_LOW} | TCK clock low time | | t _{TCK} /2 | | ns |
| t _{TCK_HIGH} | TCK clock high time | | t _{TCK} /2 | | ns |
| t _{TCK_RISE} | TCK rise time | 0 | | 10 | ns |
| t _{TCK_FALL} | TCK fall time | 0 | | 10 | ns |
| t _{TMS_SU} | TMS setup time to TCK rise | 28 | | | ns |
| t _{TMS_HLD} | TMS hold time from TCK rise | 4 | | | ns |
| t _{TDI_SU} | TDI setup time to TCK rise | 18 | | | ns |
| t _{TDI_HLD} | TDI hold time from TCK rise | 4 | | | ns |
| t _{TDO_ZDV} | TCK fall to data valid from high impedance | | TBD | 42 | ns |
| t _{TDO_DV} | TCK fall to data valid from data valid | | TBD | 40 | ns |
| t _{TDO_DVZ} | TCK fall to high impedance from data valid | | TBD | 33 | ns |

6 Detailed Description

6.1 Processor and Execution Features

The ARM Cortex-M4 processor provides a high-performance low-cost platform that meets system requirements of minimal memory implementation, reduced pin count, and low power consumption, while delivering outstanding computational performance and exceptional system response to interrupts. The Thumb-2 mixed 16- and 32-bit instruction set of the processor delivers the high performance that is expected of a 32-bit ARM core in a compact memory size usually associated with 8- and 16-bit devices (typically in the range of a few kilobytes of memory needed for microcontroller-class applications).

In the MSP432P401x devices, the Cortex-M4 processor can run up to 48 MHz, delivering high performance for the targeted class of applications, while at the same time maintaining ultra-low active power consumption.

6.1.1 Floating Point Unit

The Cortex-M4 processor on the MSP432P401x devices includes a tightly coupled Floating Point Unit (FPU). The FPU is an IEEE754 compliant single precision floating point module supporting add, subtract, multiply, divide, accumulate, and square-root operations. It also provides conversion between fixed-point and floating-point data formats and floating point constant instructions.

6.1.2 Memory Protection Unit

The Cortex-M4 processor on the MSP432P401x devices includes a tightly coupled Memory Protection Unit (MPU) that supports up to eight protection regions. Applications can use this to enforce memory privilege rules, thus allowing isolation of processes from each other, or enforce memory access rules. These features are typically required for operating system handling purposes.

6.1.3 Nested Vectored Interrupt Controller

The MSP432P401x devices include a Nested Vectored Interrupt Controller (NVIC) that supports up to 64 interrupts with eight levels of interrupt priority. The Cortex-M4 NVIC architecture allows for low latency, efficient interrupt/event handling, and seamless integration to device-level power-control strategies.

6.1.4 SYSTICK

The Cortex-M4 includes an integrated system timer, SysTick, which provides a simple, 24-bit clear-on-write, decrementing, wrap-on-zero counter with a flexible control mechanism. The counter can be used in several different ways, and is typically deployed either for Operating System related purposes or as a general purpose alarm mechanism.

6.1.5 Debug and Trace Features

The Cortex-M4 processor implements a complete hardware debug solution, providing high system visibility of the processor and memory through either a traditional 4-pin JTAG port or a 2-pin Serial Wire Debug (SWD) port, typically ideal for microcontrollers and other small package devices. The SWJ-DP interface combines the SWD and JTAG debug ports into one module, allowing a seamless switch between the 2-pin and 4-pin modes of operation, depending on application needs.

For system trace, the processor integrates an Instrumentation Trace Macrocell (ITM) alongside data watchpoints and a profiling unit. To enable simple and cost-effective profiling of the system trace events, a Serial Wire Viewer (SWV) can export a stream of software-generated messages, data trace, and profiling information through a single pin.

NOTE

For detailed specifications and information on the programmers model for the Cortex-M4 CPU as well as the associated peripherals mentioned throughout [Section 6.1](#), see the appropriate reference manual at www.arm.com.

6.2 Memory Map

The device supports a 4-GB address space that is divided into eight 512-MB zones (see [Figure 6-1](#)).



Figure 6-1. Device Memory Zones

6.2.1 CODE Zone Memory Map

The region from 0x0000_0000 to 0x1FFF_FFFF is defined as the Code zone, and is accessible through the ICODE and DCODE buses of the Cortex-M4 processor as well as through the system DMA. This region maps the flash, the ROM as well as the internal SRAM (permitting optimal single cycle execution from the SRAM).

The MSP432P401x specific memory map of the Code Zone, as visible to the user code (see [Figure 6-2](#)).

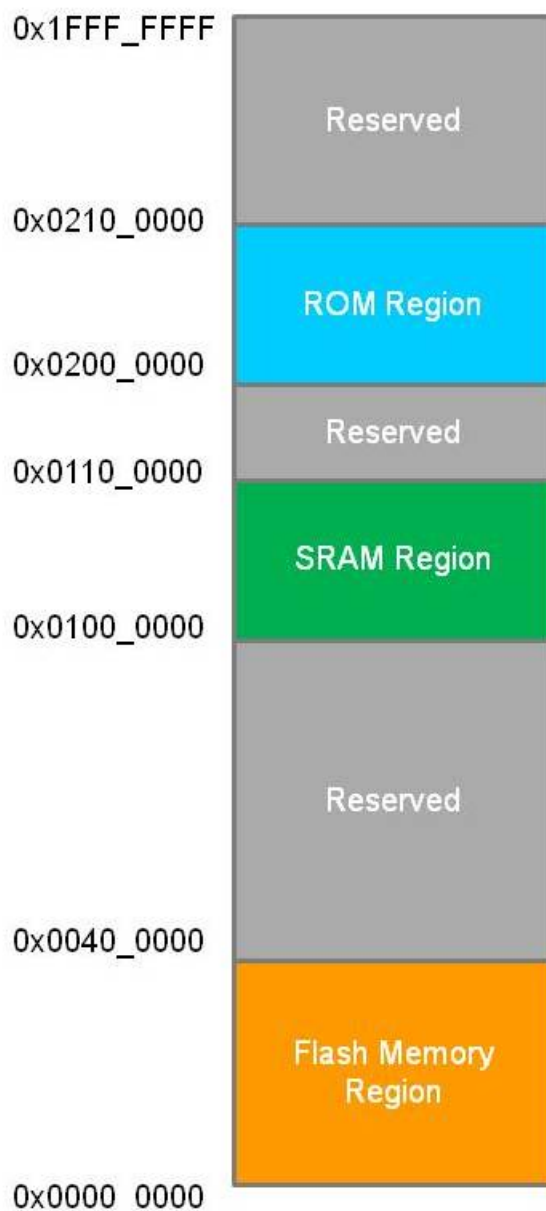


Figure 6-2. CODE Zone Memory Map

6.2.1.1 Flash Memory Region

The 4-MB region from 0x0000_0000 to 0x003F_FFFF is defined as the flash memory region. This region is further divided into different types of flash memory regions which are explained in [Section 6.3.1](#).

6.2.1.2 SRAM Memory Region

The 1-MB region from 0x0100_0000 to 0x010F_FFFF is defined as the SRAM region. This region is also aliased in the SRAM *zone* of the device, thereby allowing efficient access to the SRAM, both for instruction fetches as well as data reads. Refer to [Section 6.3.2](#) for more details.

6.2.1.3 ROM Memory Region

The 1-MB region from 0x0200_0000 to 0x020F_FFFF is defined as the ROM memory region. Details about the ROM memory can be found in [Section 6.3.3](#).

6.2.2 SRAM Zone Memory Map

The SRAM Zone of the device lies in the address range of 0x2000_0000 to 0x3FFF_FFFF. This is further divided as shown in [Figure 6-3](#).

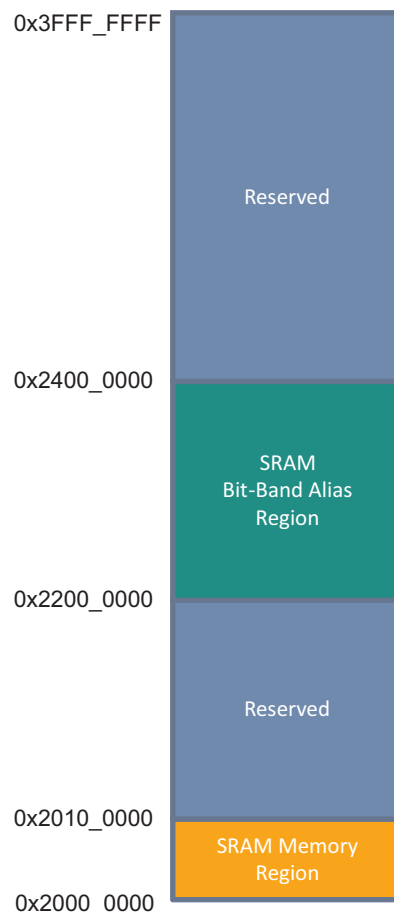


Figure 6-3. SRAM Zone Memory Map

6.2.2.1 SRAM Memory Region

The 1-MB region from 0x2000_0000 to 0x200F_FFFF is defined as the SRAM region. The SRAM memory accessible in this region is also aliased in the Code zone of the device, thereby allowing efficient access to the SRAM, both for instruction fetches as well as data reads. Refer to [Section 6.3.2](#) for details about the SRAM memory.

6.2.2.2 SRAM Bit Band Alias Region

The 32-MB region from 0x2200_0000 through 0x23FF_FFFF forms the bit-band alias region for the 1-MB SRAM region. Bit-banding is a feature of the Cortex-M4 processor and allows the application to set or clear individual bits throughout the SRAM memory space without using the pipeline bandwidth of the processor to carry out an exclusive read-modify-write sequence.

6.2.3 Peripheral Zone Memory Map

The Peripheral Zone of the device lies in the address range of 0x4000_0000 to 0x5FFF_FFFF. This is further divided as shown in [Figure 6-4](#).

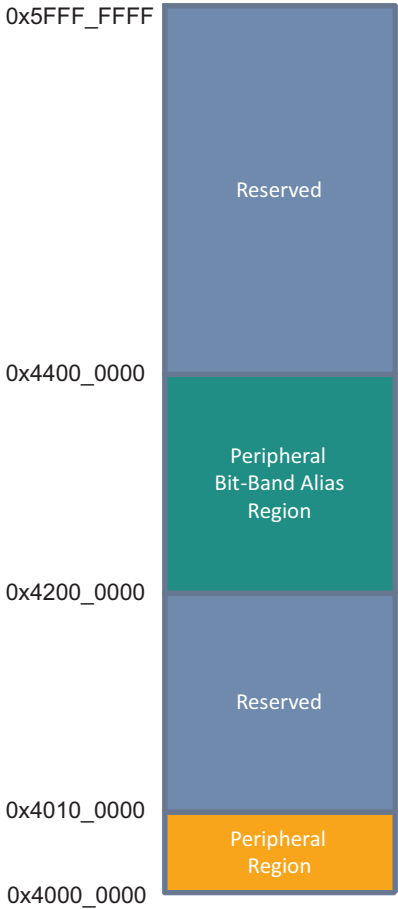


Figure 6-4. Peripheral Zone Memory Map

6.2.3.1 Peripheral Region

The 1-MB region from 0x4000_0000 to 0x400F_FFFF is dedicated to the system and application control peripherals of the device. On the MSP432P401x devices, a total of 128KB of this region is dedicated for peripherals, while the rest is marked as reserved. The peripheral allocation within this 128-KB space is listed in [Table 6-1](#). Note that all peripherals may not be available in all devices of the family (details in the Remarks column). If a peripheral is listed as NA for a particular device, the corresponding address space must be treated as reserved.

NOTE

Peripherals that are marked as 16-bit should be accessed through byte or half-word size read/write only. Any 32-bit access to these peripherals results in a bus error response.

Table 6-1. Peripheral Address Offsets

| ADDRESS RANGE | PERIPHERAL | REMARKS |
|-------------------------|------------|-------------------|
| 0x4000_0000–0x4000_03FF | Timer_A0 | 16-bit peripheral |
| 0x4000_0400–0x4000_07FF | Timer_A1 | 16-bit peripheral |
| 0x4000_0800–0x4000_0BFF | Timer_A2 | 16-bit peripheral |
| 0x4000_0C00–0x4000_0FFF | Timer_A3 | 16-bit peripheral |
| 0x4000_1000–0x4000_13FF | eUSCI_A0 | 16-bit peripheral |
| 0x4000_1400–0x4000_17FF | eUSCI_A1 | 16-bit peripheral |
| 0x4000_1800–0x4000_1BFF | eUSCI_A2 | 16-bit peripheral |

Table 6-1. Peripheral Address Offsets (continued)

| ADDRESS RANGE | PERIPHERAL | REMARKS |
|-------------------------|-------------------------|----------------------------|
| 0x4000_1C00–0x4000_1FFF | eUSCI_A3 | 16-bit peripheral |
| 0x4000_2000–0x4000_23FF | eUSCI_B0 | 16-bit peripheral |
| 0x4000_2400–0x4000_27FF | eUSCI_B1 | 16-bit peripheral |
| 0x4000_2800–0x4000_2BFF | eUSCI_B2 | 16-bit peripheral |
| 0x4000_2C00–0x4000_2FFF | eUSCI_B3 | 16-bit peripheral |
| 0x4000_3000–0x4000_33FF | REF_A | 16-bit peripheral |
| 0x4000_3400–0x4000_37FF | COMP_E0 | 16-bit peripheral |
| 0x4000_3800–0x4000_3BFF | COMP_E1 | 16-bit peripheral |
| 0x4000_3C00–0x4000_3FFF | AES256 | 16-bit peripheral |
| 0x4000_4000–0x4000_43FF | CRC32 | 16-bit peripheral |
| 0x4000_4400–0x4000_47FF | RTC_C | 16-bit peripheral |
| 0x4000_4800–0x4000_4BFF | WDT_A | 16-bit peripheral |
| 0x4000_4C00–0x4000_4FFF | Port Module | 16-bit peripheral |
| 0x4000_5000–0x4000_53FF | Port Mapping Controller | 16-bit peripheral |
| 0x4000_5400–0x4000_57FF | Capacitive Touch I/O 0 | 16-bit peripheral |
| 0x4000_5800–0x4000_5BFF | Capacitive Touch I/O 1 | 16-bit peripheral |
| 0x4000_5C00–0x4000_8FFF | Reserved | Read only, always reads 0h |
| 0x4000_9000–0x4000_BFFF | Reserved | Read only, always reads 0h |
| 0x4000_C000–0x4000_CFFF | Timer32 | |
| 0x4000_D000–0x4000_DFFF | Reserved | Read only, always reads 0h |
| 0x4000_E000–0x4000_FFFF | DMA | |
| 0x4001_0000–0x4001_03FF | PCM | |
| 0x4001_0400–0x4001_07FF | CS | |
| 0x4001_0800–0x4001_0FFF | PSS | |
| 0x4001_1000–0x4001_17FF | Flash Controller | |
| 0x4001_1800–0x4001_1BFF | Reserved | Read only, always reads 0h |
| 0x4001_1C00–0x4001_1FFF | Reserved | Read only, always reads 0h |
| 0x4001_2000–0x4001_23FF | ADC14 | |
| 0x4001_2400–0x4001_FFFF | Reserved | Read only, always reads 0h |

6.2.3.2 Peripheral Bit Band Alias Region

The 32-MB region from 0x4200_0000 through 0x43FF_FFFF forms the bit-band alias region for the 1MB Peripheral region. Bit-banding is a feature of the Cortex-M4 processor and allows the application to set/clear individual bits throughout the peripheral memory space without using the pipeline bandwidth of the processor to carry out an exclusive read-modify-write sequence.

NOTE

The restriction of accessing 16-bit peripherals only through byte or half-word accesses also applies to the corresponding bit-band region of these peripherals. In other words, writes to the bit-band alias region for these peripherals must be in the form of byte or half-word accesses only.

6.2.4 Debug and Trace Peripheral Zone

This zone maps the internal as well as external PPB regions of the Cortex-M4. The following peripherals are mapped to this zone

- Core and System debug control registers (internal PPB)
- NVIC and other registers in the System Control space of the Cortex-M4 (internal PPB)
- FPB, DWT, ITM (internal PPB)
- TPIU, Debug ROM table (external PPB)
- Reset Controller (external PPB)
- System Controller (external PPB)

Table 6-2. Debug Zone Memory Map

| ADDRESS RANGE | MODULE OR PERIPHERAL | REMARKS |
|--------------------------|--------------------------------|--------------|
| 0xE000_0000–0xE000_0FFF | ITM | Internal PPB |
| 0xE000_1000–0xE000_1FFF | DWT | Internal PPB |
| 0xE0000_2000–0xE000_2FFF | FPB | Internal PPB |
| 0xE000_3000–0xE000_DFFF | Reserved | Internal PPB |
| 0xE000_E000–0xE000_EFFF | Cortex-M4 System Control Space | Internal PPB |
| 0xE000_F000–0xE003_FFFF | Reserved | Internal PPB |
| 0xE004_0000–0xE004_0FFF | TPIU | External PPB |
| 0xE004_1000–0xE004_1FFF | Reserved | External PPB |
| 0xE004_2000–0xE004_23FF | Reset Controller | External PPB |
| 0xE004_2400–0xE004_2FFF | Reserved | External PPB |
| 0xE004_3000–0xE004_33FF | System Controller | External PPB |
| 0xE004_3400–0xE004_3FFF | Reserved | External PPB |
| 0xE004_4000–0xE004_43FF | System Controller | External PPB |
| 0xE004_4400–0xE00F_EFFF | Reserved | External PPB |
| 0xE00F_F000–0xE00F_FFFF | ROM Table (External PPB) | External PPB |
| 0xE010_0000–0xFFFF_FFFF | Reserved | Vendor Space |

NOTE

Refer to the Cortex-M4 TRM for the address maps of the ARM modules listed above

NOTE

The region from 0xE004_4000–0xE004_43FF is reserved for System Controller registers. These registers are detailed in various sections of this data sheet

6.3 Memories on the MSP432P401x

The MSP432P401x devices include flash and SRAM memories for general application purposes. In addition, the devices include a backup memory (a portion of total available SRAM) that is retained in low-power modes.

6.3.1 Flash Memory

The MSP432P401x devices include a high-endurance low-power flash memory that supports up to 20000 write and erase cycles. The flash memory is 128 bits wide thereby enabling high code execution performance by virtue of each fetch returning up to four 32-bit instructions (or up to eight 16-bit instructions). The flash is further divided into two types of subregions: Main Memory and Information Memory.

From a physical perspective the flash memory comprises of two banks, with the main and information memory regions divided equally between the two banks. This permits application to carry out a simultaneous read or execute operation from one bank while the other bank may be undergoing a program or erase operation.

The memory map of flash on MSP432P401x devices is shown in Figure 6-5.

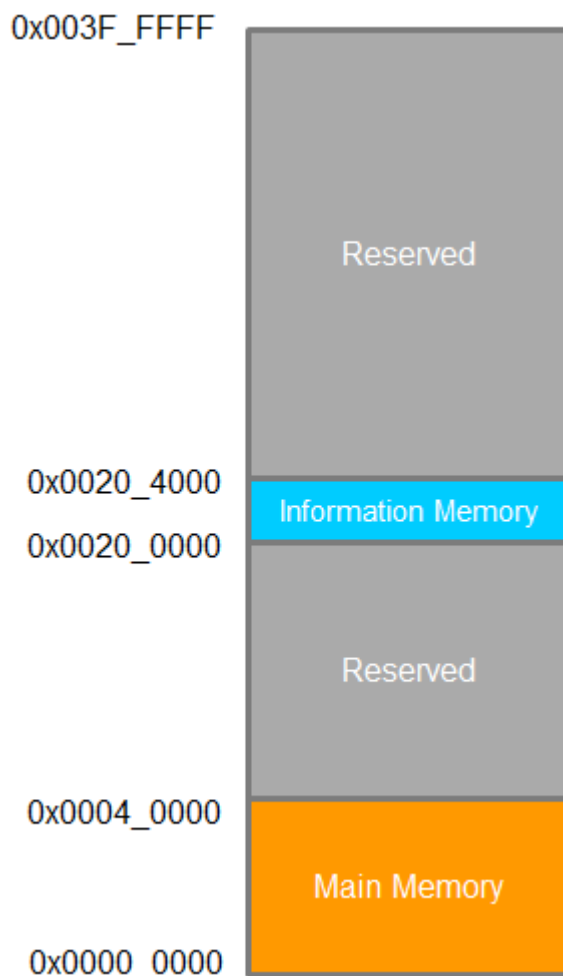


Figure 6-5. Flash Memory Map

6.3.1.1 Flash Main Memory (0x0000_0000 to 0x0003_FFFF)

The flash main memory on MSP432P401x devices can be up to 256KB. Flash main memory consists of up to 64 sectors of 4KB each, with a minimum erase granularity of 4KB (1 sector). The main memory can be viewed as two independent, identical banks of up to 128KB each, allowing simultaneous read/execute from one bank while the other bank is undergoing program/erase operation.

6.3.1.1.1 Flash Size Register (Address = 0xE004_3020h)

This register reflects the size of flash main memory available on the device.

Figure 6-6. SYS_FLASH_SIZE Register

| | | | | | | | | | | | | | | | |
|------|----|----|----|----|----|----|----|----|----|----|----|----|-----|----|----|
| 31 | 30 | 29 | 28 | 27 | 26 | 25 | 24 | 23 | 22 | 21 | 20 | 19 | 18 | 17 | 16 |
| SIZE | | | | | | | | | | | | | | | |
| r | r | r | r | r | r | r | r | r | r | r | r | r | r-1 | r | r |
| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| SIZE | | | | | | | | | | | | | | | |
| r | r | r | r | r | r | r | r | r | r | r | r | r | r | r | r |

Table 6-3. SYS_FLASH_SIZE Register Description

| BIT | FIELD | TYPE | RESET | DESCRIPTION |
|------|-------|------|----------|--|
| 31-0 | SIZE | R | Variable | Indicates the size (in bytes) of the flash main memory on the device. This is divided equally between the two banks. |

6.3.1.2 Flash Information Memory (0x0020_0000 to 0x0020_3FFF)

The flash information memory region is 16KB. Flash information memory consists of four sectors of 4KB each, with a minimum erase granularity of 4KB (1 sector). The information memory can be viewed as two independent blocks of 8KB each, which allows read or execute from one block while the other block is undergoing a program or erase operation. [Table 6-4](#) describes different regions of flash information memory and the contents of each of the regions. The flash information memory region that contains the device descriptor (TLV) is factory configured for protection against write or erase operations.

Table 6-4. Flash Information Memory Regions

| REGION | ADDRESS RANGE | CONTENTS | WRITE AND ERASE PROTECTED? |
|------------------|-------------------------|-----------------------------|----------------------------|
| Bank 0, Sector 0 | 0x0020_0000–0x0020_0FFF | Flash Boot-override Mailbox | No |
| Bank 0, Sector 1 | 0x0020_1000–0x0020_1FFF | Device Descriptor (TLV) | Yes |
| Bank 1, Sector 0 | 0x0020_2000–0x0020_2FFF | TI BSL | No |
| Bank 1, Sector 1 | 0x0020_3000–0x0020_3FFF | TI BSL | No |

6.3.1.3 Flash Operation

The flash memory provides multiple read and program modes of operation that the application can deploy. Up to 128 bits (memory word width) can be programmed (set from 1 to 0) in a single program operation. Although the CPU data buses are 32 bits wide, the flash can buffer 128-bit write data before initiating flash programming, thereby making it more seamless and power efficient for software to program large blocks of data at a time. In addition, the flash memory also supports a burst write mode that takes less time when compared to programming words individually. Refer to [Flash Memory](#) for information on timing parameters.

The flash main and information memory regions offer write/erase protection control at a sector granularity to enable software to optimize operations like mass erase while protecting certain regions of the flash. In low-power modes of operation, the flash memory is disabled and put in a power-down state to minimize leakage.

For details on the flash memory and its various modes of operation and configuration, refer to the *Flash Controller* chapter in the *MSP432P4xx Family Technical Reference Manual* ([SLAU356](#)).

NOTE

Depending on the CPU (MCLK) frequency and the active mode in use, the flash may need to be accessed with single/multiple wait states. Whenever there is a change required in the operating frequency, it is the responsibility of the application to ensure that the flash access wait states are configured correctly before the frequency change is effected. Refer to electrical specification for details on flash wait state requirements.

6.3.2 SRAM

The MSP432P401x devices support up to 64KB of SRAM memory, with the rest of the 1MB SRAM memory region treated as reserved. The SRAM memory is aliased in *both* Code as well as SRAM memory zones. This enables fast, single cycle execution of code from the SRAM, as the Cortex-M4 processor pipelines instruction fetches to memory zones other than the Code space. As with the flash memory, the SRAM can be powered down or placed in a low leakage retention state in low-power modes of operation.

The memory map of SRAM on MSP432P401x devices is shown in [Figure 6-7](#).

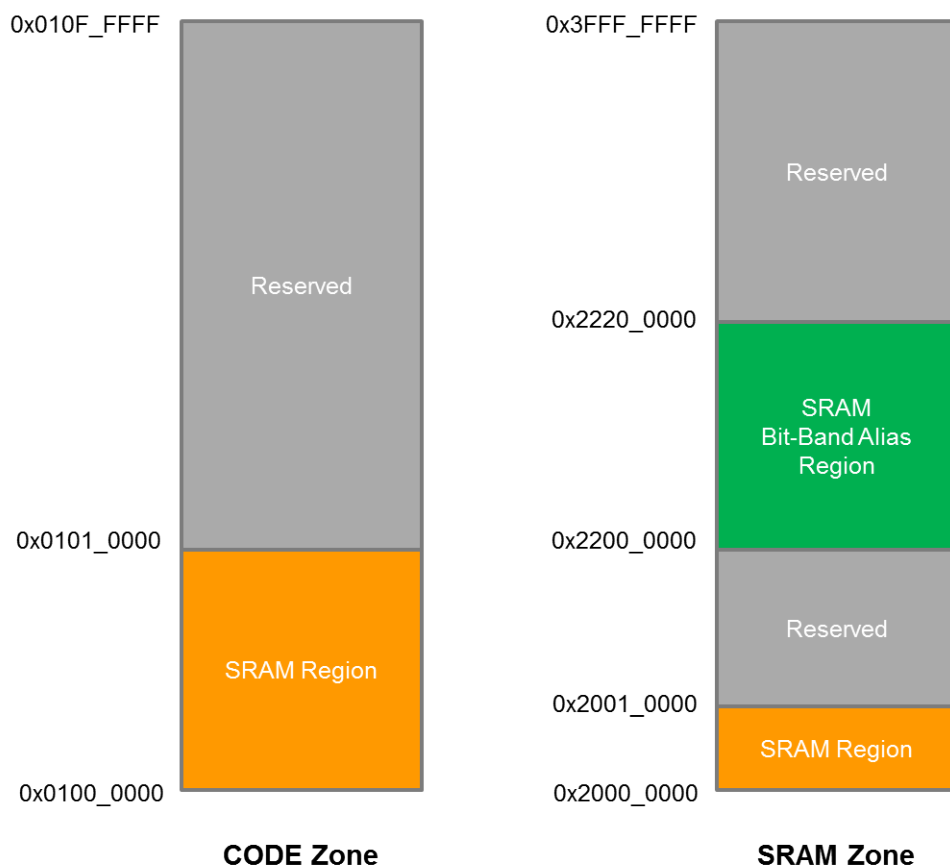


Figure 6-7. SRAM Memory Map

6.3.2.1 SRAM Bank Enable Configuration

The application can choose to optimize the power consumption of the SRAM. In order to enable this, the SRAM memory is divided into 8KB banks that can individually be powered down. Banks that are powered down remain powered down in both active as well as low-power modes of operation, thereby limiting any unnecessary inrush current when the device transitions between active and retention based low-power modes. The application can also choose to disable one (or more) banks for a certain stage in the processing and re-enable it for another stage. Refer to [Section 6.3.2.3](#) for details on how individual banks can be controlled by the application.

Whenever a particular bank is disabled, reads to its address space return 0h, and writes are discarded. To prevent 'holes' in the memory map, if a particular bank is enabled, all the lower banks are forced to enabled state as well. This ensures a contiguous memory map through the set of enabled banks instead of a possible disabled bank appearing between enabled banks.

NOTE

Bank0 is **always** enabled and cannot be powered down.

NOTE

When any SRAM bank is enabled or disabled, accesses to the SRAM are temporarily stalled to prevent spurious reads. This is handled transparently and does not require any code intervention. Refer to SRAM characteristics in the electrical specification for the SRAM bank enable or disable latency.

6.3.2.2 SRAM Bank Retention Configuration and Backup Memory

The application can choose to optimize the leakage power consumption of the SRAM in LPM3 and LPM4 modes of operation as well. In order to enable this, each SRAM bank can be individually configured for retention. Banks that are enabled for retention retain their data through the LPM3 and LPM4 modes. The application can also choose to retain a subset of the enabled banks.

For example, the application may need 32KB of SRAM for its processing needs (4 banks are kept enabled). However, of these four banks, only one bank may contain critical data that must be retained in LPM3 or LPM4 modes while the rest are powered off completely to minimize power consumption. Refer to [Section 6.3.2.3](#) for details on how individual banks can be controlled by the application.

Bank0 of SRAM is **always** retained and cannot be powered down. Therefore, it also operates up as a possible backup memory in the LPM3, LPM4, and LPM3.5 modes of operation.

6.3.2.3 SRAM Status and Configuration Registers

This section lists the registers that can be used to configure and/or monitor status regarding the SRAM.

6.3.2.3.1 SRAM Size Register (Address = 0xE004_3010h)

This register reflects the size of the SRAM available on the device.

Figure 6-8. SYS_SRAM_SIZE Register

| | | | | | | | | | | | | | | | |
|------|----|----|----|----|----|----|----|----|----|----|----|----|----|----|----|
| 31 | 30 | 29 | 28 | 27 | 26 | 25 | 24 | 23 | 22 | 21 | 20 | 19 | 18 | 17 | 16 |
| SIZE | | | | | | | | | | | | | | | |
| r | r | r | r | r | r | r | r | r | r | r | r | r | r | r | r |
| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| SIZE | | | | | | | | | | | | | | | |
| r | r | r | r | r | r | r | r | r | r | r | r | r | r | r | r |

Table 6-5. SYS_SRAM_SIZE Register Description

| BIT | FIELD | TYPE | RESET | DESCRIPTION |
|------|-------|------|----------|--|
| 31-0 | SIZE | R | Variable | Indicates the size (in bytes) of SRAM present on the device. |

NOTE

The SRAM on the MSP432P401x devices is divided into equal size banks of 8KB each. For example, if the total SRAM available is 32KB, the device contains 4 SRAM banks.

6.3.2.3.2 SRAM Bank Enable Register (Address = E004_3014h)

This register configures which bank of the SRAM is powered up and available for the application. The application can choose to enable or disable SRAM banks on the fly. While the SRAM banks are being powered up or down, accesses to the SRAM space is temporarily stalled and is completed when the SRAM banks are ready. Accesses to the rest of the memory map remain unaffected.

Figure 6-9. SYS_SRAM_BANKEN Register

| | | | | | | | | | | | | | | | |
|----------|----|----|----|----|----|----|----|---------|---------|---------|---------|---------|---------|---------|----------|
| 31 | 30 | 29 | 28 | 27 | 26 | 25 | 24 | 23 | 22 | 21 | 20 | 19 | 18 | 17 | 16 |
| Reserved | | | | | | | | | | | | | | | SRAM_RDY |
| r | r | r | r | r | r | r | r | r | r | r | r | r | r | r | r-0 |
| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| Reserved | | | | | | | | BNK7_EN | BNK6_EN | BNK5_EN | BNK4_EN | BNK3_EN | BNK2_EN | BNK1_EN | BNK0_EN |
| r | r | r | r | r | r | r | r | rw-<1> | rw-<1> | rw-<1> | rw-<1> | rw-<1> | rw-<1> | rw-<1> | r-1 |

Table 6-6. SYS_SRAM_BANKEN Register Description

| BIT | FIELD | TYPE | RESET | DESCRIPTION |
|-------|-------------------------|------|-------|---|
| 31-17 | Reserved | R | 0h | Reserved. Reads return 0h |
| 16 | SRAM_RDY ⁽¹⁾ | R | 0h | 1b = SRAM is ready for accesses. All SRAM banks are enabled or disabled according to values of bits 7:0 of this register 0b = SRAM is not ready for accesses. Banks are undergoing the enable/disable sequence, and reads/Writes to SRAM will be stalled until the banks are ready |
| 15-8 | Reserved | R | 0h | Reserved. Reads return 0h |

(1) This bit will automatically be set to 0 whenever any of the Bank Enable bits in this register are changed, which will in turn trigger off a power up/down of the impacted SRAM blocks. It will set back to 1 after the power sequence is complete and the SRAM blocks are ready for subsequent read/write accesses

Table 6-6. SYS_SRAM_BANKEN Register Description (continued)

| BIT | FIELD | TYPE | RESET | DESCRIPTION |
|-----|------------------------|------|-------|--|
| 7 | BNK7_EN ⁽²⁾ | RW | 1h | 0b = Disables Bank7 of the SRAM 1b = enables Bank7 of the SRAM When set to 1, bank enable bits for all banks below this bank are set to 1 as well. |
| 6 | BNK6_EN ⁽²⁾ | RW | 1h | 0b = Disables Bank6 of the SRAM 1b = enables Bank6 of the SRAM When set to 1, bank enable bits for all banks below this bank are set to 1 as well. |
| 5 | BNK5_EN ⁽²⁾ | RW | 1h | 0b = Disables Bank5 of the SRAM 1b = enables Bank5 of the SRAM When set to 1, bank enable bits for all banks below this bank are set to 1 as well. |
| 4 | BNK4_EN ⁽²⁾ | RW | 1h | 0b = Disables Bank4 of the SRAM 1b = enables Bank4 of the SRAM When set to 1, bank enable bits for all banks below this bank are set to 1 as well. |
| 3 | BNK3_EN ⁽²⁾ | RW | 1h | 0b = Disables Bank3 of the SRAM 1b = enables Bank3 of the SRAM When set to 1, bank enable bits for all banks below this bank are set to 1 as well. |
| 2 | BNK2_EN ⁽²⁾ | RW | 1h | 0b = Disables Bank2 of the SRAM 1b = enables Bank2 of the SRAM When set to 1, bank enable bits for all banks below this bank are set to 1 as well. |
| 1 | BNK1_EN ⁽²⁾ | RW | 1h | 0b = Disables Bank1 of the SRAM 1b = enables Bank1 of the SRAM When set to 1, bank enable bits for all banks below this bank are set to 1 as well. |
| 0 | BNK0_EN | R | 1h | When 1, enables Bank0 of the SRAM |

(2) Writes to this bit are allowed ONLY when the SRAM_RDY bit is set to 1. If the bit is 0, it indicates that the SRAM banks are not ready, and writes to this bit will be ignored

The [SRAM Bank Enable Register](#) controls which banks of the SRAM are enabled for read/write accesses. There is one bit for each available bank (unused bits are reserved). Banks that are not enabled are powered down to minimize power consumption. Each bit in this register corresponds to one bank of the SRAM. Banks may **only** be enabled in a contiguous form. For example:

- If there are eight banks in the device, values of 00111111 and 00000111 are acceptable.
- Values like 00010111 are not valid, and the resultant bank configuration will be set to 00011111.
- For example, for a 4-bank SRAM, the only allowed values are 0001, 0011, 0111, and 1111

NOTE

Bank0 is **always** enabled and cannot be disabled. In the case of all other banks, any enable/disable change will result in the SRAM_RDY bit of the SYS_SRAM_BANKEN register being set to 0 until the configuration change is effective. Any accesses to the SRAM will be stalled during this time frame, and resumed only after the SRAM banks are ready for read or write operations.

6.3.2.3.3 SRAM Bank Retention Control Register (Address = E004_3018h)

This register controls which bank of the SRAM is retained when the device enters LPM3 or LPM4 modes. Any bank that is not enabled for retention will be completely powered down in these modes and will lose its data

Figure 6-10. SYS_SRAM_BANKRET Register

| | | | | | | | | | | | | | | | |
|----------|----|----|----|----|----|----|----|----------|----------|----------|----------|----------|----------|----------|----------|
| 31 | 30 | 29 | 28 | 27 | 26 | 25 | 24 | 23 | 22 | 21 | 20 | 19 | 18 | 17 | 16 |
| Reserved | | | | | | | | | | | | | | | SRAM_RDY |
| r | r | r | r | r | r | r | r | r | r | r | r | r | r | r | r |
| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| Reserved | | | | | | | | BNK7_RET | BNK6_RET | BNK5_RET | BNK4_RET | BNK3_RET | BNK2_RET | BNK1_RET | BNK0_RET |
| r | r | r | r | r | r | r | r | rw-0 | rw-0 | rw-0 | rw-0 | rw-0 | rw-0 | rw-0 | r-1 |

Table 6-7. SYS_SRAM_BANKRET Register Description

| BIT | FIELD | TYPE | RESET | DESCRIPTION |
|-------|------------------------------|------|-------|---|
| 31-17 | Reserved | R | 0h | Reserved. Reads return 0h |
| 16 | SRAM_RDY ⁽¹⁾ | R | 0h | 1b = SRAM is ready for accesses. All SRAM banks are enabled or disabled for retention according to values of bits 7:0 of this register 0b = SRAM banks are being set up for retention. Entry into LPM3, LPM4 should not be attempted until this bit is set to 1. |
| 15-8 | Reserved | R | 0h | Reserved. Reads return 0h |
| 7 | BNK7_RET ⁽²⁾⁽³⁾ | RW | 0h | 0b = Bank7 of the SRAM is not retained in LPM3 or LPM4 1b = Bank7 of the SRAM is retained in LPM3 or LPM4 |
| 6 | BNK6_RET ^{(2), (3)} | RW | 0h | 0b = Bank6 of the SRAM is not retained in LPM3 or LPM4 1b = Bank6 of the SRAM is retained in LPM3 or LPM4 |
| 5 | BNK5_RET ⁽²⁾⁽³⁾ | RW | 0h | 0b = Bank5 of the SRAM is not retained in LPM3 or LPM4 1b = Bank5 of the SRAM is retained in LPM3 or LPM4 |
| 4 | BNK4_RET ⁽²⁾⁽³⁾ | RW | 0h | 0b = Bank4 of the SRAM is not retained in LPM3 or LPM4 1b = Bank4 of the SRAM is retained in LPM3 or LPM4 |
| 3 | BNK3_RET ^{(2), (3)} | RW | 0h | 0b = Bank3 of the SRAM is not retained in LPM3 or LPM4 1b = Bank3 of the SRAM is retained in LPM3 or LPM4 |
| 2 | BNK2_RET ⁽²⁾⁽³⁾ | RW | 0h | 0b = Bank2 of the SRAM is not retained in LPM3 or LPM4 1b = Bank2 of the SRAM is retained in LPM3 or LPM4 |
| 1 | BNK1_RET ⁽²⁾⁽³⁾ | RW | 0h | 0b = Bank1 of the SRAM is not retained in LPM3 or LPM4 1b = Bank1 of the SRAM is retained in LPM3 or LPM4 |
| 0 | BNK0_RET | R | 1h | Bank0 is always retained in LPM3, LPM4 and LPM3.5 modes of operation |

- (1) This bit will automatically be set to 0 whenever any of the BNKx_RET bits in this register are changed. It will set back to 1 after the SRAM controller has recognized the new BNKx_RET values.
- (2) Value of this bit is a don't care when the device enters LPM3.5 or LPM4.5 modes of operation. It will always get reset and the SRAM block associated with this bit will not retain its contents.
- (3) Writes to this bit are allowed ONLY when the SRAM_RDY bit of this register is set to 1. If the SRAM_RDY bit is 0, writes to this bit will be ignored.

6.3.3 ROM

The MSP432P401x devices support 32KB of ROM memory, with the rest of the 1-MB region treated as reserved (for future upgrades). The lower 1KB of the ROM is reserved for TI internal purposes and accesses to this space will return an error response. The rest of the ROM is used for driver libraries.

NOTE

The entire ROM region returns an error response for write accesses. The lower 1KB of the ROM always returns an error response for any access.

6.4 DMA

The MSP432P401x devices implement an 8-channel ARM uDMA. This allows eight simultaneously active channels for data transfer between memory and peripherals without needing to use the bandwidth of the CPU (thereby reducing power by idling the CPU when there is no data processing required). In addition, the DMA remains active in multiple low-power modes of operation, allowing for a very low power state in which data can be transferred at low rates.

For maximum flexibility, up to eight DMA event sources can map to any of the eight channels. This is controlled through configuration registers in the DMA. In addition, the DMA can generate up to four interrupt requests (described in [Section 6.4.2](#)). For details regarding configuration of the DMA, refer to the DMA chapter in the *MSP432P4xx Family Technical Reference Manual*.

[Figure 6-11](#) shows the block diagram of the DMA.

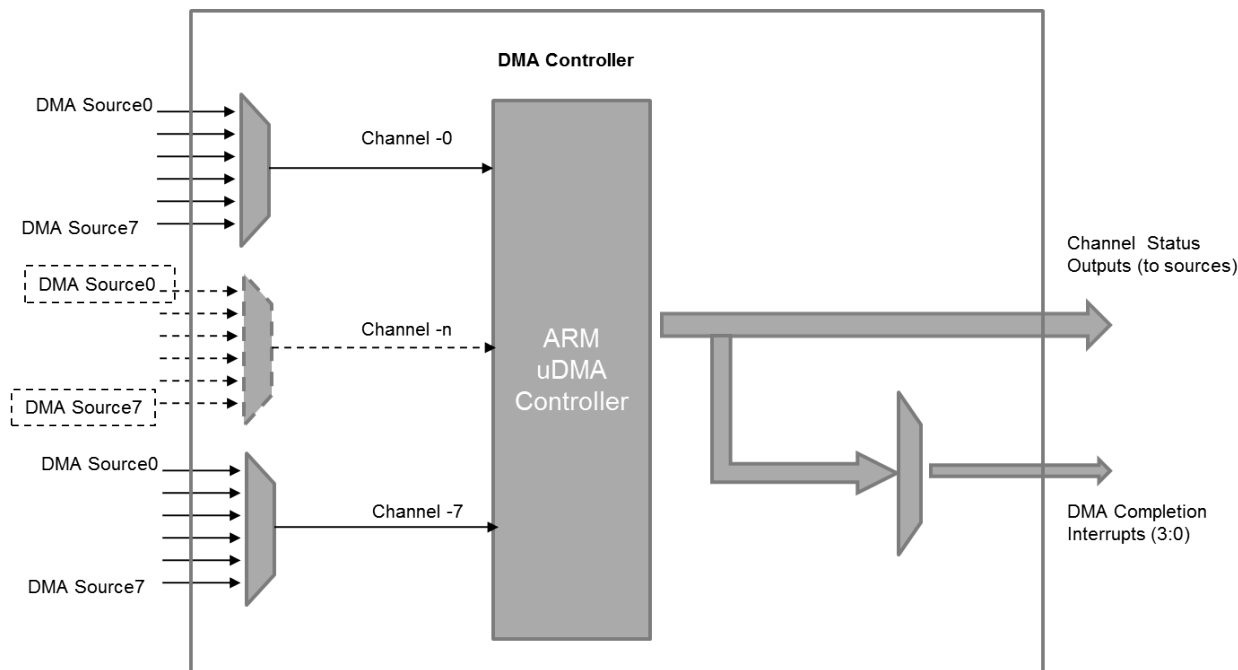


Figure 6-11. DMA Block Diagram

6.4.1 DMA Source Mapping

Each channel of the eight available channels has a control register that can select any of the device level DMA sources as the final source for that corresponding channel. [Table 6-8](#) lists the sources available for mapping to each channel, based on the value of the Source Config Register (SRCCFG).

Table 6-8. DMA Sources

| | SRCCFG = 0 | SRCCFG = 1 | SRCCFG = 2 | SRCCFG = 3 | SRCCFG = 4 | SRCCFG = 5 | SRCCFG = 6 | SRCCFG = 7 |
|------------------|------------|-------------|--------------|--------------|--------------|--------------|------------|----------------------|
| Channel 0 | Reserved | eUSCI_A0 TX | eUSCI_B0 TX0 | eUSCI_B3 TX1 | eUSCI_B2 TX2 | eUSCI_B1 TX3 | TA0CCR0 | AES256_Trigger0 |
| Channel 1 | Reserved | eUSCI_A0 RX | eUSCI_B0 RX0 | eUSCI_B3 RX1 | eUSCI_B2 RX2 | eUSCI_B1 RX3 | TA0CCR2 | AES256_Trigger1 |
| Channel 2 | Reserved | eUSCI_A1 TX | eUSCI_B1 TX0 | eUSCI_B0 TX1 | eUSCI_B3 TX2 | eUSCI_B2 TX3 | TA1CCR0 | AES256_Trigger2 |
| Channel 3 | Reserved | eUSCI_A1 RX | eUSCI_B1 RX0 | eUSCI_B0 RX1 | eUSCI_B3 RX2 | eUSCI_B2 RX3 | TA1CCR2 | Reserved |
| Channel 4 | Reserved | eUSCI_A2 TX | eUSCI_B2 TX0 | eUSCI_B1 TX1 | eUSCI_B0 TX2 | eUSCI_B3 TX3 | TA2CCR0 | Reserved |
| Channel 5 | Reserved | eUSCI_A2 RX | eUSCI_B2 RX0 | eUSCI_B1 RX1 | eUSCI_B0 RX2 | eUSCI_B3 RX3 | TA2CCR2 | Reserved |
| Channel 6 | Reserved | eUSCI_A3 TX | eUSCI_B3 TX0 | eUSCI_B2 TX1 | eUSCI_B1 TX2 | eUSCI_B0 TX3 | TA3CCR0 | DMAE0 (External Pin) |
| Channel 7 | Reserved | eUSCI_A3 RX | eUSCI_B3 RX0 | eUSCI_B2 RX1 | eUSCI_B1 RX2 | eUSCI_B0 RX3 | TA3CCR2 | ADC14 |

NOTE

Any source marked as Reserved is unused. It may be used for software-controlled DMA tasks, but typically it is reserved for enhancement purposes on future devices.

6.4.2 DMA Completion Interrupts

In the case of the ARM μ DMA controller, it is usually the responsibility of software to maintain a list of channels that have completed their operation. In order to provide further flexibility, the MSP432P401x DMA supports four DMA completion interrupts, which are mapped in the following way:

- DMA_INT0: Logical OR of all completion events **except** those that are already mapped to DMA_INT1, DMA_INT2, or DMA_INT3.
- DMA_INT1, DMA_INT2, DMA_INT3: Can be mapped to the DMA completion event of any of the eight channels

NOTE

Software must ensure that DMA_INT1, DMA_INT2, and DMA_INT3 are mapped to different channels, so that the same channel does not result in multiple interrupts at the NVIC.

6.4.3 DMA Access Privileges

The DMA has access to all the memories and peripheral configuration interfaces of the device. In the event the device is configured for IP protection, DMA access to the flash is restricted to only the lower half (second bank) of the flash main and information memory regions. This prevents the DMA from being used as an unauthorized access source into the top half (first bank) of the flash, where secure data regions are housed.

6.5 Memory Map Access Details

The bus system on the MSP432P401x devices incorporates 4 masters, which can initiate various types of transactions

- ICODE: Cortex-M4 instruction fetch bus. Accesses the Code Zone only
- DCODE: Cortex-M4 data and literal fetch bus. Accesses the Code Zone only. Debugger accesses to Code Zone also appear on this bus.
- SBUS: Cortex-M4 data read and write bus. Accesses to all zones except Code Zones and PPB memory space only. Debugger accesses to this space also appear on this bus.
- DMA: Access to all zones except the PPB memory space

NOTE

The PPB space is dedicated only to the Cortex-M4 Private Peripheral Bus.

6.5.1 Master and Slave Access Priority Settings

Table 6-9 lists all the available masters (rows) and their access permissions to slaves (columns). If multiple masters can access one slave, the table lists access priorities if arbitration is required. A lower number in the table indicates a higher arbitration priority (the priority is always fixed).

Table 6-9. Master and Slave Access Priority

| | FLASH MEMORY | ROM | SRAM | PERIPHERALS |
|--------------|------------------|-----|------------------|-------------|
| ICODE | 3 | 2 | 4 | NA |
| DCODE | 2 ⁽¹⁾ | 1 | 2 | NA |
| SBUS | NA | NA | 3 | 2 |
| DMA | 1 ⁽²⁾ | NA | 1 ⁽³⁾ | 1 |

- (1) Access from the DCODE to flash memory may be restricted if the device is operating in a secure mode
- (2) Access from DMA to flash memory will be restricted to Bank 1 if the device is operating in a secure mode with IP protection enabled. In such cases, access to Bank0 will return an error response
- (3) Although the SRAM is mapped to both Code and System spaces, accesses from DMA to SRAM must use the System space addressing ONLY.

6.5.2 Memory Map Access Response

The following table consolidates the access responses to the entire memory map of the MSP432P401x devices.

Table 6-10. Memory Map Access Response

| ADDRESS RANGE | DESCRIPTION | READ ⁽¹⁾ | WRITE ⁽¹⁾ | INSTRUCTION FETCH ⁽¹⁾ |
|-------------------------|---------------------------|---------------------|------------------------|----------------------------------|
| 0x0000_0000–0x0003_FFFF | Flash Main Memory | OK | OK ^{(2), (3)} | OK |
| 0x0004_0000–0x001F_FFFF | Reserved | Error | Error | Error |
| 0x0020_0000–0x0020_3FFF | Flash Information Memory | OK | OK ⁽³⁾ | OK |
| 0x0020_4000–0x00FF_FFFF | Reserved | Error | Error | Error |
| 0x0100_0000–0x0100_FFFF | SRAM | OK | OK | OK |
| 0x0101_0000–0x01FF_FFFF | Reserved | Error | Error | Error |
| 0x0200_0000–0x0200_03FF | ROM (Reserved) | Error | Error | Error |
| 0x0200_0400–0x0200_7FFF | ROM | OK | Error | OK |
| 0x0200_8000–0x1FFF_FFFF | Reserved | Error | Error | Error |
| 0x2000_0000–0x2000_FFFF | SRAM | OK | OK | OK |
| 0x2001_0000–0x21FF_FFFF | Reserved | Error | Error | Error |
| 0x2200_0000–0x23FF_FFFF | SRAM bit-band alias | OK ⁽⁴⁾ | OK | Error |
| 0x2400_0000–0x3FFF_FFFF | Reserved | Error | Error | Error |
| 0x4000_0000–0x4001_FFFF | Peripheral | OK | OK | Error |
| 0x4002_0000–0x41FF_FFFF | Reserved | Error | Error | Error |
| 0x4200_0000–0x43FF_FFFF | Peripheral bit-band alias | OK ⁽⁴⁾ | OK | Error |
| 0x4400_0000–0xDFFF_FFFF | Reserved | Error | Error | Error |

- (1) A 'reserved' memory region returns 0h on reads and instruction fetches. Writes to this region are ignored.
- (2) If the User memory address is part of a secure region, this access returns an error if it is initiated by an unauthorized source. For more details, refer to the device security application note.
- (3) Writes to this address are ignored if the concerned sector has write protection enabled.
- (4) Reads from the bit-band region return 00h if the bit is clear and 01h if the bit is set.

Table 6-10. Memory Map Access Response (continued)

| ADDRESS RANGE | DESCRIPTION | READ ⁽¹⁾ | WRITE ⁽¹⁾ | INSTRUCTION FETCH ⁽¹⁾ |
|-------------------------|---------------------------------|---------------------|----------------------|-------------------------------------|
| 0xE000_0000–0xE003_FFFF | Internal PPB ⁽⁵⁾ | OK | OK | Error |
| 0xE004_0000–0xE004_0FFF | TPIU (External PPB) | OK | OK | Error |
| 0xE004_1000–0xE004_1FFF | Reserved | Reserved | Reserved | Error |
| 0xE004_2000–0xE004_23FF | Reset Controller (External PPB) | OK | OK | Error |
| 0xE004_2400–0xE004_2FFF | Reserved | Reserved | Reserved | Error |
| 0xE004_3000–0xE004_33FF | SYSCTL (External PPB) | OK | OK | Error |
| 0xE004_3400–0xE004_3FFF | Reserved | Reserved | Reserved | Error |
| 0xE004_4000–0xE004_43FF | SYSCTL (External PPB) | OK | OK | Error |
| 0xE004_4400–0xE00F_EFFF | Reserved | Reserved | Reserved | Error |
| 0xE00F_F000–0xE00F_FFFF | ROM Table (External PPB) | OK | OK | Error |
| 0xE010_0000–0xFFFF_FFFF | Reserved | Error | Error | Error |

(5) Refer to the Cortex®-M4 TRM for details of the memory map of the internal PPB.

6.6 Interrupts

The Cortex-M4 processor on MSP432P401x devices implements an NVIC with 64 external interrupt lines and 8 levels of priority. From an application perspective, the interrupt sources at the device level are divided into two classes, the NMI and the User Interrupts. Internally, the CPU exception model handles the various exceptions (internal and external events including CPU instruction, memory, and bus fault conditions) in a fixed and configurable order of priority. For details on the handling of various exception priorities (including CPU reset and fault models), see the ARM-V7M architecture reference manual at www.arm.com.

6.6.1 NMI

The NMI input of the NVIC has the following possible sources

- External NMI pin (if configured in NMI mode)
- Oscillator fault condition
- Power Supply System (PSS) generated interrupts
- Power Control Manager (PCM) generated interrupts

The source that finally feeds the NMI of the NVIC is configured through the NMI Control register, explained in [Section 6.6.1.1](#).

6.6.1.1 NMI Control and Status Register [Address = E004_3004h]

Figure 6-12. SYS_NMI_CTLSTAT Register

| | | | | | | | |
|----------|----|----|----|---------|---------|---------|--------|
| 31 | 30 | 29 | 28 | 27 | 26 | 25 | 24 |
| Reserved | | | | | | | |
| r | r | r | r | r | r | r | r |
| 23 | 22 | 21 | 20 | 19 | 18 | 17 | 16 |
| Reserved | | | | PIN_FLG | PCM_FLG | PSS_FLG | CS_FLG |
| r | r | r | r | rw-0 | r-0 | r-0 | r-0 |
| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 |
| Reserved | | | | | | | |
| r | r | r | r | r | r | r | r |
| 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| Reserved | | | | PIN_SRC | PCM_SRC | PSS_SRC | CS_SRC |
| r | r | r | r | rw-0 | rw-1 | rw-1 | rw-1 |

Table 6-11. SYS_NMI_CTLSTAT Register Description

| BITS | FIELD | TYPE | RESET | DESCRIPTION |
|-------|---------------------------|------|-------|---|
| 31-20 | Reserved | R | 0h | Reserved. Reads return 0h |
| 19 | PIN_FLG | RW | 0h | 0b = Indicates the RSTn/NMI pin was not the source of NMI 1b = Indicates the RSTn/NMI pin was the source of NMI |
| 18 | PCM_FLG | R | 0h | 0b = Indicates the PCM interrupt was not the source of NMI 1b = Indicates the PCM interrupt was the source of NMI This flag gets auto-cleared when the corresponding source flag in the PCM is cleared |
| 17 | PSS_FLG | R | 0h | 0b = Indicates the PSS interrupt was not the source of NMI 1b = Indicates the PSS interrupt was the source of NMI This flag gets auto-cleared when the corresponding source flag in the PSS is cleared |
| 16 | CS_FLG | R | 0h | 0b = Indicates CS interrupt was not the source of NMI 1b = Indicates CS interrupt was the source of NMI This flag gets auto-cleared when the corresponding source flag in the CS is cleared |
| 15-4 | Reserved | R | 0h | Reserved. Reads return 0h |
| 3 | PIN_SRC ⁽¹⁾⁽²⁾ | RW | 0h | 0b = Configures the RSTn/NMI pin as a source of POR Class Reset 1b = Configures the RSTn/NMI pin as a source of NMI Note: Setting this bit to 1 prevents the RSTn pin from being used as a reset. An NMI is triggered by the pin only if a negative edge is detected. |
| 2 | PCM_SRC | RW | 1h | 0b = Disables the PCM interrupt as a source of NMI 1b = Enables the PCM interrupt as a source of NMI |
| 1 | PSS_SRC | RW | 1h | 0b = Disables the PSS interrupt as a source of NMI 1b = Enables the PSS interrupt as a source of NMI |

- (1) When the device enters LPM3/LPM4 modes of operation, the functionality selected by this bit will be retained. If selected as an NMI, activity on this pin in LPM3/LPM4 will wake the device and process the interrupt, without causing a POR. If selected as a Reset, activity on this pin in LPM3/LPM4 will cause a device level POR
- (2) When the device enters LPM3.5/LPM4.5 modes of operation, this bit will *always* be cleared to 0. In other words, the RSTn/NMI pin will always assume a reset functionality in LPM3.5/LPM4.5 modes.

Table 6-11. SYS_NMI_CTLSTAT Register Description (continued)

| BIT | FIELD | TYPE | RESET | DESCRIPTION |
|-----|--------|------|-------|---|
| 0 | CS_SRC | RW | 1h | 0b = Disables CS interrupt as a source of NMI 1b = Enables CS interrupt as a source of NMI |

6.6.2 Device-Level User Interrupts

Table 6-12 lists the various interrupt sources and their connection to the NVIC inputs

NOTE

Some sources may have multiple interrupt conditions, in which case the appropriate interrupt status/flag register of the source must be examined to differentiate between the generating conditions.

Table 6-12. NVIC Interrupts

| NVIC INTERRUPT INPUT | SOURCE | FLAGS IN SOURCE |
|----------------------|------------------------|---|
| INTISR[0] | PSS ⁽¹⁾ | |
| INTISR[1] | CS ⁽¹⁾ | |
| INTISR[2] | PCM ⁽¹⁾ | |
| INTISR[3] | WDT_A | |
| INTISR[4] | FPU_INT ⁽²⁾ | Combined interrupt from flags in the FPSCR (part of Cortex-M4 FPU) |
| INTISR[5] | Flash Controller | Flash Controller interrupt flags |
| INTISR[6] | COMP_E0 | Comparator_E0 interrupt flags |
| INTISR[7] | COMP_E1 | Comparator_E1 interrupt flags |
| INTISR[8] | Timer_A0 | TA0CCTL0.CCIFG |
| INTISR[9] | Timer_A0 | TA0CCTLx.CCIFG (x = 1 through 4), TA0CTL.TAIFG |
| INTISR[10] | Timer_A1 | TA1CCTL0.CCIFG |
| INTISR[11] | Timer_A1 | TA1CCTLx.CCIFG (x = 1 through 4), TA1CTL.TAIFG |
| INTISR[12] | Timer_A2 | TA2CCTL0.CCIFG |
| INTISR[13] | Timer_A2 | TA2CCTLx.CCIFG (x = 1 through 4), TA2CTL.TAIFG |
| INTISR[14] | Timer_A3 | TA3CCTL0.CCIFG |
| INTISR[15] | Timer_A3 | TA3CCTLx.CCIFG (x = 1 through 4), TA3CTL.TAIFG |
| INTISR[16] | eUSCI_A0 | UART/SPI mode Tx/Rx/Status Flags |
| INTISR[17] | eUSCI_A1 | UART/SPI mode Tx/Rx/Status Flags |
| INTISR[18] | eUSCI_A2 | UART/SPI mode Tx/Rx/Status Flags |
| INTISR[19] | eUSCI_A3 | UART/SPI mode Tx/Rx/Status Flags |
| INTISR[20] | eUSCI_B0 | SPI/I ² C mode Tx/Rx/Status Flags (I ² C in multi-slave mode) |
| INTISR[21] | eUSCI_B1 | SPI/I ² C mode Tx/Rx/Status Flags (I ² C in multi-slave mode) |
| INTISR[22] | eUSCI_B2 | SPI/I ² C mode Tx/Rx/Status Flags (I ² C in multi-slave mode) |
| INTISR[23] | eUSCI_B3 | SPI/I ² C mode Tx/Rx/Status Flags (I ² C in multi-slave mode) |
| INTISR[24] | ADC14 | IFG[0-31], LO/IN/HI-IFG, RDYIFG, OVIFG, TOVIFG |
| INTISR[25] | Timer32_INT1 | Timer32 Interrupt for Timer1 |
| INTISR[26] | Timer32_INT2 | Timer32 Interrupt for Timer2 |
| INTISR[27] | Timer32_INTC | Timer32 Combined Interrupt |
| INTISR[28] | AES256 | AESRDYIFG |
| INTISR[29] | RTC_C | OFIFG, RDYIFG, TEVIFG, AIFG, RT0PSIFG, RT1PSIFG |
| INTISR[30] | DMA_ERR | DMA error interrupt |

(1) This source can also be mapped to the system NMI. Refer to the *MSP432P4xx Family Technical Reference Manual* for more details.

(2) The FPU of the Cortex-M4 can generate interrupts due to multiple floating point exceptions. It is the responsibility of software to process and clear the interrupt flags in the FPSCR.

Table 6-12. NVIC Interrupts (continued)

| NVIC INTERRUPT INPUT | SOURCE | FLAGS IN SOURCE |
|----------------------|-------------------------|---------------------------|
| INTISR[31] | DMA_INT3 | DMA completion interrupt3 |
| INTISR[32] | DMA_INT2 | DMA completion interrupt2 |
| INTISR[33] | DMA_INT1 | DMA completion interrupt1 |
| INTISR[34] | DMA_INT0 ⁽³⁾ | DMA completion interrupt0 |
| INTISR[35] | I/O Port P1 | P1IFG.x (x = 0 through 7) |
| INTISR[36] | I/O Port P2 | P2IFG.x (x = 0 through 7) |
| INTISR[37] | I/O Port P3 | P3IFG.x (x = 0 through 7) |
| INTISR[38] | I/O Port P4 | P4IFG.x (x = 0 through 7) |
| INTISR[39] | I/O Port P5 | P5IFG.x (x = 0 through 7) |
| INTISR[40] | I/O Port P6 | P6IFG.x (x = 0 through 7) |
| INTISR[41] | Reserved | |
| INTISR[42] | Reserved | |
| INTISR[43] | Reserved | |
| INTISR[44] | Reserved | |
| INTISR[45] | Reserved | |
| INTISR[46] | Reserved | |
| INTISR[47] | Reserved | |
| INTISR[48] | Reserved | |
| INTISR[49] | Reserved | |
| INTISR[50] | Reserved | |
| INTISR[51] | Reserved | |
| INTISR[52] | Reserved | |
| INTISR[53] | Reserved | |
| INTISR[54] | Reserved | |
| INTISR[55] | Reserved | |
| INTISR[56] | Reserved | |
| INTISR[57] | Reserved | |
| INTISR[58] | Reserved | |
| INTISR[59] | Reserved | |
| INTISR[60] | Reserved | |
| INTISR[61] | Reserved | |
| INTISR[62] | Reserved | |
| INTISR[63] | Reserved | |

(3) DMA_INT0 has a different functionality from DMA_INT1/2/3. Refer to [Section 6.4.2](#) for more details.

NOTE

The Interrupt Service Routine (ISR) **must** ensure that the relevant interrupt flag in the source peripheral is cleared before returning from the ISR. If this is not done, the same interrupt may get incorrectly pended again as a new event, even though the event has already been processed by the ISR. As there may be a few cycles of delay between the execution of the write command and the actual write reflecting in the peripheral's interrupt flag register, the recommendation is to carry out the write and wait for a few cycles before exiting the ISR. Alternatively, the application can do an explicit read to ensure that the flag was cleared before exiting the ISR.

6.7 System Control

System Control comprises the modules that govern the overall behavior of the device, including power management, operating modes, clocks, reset handling, and user configuration settings.

6.7.1 Device Resets

The MSP432P401x devices support multiple classes of reset. Each class results in a different level of initiation of device logic, thus offering the application developer the capability of initiating different resets based reset requirements during code development and debug. The following subsections cover the classes of reset in the device

6.7.1.1 Power On/Off Reset (POR)

The POR initiates a complete initialization of the application settings and device configuration information. This class of reset may be initiated either by the PSS, the PCM, the RSTn pin, the Clock System upon DCO external resistor short circuit fault or the device emulation logic (through the debugger). From an application perspective, all sources of POR return the device to the same state of initialization.

NOTE

Depending on the source of the reset, the device may exhibit different wake-up latencies from the POR. This implementation enables optimization of the reset recovery time.

6.7.1.2 Reboot Reset

The Reboot Reset is identical to the POR, and allows the application to emulate a POR class reset without needing to power cycle the device or activating the RSTn pin. It can also be initiated through the debugger, and hence does not affect the debug connection to the device. On the other hand, a POR will result in a debug disconnect.

6.7.1.2.1 Reboot Control Register (Address = E004_3000h)

Figure 6-13. SYS_REBOOT_CTL Register

| | | | | | | | | | | | | | | | |
|----------|----|----|----|----|----|----|----|----------|----|----|----|----|----|----|------------|
| 31 | 30 | 29 | 28 | 27 | 26 | 25 | 24 | 23 | 22 | 21 | 20 | 19 | 18 | 17 | 16 |
| Reserved | | | | | | | | | | | | | | | |
| r | r | r | r | r | r | r | r | r | r | r | r | r | r | r | r |
| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| WKEY | | | | | | | | Reserved | | | | | | | REBO OT |
| w | w | w | w | w | w | w | w | r | r | r | r | r | r | r | w |

Table 6-13. SYS_REBOOT_CTL Register Description

| BIT | FIELD | TYPE | RESET | DESCRIPTION |
|-------|----------|------|-------|---|
| 31-16 | Reserved | R | 0h | Reserved. Reads return 0h |
| 15-8 | WKEY | W | 0h | Key to enable writes to bit 0. Bit 0 is written only if WKEY is 69h in the same write cycle |
| 7-1 | Reserved | R | 0h | Reserved. Reads return 0h |
| 0 | REBOOT | W | 0h | Write 1 initiates a Reboot of the device |

6.7.1.3 Hard Reset

The Hard Reset resets all modules that are set up or modified by the application. This includes all peripherals as well as the non debug logic of the Cortex-M4. The MSP432P401x devices support up to 16 sources of Hard Reset. The following table lists the reset source allocation. The Reset Controller registers can be used to identify the possible source of reset in the device. For further details, refer to Reset Controller chapter in the *MSP432P4xx Family Technical Reference Manual* ([SLAU356](#)).

Table 6-14. MSP432P401x Hard Reset Sources

| RESET SOURCE NUMBER | SOURCE |
|------------------------|--|
| 0 | SYSRESETREQ (System reset output of Cortex-M4) |
| 1 | WDT_A Time-out ⁽¹⁾ |
| 2 | WDT_A Password Violation ⁽¹⁾ |
| 3 | Flash Controller ⁽²⁾ |
| 4 | Reserved ⁽³⁾ |
| 5 | Reserved ⁽³⁾ |
| 6 | Reserved ⁽³⁾ |
| 7 | Reserved ⁽³⁾ |
| 8 | Reserved ⁽³⁾ |
| 9 | Reserved ⁽³⁾ |
| 10 | Reserved ⁽³⁾ |
| 11 | Reserved ⁽³⁾ |
| 12 | Reserved ⁽³⁾ |
| 13 | Reserved ⁽³⁾ |
| 14 | CS ⁽⁴⁾ |
| 15 | PCM ⁽⁵⁾ |

- (1) The WDT_A generated resets can be mapped either as a Hard Reset or a Soft Reset.
- (2) The Flash Controller can generate a reset if a voltage anomaly is detected that can corrupt only flash reads, and not the rest of the system.
- (3) 'Reserved' indicates that this source of Hard Reset is currently unused and left for future expansion.
- (4) The CS is technically not a true source of a Hard Reset, but if a Hard Reset occurs during clock source/frequency changes, it may extend the reset to allow the clocks to settle before releasing the system. This prevents chances of nondeterministic behavior.
- (5) The PCM is technically not a true source of a Hard Reset, but if a Hard Reset causes power mode changes, it may extend the reset to allow the system to settle before releasing the Reset. This prevents chances of nondeterministic behavior.

6.7.1.4 Soft Reset

The Soft Reset resets only the execution component of the system, which is the non debug logic in the Cortex-M4 and the WDT_A. This reset remains nonintrusive to all other peripherals and system components. The MSP432P401x devices support up to 16 sources of Soft Reset. The following table lists the reset source allocation. The Reset Controller registers can be used to identify the possible source of reset in the design. For further details, refer to Reset Controller chapter in the *MSP432P4xx Family Technical Reference Manual* ([SLAU356](#)).

Table 6-15. MSP432P401x Soft Reset Sources

| RESET SOURCE NUMBER | SOURCE |
|---------------------|---|
| 0 | CPU LOCKUP Condition (LOCKUP output of Cortex-M4) |
| 1 | WDT_A Time-out ⁽¹⁾ |
| 2 | WDT_A Password Violation ⁽¹⁾ |
| 3 | Reserved ⁽²⁾ |
| 4 | Reserved ⁽²⁾ |
| 5 | Reserved ⁽²⁾ |
| 6 | Reserved ⁽²⁾ |
| 7 | Reserved ⁽²⁾ |
| 8 | Reserved ⁽²⁾ |
| 9 | Reserved ⁽²⁾ |
| 10 | Reserved ⁽²⁾ |
| 11 | Reserved ⁽²⁾ |
| 12 | Reserved ⁽²⁾ |
| 13 | Reserved ⁽²⁾ |
| 14 | Reserved ⁽²⁾ |
| 15 | Reserved ⁽²⁾ |

(1) The WDT_A generated resets can be mapped either as a Hard Reset or a Soft Reset.

(2) 'Reserved' indicates that this source of Soft Reset is currently unused and left for future expansion.

NOTE

To support and enhance debug of reset conditions, the Reset Controller is located on the PPB of the device. This allows the Reset Controller to remain accessible even if the device is stuck in a Hard or Soft reset state. The Reset Controller permits overrides for Hard and Soft resets, thereby allowing regaining control of the device and isolating the cause of the stuck reset.

6.7.2 Power Supply System (PSS)

The PSS controls all the power supply related functionality of the device. It consists of the following components

6.7.2.1 VCCDET

The VCCDET monitors the input voltage applied at the DVCC and AVCC pins of the device. When the V_{CC} is found to be below the operating range of the VCCDET trip points, it generates a brownout condition, thereby initiating a device reset (POR class reset).

6.7.2.2 Supply Supervisor and Monitor for High Side (SVSMH)

The SVSMH supervises and monitors the V_{CC} . SVSMH has a programmable threshold setting and can be used by the application to generate a reset or an interrupt if the V_{CC} dips below the desired threshold. In supervisor mode, the SVSMH generates a device reset (POR class reset). In monitor mode, the SVSMH generates an interrupt. The SVSMH can also be disabled if monitoring and supervision of the supply voltage are not required (offers further power savings).

6.7.2.3 Core Voltage Regulator

The MSP432P401x devices can be programmed to operate either with an LDO or with a DC-DC as the voltage regulator for the digital logic in the core domain of the device. The DC-DC offers significant boost in power efficiency for high-current high-performance applications. The LDO is a highly efficient regulator that offers power advantages at lower V_{CC} ranges and in the ultra-low-power modes of operation.

The core operating voltage (output of the LDO or DC-DC) is automatically set by the device depending on the selected operating mode of the device (refer to [Table 6-16](#) for further details). The device offers seamless switching between LDO and DC-DC operating modes and also implements a seamless DC-DC fail-safe mechanism.

6.7.2.4 Supply Supervisor for Low Side (SVSL)

The SVSL monitors the low-side (core domain) voltage of the device (also available at the V_{CORE} pin). If the core voltage drops below the trip threshold of the SVSL, the SVSL generates a device reset (POR class reset). The SVSL can also be disabled if supervision of the core voltage is not required (offers further power savings).

6.7.3 Power Control Manager (PCM)

The PCM controls the operating modes of the device and the switching between the modes. This is controlled by the application, which can choose modes to meet its power and performance requirements. [Table 6-16](#) lists the operating modes of the device.

Table 6-16. MSP432P401x Operating Modes

| OPERATING MODE | DESCRIPTION |
|------------------|---|
| AM_LDO_VCORE0 | LDO based active mode, medium performance, core voltage level 0 |
| LPM0_LDO_VCORE0 | Same as above, except that CPU is OFF (no code execution) |
| AM_LDO_VCORE1 | LDO based active mode, maximum performance, core voltage level 1 |
| LPM0_LDO_VCORE1 | Same as above, except that CPU is OFF (no code execution) |
| AM_DCDC_VCORE0 | DC-DC based active mode, medium performance, core voltage level 0 |
| LPM0_DCDC_VCORE0 | Same as above, except that CPU is OFF (no code execution) |
| AM_DCDC_VCORE1 | DC-DC based active mode, maximum performance, core voltage level 1 |
| LPM0_DCDC_VCORE1 | Same as above, except that CPU is OFF (no code execution) |
| AM_LF_VCORE0 | LDO based low frequency active mode, core voltage level 0 |
| LPM0_LF_VCORE0 | Same as above, except that CPU is OFF (no code execution) |
| AM_LF_VCORE1 | LDO based low frequency active mode, core voltage level 1 |
| LPM0_LF_VCORE1 | Same as above, except that CPU is OFF (no code execution) |
| LPM3_VCORE0 | LDO based low-power mode with full state retention, core voltage level 0, RTC and WDT can be active |
| LPM3_VCORE1 | LDO based low-power mode with full state retention, core voltage level 1, RTC and WDT can be active |
| LPM4_VCORE0 | LDO based low-power mode with full state retention, core voltage level 0, all peripherals disabled. |
| LPM4_VCORE1 | LDO based low-power mode with full state retention, core voltage level 1, all peripherals disabled |
| LPM3.5 | LDO based low-power mode, core voltage level 0, no retention of peripheral registers, RTC and WDT can be active |
| LPM4.5 | Core voltage turned off, wake-up only through Pin Reset or Wake-up capable I/O's |

6.7.4 Clock System (CS)

The CS contains the sources of the various clocks in the device and also controls the mapping between sources and the clock domains in the device.

6.7.4.1 LFXT

The LFXT supports 32.768-kHz low-frequency crystals.

6.7.4.2 HFXT

The HFXT supports high-frequency crystals up to 48 MHz.

6.7.4.3 DCO

The DCO is a power-efficient tunable internal oscillator that generates up to 48 MHz. It also supports a high-precision mode when using an external precision resistor.

6.7.4.4 Very Low-Power Low-Frequency Oscillator (VLO)

The VLO is an ultra-low-power internal oscillator that generates a low-accuracy clock at typical frequency of 9.4 kHz.

6.7.4.5 Low Frequency Reference Oscillator (REFO)

The REFO can be used as an alternate low-power lower-accuracy source of a 32.768-kHz clock instead of the LFXT. REFO can also be programmed to generate a 128-kHz clock.

6.7.4.6 Module Oscillator (MODOSC)

The MODOSC is an internal clock source that has a very low latency wake-up time. MODOSC is factory-calibrated to a frequency of 25 MHz. It is typically used to supply a 'clock on request' to modules like the ADC (when in 1-Msps conversion mode).

6.7.4.7 System Oscillator (SYSOSC)

The SYSOSC is a lower-frequency version of the MODOSC and is factory calibrated to a frequency of 5 MHz. It drives the ADC sampling clock in the 200-ksps conversion mode. In addition, it is also used for timing of various system-level control and management operations.

6.7.4.8 Fail-Safe Mechanisms

All clock sources that operate with external components have a built-in fail-safe mechanism that automatically switches to the relevant backup source, thereby ensuring that spurious or unstable clocks never impact the device behavior.

6.7.5 System Controller (SYSCTL)

The SYSCTL is a set of various miscellaneous features of the device, including SRAM bank configuration, RSTn/NMI function selection, and peripheral halt control. In addition, the SYSCTL enables device security features like JTAG and SWD lock and IP protection, which can be used to protect unauthorized accesses either to the entire device memory map or to certain selected regions of the flash. [Table 6-17](#) lists the registers that are part of SYSCTL. Only the offsets of the registers are listed—the entire addresses are listed with the complete register definitions elsewhere this data sheet.

Table 6-17. SYSCTL Registers

| OFFSET | ACRONYM | REGISTER NAME | SECTION |
|--------|---------------------|--|-----------------------------------|
| 000h | SYS_REBOOT_CTL | Reboot Control Register | Section 6.7.1.2.1 |
| 004h | SYS_NMI_CTLSTAT | NMI Control and Status Register | Section 6.6.1.1 |
| 008h | SYS_WDTRESET_CTL | Watchdog Reset Control Register | Section 6.8.7.1 |
| 00Ch | SYS_PERIHalt_CTL | Peripheral Halt Control Register | Section 6.9.2 |
| 010h | SYS_SRAM_SIZE | SRAM Size Register | Section 6.3.2.3.1 |
| 014h | SYS_SRAM_BANKEN | SRAM Bank Enable Register | Section 6.3.2.3.2 |
| 018h | SYS_SRAM_BANKRET | SRAM Bank Retention Control Register | Section 6.3.2.3.3 |
| 020h | SYS_FLASH_SIZE | Flash Size Register | Section 6.3.1.1.1 |
| 030h | SYS_DIO_GLTFILT_CTL | Digital I/O Glitch Filter Control Register | Section 6.8.1.1.1 |

NOTE

As is the case with the Cortex-M4 system control registers (housed on the internal PPB space), the System Controller module registers are mapped to the Cortex-M4 external PPB. This keeps the System Controller module accessible even when the Hard and/or Soft resets are active.

6.8 Peripherals

6.8.1 Digital I/O

There are up to 10 8-bit I/O ports implemented:

- All individual I/O bits are independently programmable.
- Any combination of input, output, and interrupt conditions is possible.
- Programmable pullup or pulldown on all ports.
- Edge-selectable interrupt capability is available on ports P1 through P6.
- Wake-up capability from LPM3, LPM4, LPM3.5, and LPM4.5 modes over ports P1 through P6.
- Read/write access to port-control registers is supported by all instructions.
- Ports can be accessed byte-wise or in pairs (16bit widths).
- Capacitive Touch functionality is supported on all pins of ports P1 through P10 and PJ.
- Glitch filtering capability on selected digital I/Os.

6.8.1.1 Glitch Filtering on Digital I/Os

Some of the interrupt and wake-up capable digital I/Os have the capability to suppress glitches through the use of analog glitch filter to prevent unintentional interrupt or wake-up during device operation. The analog filter will suppress a minimum of 250ns wide glitches. The glitch filter on these selected digital I/Os is enabled by default. If the glitch filtering capability is not required in the application there is a provision to bypass them by programming the SYS_DIO_GLTFILT_CTL register. When GLTFILT_EN bit in this register is cleared then glitch filters on all the digital I/Os are bypassed at once. The glitch filter is automatically bypassed on a digital I/O when it is configured for peripheral or analog functionality by programming the respective PySEL0.x, PySEL1.x registers.

NOTE

The glitch filter is implemented on the following digital I/Os on MSP432P401x devices: P1.0, P1.4, P1.5, P3.0, P3.4, P3.5, P6.6, P6.7.

6.8.1.1.1 Digital I/O Glitch Filter Control Register [Address = E004_0030h]**Figure 6-14. SYS_DIO_GLTFLT_CTL Register**

| | | | | | | | | | | | | | | | |
|----------|----|----|----|----|----|----|----|----|----|----|----|----|----|----|-----------|
| 31 | 30 | 29 | 28 | 27 | 26 | 25 | 24 | 23 | 22 | 21 | 20 | 19 | 18 | 17 | 16 |
| Reserved | | | | | | | | | | | | | | | |
| r | r | r | r | r | r | r | r | r | r | r | r | r | r | r | r |
| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| Reserved | | | | | | | | | | | | | | | GLTFLT_EN |
| r | r | r | r | r | r | r | r | r | r | r | r | r | r | r | rw-1 |

Table 6-18. SYS_DIO_GLTFLT_CTL Register Description

| BITS | FIELD | TYPE | RESET | DESCRIPTION |
|------|-----------|------|-------|---|
| 31-1 | Reserved | R | 0h | Reserved. Always reads 0h. |
| 0 | GLTFLT_EN | RW | 1h | 0b = Disables glitch filter on the digital I/Os. 1b = Enables glitch filter on the digital I/Os. |

6.8.2 Port Mapping Controller (PMAPCTL)

The port mapping controller allows flexible and reconfigurable mapping of digital functions.

6.8.2.1 Port Mapping Definitions

The port mapping controller on MSP432P401x devices allows reconfigurable mapping of digital functions over ports P2, P3, and P7.

Table 6-19. Port Mapping, Mnemonics, and Functions

| VALUE | PxMAPy MNEMONIC | INPUT PIN FUNCTION | OUTPUT PIN FUNCTION |
|-------|-----------------|--|---------------------|
| 0 | PM_NONE | None | DVSS |
| 1 | PM_UCA0CLK | eUSCI_A0 clock input/output (direction controlled by eUSCI) | |
| 2 | PM_UCA0RXD | eUSCI_A0 UART RXD (direction controlled by eUSCI – Input) | |
| | PM_UCA0SOMI | eUSCI_A0 SPI slave out master in (direction controlled by eUSCI) | |
| 3 | PM_UCA0TXD | eUSCI_A0 UART TXD (direction controlled by eUSCI – Output) | |
| | PM_UCA0SIMO | eUSCI_A0 SPI slave in master out (direction controlled by eUSCI) | |
| 4 | PM_UCB0CLK | eUSCI_B0 clock input/output (direction controlled by eUSCI) | |
| 5 | PM_UCB0SDA | eUSCI_B0 I ² C data (open drain and direction controlled by eUSCI) | |
| | PM_UCB0SIMO | eUSCI_B0 SPI slave in master out (direction controlled by eUSCI) | |
| 6 | PM_UCB0SCL | eUSCI_B0 I ² C clock (open drain and direction controlled by eUSCI) | |
| | PM_UCB0SOMI | eUSCI_B0 SPI slave out master in (direction controlled by eUSCI) | |
| 7 | PM_UCA1STE | eUSCI_A1 SPI slave transmit enable (direction controlled by eUSCI) | |
| 8 | PM_UCA1CLK | eUSCI_A1 clock input/output (direction controlled by eUSCI) | |
| 9 | PM_UCA1RXD | eUSCI_A1 UART RXD (direction controlled by eUSCI – Input) | |
| | PM_UCA1SOMI | eUSCI_A1 SPI slave out master in (direction controlled by eUSCI) | |
| 10 | PM_UCA1TXD | eUSCI_A1 UART TXD (direction controlled by eUSCI – Output) | |
| | PM_UCA1SIMO | eUSCI_A1 SPI slave in master out (direction controlled by eUSCI) | |
| 11 | PM_UCA2STE | eUSCI_A2 SPI slave transmit enable (direction controlled by eUSCI) | |

Table 6-19. Port Mapping, Mnemonics, and Functions (continued)

| VALUE | PxMAPy MNEMONIC | INPUT PIN FUNCTION | OUTPUT PIN FUNCTION |
|--------------------------|-----------------|---|------------------------------|
| 12 | PM_UCA2CLK | eUSCI_A2 clock input/output (direction controlled by eUSCI) | |
| 13 | PM_UCA2RXD | eUSCI_A2 UART RXD (direction controlled by eUSCI – Input) | |
| | PM_UCA2SOMI | eUSCI_A2 SPI slave out master in (direction controlled by eUSCI) | |
| 14 | PM_UCA2TXD | eUSCI_A2 UART TXD (direction controlled by eUSCI – Output) | |
| | PM_UCA2SIMO | eUSCI_A2 SPI slave in master out (direction controlled by eUSCI) | |
| 15 | PM_UCB2STE | eUSCI_B2 SPI slave transmit enable (direction controlled by eUSCI) | |
| 16 | PM_UCB2CLK | eUSCI_B2 clock input/output (direction controlled by eUSCI) | |
| 17 | PM_UCB2SDA | eUSCI_B2 I ² C data (open drain and direction controlled by eUSCI) | |
| | PM_UCB2SIMO | eUSCI_B2 SPI slave in master out (direction controlled by eUSCI) | |
| 18 | PM_UCB2SCL | eUSCI_B2 I ² C clock (open drain and direction controlled by eUSCI) | |
| | PM_UCB2SOMI | eUSCI_B2 SPI slave out master in (direction controlled by eUSCI) | |
| 19 | PM_TA0.0 | TA0 CCR0 capture input CCI0A | TA0 CCR0 compare output Out0 |
| 20 | PM_TA0.1 | TA0 CCR1 capture input CCI1A | TA0 CCR1 compare output Out1 |
| 21 | PM_TA0.2 | TA0 CCR2 capture input CCI2A | TA0 CCR2 compare output Out2 |
| 22 | PM_TA0.3 | TA0 CCR3 capture input CCI3A | TA0 CCR3 compare output Out3 |
| 23 | PM_TA0.4 | TA0 CCR4 capture input CCI4A | TA0 CCR4 compare output Out4 |
| 24 | PM_TA1.1 | TA1 CCR1 capture input CCI1A | TA1 CCR1 compare output Out1 |
| 25 | PM_TA1.2 | TA1 CCR2 capture input CCI2A | TA1 CCR2 compare output Out2 |
| 26 | PM_TA1.3 | TA1 CCR3 capture input CCI3A | TA1 CCR3 compare output Out3 |
| 27 | PM_TA1.4 | TA1 CCR4 capture input CCI4A | TA1 CCR4 compare output Out4 |
| 28 | PM_TA0CLK | Timer_A0 external clock input | None |
| | PM_C0OUT | None | Comparator-E0 output |
| 29 | PM_TA1CLK | Timer_A1 external clock input | None |
| | PM_C1OUT | None | Comparator-E1 output |
| 30 | PM_DMAE0 | DMAE0 input | None |
| | PM_SMCLK | None | SMCLK |
| 31 (0FFh) ⁽¹⁾ | PM_ANALOG | Disables the output driver as well as the input Schmitt-trigger to prevent parasitic cross currents when applying analog signals. | |

(1) The value of the PM_ANALOG mnemonic is set to 31. The port mapping registers are 5 bits wide, and the upper bits are ignored, which results in a read value of 31.

Table 6-20. Default Mapping

| PIN NAME | PxMAPy MNEMONIC | INPUT PIN FUNCTION | OUTPUT PIN FUNCTION |
|---------------------------------|----------------------------|---|------------------------------|
| P2.0/PM_UCA1STE | PM_UCA1STE | eUSCI_A1 SPI slave transmit enable (direction controlled by eUSCI) | |
| P2.1/PM_UCA1CLK | PM_UCA1CLK | eUSCI_A1 clock input/output (direction controlled by eUSCI) | |
| P2.2/PM_UCA1RXD/ PM_UCA1SOMI | PM_UCA1RXD/ PM_UCA1SOMI | eUSCI_A1 UART RXD (direction controlled by eUSCI – Input) eUSCI_A1 SPI slave out master in (direction controlled by eUSCI) | |
| P2.3/PM_UCA1TXD/ PM_UCA1SIMO | PM_UCA1TXD/ PM_UCA1SIMO | eUSCI_A1 UART TXD (direction controlled by eUSCI – output)/ eUSCI_A1 SPI slave in master out (direction controlled by eUSCI) | |
| P2.4/PM_TA0.1 ⁽¹⁾ | PM_TA0.1 | TA0 CCR1 capture input CCI1A | TA0 CCR1 compare output Out1 |
| P2.5/PM_TA0.2 ⁽¹⁾ | PM_TA0.2 | TA0 CCR2 capture input CCI2A | TA0 CCR2 compare output Out2 |
| P2.6/PM_TA0.3 ⁽¹⁾ | PM_TA0.3 | TA0 CCR3 capture input CCI3A | TA0 CCR3 compare output Out3 |
| P2.7/PM_TA0.4 ⁽¹⁾ | PM_TA0.4 | TA0 CCR4 capture input CCI4A | TA0 CCR4 compare output Out4 |
| P3.0/PM_UCA2STE | PM_UCA2STE | eUSCI_A2 SPI slave transmit enable (direction controlled by eUSCI) | |
| P3.1/PM_UCA2CLK | PM_UCA2CLK | eUSCI_A2 clock input/output (direction controlled by eUSCI) | |
| P3.2/PM_UCA2RXD/ PM_UCA2SOMI | PM_UCA2RXD/ PM_UCA2SOMI | eUSCI_A2 UART RXD (direction controlled by eUSCI – input)/ eUSCI_A2 SPI slave out master in (direction controlled by eUSCI) | |

(1) Not available on the 64-pin RGC package.

Table 6-20. Default Mapping (continued)

| PIN NAME | PxMAPy MNEMONIC | INPUT PIN FUNCTION | OUTPUT PIN FUNCTION |
|-----------------------------------|----------------------------|---|------------------------------|
| P3.3/PM_UCA2TXD/ PM_UCA2SIMO | PM_UCA2TXD/ PM_UCA2SIMO | eUSCI_A2 UART TXD (direction controlled by eUSCI – output)/ eUSCI_A2 SPI slave in master out (direction controlled by eUSCI) | |
| P3.4/PM_UCB2STE | PM_UCB2STE | eUSCI_B2 SPI slave transmit enable (direction controlled by eUSCI) | |
| P3.5/PM_UCB2CLK | PM_UCB2CLK | eUSCI_B2 clock input/output (direction controlled by eUSCI) | |
| P3.6/PM_UCB2SIMO/ PM_UCB2SDA | PM_UCB2SIMO/ PM_UCB2SDA | eUSCI_B2 SPI slave in master out (direction controlled by eUSCI)/ eUSCI_B2 I ² C data (open drain and direction controlled by eUSCI) | |
| P3.7/PM_UCB2SOMI/ PM_UCB2SCL | PM_UCB2SOMI/ PM_UCB2SCL | eUSCI_B2 SPI slave out master in (direction controlled by eUSCI)/ eUSCI_B2 I ² C clock (open drain and direction controlled by eUSCI) | |
| P7.0/PM_SMCLK/ PM_DMAE0 | PM_SMCLK/ PM_DMAE0 | DMAE0 input | SMCLK |
| P7.1/PM_C0OUT/ PM_TA0CLK | PM_C0OUT/ PM_TA0CLK | Timer_A0 external clock input | Comparator-E0 output |
| P7.2/PM_C1OUT/ PM_TA1CLK | PM_C1OUT/ PM_TA1CLK | Timer_A1 external clock input | Comparator-E1 output |
| P7.3/PM_TA0.0 | PM_TA0.0 | TA0 CCR0 capture input CCI0A | TA0 CCR0 compare output Out0 |
| P7.4/PM_TA1.4/C0.5 ⁽¹⁾ | PM_TA1.4 | TA1 CCR4 capture input CCI4A | TA1 CCR4 compare output Out4 |
| P7.5/PM_TA1.3/C0.4 ⁽¹⁾ | PM_TA1.3 | TA1 CCR3 capture input CCI3A | TA1 CCR3 compare output Out3 |
| P7.6/PM_TA1.2/C0.3 ⁽¹⁾ | PM_TA1.2 | TA1 CCR2 capture input CCI2A | TA1 CCR2 compare output Out2 |
| P7.7/PM_TA1.1/C0.2 ⁽¹⁾ | PM_TA1.1 | TA1 CCR1 capture input CCI1A | TA1 CCR1 compare output Out1 |

6.8.3 Timer_A

Timers TA0, TA1, TA2 and TA3 are 16-bit timers/counters (Timer_A type) with five capture/compare registers each. Each timer supports multiple capture/compares, PWM outputs, and interval timing. Each has extensive interrupt capabilities. Interrupts may be generated from the counter on overflow conditions and from each of the capture/compare registers.

6.8.3.1 Timer_A Signal Connection Tables

Table 6-21 through Table 6-24 list the interface signals of the Timer_A modules on the device and connections of the interface signals to the corresponding pins or internal signals. The following rules apply to the naming conventions used.

- The first column lists the device level pin or internal signal that sources the clocks and/or triggers into the Timer. The default assumption is that these are pins, unless specifically marked as (internal). Nomenclature used for internal signals is as follows:
 - CxOUT: output from Comparator 'x'.
 - TAx_Cy: Output from Timer 'x', Capture/Compare module 'y'.
- The second column lists the input signals of the Timer module.
- The third column lists the submodule of the Timer and also implies the functionality (Timer, Capture (Inputs or Triggers), or Compare (Outputs or PWM)).
- The fourth column lists the output signals of the Timer module.
- The fifth column lists the device level pin or internal signal that is driven by the outputs of the Timer. The default assumption is that these are pins, unless specifically marked as (internal).

NOTE

The pin names listed in the tables are the complete names. It is the responsibility of the software to ensure that the pin is used in the intended mode for the targeted Timer functionality.

NOTE

Internal signals that are sourced by the Timer outputs may connect to other modules (other Timers, ADC, etc) in the device (as trigger sources).

Table 6-21. TA0 Signal Connections

| DEVICE INPUT PIN OR INTERNAL SIGNAL | MODULE INPUT SIGNAL | MODULE BLOCK | MODULE OUTPUT SIGNAL | DEVICE OUTPUT PIN OR INTERNAL SIGNAL |
|-------------------------------------|---------------------|--------------|----------------------|---|
| P7.1/PM_C0OUT/PM_TA0CLK | TACLK | Timer | N/A | N/A |
| ACLK (internal) | ACLK | | | |
| SMCLK (internal) | SMCLK | | | |
| C0OUT (internal) | INCLK | | | |
| P7.3/PM_TA0.0 | CCI0A | CCR0 | TA0 | P7.3/PM_TA0.0 TA0_C0 (internal) |
| DV _{SS} | CCI0B | | | |
| DV _{SS} | GND | | | |
| DV _{CC} | V _{CC} | | | |
| P2.4/PM_TA0.1 | CCI1A | CCR1 | TA1 | P2.4/PM_TA0.1 TA0_C1 (internal) ADC14 (internal) ADC14SHSx = {1} |
| ACLK (internal) | CCI1B | | | |
| DV _{SS} | GND | | | |
| DV _{CC} | V _{CC} | | | |
| P2.5/PM_TA0.2 | CCI2A | CCR2 | TA2 | P2.5/PM_TA0.2 TA0_C2 (internal) ADC14 (internal) ADC14SHSx = {2} |
| C0OUT (internal) | CCI2B | | | |
| DV _{SS} | GND | | | |
| DV _{CC} | V _{CC} | | | |
| P2.6/PM_TA0.3 | CCI3A | CCR3 | TA3 | P2.6/PM_TA0.3 TA0_C3 (internal) |
| C1OUT (internal) | CCI3B | | | |
| DV _{SS} | GND | | | |
| DV _{CC} | V _{CC} | | | |
| P2.7/PM_TA0.4 | CCI4A | CCR4 | TA4 | P2.7/PM_TA0.4 TA0_C4 (internal) |
| TA1_C4 (Internal) | CCI4B | | | |
| DV _{SS} | GND | | | |
| DV _{CC} | V _{CC} | | | |

Table 6-22. TA1 Signal Connections

| DEVICE INPUT PIN OR INTERNAL SIGNAL | MODULE INPUT SIGNAL | MODULE BLOCK | MODULE OUTPUT SIGNAL | DEVICE OUTPUT PIN OR INTERNAL SIGNAL |
|-------------------------------------|---------------------|--------------|----------------------|--|
| P7.2/PM_C1OUT/PM_TA1CLK | TACLK | Timer | N/A | N/A |
| ACLK (internal) | ACLK | | | |
| SMCLK (internal) | SMCLK | | | |
| C1OUT (internal) | INCLK | | | |
| P8.0/UCB3STE/TA1.0/C0.1 | CCI0A | CCR0 | TA0 | P8.0/UCB3STE/TA1.0/C0.1 TA1_C0 (internal) |
| DV _{SS} | CCI0B | | | |
| DV _{SS} | GND | | | |
| DV _{CC} | V _{CC} | | | |
| P7.7/PM_TA1.1/C0.2 | CCI1A | CCR1 | TA1 | P7.7/PM_TA1.1/C0.2 TA1_C1 (internal) ADC14 (internal) ADC14SHSx = {3} |
| ACLK (internal) | CCI1B | | | |
| DV _{SS} | GND | | | |
| DV _{CC} | V _{CC} | | | |
| P7.6/PM_TA1.2/C0.3 | CCI2A | CCR2 | TA2 | P7.6/PM_TA1.2/C0.3 TA1_C2 (internal) ADC14 (internal) ADC14SHSx = {4} |
| C0OUT (internal) | CCI2B | | | |
| DV _{SS} | GND | | | |
| DV _{CC} | V _{CC} | | | |
| P7.5/PM_TA1.3/C0.4 | CCI3A | CCR3 | TA3 | P7.5/PM_TA1.3/C0.4 TA1_C3 (internal) |
| C1OUT (internal) | CCI3B | | | |
| DV _{SS} | GND | | | |
| DV _{CC} | V _{CC} | | | |
| P7.4/PM_TA1.4/C0.5 | CCI4A | CCR4 | TA4 | P7.4/PM_TA1.4/C0.5 TA1_C4 (internal) |
| TA0_C4 (internal) | CCI4B | | | |
| DV _{SS} | GND | | | |
| DV _{CC} | V _{CC} | | | |

Table 6-23. TA2 Signal Connections

| DEVICE INPUT PIN OR INTERNAL SIGNAL | MODULE INPUT SIGNAL | MODULE BLOCK | MODULE OUTPUT SIGNAL | DEVICE OUTPUT PIN OR INTERNAL SIGNAL |
|--|---------------------|--------------|----------------------|--|
| P4.2/ACLK/TA2CLK/A11 | TACLK | Timer | N/A | N/A |
| ACLK (internal) | ACLK | | | |
| SMCLK (internal) | SMCLK | | | |
| From Capacitive Touch I/O 0 (internal) | INCLK | | | |
| P8.1/UCB3CLK/TA2.0/C0.0 | CCI0A | CCR0 | TA0 | P8.1/UCB3CLK/TA2.0/C0.0 TA2_C0 (internal) |
| DV _{SS} | CCI0B | | | |
| DV _{SS} | GND | | | |
| DV _{CC} | V _{CC} | | | |
| P5.6/TA2.1/VREF+/VeREF+/C1.7 | CCI1A | CCR1 | TA1 | P5.6/TA2.1/VREF+/VeREF+/C1.7 TA2_C1 (internal) ADC14 (internal) ADC14SHSx = {5} |
| ACLK (internal) | CCI1B | | | |
| DV _{SS} | GND | | | |
| DV _{CC} | V _{CC} | | | |
| P5.7/TA2.2/VREF-/VeREF-/C1.6 | CCI2A | CCR2 | TA2 | P5.7/TA2.2/VREF-/VeREF-/C1.6 TA2_C2 (internal) ADC14 (internal) ADC14SHSx = {6} |
| COOUT (internal) | CCI2B | | | |
| DV _{SS} | GND | | | |
| DV _{CC} | V _{CC} | | | |
| P6.6/TA2.3/UCB3SIMO/UCB3SDA/C1.1 | CCI3A | CCR3 | TA3 | P6.6/TA2.3/UCB3SIMO/ UCB3SDA/C1.1 TA2_C3 (internal) |
| TA3_C3 (internal) | CCI3B | | | |
| DV _{SS} | GND | | | |
| DV _{CC} | V _{CC} | | | |
| P6.7/TA2.4/UCB3SOMI/UCB3SCL/C1.0 | CCI4A | CCR4 | TA4 | P6.7/TA2.4/UCB3SOMI/ UCB3SCL/C1.0 TA2_C4 (internal) |
| From Capacitive Touch I/O 0 (internal) | CCI4B | | | |
| DV _{SS} | GND | | | |
| DV _{CC} | V _{CC} | | | |

Table 6-24. TA3 Signal Connections

| DEVICE INPUT PIN OR INTERNAL SIGNAL | MODULE INPUT SIGNAL | MODULE BLOCK | MODULE OUTPUT SIGNAL | DEVICE OUTPUT PIN OR INTERNAL SIGNAL |
|--|---------------------|--------------|----------------------|--|
| P8.3/TA3CLK/A22 | TACLK | Timer | N/A | N/A |
| ACLK (internal) | ACLK | | | |
| SMCLK (internal) | SMCLK | | | |
| From Capacitive Touch I/O 1 (internal) | INCLK | | | |
| P10.4/TA3.0/C0.7 | CCI0A | CCR0 | TA0 | P10.4/TA3.0/C0.7 TA3_C0 (internal) |
| DV _{SS} | CCI0B | | | |
| DV _{SS} | GND | | | |
| DV _{CC} | V _{CC} | | | |
| P10.5/TA3.1/C0.6 | CCI1A | CCR1 | TA1 | P10.5/TA3.1/C0.6 TA3_C1 (internal) ADC14 (internal) ADC14SHSx = {7} |
| ACLK (internal) | CCI1B | | | |
| DV _{SS} | GND | | | |
| DV _{CC} | V _{CC} | | | |
| P8.2/TA3.2/A23 | CCI2A | CCR2 | TA2 | P8.2/TA3.2/A23 TA3_C2 (internal) |
| COOUT (internal) | CCI2B | | | |
| DV _{SS} | GND | | | |
| DV _{CC} | V _{CC} | | | |
| P9.2/TA3.3 | CCI3A | CCR3 | TA3 | P9.2/TA3.3 TA3_C3 (internal) |
| TA2_C3 (internal) | CCI3B | | | |
| DV _{SS} | GND | | | |
| DV _{CC} | V _{CC} | | | |
| P9.3/TA3.4 | CCI4A | CCR4 | TA4 | P9.3/TA3.4 TA3_C4 (internal) |
| From Capacitive Touch I/O 1 (internal) | CCI4B | | | |
| DV _{SS} | GND | | | |
| DV _{CC} | V _{CC} | | | |

6.8.4 Timer32

Timer32 is an ARM dual 32-bit timer module. It contains two 32-bit timers, each of which can be configured as two independent 16-bit timers. The two timers can generate independent events or a combined event, which can be processed according to application requirements.

6.8.5 Enhanced Universal Serial Communication Interface (eUSCI)

The eUSCI modules are used for serial data communication. The eUSCI module supports synchronous communication protocols such as SPI (3-pin or 4-pin) and I²C, and asynchronous communication protocols such as UART, enhanced UART with automatic baudrate detection, and IrDA.

The eUSCI_An module provides support for SPI (3-pin or 4-pin), UART, enhanced UART, and IrDA.

The eUSCI_Bn module provides support for SPI (3-pin or 4-pin) and I²C.

The MSP432P401x devices offer up to four eUSCI_A and four eUSCI_B modules.

6.8.6 Real-Time Clock (RTC_C)

The RTC_C module contains an integrated real-time clock. It integrates an internal calendar which compensates for months with less than 31 days and includes leap year correction. The RTC_C also supports flexible alarm functions, offset-calibration and temperature compensation. The RTC_C operation is available in LPM3 and LPM3.5 modes to minimize power consumption.

6.8.7 Watchdog Timer (WDT_A)

The primary function of the WDT_A module is to perform a controlled system restart after a software problem occurs. If the selected time interval expires, a system reset is generated. If the watchdog function is not needed in an application, the module can be configured as an interval timer and can generate interrupts at selected time intervals.

The watchdog can generate a reset either on a time-out or a password violation. This reset can be configured to generate either a Hard Reset or a Soft Reset into the system. Refer to the *MSP432P4xx Family Technical Reference Manual* for more details.

Table 6-25. WDT_A Clocks

| WDTSELx | NORMAL OPERATION (WATCHDOG AND INTERVAL TIMER MODE) |
|---------|--|
| 00 | SMCLK |
| 01 | ACLK |
| 10 | VLOCLK |
| 11 | BCLK |

CAUTION

The WDT **must** be set to interval mode before transitioning into the LPM3 or LPM3.5 modes of operation. This allows the WDT event to wake the device and return it to active modes of operation. Using the WDT in watchdog mode may result in nondeterministic behavior due to the generated reset.

6.8.7.1 Watchdog Reset Control Register [Address = E004_3008h]

Figure 6-15. SYS_WDTRESET_CTL Register

| | | | | | | | | | | | | | | | |
|----------|----|----|----|----|----|----|----|----|----|----|----|----|----|---------------|-------------|
| 31 | 30 | 29 | 28 | 27 | 26 | 25 | 24 | 23 | 22 | 21 | 20 | 19 | 18 | 17 | 16 |
| Reserved | | | | | | | | | | | | | | | |
| r | r | r | r | r | r | r | r | r | r | r | r | r | r | r | r |
| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| Reserved | | | | | | | | | | | | | | VIOLA TION | TIMEO UT |
| r | r | r | r | r | r | r | r | r | r | r | r | r | r | rw-1 | rw-1 |

Table 6-26. SYS_WDTRESET_CTL Register Description

| Bit | Field | Type | Reset | Description |
|------|-----------|------|-------|--|
| 31-2 | Reserved | R | 0h | Reserved. Reads return 0h |
| 1 | VIOLATION | RW | 1h | 0b = WDT password violation event generates Soft reset 1b = WDT password violation event generates Hard reset |
| 0 | TIMEOUT | RW | 1h | 0b = WDT time-out event generates Soft reset 1b = WDT time-out event generates Hard reset |

CAUTION

The WDT should ideally be configured to generate a Hard Reset into the system. A Soft Reset will reset the CPU, but leave the rest of the system and peripherals unaffected. As a result if the WDT is configured to generate a Soft Reset, the application should assume responsibility for the fact that a Soft Reset can corrupt an ongoing transaction from the CPU into the system.

6.8.8 ADC14

The ADC14 module supports fast, 14-bit analog-to-digital conversions with differential and single-ended inputs. The module implements a 14-bit SAR core, sample select control, reference generator and a conversion result buffer. The window comparators with a lower and upper limit allow CPU independent result monitoring through different window comparator interrupt flags.

The available ADC14 external trigger sources are summarized in [Table 6-27](#).

The available multiplexing between internal and external analog inputs of ADC14 is listed in [Table 6-28](#), [Table 6-29](#), [Table 6-30](#).

Table 6-27. ADC14 Trigger Signal Connections

| ADC14SHSx | | CONNECTED TRIGGER SOURCE |
|-----------|---------|--------------------------|
| BINARY | DECIMAL | |
| 000 | 0 | Software (ADC14SC) |
| 001 | 1 | TA0_C1 |
| 010 | 2 | TA0_C2 |
| 011 | 3 | TA1_C1 |
| 100 | 4 | TA1_C2 |
| 101 | 5 | TA2_C1 |
| 110 | 6 | TA2_C2 |
| 111 | 7 | TA3_C1 |

Table 6-28. ADC14 Channel Mapping on 100PZ Devices

| ADC14 CHANNEL | EXTERNAL CHANNEL SOURCE (CONTROL BIT = 0) | INTERNAL CHANNEL SOURCE (CONTROL BIT = 1) ⁽¹⁾ | CONTROL BIT ⁽²⁾ |
|---------------|---|--|----------------------------|
| Channel 23 | A23 | Battery Monitor | ADC14BATMAP |
| Channel 22 | A22 | Temperature Sensor | ADC14TCMAP |
| Channel 21 | A21 | NA (Reserved) | ADC14CH0MAP |
| Channel 20 | A20 | NA (Reserved) | ADC14CH1MAP |
| Channel 19 | A19 | NA (Reserved) | ADC14CH2MAP |
| Channel 18 | A18 | NA (Reserved) | ADC14CH3MAP |

- (1) If an internal source is marked as NA or Reserved, it indicates that only the external source is available for that channel.
- (2) Refer to the ADC14 chapter in the *MSP432P4xx Family Technical Reference Manual* for details on the registers that contain the control bits listed in the table.

Table 6-29. ADC14 Channel Mapping on 80ZXH Devices

| ADC14 CHANNEL | EXTERNAL CHANNEL SOURCE (CONTROL BIT = 0) | INTERNAL CHANNEL SOURCE (CONTROL BIT = 1) ⁽¹⁾ | CONTROL BIT ⁽²⁾ |
|---------------|--|---|----------------------------|
| Channel 15 | A15 | Battery Monitor | ADC14BATMAP |
| Channel 14 | A14 | Temperature Sensor | ADC14TCMAP |
| Channel 13 | A13 | NA (Reserved) | ADC14CH0MAP |
| Channel 12 | A12 | NA (Reserved) | ADC14CH1MAP |
| Channel 11 | A11 | NA (Reserved) | ADC14CH2MAP |
| Channel 10 | A10 | NA (Reserved) | ADC14CH3MAP |

- (1) If an internal source is marked as NA or Reserved, it indicates that only the external source is available for that channel.
- (2) Refer to the ADC14 chapter in the *MSP432P4xx Family Technical Reference Manual* for details on the registers that contain the control bits listed in the table.

Table 6-30. ADC14 Channel Mapping on 64RGC Devices

| ADC14 CHANNEL | EXTERNAL CHANNEL SOURCE (CONTROL BIT = 0) | INTERNAL CHANNEL SOURCE (CONTROL BIT = 1) ⁽¹⁾ | CONTROL BIT ⁽²⁾ |
|---------------|--|---|----------------------------|
| Channel 11 | A11 | Battery Monitor | ADC14BATMAP |
| Channel 10 | A10 | Temperature Sensor | ADC14TCMAP |
| Channel 9 | A9 | NA (Reserved) | ADC14CH0MAP |
| Channel 8 | A8 | NA (Reserved) | ADC14CH1MAP |
| Channel 7 | A7 | NA (Reserved) | ADC14CH2MAP |
| Channel 6 | A6 | NA (Reserved) | ADC14CH3MAP |

- (1) If an internal source is marked as NA or Reserved, it indicates that only the external source is available for that channel.
- (2) Refer to the ADC14 chapter in the *MSP432P4xx Family Technical Reference Manual* for details on the registers that contain the control bits listed in the table.

6.8.9 Comparator_E (COMP_E)

The primary function of the COMP_E module is to support precision slope analog-to-digital conversions, battery voltage supervision, and monitoring of external analog signals.

There are two COMP_E modules available on the MSP432P401x devices.

6.8.10 Shared Reference (REF_A)

The REF_A is responsible for generation of all critical reference voltages that can be used by the various analog peripherals in the device. The reference voltage from REF_A can also be switched on to device pin for external use.

6.8.11 CRC32

The CRC32 module produces a signature based on a sequence of entered data values and can be used for data checking purposes. It supports both a CRC32 and a CRC16 computation.

- The CRC16 computation signature is based on the CRC16-CCITT standard.
- The CRC32 computation signature is based on the CRC32-ISO3309 standard.

6.8.12 AES256 Accelerator

The AES accelerator module performs encryption and decryption of 128-bit data with 128-bit, 192-bit, or 256-bit keys according to the Advanced Encryption Standard (AES) (FIPS PUB 197) in hardware.

6.8.13 True Random Seed

The Device Descriptor Information (TLV) section contains a 128-bit true random seed that can be used to implement a deterministic random number generator.

6.9 Code Development and Debug

The MSP432P401x devices support various methods through which the user can carry out code development and debug on the device.

6.9.1 JTAG and Serial Wire Debug (SWD) Based Development, Debug and Trace

The device supports both 4-pin JTAG and the 2-pin SWD modes of operation. The device is compatible with all standard Cortex-M4 debuggers available in the market today. The debug logic in the device has been designed to remain minimally intrusive to the application state. In low-power modes, the user can enable the debugger to override the state of the PSS, thereby gaining access to debug and trace features.

In 2-pin SWD mode, the TDO pin can be used to export serial wire trace output (SWO) data. In addition, the TDI and TDO pins of the device can be reassigned as user I/Os. Refer to sections [Section 6.10.22](#) and [Section 6.10.23](#) for more details.

NOTE

If the device has activated debug security, debugger accesses into the device is completely disabled. The debugger, however, is still be able to scan the run/halt state of the CPU. Further control of and visibility into the device is possible only after initiating a mass erase of the device flash contents.

6.9.2 Peripheral Halt Control Register [Address = E004_300Ch]

This register allows the user independent control over the functionality of device peripherals during code development and debug. When the CPU is halted, the bits in this register can control whether the corresponding peripheral freezes its operation (such as incrementing, transmit, and receive) or continues its operation (debug remains nonintrusive). The registers of the peripheral remain accessible irrespective of the values in the Halt Control Register

Figure 6-16. SYS_PERIHALT_CTL Register

| | | | | | | | | | | | | | | | |
|----------|------|-------|------|------|------|------|------|------|------|------|------|------|------|------|------|
| 31 | 30 | 29 | 28 | 27 | 26 | 25 | 24 | 23 | 22 | 21 | 20 | 19 | 18 | 17 | 16 |
| Reserved | | | | | | | | | | | | | | | |
| r | r | r | r | r | r | r | r | r | r | r | r | r | r | r | r |
| 15 | 14 | 13 | 12 | 11 | 10 | 9 | 8 | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| DMA | WDTA | ADC14 | eUB3 | eUB2 | eUB1 | eUB0 | eUA3 | eUA2 | eUA1 | eUA0 | T32 | TA3 | TA2 | TA1 | TA0 |
| rw-0 | rw-1 | rw-0 | rw-0 | rw-0 | rw-0 | rw-0 | rw-0 | rw-0 | rw-0 | rw-0 | rw-0 | rw-0 | rw-0 | rw-0 | rw-0 |

Table 6-31. SYS_PERIHALT_CTL Register Description

| BIT | FIELD | TYPE | RESET | DESCRIPTION |
|-------|----------|------|-------|---|
| 31-16 | Reserved | R | 0h | Reserved. Reads return 0h |
| 15 | DMA | RW | 0h | 0b = IP operation unaffected when CPU is halted 1b = freezes IP operation when CPU is halted |
| 14 | WDTA | RW | 1h | 0b = IP operation unaffected when CPU is halted 1b = freezes IP operation when CPU is halted |
| 13 | ADC14 | RW | 0h | 0b = IP operation unaffected when CPU is halted 1b = freezes IP operation when CPU is halted |

Table 6-31. SYS_PERIHALT_CTL Register Description (continued)

| BITS | FIELD | TYPE | RESET | DESCRIPTION |
|------|-------|------|-------|---|
| 12 | eUB3 | RW | 0h | 0b = IP operation unaffected when CPU is halted 1b = freezes IP operation when CPU is halted |
| 11 | eUB2 | RW | 0h | 0b = IP operation unaffected when CPU is halted 1b = freezes IP operation when CPU is halted |
| 10 | eUB1 | RW | 0h | 0b = IP operation unaffected when CPU is halted 1b = freezes IP operation when CPU is halted |
| 9 | eUB0 | RW | 0h | 0b = IP operation unaffected when CPU is halted 1b = freezes IP operation when CPU is halted |
| 8 | eUA3 | RW | 0h | 0b = IP operation unaffected when CPU is halted 1b = freezes IP operation when CPU is halted |
| 7 | eUA2 | RW | 0h | 0b = IP operation unaffected when CPU is halted 1b = freezes IP operation when CPU is halted |
| 6 | eUA1 | RW | 0h | 0b = IP operation unaffected when CPU is halted 1b = freezes IP operation when CPU is halted |
| 5 | eUA0 | RW | 0h | 0b = IP operation unaffected when CPU is halted 1b = freezes IP operation when CPU is halted |
| 4 | T32 | RW | 0h | 0b = IP operation unaffected when CPU is halted 1b = freezes IP operation when CPU is halted |
| 3 | TA3 | RW | 0h | 0b = IP operation unaffected when CPU is halted 1b = freezes IP operation when CPU is halted |
| 2 | TA2 | RW | 0h | 0b = IP operation unaffected when CPU is halted 1b = freezes IP operation when CPU is halted |
| 1 | TA1 | RW | 0h | 0b = IP operation unaffected when CPU is halted 1b = freezes IP operation when CPU is halted |
| 0 | TA0 | RW | 0h | 0b = IP operation unaffected when CPU is halted 1b = freezes IP operation when CPU is halted |

6.9.3 Bootstrap Loader (BSL)

After any POR class reset, the MSP432P401x devices automatically check for presence of user code in the flash. If the user code is not present, the BSL routine is invoked.

6.10 Input/Output Schematics

6.10.1 Port P1, P1.0 to P1.7, Input/Output With Schmitt Trigger

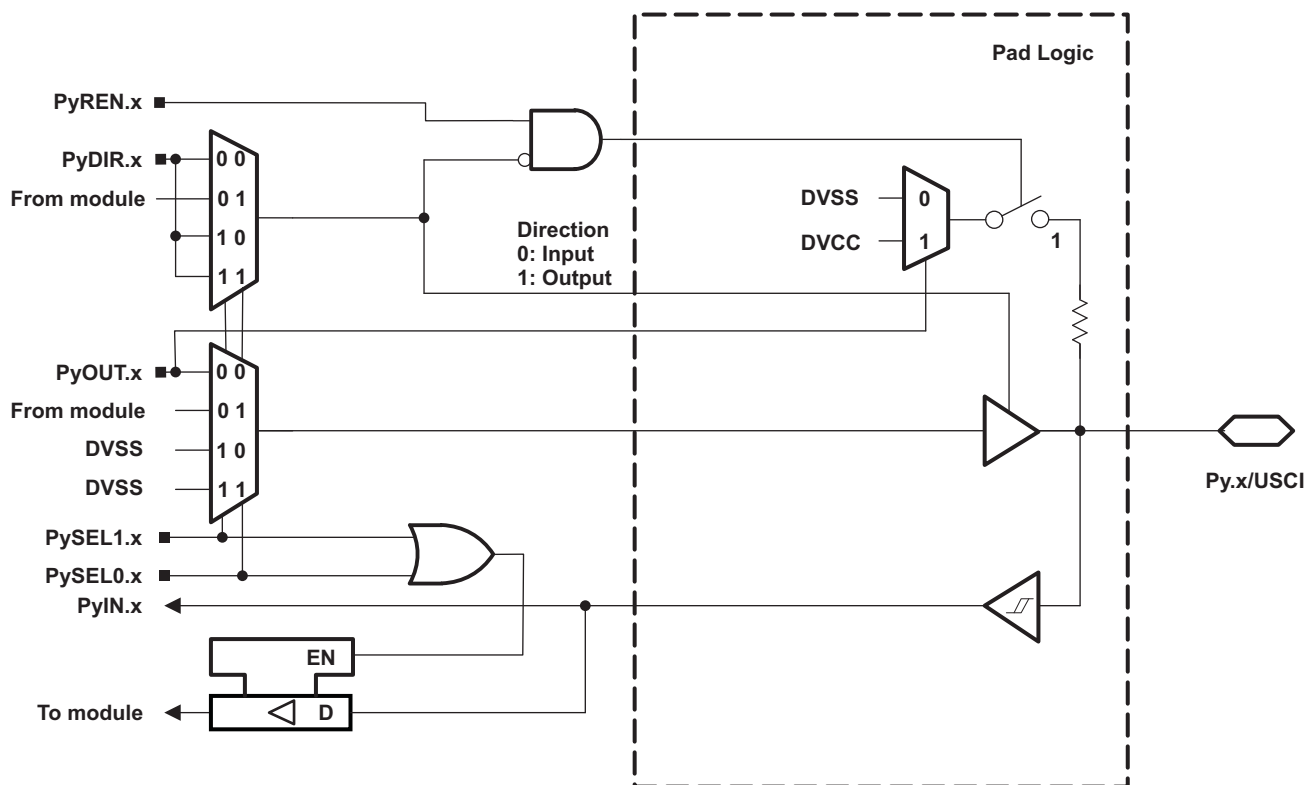


Figure 6-17. Py.x/USCI Pin Schematic

Table 6-32. Port P1 (P1.0 to P1.7) Pin Functions

| PIN NAME (P1.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | |
|-----------------------|---|------------------|--|----------|----------|
| | | | P1DIR.x | P1SEL1.x | P1SEL0.x |
| P1.0/UCA0STE | 0 | P1.0 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCA0STE | X ⁽²⁾ | 0 | 1 |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 1 |
| | | DVSS | 1 | | |
| P1.1/UCA0CLK | 1 | P1.1 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCA0CLK | X ⁽²⁾ | 0 | 1 |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 1 |
| | | DVSS | 1 | | |
| P1.2/UCA0RXD/UCA0SOMI | 2 | P1.2 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCA0RXD/UCA0SOMI | X ⁽²⁾ | 0 | 1 |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 1 |
| | | DVSS | 1 | | |
| P1.3/UCA0TXD/UCA0SIMO | 3 | P1.3 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCA0TXD/UCA0SIMO | X ⁽²⁾ | 0 | 1 |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 1 |
| | | DVSS | 1 | | |
| P1.4/UCB0STE | 4 | P1.4 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCB0STE | X ⁽³⁾ | 0 | 1 |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 1 |
| | | DVSS | 1 | | |
| P1.5/UCB0CLK | 5 | P1.5 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCB0CLK | X ⁽³⁾ | 0 | 1 |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 1 |
| | | DVSS | 1 | | |
| P1.6/UCB0SIMO/UCB0SDA | 6 | P1.6 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCB0SIMO/UCB0SDA | X ⁽³⁾ | 0 | 1 |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 1 |
| | | DVSS | 1 | | |

(1) X = Don't care

(2) Direction controlled by eUSCI_A0 module.

(3) Direction controlled by eUSCI_B0 module.

Table 6-32. Port P1 (P1.0 to P1.7) Pin Functions (continued)

| PIN NAME (P1.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | |
|-----------------------|---|------------------|--|----------|----------|
| | | | P1DIR.x | P1SEL1.x | P1SEL0.x |
| P1.7/UCB0SOMI/UCB0SCL | 7 | P1.7 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCB0SOMI/UCB0SCL | X ⁽³⁾ | 0 | 1 |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 1 |
| | | DVSS | 1 | | |

6.10.2 Port P2, P2.0 to P2.3, Input/Output With Schmitt Trigger

Pin Schematic: see [Figure 6-17](#)

Table 6-33. Port P2 (P2.0 to P2.3) Pin Functions

| PIN NAME (P2.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | | |
|-----------------------------|---|------------------|--|----------|----------|---------|
| | | | P2DIR.x | P2SEL1.x | P2SEL0.x | P2MAPx |
| P2.0/PM_UCA1STE | 0 | P2.0 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | UCA1STE | X ⁽²⁾ | 0 | 1 | default |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | N/A | 0 | 1 | 1 | X |
| | | DVSS | 1 | | | |
| P2.1/PM_UCA1CLK | 1 | P2.1 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | UCA1CLK | X ⁽²⁾ | 0 | 1 | default |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | N/A | 0 | 1 | 1 | X |
| | | DVSS | 1 | | | |
| P2.2/PM_UCA1RXD/PM_UCA1SOMI | 2 | P2.2 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | UCA1RXD/UCA1SOMI | X ⁽²⁾ | 0 | 1 | default |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | N/A | 0 | 1 | 1 | X |
| | | DVSS | 1 | | | |
| P2.3/PM_UCA1TXD/PM_UCA1SIMO | 3 | P2.3 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | UCA1TXD/UCA1SIMO | X ⁽²⁾ | 0 | 1 | default |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | N/A | 0 | 1 | 1 | X |
| | | DVSS | 1 | | | |

(1) X = Don't care

(2) Direction controlled by eUSCI_A1 module.

6.10.3 Port P3, P3.0 to P3.7, Input/Output With Schmitt Trigger

Pin Schematic: see [Figure 6-17](#)

Table 6-34. Port P3 (P3.0 to P3.7) Pin Functions

| PIN NAME (P3.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | | |
|-----------------------------|---|------------------|--|----------|----------|---------|
| | | | P3DIR.x | P3SEL1.x | P3SEL0.x | P3MAPx |
| P3.0/PM_UCA2STE | 0 | P3.0 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | UCA2STE | X ⁽²⁾ | 0 | 1 | default |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | N/A | 0 | 1 | 1 | X |
| | | DVSS | 1 | | | |
| P3.1/PM_UCA2CLK | 1 | P3.1 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | UCA2CLK | X ⁽²⁾ | 0 | 1 | default |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | N/A | 0 | 1 | 1 | X |
| | | DVSS | 1 | | | |
| P3.2/PM_UCA2RXD/PM_UCA2SOMI | 2 | P3.2 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | UCA2RXD/UCA2SOMI | X ⁽²⁾ | 0 | 1 | default |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | N/A | 0 | 1 | 1 | X |
| | | DVSS | 1 | | | |
| P3.3/PM_UCA2TXD/PM_UCA2SIMO | 3 | P3.3 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | UCA2TXD/UCA2SIMO | X ⁽²⁾ | 0 | 1 | default |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | N/A | 0 | 1 | 1 | X |
| | | DVSS | 1 | | | |
| P3.4/PM_UCB2STE | 4 | P3.4 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | UCB2STE | X ⁽³⁾ | 0 | 1 | default |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | N/A | 0 | 1 | 1 | X |
| | | DVSS | 1 | | | |
| P3.5/PM_UCB2CLK | 5 | P3.5 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | UCB2CLK | X ⁽³⁾ | 0 | 1 | default |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | N/A | 0 | 1 | 1 | X |
| | | DVSS | 1 | | | |

(1) X = Don't care

(2) Direction controlled by eUSCI_A2 module.

(3) Direction controlled by eUSCI_B2 module.

Table 6-34. Port P3 (P3.0 to P3.7) Pin Functions (continued)

| PIN NAME (P3.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | | |
|-----------------------------|---|------------------|--|----------|----------|---------|
| | | | P3DIR.x | P3SEL1.x | P3SEL0.x | P3MAPx |
| P3.6/PM_UCB2SIMO/PM_UCB2SDA | 6 | P3.6 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | UCB2SIMO/UCB2SDA | X ⁽³⁾ | 0 | 1 | default |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | N/A | 0 | 1 | 1 | X |
| | | DVSS | 1 | | | |
| P3.7/PM_UCB2SOMI/PM_UCB2SCL | 7 | P3.7 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | UCB2SOMI/UCB2SCL | X ⁽³⁾ | 0 | 1 | default |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | N/A | 0 | 1 | 1 | X |
| | | DVSS | 1 | | | |

6.10.4 Port P9, P9.4 to P9.7, Input/Output With Schmitt Trigger

Pin Schematic: see [Figure 6-17](#)

Table 6-35. Port P9 (P9.4 to P9.7) Pin Functions

| PIN NAME (P9.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | |
|--------------------------------------|---|------------------|--|----------|----------|
| | | | P9DIR.x | P9SEL1.x | P9SEL0.x |
| P9.4/UCA3STE ⁽²⁾ | 4 | P9.4 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCA3STE | X ⁽³⁾ | 0 | 1 |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 1 |
| | | DVSS | 1 | | |
| P9.5/UCA3CLK ⁽²⁾ | 5 | P9.5 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCA3CLK | X ⁽³⁾ | 0 | 1 |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 1 |
| | | DVSS | 1 | | |
| P9.6/UCA3RXD/UCA3SOMI ⁽²⁾ | 6 | P9.6 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCA3RXD/UCA3SOMI | X ⁽³⁾ | 0 | 1 |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 1 |
| | | DVSS | 1 | | |
| P9.7/UCA3TXD/UCA3SIMO ⁽²⁾ | 7 | P9.7 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCA3TXD/UCA3SIMO | X ⁽³⁾ | 0 | 1 |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 1 |
| | | DVSS | 1 | | |

(1) X = Don't care

(2) Not available on 80ZXH and 64RGC packages.

(3) Direction controlled by eUSCI_A3 module.

6.10.5 Port P10, P10.0 to P10.3, Input/Output With Schmitt Trigger

Pin Schematic: see [Figure 6-17](#)

Table 6-36. Port P10 (P10.0 to P10.3) Pin Functions

| PIN NAME (P10.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | |
|---------------------------------------|---|------------------|--|-----------|-----------|
| | | | P10DIR.x | P10SEL1.x | P10SEL0.x |
| P10.0/UCB3STE ⁽²⁾ | 0 | P10.0 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCB3STE | X ⁽³⁾ | 0 | 1 |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 1 |
| | | DVSS | 1 | | |
| P10.1/UCB3CLK ⁽²⁾ | 1 | P10.1 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCB3CLK | X ⁽³⁾ | 0 | 1 |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 1 |
| | | DVSS | 1 | | |
| P10.2/UCB3SIMO/UCB3SDA ⁽²⁾ | 2 | P10.2 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCB3SIMO/UCB3SDA | X ⁽³⁾ | 0 | 1 |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 1 |
| | | DVSS | 1 | | |
| P10.3/UCB3SOMI/UCB3SCL ⁽²⁾ | 3 | P10.3 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCB3SOMI/UCB3SCL | X ⁽³⁾ | 0 | 1 |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 1 |
| | | DVSS | 1 | | |

(1) X = Don't care

(2) Not available on 80ZXH and 64RGC packages.

(3) Direction controlled by eUSCI_B3 module.



Figure 6-18. Py.x/Mod1/Mod2 Pin Schematic

Table 6-37. Port P2 (P2.4 to P2.7) Pin Functions

| PIN NAME (P2.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | | |
|------------------------------|---|------------|--|----------|----------|---------|
| | | | P2DIR.x | P2SEL1.x | P2SEL0.x | P2MAPx |
| P2.4/PM_TA0.1 ⁽²⁾ | 4 | P2.4 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | TA0.CCI1A | 0 | 0 | 1 | default |
| | | TA0.1 | 1 | | | |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | N/A | 0 | 1 | 1 | X |
| | | DVSS | 1 | | | |
| P2.5/PM_TA0.2 ⁽²⁾ | 5 | P2.5 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | TA0.CCI2A | 0 | 0 | 1 | default |
| | | TA0.2 | 1 | | | |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | N/A | 0 | 1 | 1 | X |
| | | DVSS | 1 | | | |
| P2.6/PM_TA0.3 ⁽²⁾ | 6 | P2.6 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | TA0.CCI3A | 0 | 0 | 1 | default |
| | | TA0.3 | 1 | | | |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | N/A | 0 | 1 | 1 | X |
| | | DVSS | 1 | | | |
| P2.7/PM_TA0.4 ⁽²⁾ | 7 | P2.7 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | TA0.CCI4A | 0 | 0 | 1 | default |
| | | TA0.4 | 1 | | | |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | N/A | 0 | 1 | 1 | X |
| | | DVSS | 1 | | | |

(1) X = Don't care

(2) Not available on the 64-pin RGC package.

PRODUCT PREVIEW

6.10.7 Port P7, P7.0 to P7.3, Input/Output With Schmitt Trigger

Pin Schematic: see [Figure 6-18](#)

Table 6-38. Port P7 (P7.0 to P7.3) Pin Functions

| PIN NAME (P7.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | | |
|-----------------------------|---|------------|--|----------|----------|---------|
| | | | P7DIR.x | P7SEL1.x | P7SEL0.x | P7MAPx |
| P7.0/PM_SMCLK/ PM_DMAE0 | 0 | P7.0 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | DMAE0 | 0 | 0 | 1 | default |
| | | SMCLK | 1 | | | |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | N/A | 0 | 1 | 1 | X |
| | | DVSS | 1 | | | |
| P7.1/PM_C0OUT/ PM_TA0CLK | 1 | P7.1 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | TA0CLK | 0 | 0 | 1 | default |
| | | C0OUT | 1 | | | |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | N/A | 0 | 1 | 1 | X |
| | | DVSS | 1 | | | |
| P7.2/PM_C1OUT/ PM_TA1CLK | 2 | P7.2 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | TA1CLK | 0 | 0 | 1 | default |
| | | C1OUT | 1 | | | |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | N/A | 0 | 1 | 1 | X |
| | | DVSS | 1 | | | |
| P7.3/PM_TA0.0 | 3 | P7.3 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | TA0.CCI0A | 0 | 0 | 1 | default |
| | | TA0.0 | 1 | | | |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | N/A | 0 | 1 | 1 | X |
| | | DVSS | 1 | | | |

(1) X = Don't care

6.10.8 Port P9, P9.2 and P9.3, Input/Output With Schmitt Trigger

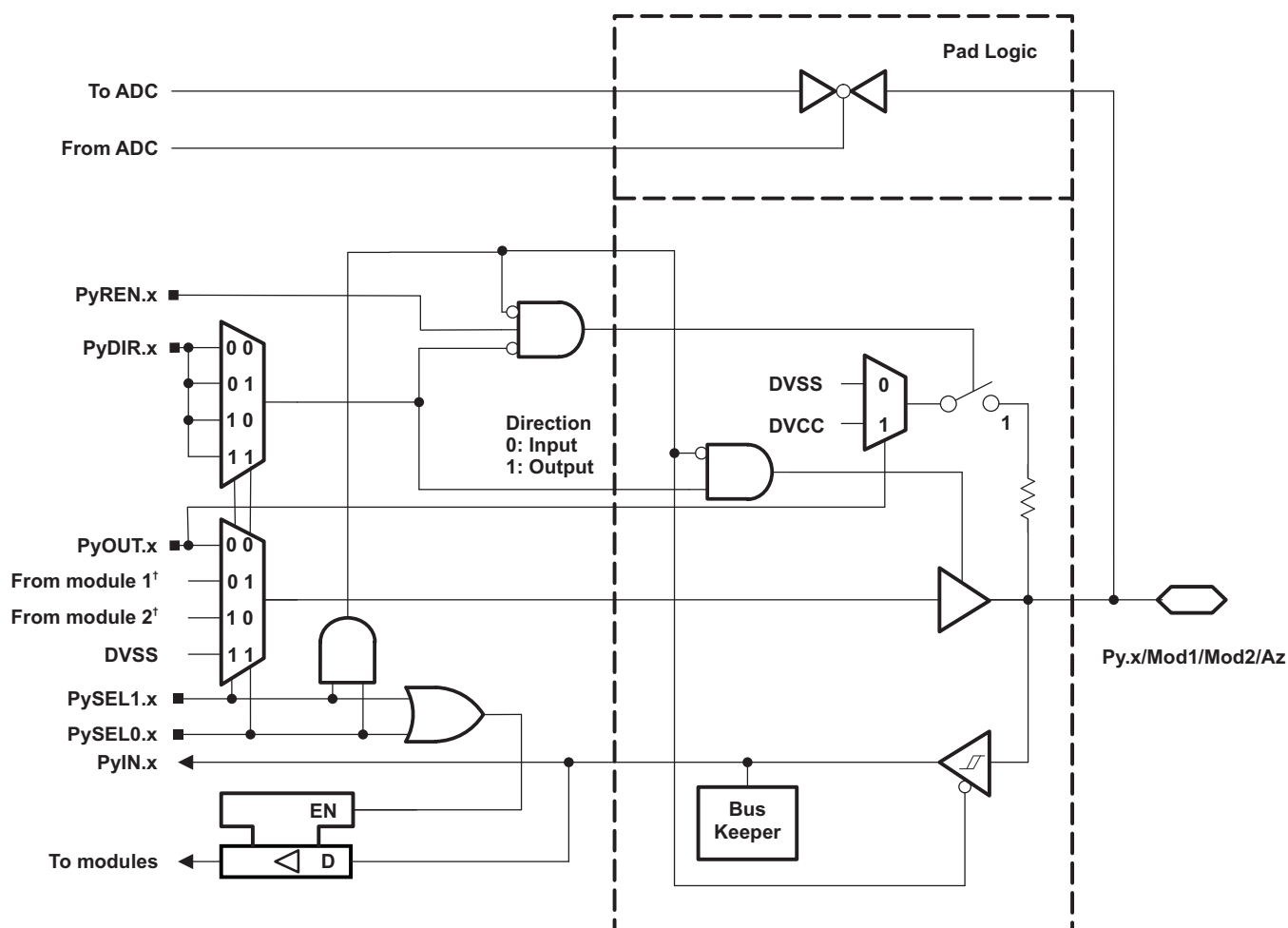
Pin Schematic: see [Figure 6-18](#)

Table 6-39. Port P9 (P9.2 and P9.3) Pin Functions

| PIN NAME (P9.x) | x | FUNCTION | CONTROL BITS OR SIGNALS | | |
|---------------------------|---|------------|-------------------------|----------|----------|
| | | | P9DIR.x | P9SEL1.x | P9SEL0.x |
| P9.2/TA3.3 ⁽¹⁾ | 2 | P9.2 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | TA3.CCI3A | 0 | 0 | 1 |
| | | TA3.3 | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 1 |
| | | DVSS | 1 | | |
| P9.3/TA3.4 ⁽¹⁾ | 3 | P9.3 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | TA3.CCI4A | 0 | 0 | 1 |
| | | TA3.4 | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 1 |
| | | DVSS | 1 | | |

(1) Not available on 80ZXH and 64RGC packages.

6.10.9 Port P4, P4.0 to P4.7, Input/Output With Schmitt Trigger



† Output will be DVSS if module 1 or module 2 function is not available. Refer to pin function tables.
Functional representation only.

Figure 6-19. Py.x/Mod1/Mod2/Az Pin Schematic

Table 6-40. Port P4 (P4.0 to P4.7) Pin Functions

| PIN NAME (P4.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | |
|-------------------------|---|--------------------|--|----------|----------|
| | | | P4DIR.x | P4SEL1.x | P4SEL0.x |
| P4.0/A13 ⁽²⁾ | 0 | P4.0 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A13 ⁽³⁾ | X | 1 | 1 |
| P4.1/A12 ⁽²⁾ | 1 | P4.1 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A12 ⁽³⁾ | X | 1 | 1 |
| P4.2/ACLK/TA2CLK/A11 | 2 | P4.2 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | ACLK | 1 | | |
| | | TA2CLK | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A11 ⁽³⁾ | X | 1 | 1 |
| P4.3/MCLK/RTCCLK/A10 | 3 | P4.3 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | MCLK | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | RTCCLK | 1 | | |
| | | A10 ⁽³⁾ | X | 1 | 1 |
| P4.4/HSMCLK/SVMHOUT/A9 | 4 | P4.4 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | HSMCLK | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | SVMHOUT | 1 | | |
| | | A9 ⁽³⁾ | X | 1 | 1 |
| P4.5/A8 | 5 | P4.5 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A8 ⁽³⁾ | X | 1 | 1 |
| P4.6/A7 | 6 | P4.6 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A7 ⁽³⁾ | X | 1 | 1 |

(1) X = Don't care

(2) Not available on the 64-pin RGC package.

(3) Setting P4SEL1.x and P4SEL0.x disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals.

Table 6-40. Port P4 (P4.0 to P4.7) Pin Functions (continued)

| PIN NAME (P4.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | |
|-----------------|---|-------------------|--|----------|----------|
| | | | P4DIR.x | P4SEL1.x | P4SEL0.x |
| P4.7/A6 | 7 | P4.7 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A6 ⁽³⁾ | X | 1 | 1 |

6.10.10 Port P5, P5.0 to P5.5, Input/Output With Schmitt Trigger

Pin Schematic: see [Figure 6-19](#)

Table 6-41. Port P5 (P5.0 to P5.5) Pin Functions

| PIN NAME (P5.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | |
|-----------------|---|-------------------|--|----------|----------|
| | | | P5DIR.x | P5SEL1.x | P5SEL0.x |
| P5.0/A5 | 0 | P5.0 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A5 ⁽²⁾ | X | 1 | 1 |
| P5.1/A4 | 1 | P5.1 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A4 ⁽²⁾ | X | 1 | 1 |
| P5.2/A3 | 2 | P5.2 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A3 ⁽²⁾ | X | 1 | 1 |
| P5.3/A2 | 3 | P5.3 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A2 ⁽²⁾ | X | 1 | 1 |
| P5.4/A1 | 4 | P5.4 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A1 ⁽²⁾ | X | 1 | 1 |
| P5.5/A0 | 5 | P5.5 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A0 ⁽²⁾ | X | 1 | 1 |

(1) X = Don't care

(2) Setting P5SEL1.x and P5SEL0.x disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals.

6.10.11 Port P6, P6.0 and P6.1, Input/Output With Schmitt Trigger

Pin Schematic: see [Figure 6-19](#)

Table 6-42. Port P6 (P6.0 and P6.1) Pin Functions

| PIN NAME (P6.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | |
|-------------------------|---|--------------------|--|----------|----------|
| | | | P6DIR.x | P6SEL1.x | P6SEL0.x |
| P6.0/A15 ⁽²⁾ | 0 | P6.0 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A15 ⁽³⁾ | X | 1 | 1 |
| P6.1/A14 ⁽²⁾ | 1 | P6.1 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A14 ⁽³⁾ | X | 1 | 1 |

(1) X = Don't care

(2) Not available on the 64-pin RGC package.

(3) Setting P6SEL1.x and P6SEL0.x disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals.

6.10.12 Port P8, P8.2 to P8.7, Input/Output With Schmitt Trigger

Pin Schematic: see [Figure 6-19](#)

Table 6-43. Port P8 (P8.2 to P8.7) Pin Functions

| PIN NAME (P8.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | |
|--------------------------------|---|--------------------|--|----------|----------|
| | | | P8DIR.x | P8SEL1.x | P8SEL0.x |
| P8.2/TA3.2/A23 ⁽²⁾ | 2 | P8.2 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | TA3.CCI2A | 0 | 0 | 1 |
| | | TA3.2 | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A23 ⁽³⁾ | X | 1 | 1 |
| P8.3/TA3CLK/A22 ⁽²⁾ | 3 | P8.3 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | TA3CLK | 0 | 0 | 1 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A22 ⁽³⁾ | X | 1 | 1 |
| P8.4/A21 ⁽²⁾ | 4 | P8.4 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A21 ⁽³⁾ | X | 1 | 1 |
| P8.5/A20 ⁽²⁾ | 5 | P8.5 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A20 ⁽³⁾ | X | 1 | 1 |
| P8.6/A19 ⁽²⁾ | 6 | P8.6 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A19 ⁽³⁾ | X | 1 | 1 |
| P8.7/A18 ⁽²⁾ | 7 | P8.7 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A18 ⁽³⁾ | X | 1 | 1 |

(1) X = Don't care

(2) Not available on 80ZXH and 64RGC packages.

(3) Setting P8SEL1.x and P8SEL0.x disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals.

6.10.13 Port P9, P9.0 and P9.1, Input/Output With Schmitt Trigger

Pin Schematic: see [Figure 6-19](#)

Table 6-44. Port P9 (P9.0 and P9.1) Pin Functions

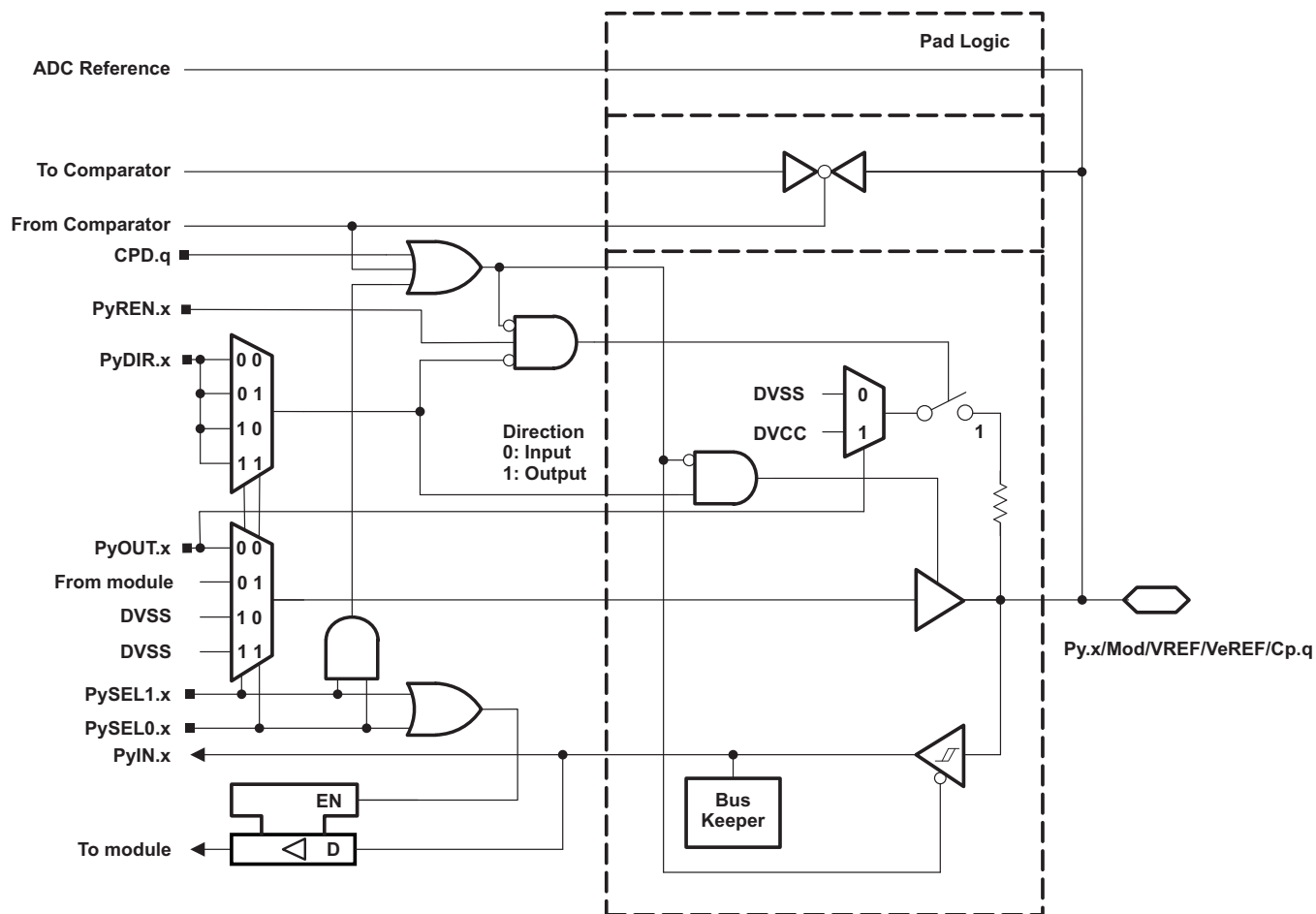
| PIN NAME (P9.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | |
|-------------------------|---|--------------------|--|----------|----------|
| | | | P9DIR.x | P9SEL1.x | P9SEL0.x |
| P9.0/A17 ⁽²⁾ | 0 | P9.0 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A17 ⁽³⁾ | X | 1 | 1 |
| P9.1/A16 ⁽²⁾ | 1 | P9.1 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | N/A | 0 | 0 | 1 |
| | | DVSS | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | A16 ⁽³⁾ | X | 1 | 1 |

(1) X = Don't care

(2) Not available on 80ZXH and 64RGC packages.

(3) Setting P9SEL1.x and P9SEL0.x disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals.

6.10.14 Port P5, P5.6 and P5.7, Input/Output With Schmitt Trigger



Functional representation only.

Figure 6-20. Py.x/Mod/VREF/VeREF/Cp.q Pin Schematic

PRODUCT PREVIEW

Table 6-45. Port P5 (P5.6 and P5.7) Pin Functions

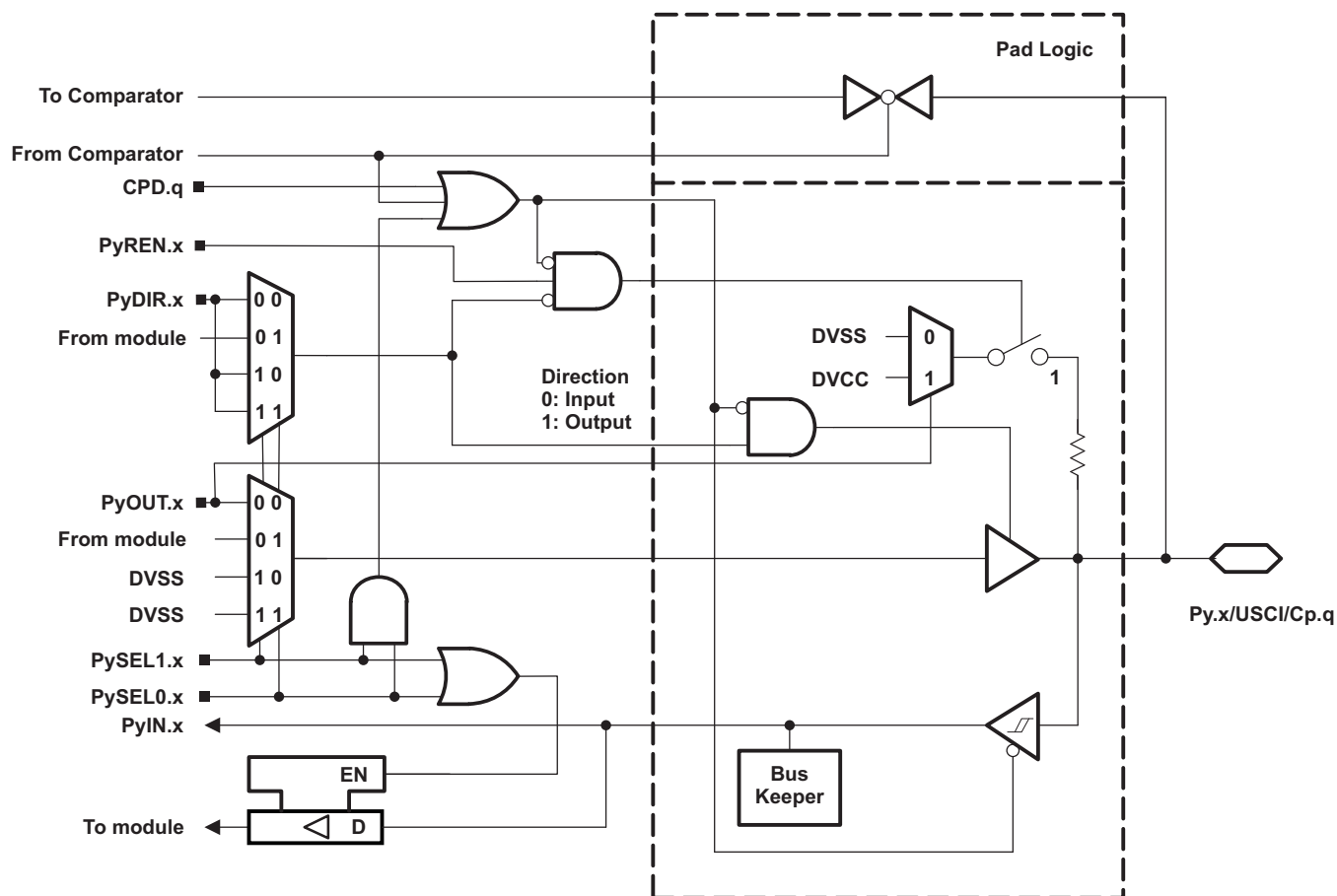
| PIN NAME (P5.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | |
|------------------------------|---|---------------------------------------|--|----------|----------|
| | | | P5DIR.x | P5SEL1.x | P5SEL0.x |
| P5.6/TA2.1/VREF+/VeREF+/C1.7 | 6 | P5.6 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | TA2.CCI1A | 0 | 0 | 1 |
| | | TA2.1 | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | VREF+, VeREF+, C1.7 ⁽²⁾⁽³⁾ | X | 1 | 1 |
| P5.7/TA2.2/VREF-/VeREF-/C1.6 | 7 | P5.7 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | TA2.CCI2A | 0 | 0 | 1 |
| | | TA2.2 | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | VREF-, VeREF-, C1.6 ⁽²⁾⁽³⁾ | X | 1 | 1 |

(1) X = Don't care

(2) Setting P5SEL1.x and P5SEL0.x disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals.

(3) Setting the CEPD.q bit of the comparator disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals. Selecting the C1.q input pin to the comparator multiplexer with the CEIPSEL or CEIMSEL bits automatically disables the output driver and input buffer for that pin, regardless of the state of the associated CEPD.q bit.

6.10.15 Port P6, P6.2 to P6.5, Input/Output With Schmitt Trigger



Functional representation only.

Figure 6-21. Py.x/USCI/Cp.q Pin Schematic

PRODUCT PREVIEW

Table 6-46. Port P6 (P6.2 to P6.5) Pin Functions

| PIN NAME (P6.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | |
|---|---|------------------------|--|----------|----------|
| | | | P6DIR.x | P6SEL1.x | P6SEL0.x |
| P6.2/UCB1STE/C1.5 ⁽²⁾ | 2 | P6.2 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCB1STE | X ⁽³⁾ | 0 | 1 |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | C1.5 ⁽⁴⁾⁽⁵⁾ | X | 1 | 1 |
| P6.3/UCB1CLK/C1.4 ⁽²⁾ | 3 | P6.3 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCB1CLK | X ⁽³⁾ | 0 | 1 |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | C1.4 ⁽⁴⁾⁽⁵⁾ | X | 1 | 1 |
| P6.4/UCB1SIMO/UCB1SDA/C1.3 ⁽²⁾ | 4 | P6.4 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCB1SIMO/UCB1SDA | X ⁽³⁾ | 0 | 1 |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | C1.3 ⁽⁴⁾⁽⁵⁾ | X | 1 | 1 |
| P6.5/UCB1SOMI/UCB1SCL/C1.2 ⁽²⁾ | 5 | P6.5 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCB1SOMI/UCB1SCL | X ⁽³⁾ | 0 | 1 |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | C1.2 ⁽⁴⁾⁽⁵⁾ | X | 1 | 1 |

(1) X = Don't care

(2) Not available on the 64-pin RGC package.

(3) Direction controlled by eUSCI_B1 module.

(4) Setting P6SEL1.x and P6SEL0.x disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals.

(5) Setting the CEPD.q bit of the comparator disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals. Selecting the C1.q input pin to the comparator multiplexer with the CEIPSEL or CEIMSEL bits automatically disables the output driver and input buffer for that pin, regardless of the state of the associated CEPD.q bit.

6.10.16 Port P6, P6.6 and P6.7, Input/Output With Schmitt Trigger

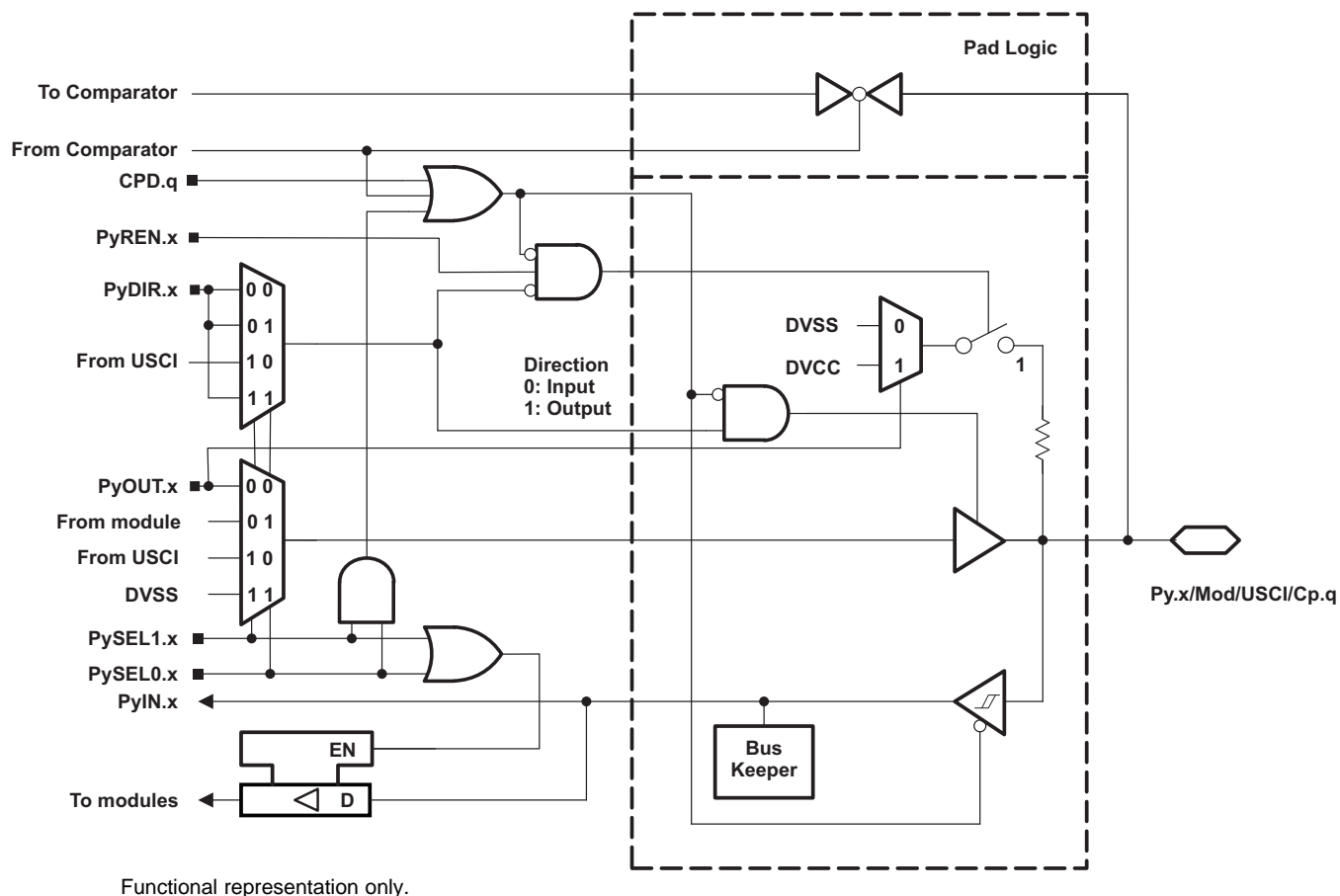


Figure 6-22. Py.x/Mod/USCI/Cp.q Pin Schematic

Table 6-47. Port P6 (P6.6 and P6.7) Pin Functions

| PIN NAME (P6.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | |
|----------------------------------|---|------------------------|--|----------|----------|
| | | | P6DIR.x | P6SEL1.x | P6SEL0.x |
| P6.6/TA2.3/UCB3SIMO/UCB3SDA/C1.1 | 6 | P6.6 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | TA2.CCI3A | 0 | 0 | 1 |
| | | TA2.3 | 1 | | |
| | | UCB3SIMO/UCB3SDA | X ⁽²⁾ | 1 | 0 |
| | | C1.1 ⁽³⁾⁽⁴⁾ | X | 1 | 1 |
| P6.7/TA2.4/UCB3SOMI/UCB3SCL/C1.0 | 7 | P6.7 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | TA2.CCI4A | 0 | 0 | 1 |
| | | TA2.4 | 1 | | |
| | | UCB3SOMI/UCB3SCL | X ⁽²⁾ | 1 | 0 |
| | | C1.0 ⁽³⁾⁽⁴⁾ | X | 1 | 1 |

(1) X = Don't care

(2) Direction controlled by eUSCI_B3 module.

(3) Setting P6SEL1.x and P6SEL0.x disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals.

(4) Setting the CEPD.q bit of the comparator disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals. Selecting the C1.q input pin to the comparator multiplexer with the CEIPSEL or CEIMSEL bits automatically disables the output driver and input buffer for that pin, regardless of the state of the associated CEPD.q bit.

6.10.17 Port P8, P8.0 and P8.1, Input/Output With Schmitt Trigger

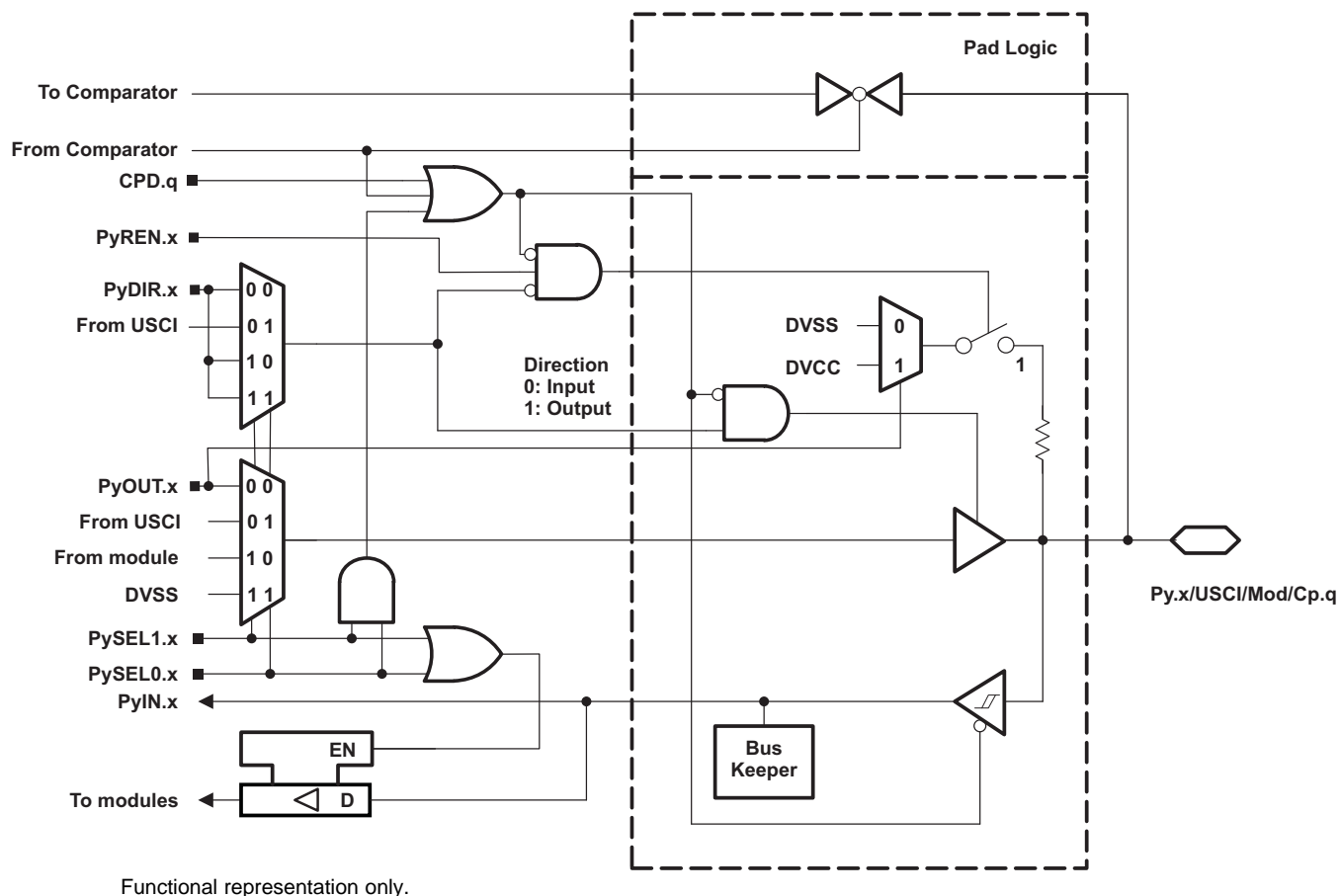


Figure 6-23. Py.x/USCI/Mod/Cp.q Pin Schematic

Table 6-48. Port P8 (P8.0 and P8.1) Pin Functions

| PIN NAME (P8.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | |
|-------------------------|---|------------------------|--|----------|----------|
| | | | P8DIR.x | P8SEL1.x | P8SEL0.x |
| P8.0/UCB3STE/TA1.0/C0.1 | 0 | P8.0 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCB3STE | X ⁽²⁾ | 0 | 1 |
| | | TA1.CCI0A | 0 | 1 | 0 |
| | | TA1.0 | 1 | | |
| | | C0.1 ⁽³⁾⁽⁴⁾ | X | 1 | 1 |
| P8.1/UCB3CLK/TA2.0/C0.0 | 1 | P8.1 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | UCB3CLK | X ⁽²⁾ | 0 | 1 |
| | | TA2.CCI0A | 0 | 1 | 0 |
| | | TA2.0 | 1 | | |
| | | C0.0 ⁽³⁾⁽⁴⁾ | X | 1 | 1 |

(1) X = Don't care

(2) Direction controlled by eUSCI_B3 module.

(3) Setting P8SEL1.x and P8SEL0.x disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals.

(4) Setting the CEPD.q bit of the comparator disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals. Selecting the C0.q input pin to the comparator multiplexer with the CEIPSEL or CEIMSEL bits automatically disables the output driver and input buffer for that pin, regardless of the state of the associated CEPD.q bit.

6.10.18 Port P10, P10.4 and P10.5, Input/Output With Schmitt Trigger

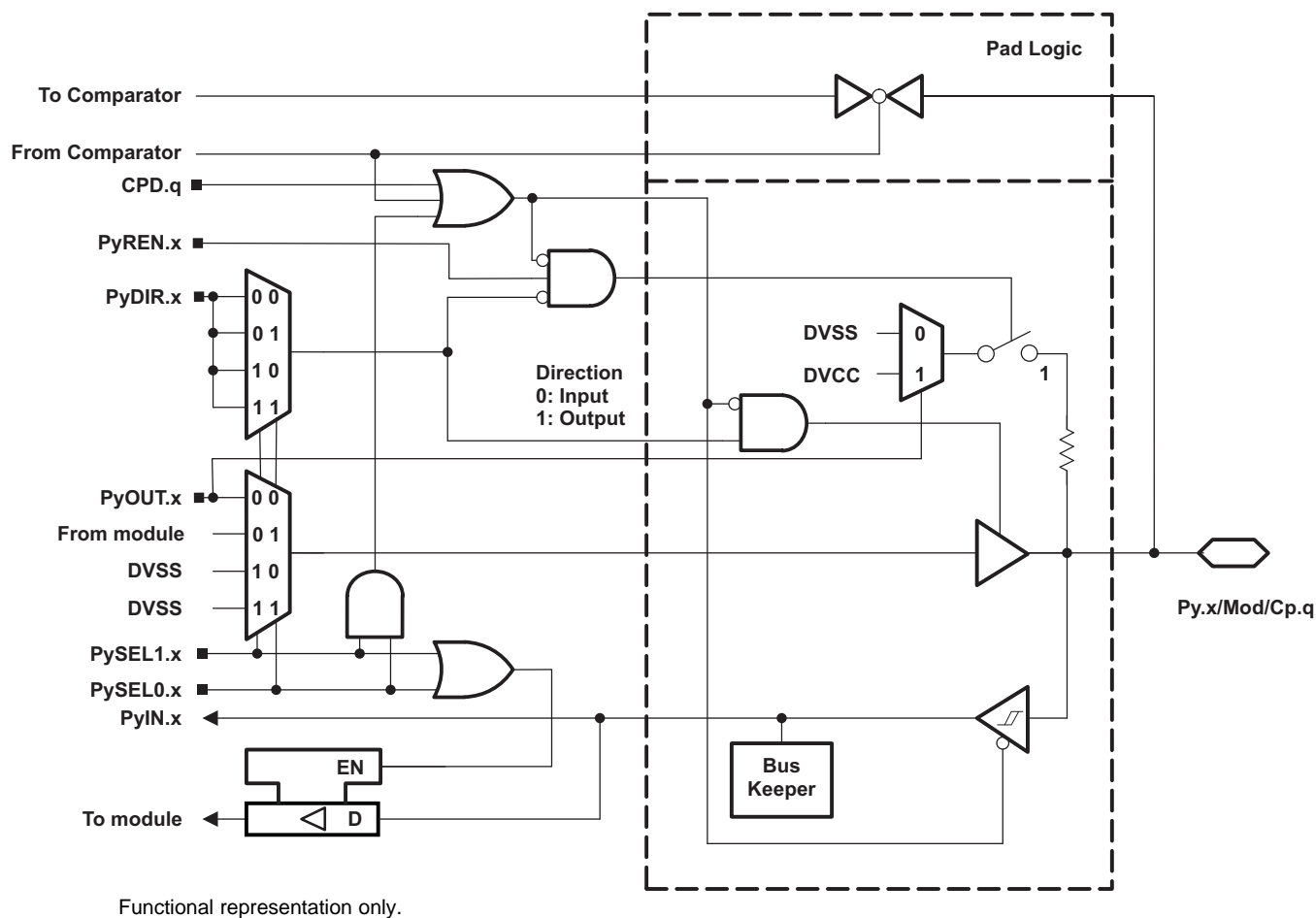


Figure 6-24. Py.x/Mod/Cp.q Pin Schematic

PRODUCT PREVIEW

Table 6-49. Port P10 (P10.4 and P10.5) Pin Functions

| PIN NAME (P10.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | |
|---------------------------------|---|------------------------|--|-----------|-----------|
| | | | P10DIR.x | P10SEL1.x | P10SEL0.x |
| P10.4/TA3.0/C0.7 ⁽²⁾ | 4 | P10.4 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | TA3.CCI0A | 0 | 0 | 1 |
| | | TA3.0 | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | C0.7 ⁽³⁾⁽⁴⁾ | X | 1 | 1 |
| P10.5/TA3.1/C0.6 ⁽²⁾ | 5 | P10.5 (I/O) | I: 0; O: 1 | 0 | 0 |
| | | TA3.CCI1A | 0 | 0 | 1 |
| | | TA3.1 | 1 | | |
| | | N/A | 0 | 1 | 0 |
| | | DVSS | 1 | | |
| | | C0.6 ⁽³⁾⁽⁴⁾ | X | 1 | 1 |

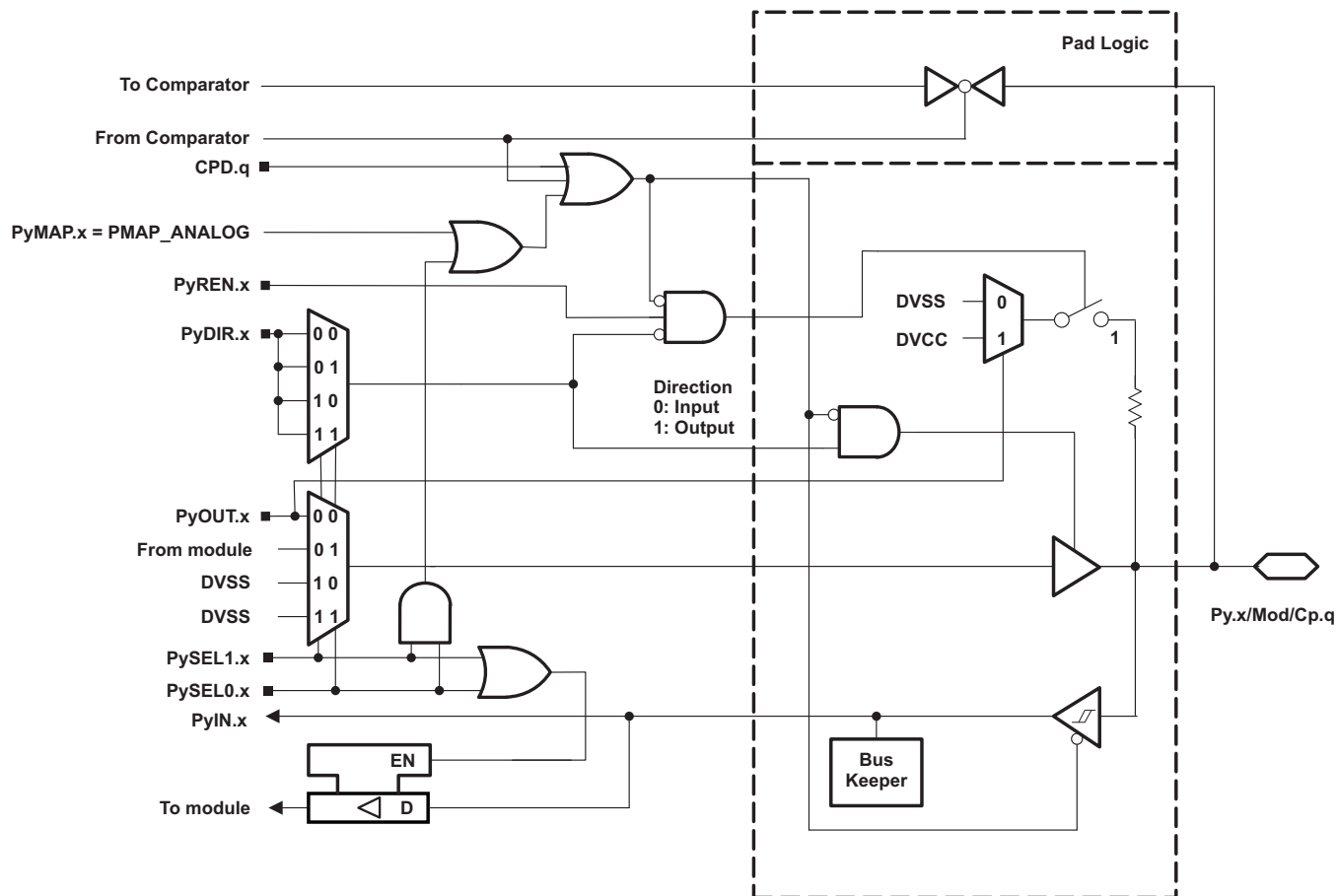
(1) X = Don't care

(2) Not available on 80ZXH and 64RGC packages.

(3) Setting P10SEL1.x and P10SEL0.x disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals.

(4) Setting the CEPD.q bit of the comparator disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals. Selecting the C0.q input pin to the comparator multiplexer with the CEIPSEL or CEIMSEL bits automatically disables the output driver and input buffer for that pin, regardless of the state of the associated CEPD.q bit.

6.10.19 Port P7, P7.4 to P7.7, Input/Output With Schmitt Trigger



Functional representation only.

Figure 6-25. Py.x/Mod/Cp.q Pin Schematic

PRODUCT PREVIEW

Table 6-50. Port P7 (P7.4 to P7.7) Pin Functions

| PIN NAME (P7.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | | |
|-----------------------------------|---|---------------------------|--|----------|----------|---------|
| | | | P7DIR.x | P7SEL1.x | P7SEL0.x | P7MAPx |
| P7.4/PM_TA1.4/C0.5 ⁽²⁾ | 4 | P7.4 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | TA1.CCI4A | 0 | 0 | 1 | default |
| | | TA1.4 | 1 | | | |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | C0.5 ⁽³⁾⁽⁴⁾⁽⁵⁾ | X | 1 | 1 | X |
| P7.5/PM_TA1.3/C0.4 ⁽²⁾ | 5 | P7.5 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | TA1.CCI3A | 0 | 0 | 1 | default |
| | | TA1.3 | 1 | | | |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | C0.4 ⁽³⁾⁽⁴⁾⁽⁵⁾ | X | 1 | 1 | X |
| P7.6/PM_TA1.2/C0.3 ⁽²⁾ | 6 | P7.6 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | TA1.CCI2A | 0 | 0 | 1 | default |
| | | TA1.2 | 1 | | | |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | C0.3 ⁽³⁾⁽⁴⁾⁽⁵⁾ | X | 1 | 1 | X |
| P7.7/PM_TA1.1/C0.2 ⁽²⁾ | 7 | P7.7 (I/O) | I: 0; O: 1 | 0 | 0 | X |
| | | TA1.CCI1A | 0 | 0 | 1 | default |
| | | TA1.1 | 1 | | | |
| | | N/A | 0 | 1 | 0 | X |
| | | DVSS | 1 | | | |
| | | C0.2 ⁽³⁾⁽⁴⁾⁽⁵⁾ | X | 1 | 1 | X |

(1) X = Don't care

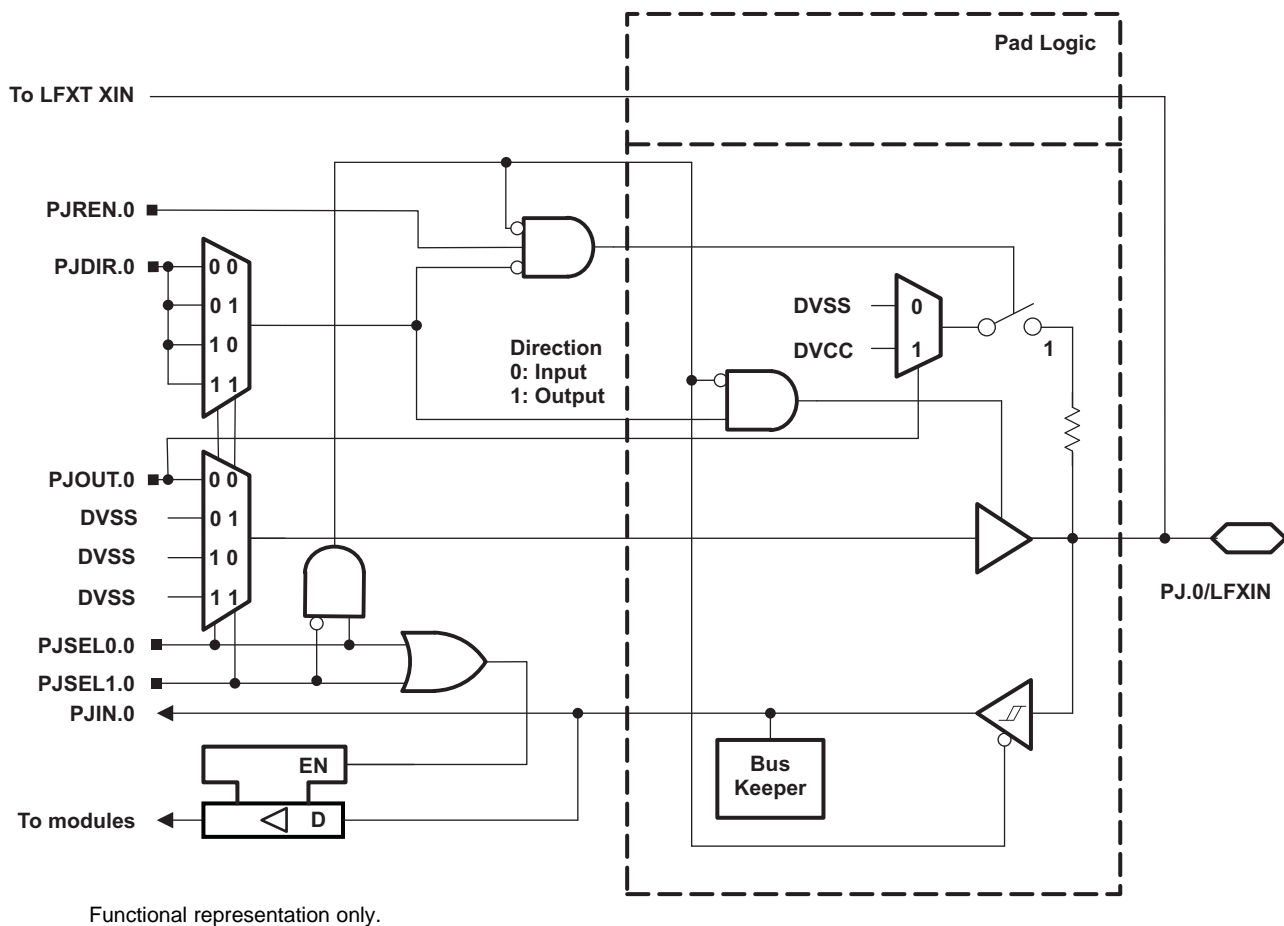
(2) Not available on the 64-pin RGC package.

(3) Setting P7SEL1.x and P7SEL0.x disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals.

(4) Setting the CEPD.q bit of the comparator disables the output driver and the input Schmitt trigger to prevent parasitic cross currents when applying analog signals. Selecting the C0.q input pin to the comparator multiplexer with the CEIPSEL or CEIMSEL bits automatically disables the output driver and input buffer for that pin, regardless of the state of the associated CEPD.q bit.

(5) Setting P7MAPx = PM_ANALOG disables the output driver and the input Schmitt trigger independent of P7SEL1.x and P7SEL0.x settings.

6.10.20 Port PJ, PJ.0 and PJ.1 Input/Output With Schmitt Trigger



PRODUCT PREVIEW



Table 6-51. Port PJ (PJ.0 and PJ.1) Pin Functions

| PIN NAME (PJ.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | | | | |
|-----------------|---|------------------------------------|--|--------------------|--------------------|----------|----------|------------------|
| | | | PJDIR.x | PJSEL1.1 | PJSEL0.1 | PJSEL1.0 | PJSEL0.0 | LFXT BYPASS |
| PJ.0/LFXIN | 0 | PJ.0 (I/O) | I: 0; O: 1 | X | X | 0 | 0 | X |
| | | N/A | 0 | X | X | 1 | X | X |
| | | DVSS | 1 | | | | | |
| | | LFXIN crystal mode ⁽²⁾ | X | X | X | 0 | 1 | 0 |
| | | LFXIN bypass mode ⁽²⁾ | X | X | X | 0 | 1 | 1 |
| PJ.1/LFXOUT | 1 | PJ.1 (I/O) | I: 0; O: 1 | 0 | 0 | 0 | 0 | 0 |
| | | | | | | 1 | X | |
| | | | | | | X | X | 1 ⁽³⁾ |
| | | N/A | 0 | see ⁽⁴⁾ | see ⁽⁴⁾ | 0 | 0 | 0 |
| | | | | | | 1 | X | |
| | | | | | | X | X | 1 ⁽³⁾ |
| | | DVSS | 1 | see ⁽⁴⁾ | see ⁽⁴⁾ | 0 | 0 | 0 |
| | | | | | | 1 | X | |
| | | | | | | X | X | 1 ⁽³⁾ |
| | | LFXOUT crystal mode ⁽²⁾ | X | X | X | 0 | 1 | 0 |

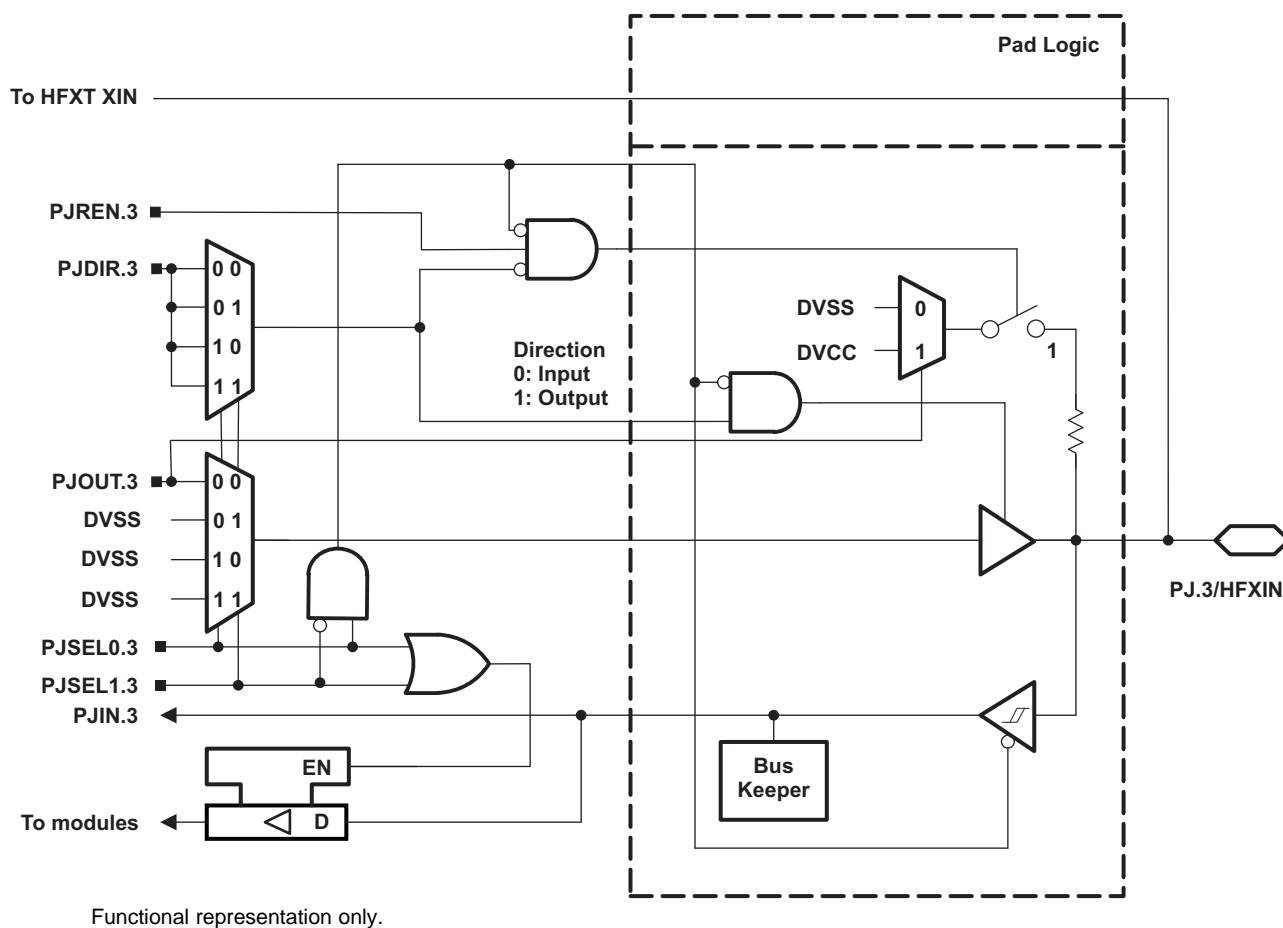
(1) X = Don't care

(2) Setting PJSEL1.0 = 0 and PJSEL0.0 = 1 causes the general-purpose I/O to be disabled. When LFXTBYPASS = 0, PJ.0 and PJ.1 are configured for crystal operation and PJSEL1.1 and PJSEL0.1 are do not care. When LFXTBYPASS = 1, PJ.0 is configured for bypass operation and PJ.1 is configured as general-purpose I/O.

(3) When PJ.0 is configured in bypass mode, PJ.1 is configured as general-purpose I/O.

(4) With PJSEL0.1 = 1 or PJSEL1.1 = 1 the general-purpose I/O functionality is disabled. No input function is available. When configured as output, the pin is actively pulled to zero.

6.10.21 Port PJ, PJ.2 and PJ.3 Input/Output With Schmitt Trigger



Functional representation only.

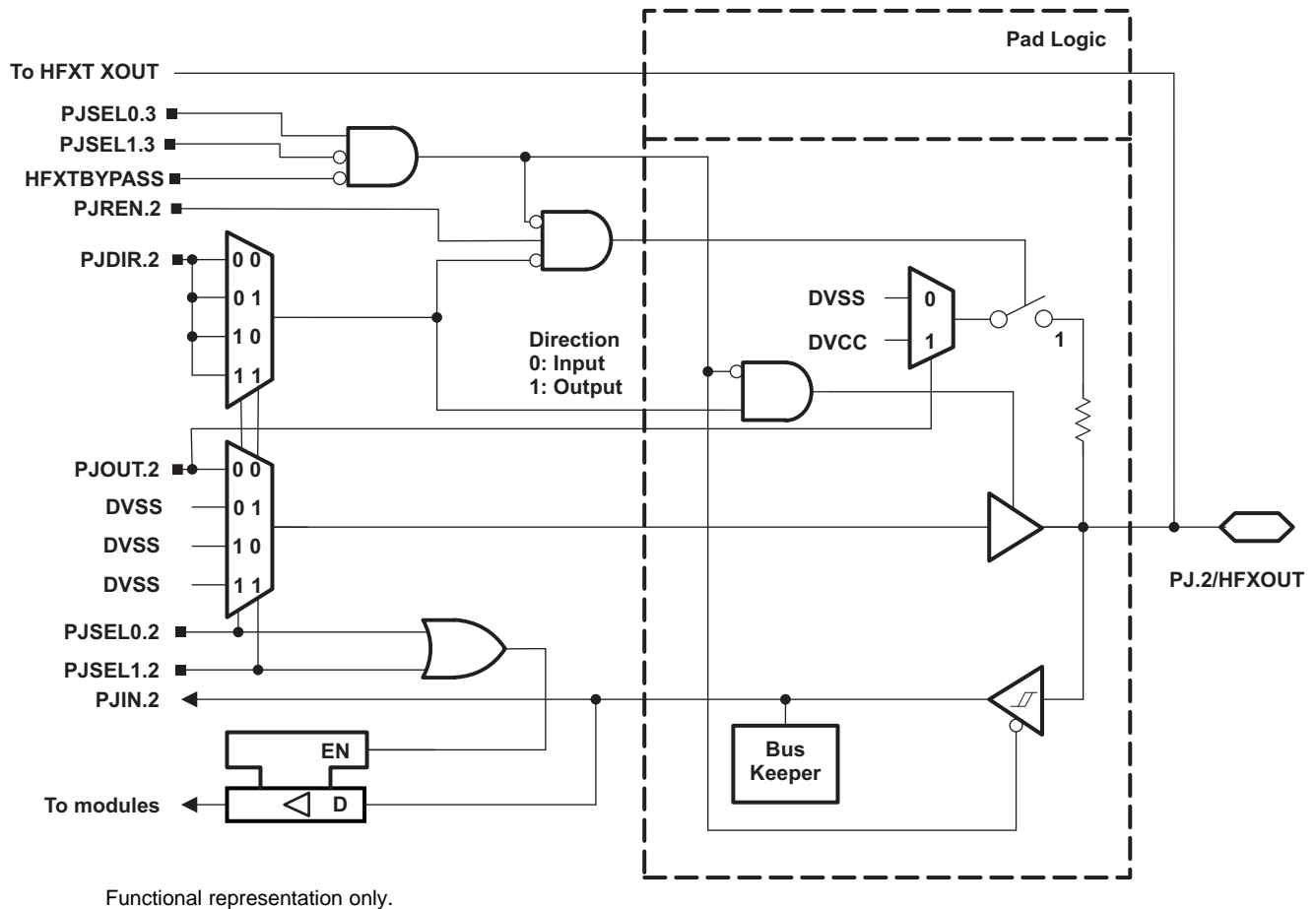


Table 6-52. Port PJ (PJ.2 and PJ.3) Pin Functions

| PIN NAME (PJ.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | | | | |
|-----------------|---|------------------------------------|--|--------------------|--------------------|----------|----------|------------------|
| | | | PJDIR.x | PJSEL1.2 | PJSEL0.2 | PJSEL1.3 | PJSEL0.3 | HFXT BYPASS |
| PJ.3/HFXIN | 3 | PJ.3 (I/O) | I: 0; O: 1 | X | X | 0 | 0 | X |
| | | N/A | 0 | X | X | 1 | X | X |
| | | DVSS | 1 | | | | | |
| | | HFXIN crystal mode ⁽²⁾ | X | X | X | 0 | 1 | 0 |
| | | HFXIN bypass mode ⁽²⁾ | X | X | X | 0 | 1 | 1 |
| PJ.2/HFXOUT | 2 | PJ.2 (I/O) | I: 0; O: 1 | 0 | 0 | 0 | 0 | 0 |
| | | | | | | 1 | X | |
| | | | | | | X | X | 1 ⁽³⁾ |
| | | N/A | 0 | see ⁽⁴⁾ | see ⁽⁴⁾ | 0 | 0 | 0 |
| | | | | | | 1 | X | |
| | | | | | | X | X | 1 ⁽³⁾ |
| | | DVSS | 1 | see ⁽⁴⁾ | see ⁽⁴⁾ | 0 | 0 | 0 |
| | | | | | | 1 | X | |
| | | | | | | X | X | 1 ⁽³⁾ |
| | | HFXOUT crystal mode ⁽²⁾ | X | X | X | 0 | 1 | 0 |

(1) X = Don't care

(2) Setting PJSEL1.3 = 0 and PJSEL0.3 = 1 causes the general-purpose I/O to be disabled. When HFXTBYPASS = 0, PJ.2 and PJ.3 are configured for crystal operation and PJSEL1.2 and PJSEL0.2 are do not care. When HFXTBYPASS = 1, PJ.3 is configured for bypass operation and PJ.2 is configured as general-purpose I/O.

(3) When PJ.3 is configured in bypass mode, PJ.2 is configured as general-purpose I/O.

(4) With PJSEL0.2 = 1 or PJSEL1.2 = 1 the general-purpose I/O functionality is disabled. No input function is available. When configured as output, the pin is actively pulled to zero.

6.10.22 Port PJ, PJ.4 and PJ.5 Input/Output With Schmitt Trigger

Table 6-53. Port PJ (PJ.4 to PJ.5) Pin Functions

| PIN NAME (P7.x) | x | FUNCTION | CONTROL BITS OR SIGNALS ⁽¹⁾ | | | | SWJ MODE OF OPERATION ⁽¹⁾ |
|---|---|------------|--|----------|----------|------------------------|--------------------------------------|
| | | | PJDIR.x | PJSEL1.x | PJSEL0.x | PJMAPx | |
| PJ.4/TDI/ADC14CLK ⁽²⁾ , | 4 | PJ.4 (I/O) | I: 0; O: 1 | 0 | 0 | X | X |
| | | TDI | X | 0 | 1 | default ⁽³⁾ | JTAG (4 wire) |
| | | DVcc | | | | | SWD (2 wire) |
| | | ADC12CLK | 1 | 1 | 0 | X | X |
| | | DVcc | X | 1 | 1 | X | X |
| PJ.5/TDO/SWO ⁽⁴⁾ , ⁽⁵⁾ | 5 | PJ.5 (I/O) | I: 0; O: 1 | 0 | 0 | X | X |
| | | TDO | X | 0 | 1 | default ⁽³⁾ | JTAG (4 wire) |
| | | SWO | | | | | SWD (2 wire) |
| | | Hi-Z | X | 1 | X | X | X |

(1) X indicates that the value of the control signal or mode of operation has no effect on the functionality.

(2) This pin is internally pulled up if PJSEL0 is 1.

(3) The 'default' value in the table indicates the functionality that is selected whenever a Hard Reset (or higher class reset) occurs.

(4) This pin is has NO internal pull feature. If used in User IO mode or left unused, it must be pulled to GND through an external pulldown resistor.

(5) After any Hard Reset (or higher class reset), this pin returns to TDO functionality with the SWJ in JTAG (4 wire) mode of operation. If used as a User IO, it reflects the value of the external pullup until the PJSELx bits are reconfigured to the value 00.

6.10.23 Ports SWCLKTCK and SWDIOTMS With Schmitt Trigger

Table 6-54. Ports SWCLKTCK and SWDIOTMS Pin Functions

| PIN NAME | FUNCTION | SWJ MODE OF OPERATION |
|-------------------------|---------------|-----------------------|
| SWCLKTCK ⁽¹⁾ | TCK (input) | JTAG (4 wire) |
| | SWCLK (input) | SWD (2 wire) |
| SWDIOTMS ⁽²⁾ | TMS (input) | JTAG (4 wire) |
| | SWDIO (I/O) | SWD (2 wire) |

(1) This pin is internally pulled to DV_{SS}.

(2) This pin is internally pulled to DV_{CC}.

6.11 Device Descriptors (TLV)

Table 6-56 lists the contents of the device descriptor tag-length-value (TLV) structure for MSP432P401xx devices. Table 6-55 summarizes the Device IDs of the corresponding MSP432P401xx devices.

Table 6-55. Device IDs

| DEVICE | DEVICE ID |
|-----------------|-----------|
| MSP432P401RIPZ | 0000A000h |
| MSP432P401MIPZ | 0000A001h |
| MSP432P401RIZXH | 0000A002h |
| MSP432P401MIZXH | 0000A003h |
| MSP432P401RIRGC | 0000A004h |
| MSP432P401MIRGC | 0000A005h |

Table 6-56. Device Descriptor Table⁽¹⁾

| | DESCRIPTION | ADDRESS | VALUE |
|--------------------------|---|-----------|----------------|
| | TLV checksum | 00201000h | per unit |
| Info Block | Device Info Tag | 00201004h | 0000000Bh |
| | Device Info Length | 00201008h | 00000004h |
| | Device ID | 0020100Ch | See Table 6-55 |
| | HW Revision | 00201010h | 00000042h |
| | Boot-code Revision | 00201014h | 00410042h |
| | ROM Driver Library Revision | 00201018h | 01010022h |
| Die Record | Die Record Tag | 0020101Ch | 0000000Ch |
| | Die Record Length | 00201020h | 00000008h |
| | Die X Position | 00201024h | per unit |
| | Die Y Position | 00201028h | per unit |
| | Wafer ID | 0020102Ch | per unit |
| | Lot ID | 00201030h | per unit |
| | Reserved | 00201034h | per unit |
| | Reserved | 00201038h | per unit |
| | Reserved | 0020103Ch | per unit |
| | Test Results | 00201040h | FFFFFFFFh |
| Clock System Calibration | Clock System Calibration Tag | 00201044h | 00000003h |
| | Clock System Calibration Length | 00201048h | 00000010h |
| | DCO IR mode: Frequency calibration | 0020104Ch | per unit |
| | Reserved | 00201050h | FFFFFFFFh |
| | DCO IR mode: Max Positive Tune for DCORSEL 0 to 4 | 00201054h | 00000600h |
| | DCO IR mode: Max Negative Tune for DCORSEL 0 to 4 | 00201058h | 00001600h |
| | DCO IR mode: Max Positive Tune for DCORSEL 5 | 0020105Ch | 00000150h |
| | DCO IR mode: Max Negative Tune for DCORSEL 5 | 00201060h | 00001600h |
| | DCO IR mode: DCO Constant (K) for DCORSEL 0 to 4 | 00201064h | 3BA20147h |
| | DCO IR mode: DCO Constant (K) for DCORSEL 5 | 00201068h | 3B9DF117h |
| | DCO ER mode: Frequency calibration | 0020106Ch | per unit |
| | Reserved | 00201070h | FFFFFFFFh |
| | DCO ER mode: Max Positive Tune for DCORSEL 0 to 4 | 00201074h | 000005A0h |
| | DCO ER mode: Max Negative Tune for DCORSEL 0 to 4 | 00201078h | 00001600h |
| | DCO ER mode: Max Positive Tune for DCORSEL 5 | 0020107Ch | 00000140h |
| | DCO ER mode: Max Negative Tune for DCORSEL 5 | 00201080h | 00001600h |
| | DCO ER mode: DCO Constant (K) for DCORSEL 0 to 4 | 00201084h | 3BA47ED0h |
| | DCO ER mode: DCO Constant (K) for DCORSEL 5 | 00201088h | 3B9FE868h |

(1) per unit = the contents can differ from device to device

Table 6-56. Device Descriptor Table⁽¹⁾ (continued)

| | DESCRIPTION | ADDRESS | VALUE |
|-------------------|---|---------------------|-----------|
| ADC14 Calibration | ADC14 Calibration Tag | 0020108Ch | 00000005h |
| | ADC14 Calibration Length | 00201090h | 00000018h |
| | Reserved | 00201094h | FFFFFFFFh |
| | Reserved | 00201098h | FFFFFFFFh |
| | Reserved | 0020109Ch | FFFFFFFFh |
| | Reserved | 002010A0h | FFFFFFFFh |
| | Reserved | 002010A4h | FFFFFFFFh |
| | Reserved | 002010A8h | FFFFFFFFh |
| | Reserved | 002010ACh | FFFFFFFFh |
| | Reserved | 002010B0h | FFFFFFFFh |
| | Reserved | 002010B4h | FFFFFFFFh |
| | Reserved | 002010B8h | FFFFFFFFh |
| | Reserved | 002010BCh | FFFFFFFFh |
| | Reserved | 002010C0h | FFFFFFFFh |
| | Reserved | 002010C4h | FFFFFFFFh |
| | Reserved | 002010C8h | FFFFFFFFh |
| | Reserved | 002010CCh | FFFFFFFFh |
| | Reserved | 002010D0h | FFFFFFFFh |
| | Reserved | 002010D4h | FFFFFFFFh |
| | Reserved | 002010D8h | FFFFFFFFh |
| | Reserved | 002010DCh | FFFFFFFFh |
| | Reserved | 002010E0h | FFFFFFFFh |
| | Reserved | 002010E4h | FFFFFFFFh |
| | Reserved | 002010E8h | FFFFFFFFh |
| | Reserved | 002010ECh | FFFFFFFFh |
| | Reserved | 002010F0h | FFFFFFFFh |
| REF Calibration | REF Calibration Tag | 002010F4h | 00000008h |
| | REF Calibration Length | 002010F8h | 00000003h |
| | Reserved | 002010FCh | FFFFFFFFh |
| | Reserved | 00201100h | FFFFFFFFh |
| | Reserved | 00201104h | FFFFFFFFh |
| Random Number | 128-bit Random Number Tag | 00201108h | 0000000Dh |
| | 128-bit Random Number Length | 0020110Ch | 00000004h |
| | 32-bit Random Number 1 | 00201110h | per unit |
| | 32-bit Random Number 2 | 00201114h | per unit |
| | 32-bit Random Number 3 | 00201118h | per unit |
| | 32-bit Random Number 4 | 0020111Ch | per unit |
| BSL Configuration | BSL Configuration Tag | 00201120h | 0000000Fh |
| | BSL Configuration Length | 00201124h | 00000004h |
| | BSL Peripheral Interface Selection | 00201128h | FFC2D0C0h |
| | BSL Port Interface Configuration for UART | 0020112Ch | FCFFFDA0h |
| | BSL Port Interface Configuration for SPI | 00201130h | F0FF9770h |
| | BSL Port Interface Configuration for I2C | 00201134h | FCFFFF72h |
| TLV End | TLV End Word | 00201138h | 0BD0E11Dh |
| | Reserved | 0020113Ch-00201FFFh | FFFFFFFFh |

7 Applications, Implementation, and Layout

7.1 Device Connection and Layout Fundamentals

This section discusses the recommended guidelines when designing with the MSP432™ microcontrollers. These guidelines are to make sure that the device has proper connections for powering, programming, debugging, and optimum analog performance.

7.1.1 Power Supply Decoupling and Bulk Capacitors

TI recommends connecting a combination of a 4.7- μ F plus a 100-nF low-ESR ceramic decoupling capacitor to each AVCC and DVCC pin. Higher-value capacitors may be used but can impact supply rail ramp-up time. Decoupling capacitors must be placed as close as possible to the pins that they decouple (within a few millimeters). Additionally, separated grounds with a single-point connection are recommended for better noise isolation from digital to analog circuits on the board and are especially recommended to achieve high analog accuracy.

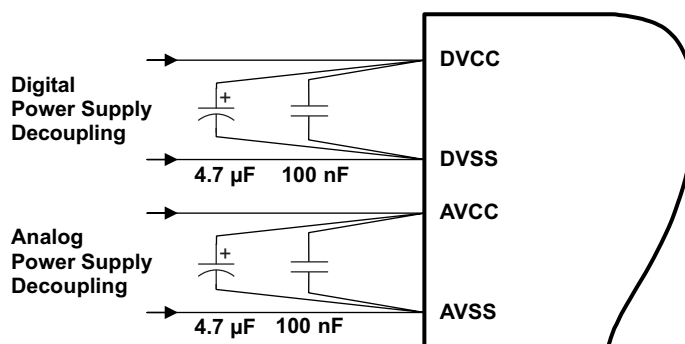


Figure 7-1. Power Supply Decoupling

7.1.2 External Oscillator

The device supports a low-frequency crystal (32.768 kHz) on the LFXT pins and a high-frequency crystal on the HFXT pins. External bypass capacitors for the crystal oscillator pins are required.

It is also possible to apply digital clock signals to the LFXIN and HFXIN input pins that meet the specifications of the respective oscillator if the appropriate LFXTBYPASS or HFXTBYPASS mode is selected. In this case, the associated LFXOUT and HFXOUT pins can be used for other purposes.

Figure 7-2 shows a typical connection diagram.

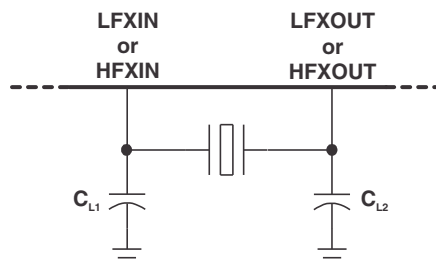


Figure 7-2. Typical Crystal Connection

See the application report *MSP430 32-kHz Crystal Oscillators* ([SLAA322](#)) for more information on selecting, testing, and designing a crystal oscillator with the MSP432 devices.

7.1.3 General Layout Recommendations

- Proper grounding and short traces for external crystal to reduce parasitic capacitance. See the application report *MSP430 32-kHz Crystal Oscillators* ([SLAA322](#)) for recommended layout guidelines.
- Proper bypass capacitors on DVCC, AVCC, and reference pins if used.
- Avoid routing any high-frequency signal close to an analog signal line. For example, keep digital switching signals such as PWM or JTAG signals away from the oscillator circuit.
- Refer to the *Circuit Board Layout Techniques* design guide ([SLOA089](#)) for a detailed discussion of printed-circuit-board (PCB) layout considerations. This document is written primarily about op amps, but the guidelines are generally applicable for all mixed-signal applications.
- Proper ESD level protection should be considered to protect the device from unintended high-voltage electrostatic discharge. See the application report *MSP430 System-Level ESD Considerations* ([SLAA530](#)) for guidelines.

7.1.4 Do's and Don'ts

TI recommends powering AVCC and DVCC pins from the same source. At a minimum, during power up, power down, and device operation, the voltage difference between AVCC and DVCC must not exceed the limits specified in the [Absolute Maximum Ratings](#) section. Exceeding the specified limits may cause malfunction of the device.

7.2 Peripheral and Interface-Specific Design Information

7.2.1 ADC14 Peripheral

7.2.1.1 Partial Schematic

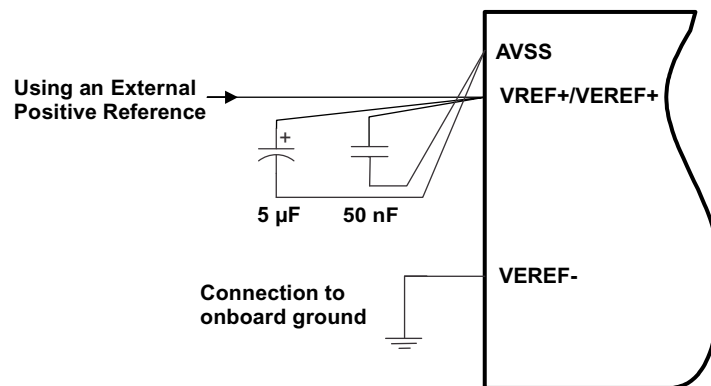


Figure 7-3. ADC14 Grounding and Noise Considerations

7.2.1.2 Design Requirements

As with any high-resolution ADC, appropriate PCB layout and grounding techniques should be followed to eliminate ground loops, unwanted parasitic effects, and noise.

Ground loops are formed when return current from the ADC flows through paths that are common with other analog or digital circuitry. If care is not taken, this current can generate small unwanted offset voltages that can add to or subtract from the reference or input voltages of the ADC. The general guidelines in [Section 7.1.1](#) combined with the connections shown in [Section 7.2.1.1](#) prevent this.

In addition to grounding, ripple and noise spikes on the power-supply lines that are caused by digital switching or switching power supplies can corrupt the conversion result. A noise-free design using separate analog and digital ground planes with a single-point connection is recommended to achieve high accuracy.

[Figure 7-3](#) shows the recommended decoupling circuit when an external voltage reference is used.

The reference voltage must be a stable voltage for accurate measurements. The capacitor values that are selected in the general guidelines filter out the high- and low-frequency ripple before the reference voltage enters the device. In this case, the 5- μ F capacitor is used to buffer the reference pin and filter any low-frequency ripple. A 50-nF bypass capacitor is used to filter out any high-frequency noise.

7.2.1.3 Layout Guidelines

Component that are shown in the partial schematic (see [Figure 7-3](#)) should be placed as close as possible to the respective device pins. Avoid long traces, because they add additional parasitic capacitance, inductance, and resistance on the signal.

Avoid routing analog input signals close to a high-frequency pin (for example, a high-frequency PWM), because the high-frequency switching can be coupled into the analog signal.

If differential mode is used for the ADC14, the analog differential input signals must be routed closely together to minimize the effect of noise on the resulting signal.

8 Device and Documentation Support

8.1 Device Support

8.1.1 Development Tools Support

All MSP432 microcontrollers are supported by a wide variety of software and hardware development tools. Tools are available from TI and various third parties. See them all at www.ti.com/msp432.

8.1.1.1 Hardware Features

| FAMILY | JTAG | SWD | NUMBER OF BREAKPOINTS | ITM | DWT | FPB |
|------------|------|-----|-----------------------|-----|-----|-----|
| MSP432P4xx | Yes | Yes | 4 | Yes | Yes | Yes |

8.1.1.2 Recommended Hardware Options

8.1.1.2.1 Target Socket Boards

The target socket boards allow easy programming and debugging of the device using JTAG or SWD. They also feature header pin outs for prototyping. The following table shows the compatible target boards and the supported packages.

| DEVICE | PACKAGE | TARGET BOARD |
|---------------|---------------------|----------------|
| MSP432P401RPZ | 100-pin QFP (PZ100) | MSP-TS432PZ100 |

8.1.1.2.2 Evaluation Kits

Evaluation kits are available for some MSP432 devices. These kits feature additional hardware components and connectivity for full system evaluation and prototyping. See www.ti.com/msp432 for details.

8.1.1.2.3 Debugging and Programming Tools

Hardware programming and debugging tools are available from TI and from third party suppliers. See a comprehensive list of available tools at www.ti.com/msp432.

8.1.1.2.4 Production Programmers

Production programmers expedite loading firmware to devices by programming several devices simultaneously. See a comprehensive list of available tools at www.ti.com/msp432.

8.1.1.3 Recommended Software Options

8.1.1.3.1 Integrated Development Environments

Software development tools are available from TI or from third party suppliers. Open source solutions are also available. The MSP432 Family is supported by Code Composer Studio™ IDE (CCS) Version 6 or higher. See a comprehensive list of available tools at www.ti.com/msp432.

8.1.1.3.2 MSPWare

MSPWare is a collection of code examples, data sheets, and other design resources for all MSP430 and MSP432 devices delivered in a convenient package. In addition to providing a complete collection of existing MSP430 and MSP432 design resources, MSPWare also includes a high-level API called Driver Library. This library makes it easy to program MSP430 or MSP432 hardware. MSPWare is available as a component of CCS or as a stand-alone package. Visit www.ti.com/msp432 to download the stand-alone package.

8.1.2 Device and Development Tool Nomenclature

To designate the stages in the product development cycle, TI assigns prefixes to the part numbers of all MSP432 MCU devices and support tools. Each MSP432 MCU commercial family member has one of three prefixes: MSP, PMS, or XMS (for example, MSP432P401R). Texas Instruments recommends two of three possible prefix designators for its support tools: MSP and MSPX. These prefixes represent evolutionary stages of product development from engineering prototypes (with XMS for devices and MSPX for tools) through fully qualified production devices and tools (with MSP for devices and MSP for tools).

Device development evolutionary flow:

XMS – Experimental device that is not necessarily representative of the final device's electrical specifications

PMS – Final silicon die that conforms to the device's electrical specifications but has not completed quality and reliability verification

MSP – Fully qualified production device

Support tool development evolutionary flow:

MSPX – Development-support product that has not yet completed Texas Instruments internal qualification testing.

MSP – Fully-qualified development-support product

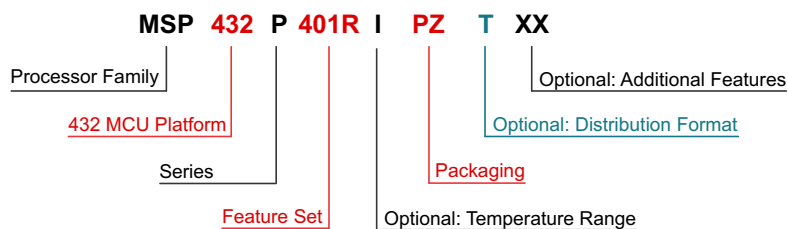
XMS and PMS devices and MSPX development-support tools are shipped against the following disclaimer:

"Developmental product is intended for internal evaluation purposes."

MSP devices and MSP development-support tools have been characterized fully, and the quality and reliability of the device have been demonstrated fully. TI's standard warranty applies.

Predictions show that prototype devices (XMS and PMS) have a greater failure rate than the standard production devices. Texas Instruments recommends that these devices not be used in any production system because their expected end-use failure rate still is undefined. Only qualified production devices are to be used.

TI device nomenclature also includes a suffix with the device family name. This suffix indicates the package type (for example, PZP) and temperature range (for example, T). [Figure 8-1](#) provides a legend for reading the complete device name for any family member.



| | | | | |
|--------------------------------------|--|--|---------------------------------|---|
| Processor Family | MSP = Mixed Signal Processor XMS = Experimental Silicon | | | |
| 432 MCU Platform | TI's 32-bit Low-Power Microcontroller Platform | | | |
| Series | P = Performance and Low-Power Series | | | |
| Feature Set | First Digit 4 = Flash based devices up to 48 MHz | Second Digit 0 = General Purpose | Third Digit 1 = ADC14 | Fourth Digit R = 256KB of Flash 64KB of SRAM M = 128KB of Flash 32KB of SRAM |
| Optional: Temperature Range | S = 0°C to 50°C I = -40°C to 85°C T = -40°C to 105°C | | | |
| Packaging | http://www.ti.com/packaging | | | |
| Optional: Distribution Format | T = Small Reel R = Large Reel No Markings = Tube or Tray | | | |
| Optional: Additional Features | -EP = Enhanced Product (-40°C to 105°C) -HT = Extreme Temperature Parts (-55°C to 150°C) -Q1 = Automotive Q100 Qualified | | | |

Figure 8-1. Device Nomenclature

8.2 Documentation Support

The following documents describe the MSP432P401x MCUs. Copies of these documents are available on the Internet at www.ti.com.

[SLAU356](#) **MSP432P4xx Family Technical Reference Manual.** Detailed information on all of the modules and peripherals available in this device family.

[SLAZ610](#) **MSP432P401R Device Erratasheet.** Describes the known exceptions to the functional specifications.

8.2.1 Related Links

[Table 8-1](#) lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 8-1. Related Links

| PARTS | PRODUCT FOLDER | SAMPLE & BUY | TECHNICAL DOCUMENTS | TOOLS & SOFTWARE | SUPPORT & COMMUNITY |
|-------------|----------------------------|----------------------------|----------------------------|----------------------------|----------------------------|
| MSP432P401R | Click here | Click here | Click here | Click here | Click here |
| MSP432P401M | Click here | Click here | Click here | Click here | Click here |

8.2.2 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

[TI E2E™ Community](#)

TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At [e2e.ti.com](#), you can ask questions, share knowledge, explore ideas, and help solve problems with fellow engineers.

[TI Embedded Processors Wiki](#)

Texas Instruments Embedded Processors Wiki. Established to help developers get started with embedded processors from Texas Instruments and to foster innovation and growth of general knowledge about the hardware and software surrounding these devices.

8.3 Trademarks

MSP430, MSP432, E2E are trademarks of Texas Instruments.

ARM, Cortex are registered trademarks of ARM Ltd.

ULPBench is a registered trademark of Embedded Microprocessor Benchmark Consortium.

All other trademarks are the property of their respective owners.

8.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

8.5 Export Control Notice

Recipient agrees to not knowingly export or re-export, directly or indirectly, any product or technical data (as defined by the U.S., EU, and other Export Administration Regulations) including software, or any controlled product restricted by other applicable national regulations, received from disclosing party under nondisclosure obligations (if any), or any direct product of such technology, to any destination to which such export or re-export is restricted or prohibited by U.S. or other applicable laws, without obtaining prior authorization from U.S. Department of Commerce and other competent Government authorities to the extent required by those laws.

8.6 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

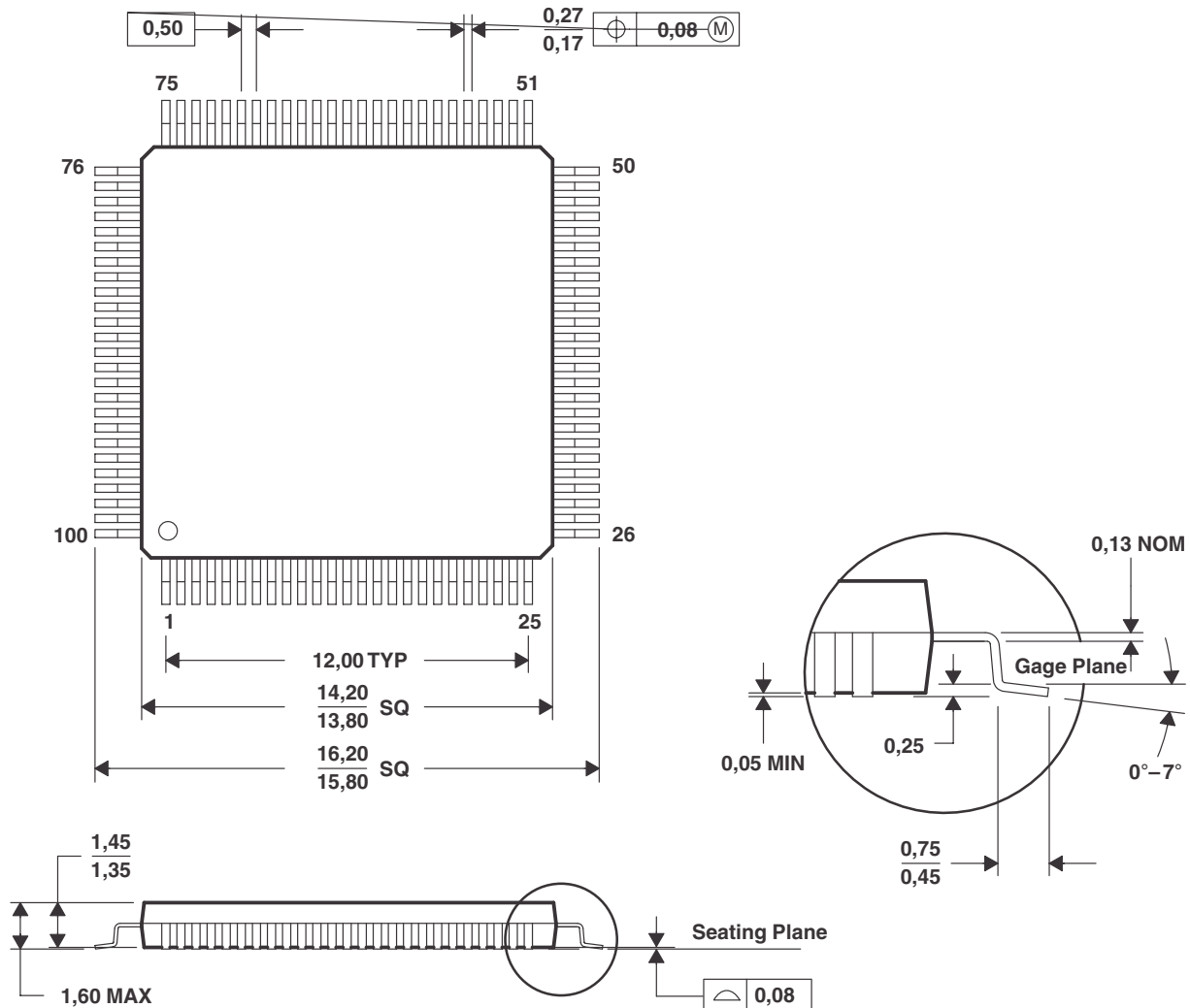
9 Mechanical, Packaging, and Orderable Information

9.1 Packaging Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PZ (S-PQFP-G100)

PLASTIC QUAD FLATPACK

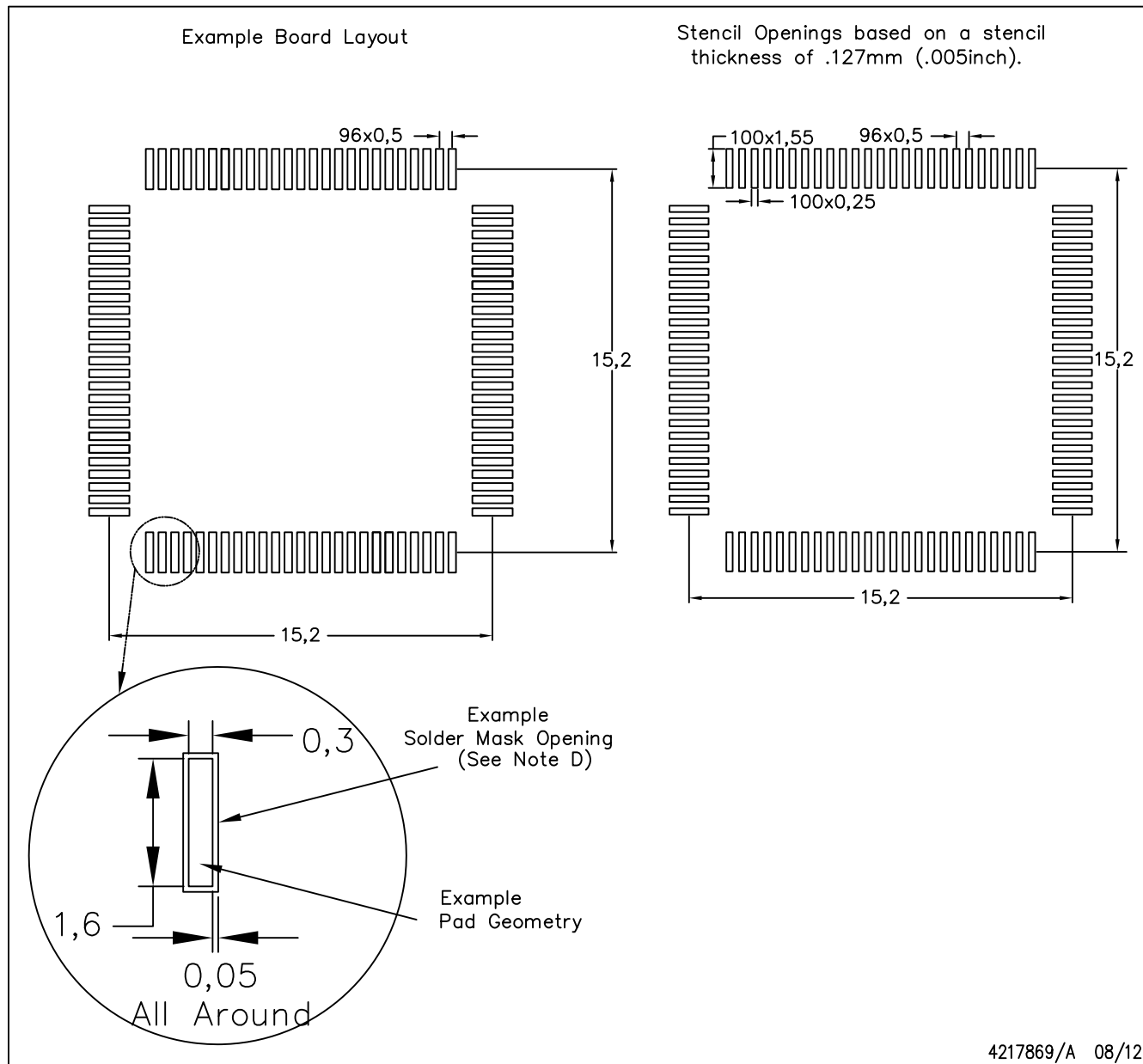


4040149/B 11/96

- NOTES:
- All linear dimensions are in millimeters.
 - This drawing is subject to change without notice.
 - Falls within JEDEC MS-026

PZ (S-PQFP-G100)

PLASTIC QUAD FLAT PACK



NOTES:

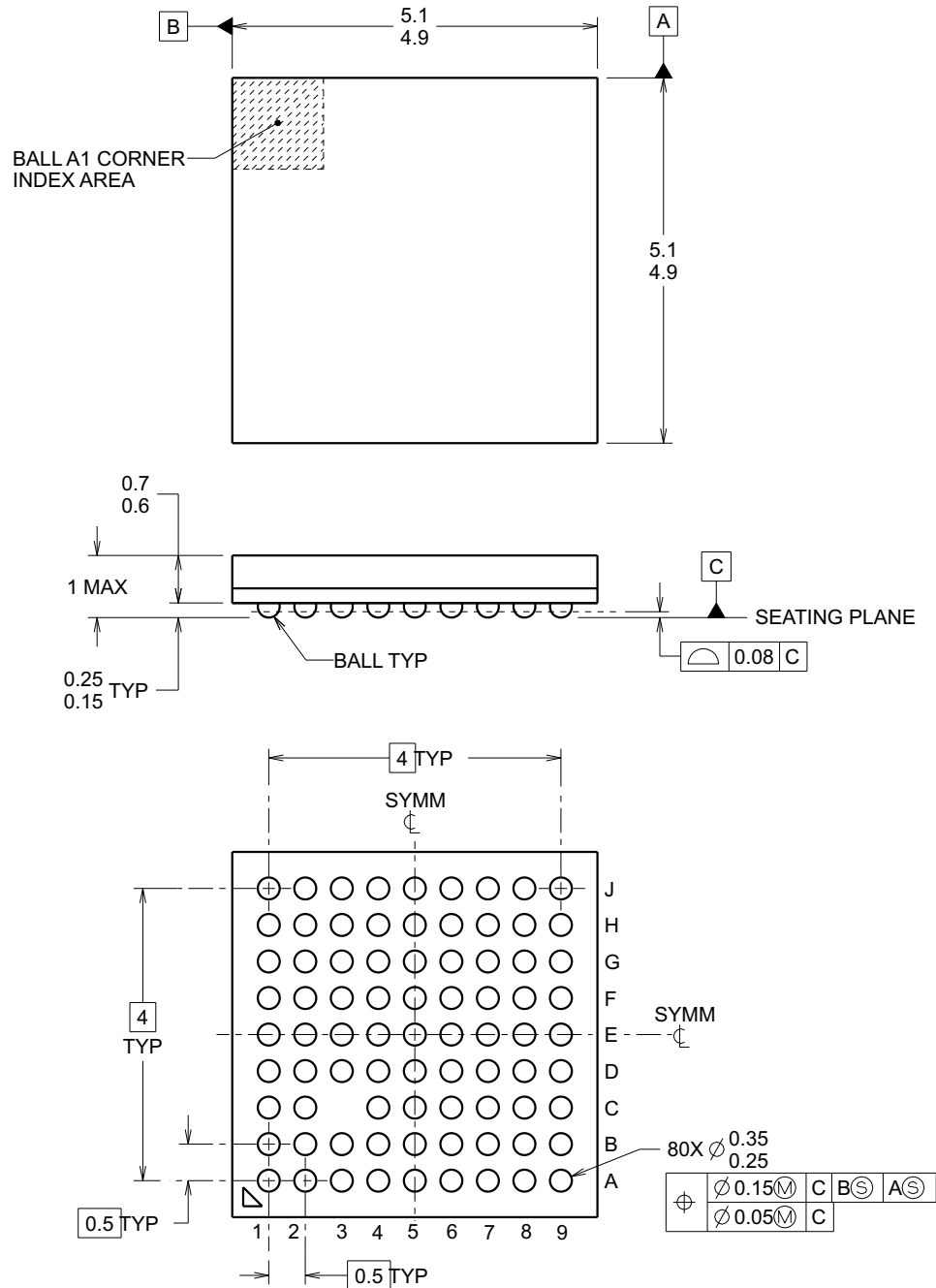
- All linear dimensions are in millimeters.
- This drawing is subject to change without notice.
- Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.
- Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

PRODUCT PREVIEW

PACKAGE OUTLINE

BALL GRID ARRAY

ZXH 80 (NFBGA - 1 mm max height)



4221325/A 01/2014

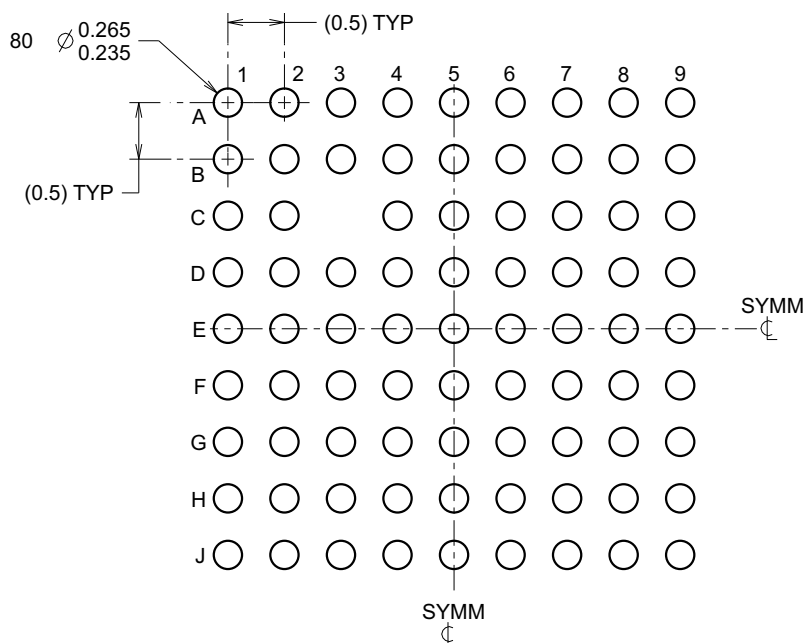
NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis is for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This is a Pb-free solder ball design.

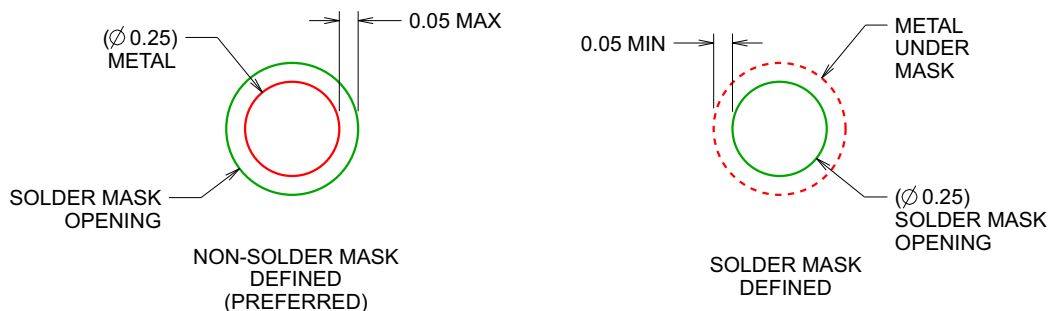
EXAMPLE BOARD LAYOUT

BALL GRID ARRAY

ZXH 80 (NFBGA - 1 mm max height)



LAND PATTERN EXAMPLE
SCALE:15X



SOLDER MASK DETAILS
NOT TO SCALE

4221325/A 01/2014

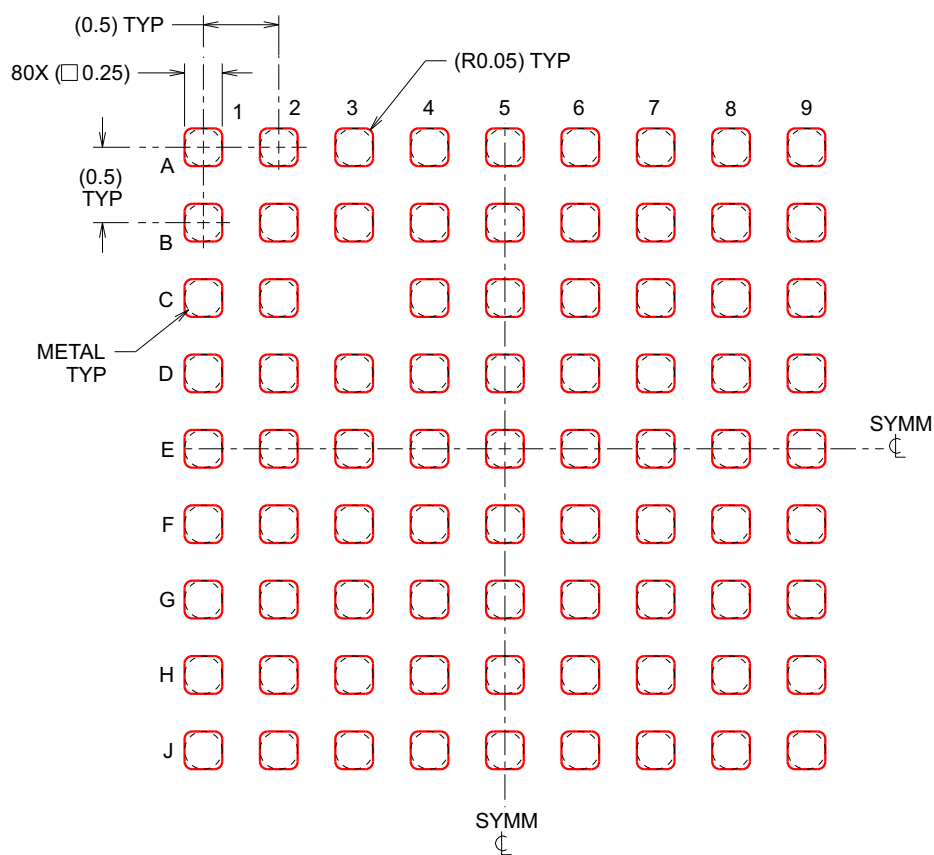
NOTES: (continued)

- Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. See Texas Instruments Literature No. SBVA017 (www.ti.com/lit/sbva017).

EXAMPLE STENCIL DESIGN

ZXH 80 (NFBGA - 1 mm max height)

BALL GRID ARRAY



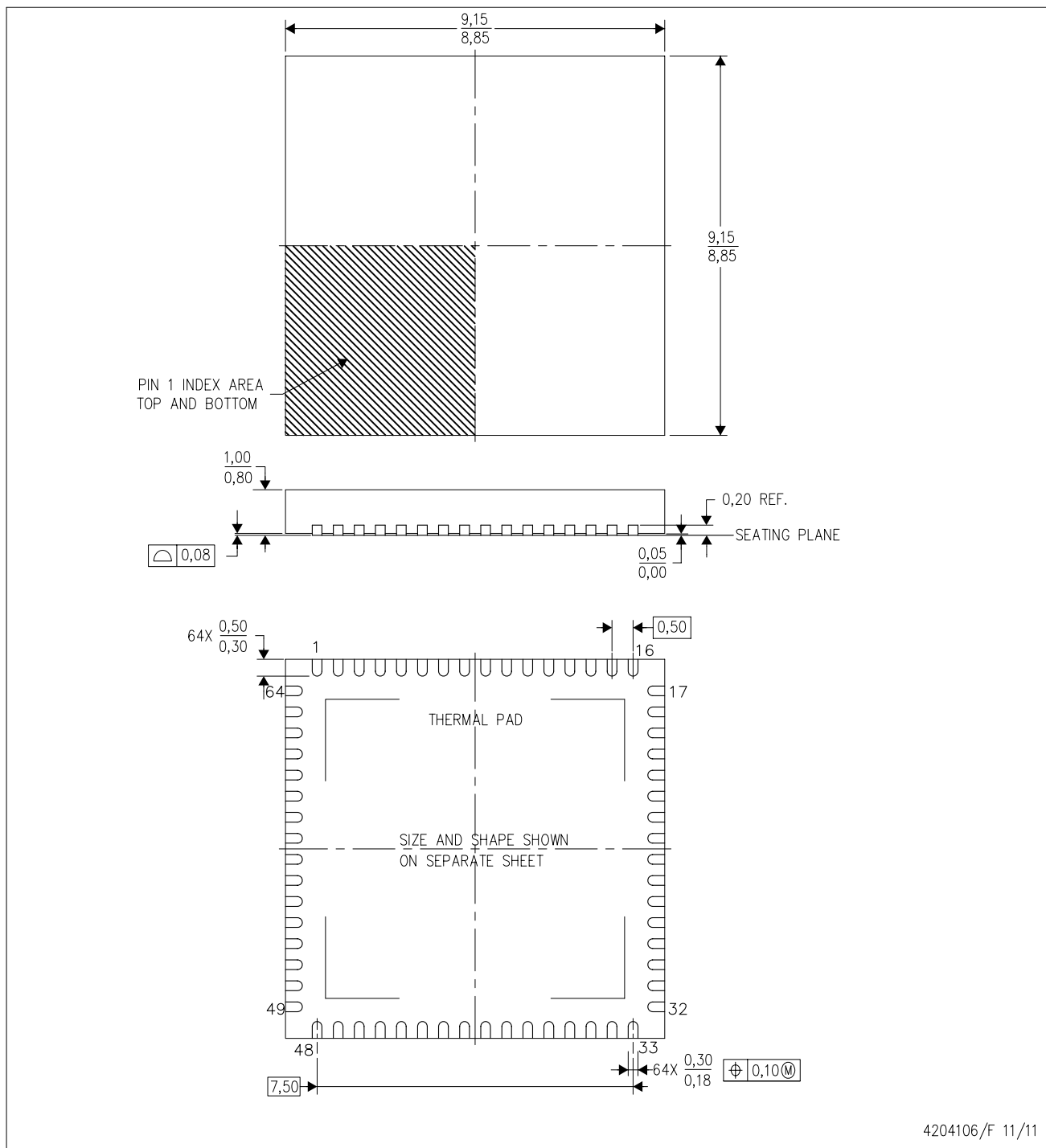
SOLDER PASTE EXAMPLE
 BASED ON 0.1 mm THICK STENCIL
 SCALE:20X

4221325/A 01/2014

NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.

RGC(S–PVQFN–N64) CUSTOM DEVICE PLASTIC QUAD FLATPACK NO-LEAD



PRODUCT PREVIEW

- NOTES:
- A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5–1994.
 - B. This drawing is subject to change without notice.
 - C. Quad Flatpack, No-leads (QFN) package configuration.
 - D. The package thermal pad must be soldered to the board for thermal and mechanical performance.
 - E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.

THERMAL PAD MECHANICAL DATA

RGC (S-PVQFN-N64)

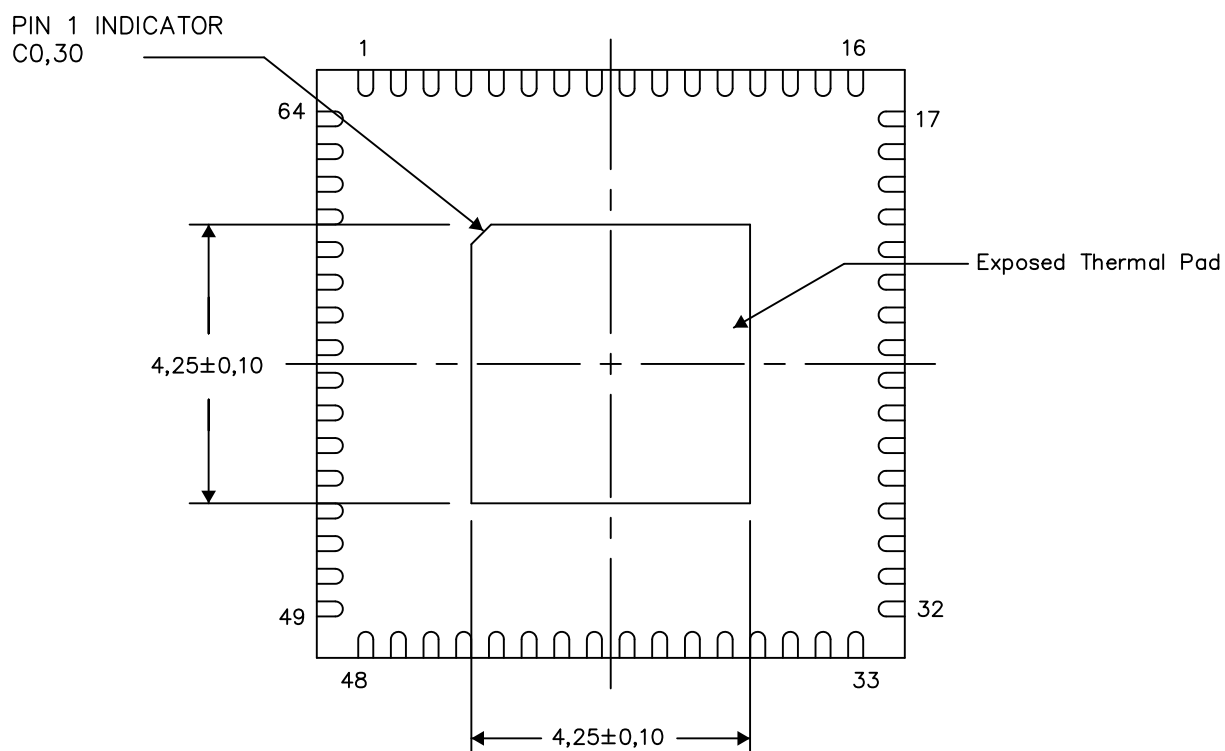
PLASTIC QUAD FLATPACK NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



NOTE: A. All linear dimensions are in millimeters

PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead/Ball Finish (6) | MSL Peak Temp (3) | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|---------------|--------------|-----------------|------|-------------|-----------------|-------------------------|----------------------|--------------|-------------------------|---------|
| XMS432P401MIPZR | PREVIEW | LQFP | PZ | 100 | 1000 | TBD | Call TI | Call TI | -40 to 85 | | |
| XMS432P401RIPZR | PREVIEW | LQFP | PZ | 100 | 1000 | TBD | Call TI | Call TI | -40 to 85 | | |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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